# 5045A DIGITAL IC TESTER

OPERATING AND SERVICE MANUAL

SERIAL PREFIX: 1932A

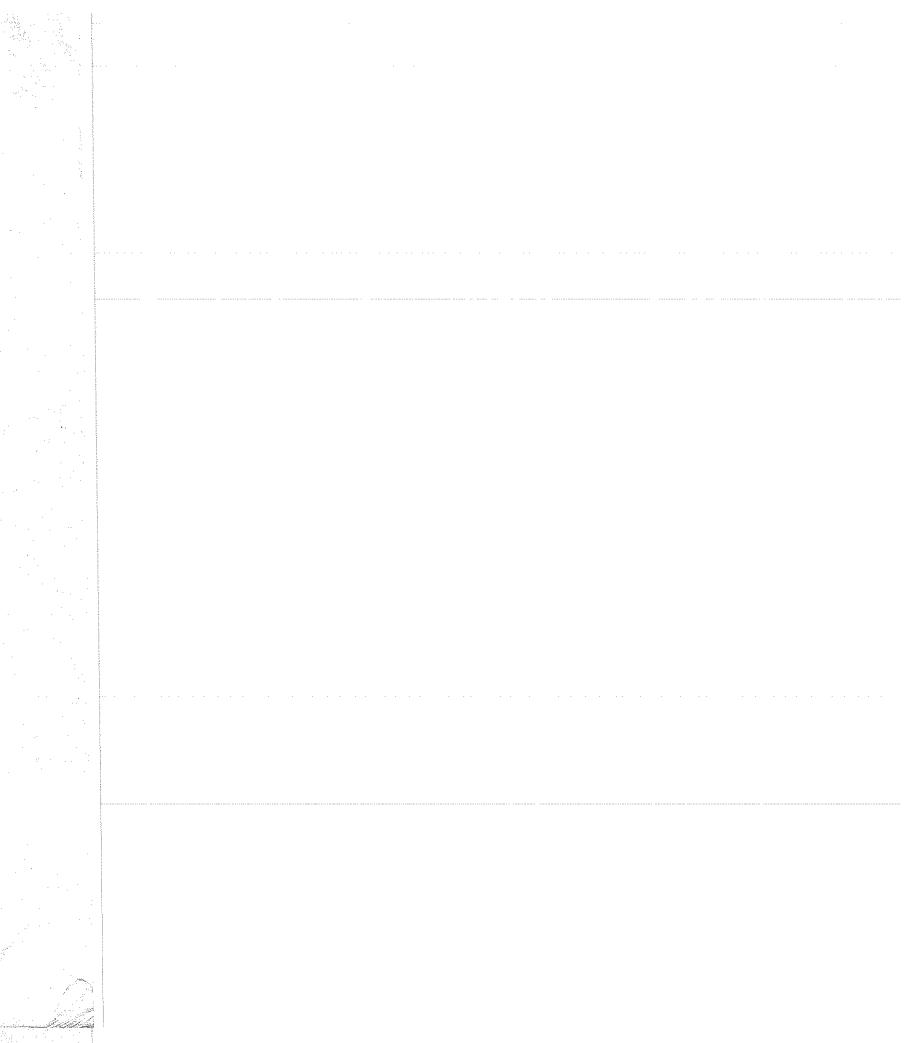
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# CERTIFICATION

Hewlett-Packard Company certifies that this instrument met its published specifications at the time of shipment from the factory. Hewlett-Packard Company further certifies that its calibration measurements are traceable to the United States National Bureau of Standards, to the extent allowed by the Bureau's calibration facility, and to the calibration facilities of other International Standards Organization members.

# WARRANTY AND ASSISTANCE

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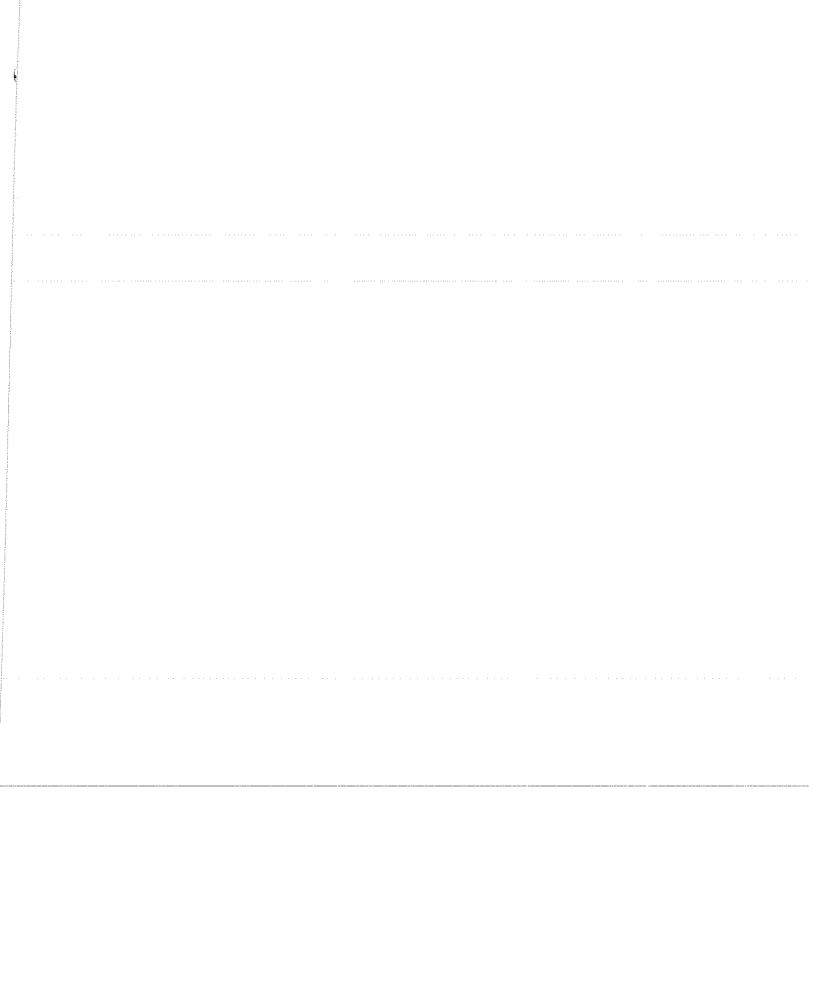
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Service contracts or customer assistance agreements are available for Hewlett-Packard products.

For any assistance, contact your nearest Hewlett-Packard Sales and Service Office. Addresses are provided at the back of this manual.

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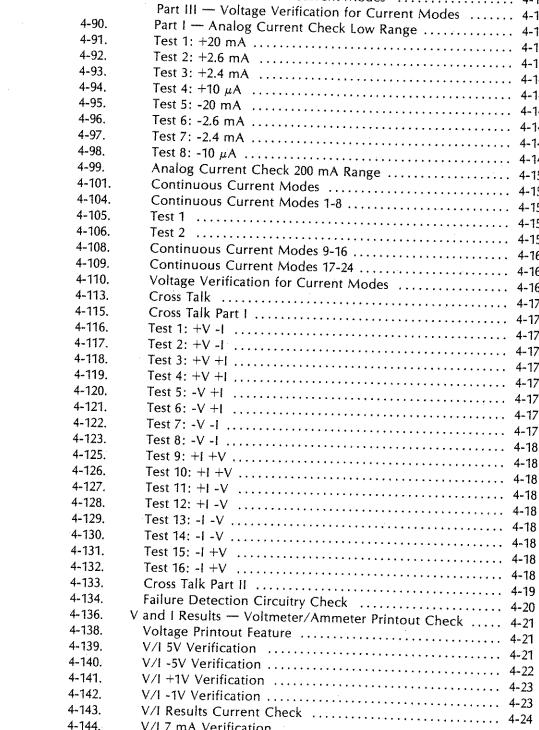
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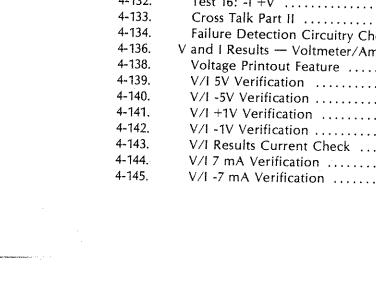
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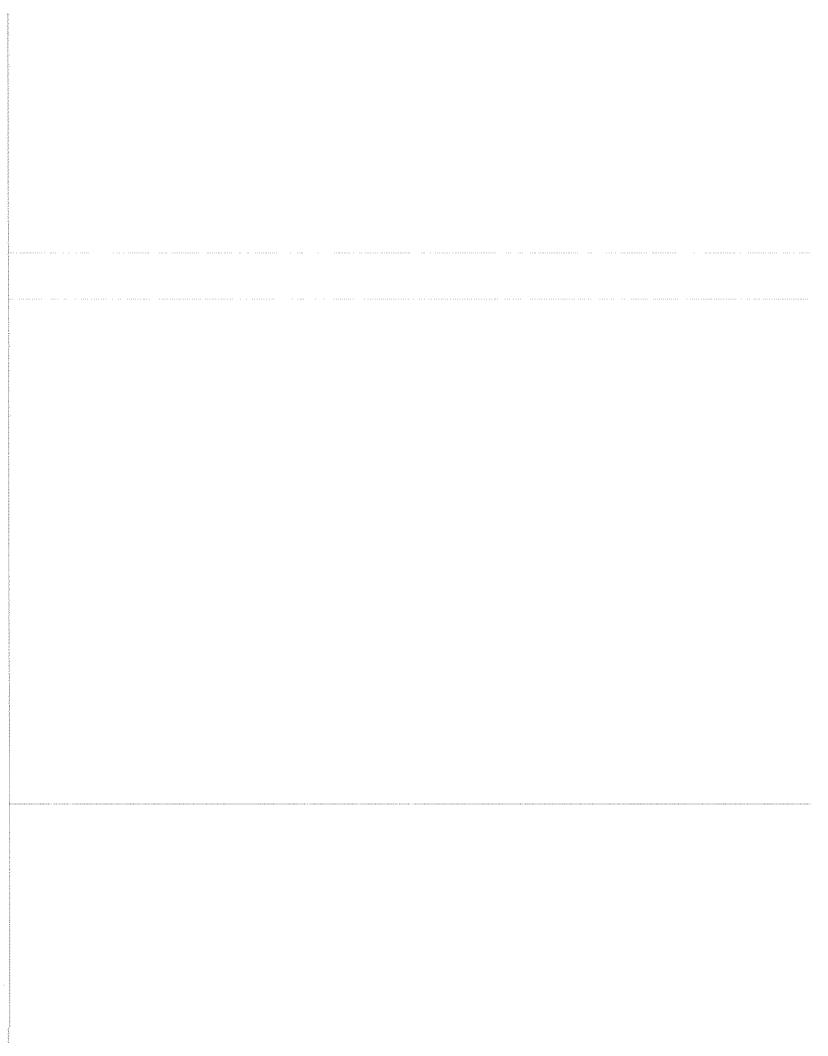
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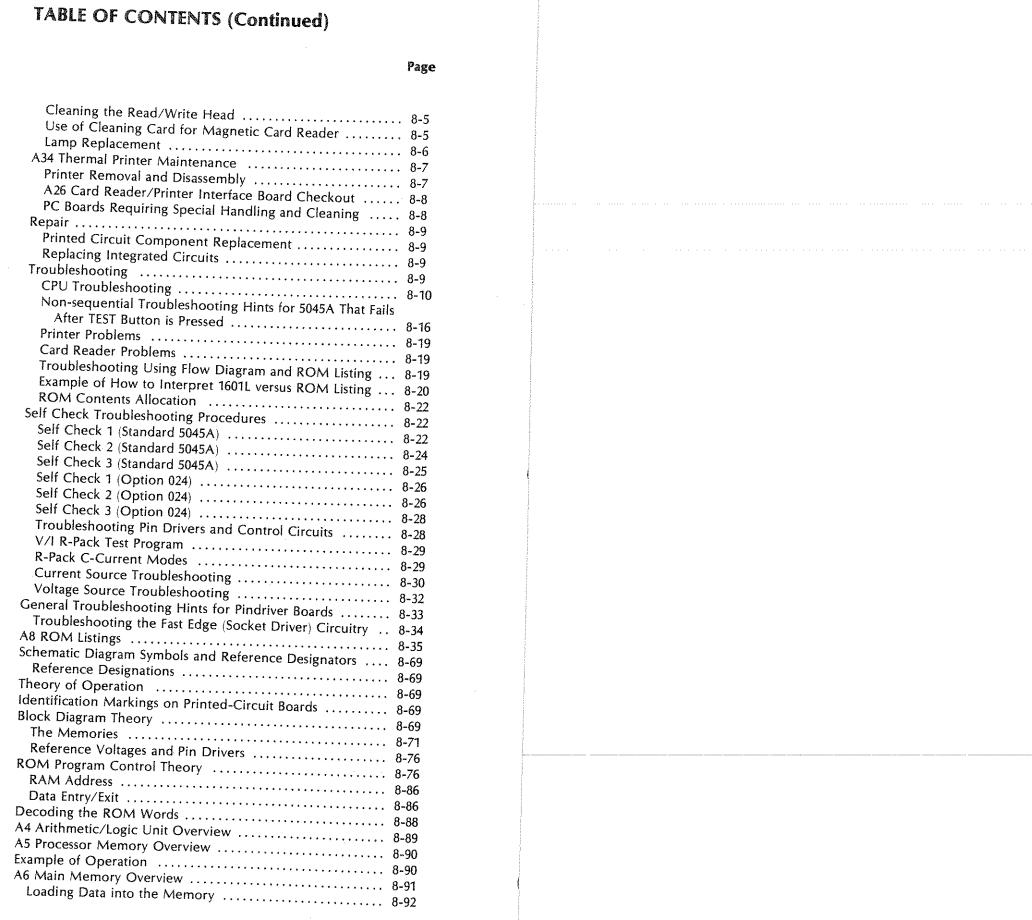
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# **SAFETY CONSIDERATIONS**

#### **GENERAL**

This is a Safety Class I instrument. This instrument has been designed and tested according to IEC Publication 348, "Safety Requirements for Electronic Measuring Apparatus".

## **OPERATION**

BEFORE APPLYING POWER verify that the power transformer primary is matched to the available line voltage and the correct fuse is installed (see Section II, Paragraph 2-6). Make sure that only fuses with the required rated current and of the specified type (normal blow, time delay, etc.) are used for replacement. The use of repaired fuses and the short-circuiting of fuseholders must be avoided. SERVICE Although this instrument has been designed in accordance with international safety standards, this manual contains information, cautions, and warnings which must be followed to ensure safe operation and to retain the instrument in safe condition. Service and adjustments should be performed only by qualified service personnel. Any adjustment, maintenance, and repair of the opened instrument under voltage should be avoided as much as possible and, when inevitable, should be carried out only by a skilled person who is aware of the hazard involved. Capacitors inside the instrument may still be charged even if the instrument has been disconnected from its source of supply. Whenever it is likely that the protection has been impaired, the instrument must be made inoperative and be secured against any unintended operation. CAUTION Do not turn on the instrument if the pin drivers (A13 thru A24) are installed and A10, 11, 12 (any one) are removed. Damage to the pin drivers may result.

# **WARNING**

IF THIS INSTRUMENT IS TO BE ENERGIZED VIA AN AUTO-TRANSFORMER (FOR VOLTAGE REDUCTION) MAKE SURE THE COMMON TERMINAL IS CONNECTED TO THE EARTHED POLE OF THE POWER SOURCE.

# WARNING

BEFORE SWITCHING ON THE INSTRUMENT, THE PROTECTIVE EARTH TERMINALS OF THE INSTRUMENT MUST BE CONNECTED TO THE PROTECTIVE CONDUCTOR OF THE (MAINS) POWER CORD. THE MAINS PLUG SHALL ONLY BE INSERTED IN A SOCKET OUTLET PROVIDED WITH A PROTECTIVE EARTH CONTACT. THE PROTECTIVE ACTION MUST NOT BE NEGATED BY THE USE OF AN EXTENSION CORD (POWER CABLE) WITHOUT A PROTECTIVE CONDUCTOR (GROUNDING).

# WARNING

THE SERVICE INFORMATION FOUND IN THIS MANUAL IS OFTEN USED WITH POWER SUPPLIED AND PROTECTIVE COVERS REMOVED FROM THE INSTRUMENT. ENERGY AVAILABLE AT MANY POINTS MAY, IF CONTACTED, RESULT IN PERSONAL INJURY.

# CAUTION

#### **BEFORE SWITCHING ON THIS INSTRUMENT:**

- 1. MAKE SURE THE INSTRUMENT IS SET TO THE VOLTAGE OF THE POWER SOURCE.
- 2. ENSURE THAT ALL DEVICES CONNECTED TO THIS INSTRUMENT ARE CONNECTED TO THE PROTECTIVE (EARTH) GROUND.
- 3. ENSURE THAT THE LINE POWER (MAINS) PLUG IS CONNECTED TO A THREE-CONDUCTOR LINE POWER OUTLET THAT HAS A PROTECTIVE (EARTH) GROUND. (GROUNDING ONE CONDUCTOR OF A TWO-CONDUCTOR OUTLET IS NOT SUFFICIENT.)
- 4. MAKE SURE THAT ONLY FUSES WITH THE REQUIRED RATED CURRENT AND OF THE SPECIFIED TYPE (NORMAL BLOW, TIME DELAY, ETC.) ARE USED FOR REPLACEMENT. THE USE OF REPAIRED FUSES AND THE SHORT-CIRCUITING OF FUSE HOLDERS MUST BE AVOIDED.

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# SECTION I GENERAL INFORMATION

# 1-1. INTRODUCTION

- 1-2. This manual provides operating and service information for the Hewlett-Packard Model 5045A Digital IC Tester. A separate User's Manual also accompanies the instrument to provide a more detailed description of the unit's operating characteristics.
- 1-3. This manual is divided into eight sections containing the following information:

SECTION I GENERAL INFORMATION covers a description of the tester, options, equipment supplied, accessories available, specifications, and recommended test equipment.

SECTION II INSTALLATION provides instructions for unpacking, inspection, preparation for use, shipment, and storage for the tester. Also covered is the power requirements for the tester.

SECTION III OPERATION covers the basic tester operating features. Describes functions of front-panel controls, programming the tester, printout data, and operator maintenance.

SECTION IV PERFORMANCE TESTS includes a list of recommended test equipment, an in-cabinet performance test and an operational verification test using magnetic cards.

SECTION V ADJUSTMENTS covers the adjustment procedure.

SECTION VI REPLACEABLE PARTS provide a complete list of the tester's replaceable parts and information for ordering parts.

SECTION VII MANUAL CHANGES provide information necessary to backdate the manual to cover earlier instruments.

SECTION VIII SERVICE contains block level theory of operation, schematic diagrams, and component locators.

#### 1-4. DESCRIPTION

1–5. The 5045A DIGITAL IC TESTER performs complete truth table testing on digital IC's contained in standard package form. The unit is compatible with TTL, ECL, CMOS, DTL, RTL, HTL, and associated logic families and is programmed by magnetic cards which contain all test conditions, including test pattern and logic simulation information. Other features include a built-in digital recorder for retrieving failure data, the ability of the tester to "learn" a ROM's output for later transfer to a magnetic card, and the ability to interface with a high-speed handler.

## 1-6. APPLICATIONS

1–7. Probably the most common type of application for the IC Tester is in-coming inspection of purchased IC's. These parts can be tested manually by hand loading or with the use of a high-speed, automatic handler when large quantities of IC's are involved.

## 1-8. INSTRUMENT IDENTIFICATION

1–9. Hewlett-Packard instruments have a 2-section, 10-character serial number (0000A00000), which is located on the rear panel. The 4-digit serial prefix identifies instrument changes. If the serial prefix of your instrument differs from that listed on the title page of this manual, there are differences between this manual and your instrument. Instruments having higher serial prefixes are covered with a "Manual Changes" sheet included with this manual. If the change sheet is missing, contact the nearest Hewlett-Packard Sales and Service Office listed at the back of this manual. Instruments having a lower serial prefix than that listed on the title page, are covered in the Manual Changes Section VII.

## 1-10. EQUIPMENT SUPPLIED

1-11. Table 1-1 lists equipment supplied.

Table 1-1. Equipment Supplied

Description	HP Part Number
Detachable Power Cord 7½ feet (231 cm) long	8120-1378
Head Cleaner Card for Magnetic Card Reader	8660-0463
Resistor Pack (R-Pack) Board	05045-60042
Diagnostic Card Kit	See paragraph 1-14
Dummy IC, 16-pin	05045-80019
Dummy IC, 24-pin (Option 024)	05045-80020
5045A User Manual	05045-90020
Monostable Multivibrator Adapter (20-pin)	05045-60041

# 1-12. Diagnostic Card Kit, 05045-60120

- 1-13. The diagnostic kit consists of the following three sets of magnetic cards:
  - a. A11 Adjustment Check Program Cards
    - 1. DAC REF Check
    - 2. +/-V Zero Adjust
    - 3. DAC V Gain Adjust
    - 4. Current Gen Preset Adjust
    - 5. +/-I Zero 1-2 Adjust
  - b. Operational Verification Test Program Cards

## R-Pack Test Cards:

- 1. V/I R-Pack 16-Pin
- 2. V/I R-Pack 24-Pin
- 3. R-Pack C-Current Modes 16-Pin
- 4. R-Rack C Current Modes 24-Pin
- 5. R-Pack Fail Detect Check 16-Pin
- 6. R-Pack Fail Detect Check 24-Pin

## Self-Check Cards:

- 7. Self Check 1 16-Pin
- 8. Self Check 1 24-Pin
- 9. Self Check 2 16-Pin
- 10. Self Check 2 24-Pin
- 11. Self Check 3 16-Pin
- 12. Self Check 3 24-Pin

- c. Performance Test Program Cards
  - 1. DAC Adjust Check
  - 2. Analog Voltage Check Part 1
  - 3. Analog Voltage Check Part 2
  - 4. Analog Current Check Low Range
  - 5. Analog Current Check 200 mA Range
  - 6. Pin Driver C-Current Modes 1-8
  - 7. Pin Driver C-Current Modes 9-16
  - 8. Pin Driver C-Current Modes 17-24
  - 9. Cross Talk Part 1
  - 10. Cross Talk Part 2
  - 11. V/I Results Voltage Check 16-Pin
  - 12. V/I Results Voltage Check 24-Pin
  - 13. V/I Results Current Check 16-Pin
  - 14. V/I Results Current Check 24-Pin
  - 15. V/I Offset Check 16-Pin
  - 16. V/I Offset Check 24-Pin
  - 17. Relay Check 16-Pin
  - 18. Relay Check 24-Pin
  - 19. Op Code Check
  - 20. Pos Fast Edge Check
  - 21. Neg Fast Edge Check
  - 22. Printer Check

# 1-14. ACCESSORIES AVAILABLE

# 1-15. Operating Accessories

- 1-16. The 5045A is programmed by prerecorded magnetic cards that are available as accessories. Each card that covers a common type IC is listed in the IC Program Catalog, Part No. 5952-7383. Cards not listed in the program catalog may be programmed at the factory. Contact the factory through your local HP Sales and Service Office (listed at the back of this manual) regarding price and delivery.
- 1-17. Any card listed in the IC Program Catalog may be ordered directly from the factory by prepaid coupon. When the coupon is received, the order is filled and returned by airmail. The coupons are ordered in books of ten by Model No. 10846A.
- 1-18. Other accessories available are:

1.	Blank magnetic cards (F	Pass/Fail)		P/N 9164-0071
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- 3. 250 foot roll of thermal paper (minimum order of six rolls) .... P/N 9281-0401
- 4. Coupon book containing ten coupons each redeemable in one preprogrammed magnetic card which is listed in the IC PROGRAM CATALOG. The coupons are mailed directly to the factory and the appropriate program card is returned by mail. The coupons expire two years from the date of receipt...Order No. 10846A

#### 1-19. SERVICE ACCESSORY

1-20. A special Extender Board, part no. 05045-60100 is available for troubleshooting the 5045A. This board plugs into a 44-pin connector in place of a PC board to allow the PC board to be extended for access.

## 1-21. COMPLEMENTARY EQUIPMENT

1-22. The 5045A is designed to allow high volume testing using automatic IC handlers. The optional interface equipment used to interface the tester to popular makes of automatic handlers is described in paragraph 1-25. The special circuits used to generate the fast rise and fall times necessary in testing digital circuits are contained in the tester's removable test head. This allows the test head to be placed within inches of the IC under test and eliminates ringing, oscillation, and slow rise/fall times problems created by long cables between tester and handler.

## 1-23. SPECIFICATIONS

1-24. Specifications for the 5045A are listed in Table 1-2.

#### 1-25. OPTIONS

- 1-26. Several options are available for the 5045A as listed below.
  - a. **Option 004** International Production Technology (IPT) Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head and cable to extend the test head. A cable to interface the control signals between the 5045A and the IPT automatic handler is also included. For more information and documentation obtain installation Note K04-59994A.
  - b. Option 005 Symtek Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head and a cable to extend the test head. A cable to interface the control and indication signals between the 5045A and the Symtek automatic handler is also included. For more information and documentation obtain Installation Note K05-59994A.
  - c. Option 006 Daymarc Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head and a cable to extend the test head. A cable to interface the control and indication signals between the 5045A and the Daymarc automatic handler is also included. For more information and documentation obtain Installation Note K06-59994A.
- d. **Option 007** Micro Component Technology Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head. A cable to interface the control and indication signals between the 5045A and the Micro Component Technology automatic handlers is also included. For more information and documentation obtain Installation Note K07-59994A.
- e. Option 008 Delta Design, Inc. Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head. A cable to interface the control and indication signals between the 5045A and the Delta Design automatic handler is also included. For more information and documentation obtain Installation Note K08-59994A.
- f. Option 009 Contrel Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head and a cable to extend the test head. A connector to allow the control and indication signals from the 5045A to be interfaced with the Control automatic handler is also included. For more information and documentation obtain Installation Note K03-59994A.

## Model 5045A General Information

Accuracy

+35 mV

±0.4 mA or ±6%\*\*

## Table 1-2. Specifications

#### TEST SET-UP METHOD:

Preprogrammed magnetic card. All test conditions including parametric information, input stimuli, and corresponding outputs are contained on the card. The program is verified each time it is loaded.

#### LOGIC FAMILY COMPATIBILITY:

Compatible with ECL, CMOS, TTL, DTL, HTL, RTL and the associated sub-families. See the IC Program Catalog for available programs.

#### LOGIC FUNCTION COMPATIBILITY:

Gates, flip-flops, monostable multivibrators, counters, shift registers, priority encoders, Schmitt triggers, parity generators/checkers, decoders/encoders, optical isolators, dual-in-line reed relays, adders, arithmetic logic units, ROM's, PROM's, static RAM's, and many more\*.

#### **DUAL TEST FOR EACH IC:**

Two test programs (Pass/Fail and Diagnostic) are supplied in the test package for each circuit. Each test is on a separate card. The Pass/Fail and Diagnostic programs are tailored to the testing requirements of the individual Logic Family.

#### TEST STRUCTURE:

Functional Tests—Truth table is verified by direct comparison between the output of a software generated IC simulator (or stored truth table for certain circuits) and the output of the device under test.

Parametric Tests—All DC parameters (voltages and currents) are tested to the manufacturers' data sheet specifications except where limited by the specifications of the Tester. Test limits are indicated in the information accompanying each magnetic card.

Continuity Test—Verifies pin contact by checking for the presence of current flow into or out of all active pins (failure of this test is shown on the "CONT" indicator).

#### **TEST PATTERN GENERATION:**

Test Patterns are derived through algorithmic techniques or from stored truth tables and are individually tailored to each IC.

#### PASS/FAIL COUNTER:

Prints the number of passed and failed devices. Count is initiated when the magnetic card is inserted.

#### **UNIVERSAL PIN DRIVERS:**

Note: The same circuit is used for driving and monitoring a pin whether that pin is an input, output, power supply, or clock. All voltages and currents can be set individually and uniquely on each pin. External test fixtures are not required.

#### Voltage applied to the device under test:

Range	Accuracy
(15 volts)	
$-7.5V \le to < -1.875V$	±25 mV
$-1.875V \le \text{to} \le +1.875V$	±15 mV
$+1.875V < to \le +7.5V$	±25 mV

(Supply Voltage, Input Voltage, and Output Voltage)

#### Current applied to the device under test:

(Supply Current, Input Current, and Output Current)

Range
Accuracy

	recurre,
-200 mA ≤ to < -2.5 mA	±0.4 mA or ±6%**
$-2.5 \text{ mA} \le \text{to} \le +2.5 \text{ mA}$	$\pm 10  \mu A  \text{or}  \pm 6\% **$
$+2.5 \text{ mA} < \text{to} \le +200 \text{ mA}$	±0.4 mA or ±6%**
Slew Rate: 30 ns/volt	

#### DIGITAL VOLTMETER/MILLIAMMETER FOR FAILED PINS:

Note: When a failure is encountered (with PRINTER: ON, V and 1 RESULTS: ON), the printing digital Voltmeter/Milliammeter records the voltage and current present

on the failed pin(s). In addition, the 5045A reduces the driving parameter which caused the failure (voltage for input pins, current for output pins) until the device no longer fails. The second voltage/current pair is also recorded.

#### Voltage

-/.JY (C) (.O/JY	_55 ///*	
-1.875V ≤ to ≤ + 1.875V	±15 mV	
$\pm 1.875V < to \le \pm 7.5V$	±35 mV	
	Current	
Range	Accuracy	
$-200 \text{ mA} \le \text{to} < -2.5 \text{ mA}$	±0.4 mA or ±6%**	
-2.5 mA < to ≤ +2.5 mA	±10 μA or ±6%**	

# +2.5 mA < to ≤ +200 mA REAR PANEL OUTPUTS:

Range 7 5V 5 to 5 -1 875V

Automatic Handler Interface: 14 pin Amphenol connector provides "End of Test", "Pass", "Fail" and "Fail Continuity" signals and accepts "Start Test". Also available is a +5V line capable of supplying up to 200 mA.

#### GENERAL:

**Power:** 100/120/220/240V (+5%, -10%), 48-66 Hz, 345 VA. **Dimensions:** 19 cm high, 42.5 cm wide, 58 cm deep (7.5 in. x 16.7 in. x 22.8 in.).

Shipping Weight: 39.1 kg (86 lbs.)
Net Weight: 27.7 kg (61 lbs)
Operating Temperature: 0°C to 50°C

Relative Humidity: 80%

#### **OPTIONS AND ACCESSORIES:**

Option 004†: Interface package for IPT Model 800 Automatic IC Handler

Option 005†: Interface package for Sym-Tek Model 7191ND Automatic IC Handler and other related models

Option 006†: Interface package for Daymarc 952/3 Automatic IC Handler

Option 007†: Interface package for Micro Component Technology Model 2604 and 2608 Automatic IC Handler.

Option 008: Interface package for Delta Model 8040 Ambient Naked DIP Handler.

**Option 009:** Interface package for Control Model H310 Automatic IC Handler.

**Option 010:** Interface package for PAE Model 3033 HR/LP Naked DIP Handler.

Option 013: Interface package for Trigon T2000 Series Multisize Ambient Test Handler.

Option 024: Expands the capability of the 5045A to 24 pins.

Option 025: Flat-Pack adapter for 14, 16, and 24-pin IC

Option 908: Rack flange kit

Option 910: Set of additional product manuals 9164-0071 Blank magnetic program card (Pass/Fail) 9164-0072 Blank magnetic program card (Diagnostic)

9281-0401 250 foot roll of thermal print paper. (minimum order six rolls)

**10845A** Preprogrammed magnetic card for any device listed in the IC PROGRAM CATALOG. The specific cards required are designated on the program card order sheet.

10846A Coupon book containing ten coupons each redeemable in one preprogrammed magnetic card which is listed in the IC PROGRAM CATALOG. The coupons are mailed directly to the factory and the appropriate program card is returned by mail. The coupons expire two years from the date of receipt.

1-5


<sup>\*</sup> Some circuits require the optional 24 pin capability.

<sup>. \*\*</sup>Whichever is greater.

<sup>†</sup> All interface packages include a test head extender cable, an interface board unique to the particular handler, and a cable to supply the control signals to the handler. This enables the test head electronics to be mounted within inches of the device under test.

- g. Option 010 Precision Automated Equipment Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head and a cable to extend the test head. A cable to interface the control and indication signals between the 5045A and the Precision automatic handler is also included. For more information and documentation obtain Installation Note K15-59994A.
- h. Option 013 Trigon Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head and a cable to extend the test head. A cable to interface the control and indication signals between the 5045A and the Trigon automatic handler is also included. For more information obtain Installation Note K14-59994A.
- i. Option 024 24-Pin Test Capability. This provides the required circuits to test 24-pin integrated circuits.
- j. **Option 025** Flat-Pack Adapter. This provides connector adapters for testing flat package integrated circuits.
- k. **Option 908** Rack Flange Kit Part No. 5060-8741. This provides the required hardware to rack mount the 5045A IC Tester.
- I. Option 910. This provides an extra set of product manuals.
- m. **K19-59994A.** Teledyne TAC Interface. This provides a cable to extended the test head. The test head is then connected to the handler. A cable to interface the control signals between the 5045A and the Teledyne automatic handler is also included. For more information and documentation obtain Installation Note K19-59994A.

## 1-27. RECOMMENDED TEST EQUIPMENT

1-28. Test equipment recommended for testing, calibration, and repair of the 5045A is listed in Table 1-3.

Table 1-3. Recommended Test Equipment

Instrument	Required Characteristics	Recommended Type
Oscilloscope	50 MHz	HP 1707B
Vertical	50 mV/div Sens >5 ns rise time	HP 1707B
Horizontal	10 ns/div bandwidth	HP 1707B
Logic State Analyzer	8 MHz, 12 channel	HP 1601L
TTL Trigger Probe	8 MHz, 4 channel w/inverting inputs	HP 10250A
TTL Logic Probe	Bad Level Detect, 10 MHz bandwidth, 10 ns pulse detect	HP 545A
TTL Logic Pulser	1 μs pulse width TTL levels	HP 546A
Voltmeter, Digital DC	±20V, 4-1/2 digit	HP 3465
Ammeter, Digital DC	5 μA -100 ms, .5% accuracy $\int$	111 3403
Power Supply DC	0-10VDC, 0-1A, current limiting	6214A

# SECTION II

# 2-1. INTRODUCTION

2-2. This section contains information for unpacking, inspection, storage, and installation. Field installation of optional equipment is included.

# 2-3. UNPACKING AND INSPECTION

2-4. If the shipping carton is damaged, inspect the tester for visible damage (scratches, dents, etc.). If the tester is damaged, notify the carrier and the nearest Hewlett-Packard Sales and Service Office immediately (offices are listed at the back of this manual). Keep the shipping carton and packing material for the carrier's inspection. The Hewlett-Packard Sales and and Service Office will arrange for repair or replacement of your instrument without waiting for the claim against the carrier to be settled.

# 2-5. INSTALLATION REQUIREMENTS

#### **CAUTION**

BEFORE CONNECTING THE INSTRUMENT TO AC POWER LINES, BE SURE THAT THE VOLTAGE SELECTOR IS PROPERLY POSITION AS DESCRIBED BELOW.

- 2-6. LINE VOLTAGE REQUIREMENTS. The 5045A is equipped with a power module that contains a printed-circuit line voltage selector to select 100, 120, 220, or 240-volt ac operation. Before applying power, the pc selector must be set to the correct position and the correct fuse must be installed as described below.
- 2–7. Power line connections are selected by the position of the plug-in circuit card in the module. When the card is plugged into the module, the only visible markings on the card indicate the line voltage to be used. The correct value of line fuse, with a 250 volt rating, must be installed after the card is inserted. This instrument uses a 3AT fuse (HP Part No. 2110-0003) for 100/120 volt operation; a 1.5AT fuse (HP Part No. 2110-0043) for 220/240 volt operation.
- 2-8. To convert from one line voltage to another, the power cord must be disconnected from the power module before the sliding window covering the fuse and card compartment can be moved to expose the fuse and circuit card.
- 2–9. Pull on the fuse lever to remove the fuse and then pull the card out of the module. The fuse lever must be held to one side to extract and insert the card. Insert the card so the marking that agrees with the line voltage to be used is visible.
- 2-10. Return fuse lever to normal position, insert correct fuse, slide plastic window over the compartment, and connect the power cord to complete the conversion.

## 2-11. Power Cables

## WARNING

TO PROTECT OPERATING AND SERVICING PERSONNEL, THIS INSTRUMENT IS EQUIPPED WITH A THREE-PIN POWER RECEPTACLE. THE CENTER PIN OF THE RECEPTACLE CONNECTS THE INSTRUMENT CHASSIS AND PANELS TO EARTH GROUND WHEN USED WITH A PROPERLY WIRED THREE-CONDUCTOR OUTLET AND POWER CABLE. IMPROPERLY GROUNDED EQUIPMENT CAN RESULT IN HAZARDOUS POTENTIALS BETWEEN EQUIPMENT.

- 2-12. LINE FREQUENCY REQUIREMENTS. The tester operates at line frequencies between 48 Hz and 66 Hz.
- 2–13. THREE-CONDUCTOR POWER CABLE. To protect the operator, the tester uses a grounded three-conductor detachable power cable shown in Figure 2–1. The male connector end is a NEMA type connector, and the female connector end is a C.E.E. type connector that mates with the 5045A rear panel power connector. Connect the power cable to a power source receptacle with a NEMA grounded third conductor. If the line power receptacle is a standard two-pin type instead of the NEMA three-pin receptacle, use a two-to-three pin adaptor (HP Part No. 1251-0048) and connect the green pigtail on the adaptor to ground.

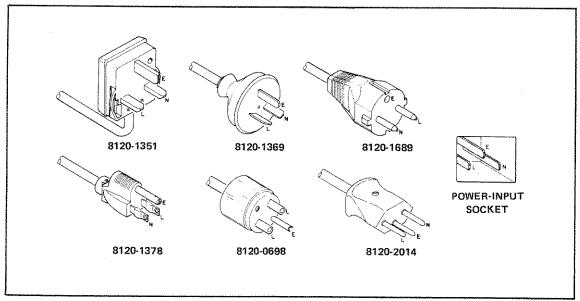


Figure 2-1. Power Cable HP Part Numbers versus Mains Plugs Available

## 2-14. REPACKING FOR SHIPMENT

2–15. If it becomes necessary to reship the tester, good commercial packing should be used. Contract packaging companies in many cities can provide dependable custom packaging on short notice. Instruments should be packed securely in a strong corrugated container (350 lb./sq. in. bursting test) with suitable filler pads between the instrument and container. The 4-corner support is not adequate, tester must also have center support. Before returning instruments to Hewlett-Packard, contact the nearest Hewlett-Packard Sales and Service Office for instructions.

# 2-16. ENVIRONMENT DURING STORAGE AND SHIPMENT

2-17. Conditions during storage and shipment should normally be limited as follows:

Maximum altitude: 25,000 feet.

Minimum temperature: -40°F (-40°C).

Maximum temperature: +167°F (+75°C).

# 2-18. Installation of 24-Pin Option 024

2-19. To extend the testing capability of the 5045A to IC's with up to 24 pins, install Option 024 as follows:

Disconnect power and remove top cover of 5045A.

#### **CAUTION**

Pin driver boards are wrapped in anti-static protective bags. These boards are very susceptible to static discharge damage. Remove each board from its bag separately and handle only by the large black heat sink or by the board extractors.

- Insert the four-pin driver board (Part No. 05045-60013) into slots A17, A18, A19, and A20.
- Perform the Operational Verification Test in Section IV to ensure proper operation.

## 2-20. Installation and Rack Mount Option 908

2-21. Install the Optional rack mount flange kit, Part No. 5061-0078 per instructions on the label provided with the kit.

#### 2-22. AUTOMATIC HANDLER SIGNALS

2-23. When an automatic handler is to be installed, the interface signals are connected via the 5045A rear panel connector J5. All signals are negative-true logic. Table 2-1 lists the signals at each active pin of connector J5. The name of the signal indicates the condition that occurs at that pin (relative to front panel indicators). Figure 2-2 shows the timing of the signals in reference to the End of Test signal. The signals occur only when the named signal condition exists. The duration of all signals is as shown, within ±5 milliseconds.

# 2-24. INSTALLATION AND OPERATION OF MONOSTABLE MULTIVIBRATOR ADAPTER A36

2-25. Insert adapter (A36) in the 24-pin test socket on the 5045A standard test head assembly. Follow card loading procedure (see paragraph 3-7) and set the switches on A36 to the ON position as noted in the IC header printout. All other switches must be set in the OFF position. The following printouts are typical for use of the multivibrator adapter.

74123 DIAGNOSTIC USE BOARD 5045-60041 SWITCH ON: ABGHINP 74123 P/F USE WITH HANDLER OR FLATPACKS ---SEE DATA SHEET---

Table 2-1. Automatic Handler Signals

J5 Pin	Signal
A CONTRACT OF THE CONTRACT OF	NOTE
	Signals are TTL levels (true = $+0.4V \otimes 6$ mA, False $+2.4V$ ).
1	Fail Cont
2	End of Test
5, 12	+5V @ 100 mA
6, 13	System Common
9	Pass
10	*Start Test
11	Fail Function

\*The Start Test signal is sent from the handler. It must have a 5 ms minimum duration and then go False at the time the End of Test signal goes true (true = 0.4V @ 6 mA, False = 2.4V).

Note: the Handler Signal Timing may be verified by executing a procedure outlined in the Performance Test, see Section IV.

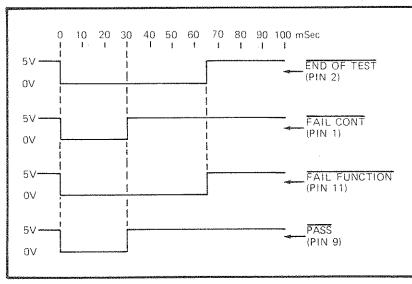


Figure 2-2. Automatic Handler Signal Timing

# SECTION III OPERATION

# 3-1. INTRODUCTION

3-2. This section contains operating information for the 5045A. This includes a description of the controls and indicators, proper setup for use with an automatic handler, printout data, a self-check procedure, and operator's maintenance. Also see 5045A Users Manual for detailed operating instructions.

## 3-3. PROGRAM CARDS

3-4. The program cards store all information unique to the testing of a particular IC. The underside of the card contains a coating of magnetic material responsible for storing this information. When using the cards, try not to touch its magnetic coating since the oil film left from your fingers can cause the card to slip as its being pulled through the card reader. Figure 3-1 shows the proper method of holding the card.

## NOTE

To prevent accidental "erasure" of the card, keep the card away from electrical motors and other such devices. Do not lay the card on top of the tester.

## **CAUTION**

LAYING THE CARD ON ABRASIVE SURFACES CAN CAUSE PERMANENT DAMAGE TO THE CARD'S MAGNETIC COATING. RETURN THE CARD TO ITS FOLDER AFTER USE.

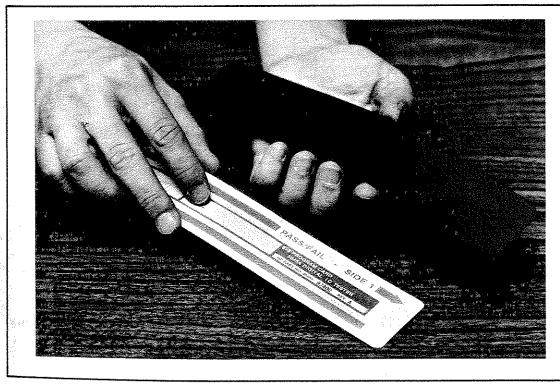


Figure 3-1. Handling the Program Cards

# 3-5. Two Tests Available

3-6. There are two program cards for each IC. One card contains a PASS/FAIL test while the other card performs a DIAGNOSTIC test. Using the PASS/FAIL test results in faster test times because of the consolidation of tests and the reduced amount of failure data available for printing. Figure 3-2 describes the pertinent information on the cards.

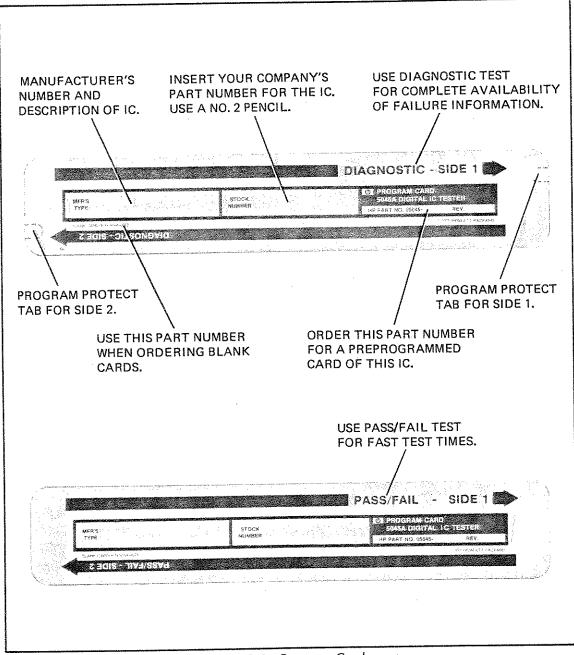


Figure 3-2. Program Cards

# 3-7. Loading the Card

3-8. Apply power, select one of the test cards, push the LOAD button, and insert side 1 of the card face up into the lower front panel slot. The instrument will automatically route the card into the machine and out the other slot. If the LOAD light stays on, it is an indication that more information is needed. Load side 2 of the magnetic card in the same manner.

# 3-9. Verification of Load Operation

3-10. Once the card is loaded, note the printer paper. If the tester accepted the card's information, it will print the manufacture's IC number and the type of test to be performed. If the tester determines that the check sum does not agree with the sum recorded on the card, it will print the word "RELOAD". In this case, push the LOAD button and reload the card.

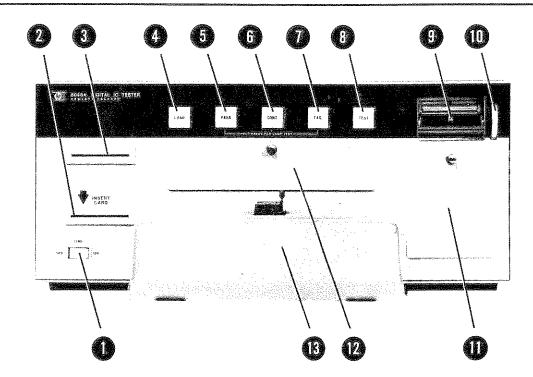
RELOAD

7476 PASS/FAIL

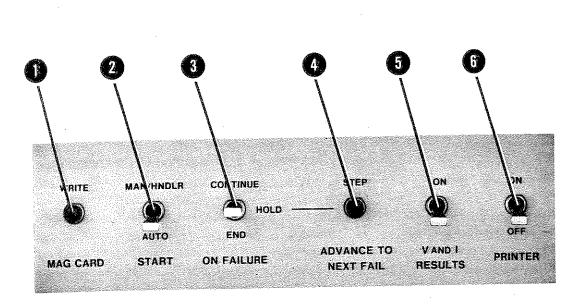
747% DIAGNOSTIC

# 3-11. Program Protect Tabs

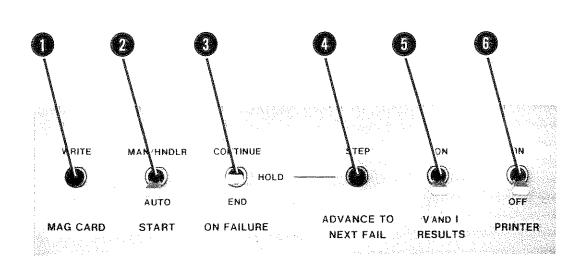
3–12. Each card contains two program protect tabs, located near the arrowheads. Removing either of these tabs prevents the operator from accidentally writing over the existing program. Once the tabs are removed, however, the card cannot be reprogrammed. If the tabs have not been removed, the card can be reprogrammed, but it is highly recommended that the card first be bulk erased.



- a. LINE switch . ON position supplies line power to the tester.
- b. Input slot ② of the card reader. Accepts the magnetic program card when LOAD button ③ is pushed. Enter card with white side up. Check that the arrow on card matches up.
- c. Output slot of the card reader. Magnetic program card exits here as program information is being accessed.
- d. LOAD button . Allows card reader to accept program card.
- e. PASS light lights to indicate the IC passed the tests given it and is considered good.
- f. CONT light lights to indicate the IC has failed the continuity test.
- g. FAIL light of flashes red when the IC fails any of its tests.
- h. TEST button . Push to initiate one test sequence on an IC. Used in the manual mode. Lamp lights to indicate that test is in progress. Can be used to terminate a test sequence by pressing while a test is in progress.
- i. Paper Deflector/Cutoff Bar guides paper out of thermal printer. Knife edge on plastic bar allows paper to tear off cleanly.
- j. Paper Advance knob . Manually rotating the knob downward advances the paper past the print head. Do not advance paper by pulling on tape or the paper will bind.
- k. Paper Tray door . To gain access to paper roll, rotate knob counterclockwise and pull.
- l. Control Panel door **1** . To gain access to controls, rotate knob counterclockwise and pull. See Figure 3-4 for description of controls.
- m. Test Head . Holds special sockets for testing IC's. Removed when using an automatic handler.



- a. MAG CARD WRITE button . When pushed, enables tester to duplicate program data onto a blank card. A preprogrammed card must be entered prior to pushing the button.
- b. START switch selects AUTO (automatic) or MAN/HNDLR (Manual/handler) position.
  - 1. In AUTO position, tester runs multiple test sequences on a single IC. Automatically initiates new test when present test is completed. Also can be used in manual test operation (see users manual).
  - Use MAN/HNDLR position when using an automatic IC handler or when manually testing using the TEST button.
- c. ON FAILURE switch affects the advance of the tests once a failure is detected.
  - 1. END ON FAILURE position terminates test sequence when a failure is detected.
  - 2. HOLD ON FAILURE position stops test sequence where the failure occurs. See description for ADVANCE TO NEXT FAIL button.
  - 3. CONTINUE ON FAILURE position allows completion of test sequences, regardless of failures. With printer on, provides a summary of failures.
- d. ADVANCE TO NEXT FAIL button is functional only when ON FAILURE switch is in the HOLD position. Pushing button advances test sequence to next failure where test sequence stops again.
- e. V AND I RESULTS switch affects content of printout when printer is turned on and an IC fails under test. Off (down) position allows printout of basic failure data. The ON position allows printout of all pins, including their voltage and current data. (V AND I printout is not available with ON FAILURE switch set to CONTINUE.)
- f. PRINTER switch . Printer becomes fully operational with switch set to ON position. Even with switch set to off position, printer will record the card-loading information.



To reduce test times and prevent handling errors, the front panel controls should be set as follows:

- a. Set the START switch at the MAN/HNDLR position.
- b. Set the ON FAILURE switch to the END position.
- c. Set the V AND I RESULTS switch to the off (down) position.
- d. Set the PRINTER switch to the OFF position.

# NOTE

It is important to use the PASS/FAIL program card to reduce the test time.

Figure 3-5. Control Settings for Handler Use

# 3-13. SELF CHECK PROCEDURE

3-14. Each day, before testing begins, a self-check procedure may be run on the tester to ensure the machine is operating properly. This procedure puts the tester through a rigorous test to ensure proper operation. The test can be found in Section IV under Operational Verification.

# 3-15. LOADING THE IC

3-16. Select the test socket that is compatible with the IC to be tested. Ensure that pin 1 of the IC matches pin 1 of the test socket (marked on the housing). Raise the test socket's locking lever, place the IC into the socket, and secure the IC into place by lowering the lever to its horizontal position.

# 3-17. MULTIPLE TESTING OF A SINGLE IC

- 3-18. Multiple testing is the ability to perform repeated test sequences on a single IC and record any failures. The IC might fail only one test in a thousand, but the failure will not go undetected. The internal counter that records the number of passes and failures is reset when a program card is first loaded. This should be done if a record is to be kept.
- 3-19. Multiple testing is also a useful mode to use when manually testing a group of IC's (i.e., without a handler). This mode eliminates the operation of pressing the TEST button for each new IC. Good IC's are indicated by the PASS light coming on shortly after the socket lever is lowered. (Between tests the FAIL light will be on, since the tester is testing an empty socket.)

# 3-20. Multiple Test Setup

3-21. Multiple testing is available by placing the START switch in the AUTO position. Also, for fast operation, set the ON FAILURE switch to END, the V AND I RESULTS switch to off (down) and the PRINTER switch to OFF. The TEST light will stay lit while the other lights reflect the test results. This method of testing is totally automatic and should *not* be used when operating from a handler. The tester may be attempting to perform a check while the handler is shifting in a new IC.

# 3-22. RETRIEVING PASS/FAIL INFORMATION

- 3-23. The tester records the number of failures even though no printing occurred. To retrieve this information, it is necessary to induce a failure (or wait until the next failure). The following procedure will cause the tester to print the number of failures and passes.
  - a. Set the START switch to MAN/HNDLR.
  - b. ON FAILURE switch to END.
  - c. Set the PRINTER switch to ON.
  - d. Remove the IC from its test socket.
  - e. Push the TEST button, once.
- 3-24. The tester will now print the failure data. Of importance here is the number of recorded failures minus one: the one that was induced. In the example below, the IC passed 45 test sequences and failed once of its own accord. If the printer had recorded only one failure (the induced one), the IC tested good.

TEST: FAN OUT
FAIL 2PASS 4'
CORRECT 1001001
PIN
STATE 1>1100010
FAIL PIN: 3

#### 3-25. DUPLICATING MAGNETIC CARDS

3-26. The Digital IC Tester has the ability of duplicating magnetic cards. The tester does this by "learning" the information from a card containing program data (a source card) and transferring that data to a blank card.

#### NOTE

Cards missing their program protect tabs cannot be reprogrammed.

## 3-27. Duplicating Procedure

- 3-28. Use the following procedure when duplicating program cards.
  - a. Set the START switch to the MAN/HNDLR position.
  - b. Push the LOAD button and insert side 1 of the source card (the card already programmed) into the tester. If the LOAD light does not go off, insert side 2 of the source card. The printer will now printout the IC number and the type of test. This verifies that proper loading has occurred. The program stored in the tester can now be transferred to the blank card.
  - c. Push the WRITE button the LOAD light should come on.
  - d. Load side 1 of the blank card into the tester. Load side 2 if the LOAD light does not turn off. Any number of cards can be made in this manner without reloading the source card.
  - e. To verify for proper duplicating, see paragraph 3-31 below.

#### 3-29. MAKING A ROM PROGRAM CARD

3-30. A feature of the tester is the ability to produce a program card for any ROM, regardless of the ROM's program. To do this, first load the PROGRAM/STIMULUS card for the type of ROM (or PROM) that you're going to test. Then insert and test a known good ROM that contains your own output pattern. The tester "learns" the ROM's program and stores that information in its memory. Next, push the WRITE button and load a *blank* card. The tester will write the ROM's stimulus sequence from the first card and the output pattern from the reference ROM onto the blank card. This newly programmed blank card now becomes the test card to which all subsequent ROM's with that pattern can be tested.

## 3-31. Verification

3-32. Once the newly programmed card contains the duplicated program information, a verification of the program should be made. Push the LOAD button and insert side 1 of the new card and then side 2, if necessary. The printer should list the test for the type of card entered.

RELOAD

7476 PASS/FAIL

7476 DIAGNOSTIC

3-33. The printer will print the word "RELOAD" if the card didn't accept all of the program information available to it. In such case, first try reloading the card, if this doesn't work reload the source card and the blank card, as described earlier.

# 3-34. CARD READER CLEANING CARD

- 3-35. The tester is supplied with a special card that cleans the head of the magnetic card reader. This card is abrasive to the head assembly, therefore use it only when necessary. For example, if the tester printed "RELOAD" after four different program cards were loaded, it would be an indication that the card reader may need cleaning. Load the card in the same manner as a regular program card. Additional instructions are given on the card.
- 3-36. Power must be turned off to terminate the cleaning operation.



## CAUTION

EXCESSIVE USE OF THIS CARD WILL DAMAGE THE READ/WRITE HEAD.



# SECTION IV PERFORMANCE TESTS

# 4-1. INTRODUCTION

4-2. The procedure described in this section tests the instruments electrical performance using the specifications listed in Table 1-2 as the performance standards.

# 4-3. EQUIPMENT REQUIRED

4-4. Equipment required for the performance tests is listed in the Recommended Test Equipment table in Section 1 (Table 1-3).

# 4-5. OPERATIONAL VERIFICATION AND PERFORMANCE TESTS

4-6. Two sets of tests are provided in the following paragraph. The Operational Verification test will indicate whether the instrument tested operates correctly in all modes. The Performance Test is more extensive and may be performed after the Operational Verification Test to measure the condition of the instrument tested with respect to the new instrument specifications. Both tests require the use of pre-programmed magnetic cards which are included as part of the Diagnostic Card Kit.

# 4-7. IN-CABINET PERFORMANCE TEST CARD

4-8. The Operational Verification Test Card, page 4-6a, is provided to allow results of the tests to be recorded. A series of these cards with data taken at periodic intervals can be used to show trends in performance.

Table 4-1. Operational Verification Test

- I. SELF CHECK 1, 2, and 3
- II. R-PACK TESTS (Precision Resistor Pack Tests)
  - a. V/I R-PACK
  - b. R-PACK C-Current Modes Check
  - c. R-PACK Failure Detect Check

## 4-9. Operational Verification Test

- 4-10. The Operational Verification Test for the 5045A IC Tester consists of several self check routines that quickly verify correct operation of the major testing modes of the instrument. This test may be run each day to verify correct operation. For a rigorous verification of all 5045A specifications, refer to the Performance Test Paragraph 4-35.
- 4-11. The Operational Verification Test is divided into two parts: Part I uses a dummy IC along with special program cards to check several programmed modes of voltages and currents. In these tests, pin drivers are used in pairs. One driver is used as a source and the other becomes a measuring device. In Part II, a special precision resistor pack is used to obtain information about individual pins and their parameters.

# 4-12. Part I: Self Checks 1, 2 and 3

a. Set the front panel switches as follows:

START — MAN/HNDLER ON FAILURE — CONTINUE V and I RESULTS — OFF (down) PRINTER — ON

b. Install the Dummy IC in the test socket. For Option 024 (24-pin instruments), use the IC (HP P/N 05045-80020). The 16-pin IC should be used for standard 16-pin instruments (HP P/N 05045-60019). The 20-pin socket adapter (HP P/N 05045-60032) must be used with 16-pin ICs.

#### 4-13. Self Check 1

a. Load the correct "Self Check 1" program card for 16-pin or 24-pin instrument. The following printout will be produced:

SELF CHECK 1 CPU RDR PRNTR OK

The printout indicates that the 5045A's card reader, central processing unit, and printer are operating properly.

Press TEST. Verify that the PASS light illuminates. There should be no printer output.

## 4-14. Self Check 2

- a. Load the correct "Self Check 2" card for 16-pin or 24-pin instrument. This self check program is a test of relative accuracy for several modes of voltage and current setup conditions.
- b. Press TEST. Verify that the PASS light illuminates. There should be no printer output.

## 4-15. Self Check 3

Note: Self check 3 will not operate with instrument serial numbers 1620A00155 and below.

- a. Load the correct "Self Check 3" card for 16-pin or 24-pin instruments. This self check program further exercises the pin driver voltage and current generators.
- b. Press TEST. Verify that the PASS light illuminates. There should be no printer output.

# 4-16. Part II: R-Pack Operational Verification Tests

a. The precision resistor pack (R-Pack HP P/N 05045-60042) is used with special program cards to gain additional information about individual voltage and current parameters for each pin of the IC tester. The R-Pack loads each pin of the IC tester with a precision  $1 \mathrm{K}\Omega$  resistor. The 24 resistors tie to a common ground point. When testing is performed, the R-Pack is inserted in the test socket and its ground lead is connected to A30TP25 (marked  $\downarrow$ ). The R-Pack tests uses the voltage and current generator along with the V and I Results function to produce a printed output for each pin.

- 4-17. The R-Pack Operational Verification consists of the following tests:
  - a. V/I Performance

Analog Accuracy
V/I Results Function

- b. Pin Driver C-Current Modes Check
- c. Failure Detect Check

## 4-18. V/I Performance Check

- 4-19. This test verifies that the pin driver voltage and current generators along with the V and I Results function are working properly.
- 4-20. Remove the Test Head cover.
  - Set 5045A Front Panel switches to: START — MAN/HNDLR ON FAILURE — HOLD V and I RESULTS — ON (UP)

PRINTER — ON

Note: all of the tests for each program card may be executed automatically by setting ON FAIL-URE to CONTINUE.

- b. Turn on 5045A and load "V/I R-PACK 24-pin" or "V/I R-PACK 16-pin" for 24-pin or 16-pin instrument, respectively.
- Install R-PACK in Test Head socket.
- d. Connect R-PACK ground lead to A30TP25 (marked 4).
- 4-21. The V/I R-Pack check consists of four operational modes with a corresponding printout for each.

#### 4-22. +7V, +7 mA Mode

- a. Press TEST.
- b. A printout similar to Figure 4-1 will be produced.
- c. All pins should be listed as failing.
- d: Note that each pin is listed twice. For example, observe the data for pin 24. The "L" in the printout denotes the programmed value of the voltage or current. The lower line denotes that 7 mA was forced (programmed) and the resultant voltage is 7.05V (1K $\Omega$  resistors are loading each pin). The upper line for pin 24 denotes that 7V was applied and the resultant current was 7.0 mA.
- e. In each printout line, the parameter of importance is the result of the forced current or applied voltage. Voltage printouts will always be on the left and current printouts on the right.
- f. For the 7V, 7 mA printout, make sure that voltage and current results for all pins are within the following limits.

7V, 7 mA 7V ±0.40V (6.60/7.40V) 7 mA ±0.40 mA (6.60/7.40 mA)

```
TEST
        7V:7MA
                    FAIL
         SPASS
                 7 MA
20
20
   7,05 V
                 ZLMA
       71.7
              7.04 MA
    7.02 V
                 71.HH
                 7 1919
       71.7
    7.04 9
                 71111
       71.9
              7.08 MA
    6.98 V
                 ZLMA
       71...\7
                 7 MA
                 71.119
24 7.05 V
CORRECT 11111111111111
      18 11 12 13
      15 16
               1. 6
                    13
  14
      20 21
              the fine Section
  24
```

Figure 4-1. Typical printout for R-Pack Test (partial printout)

#### 4-23. 1V, 1 mA

- a. Press ADVANCE TO NEXT FAIL. The "1V, 1 mA" printout will be produced.
- b. Examine the voltage and current parameters as done in paragraph 4-22.
- c. Verify the following limits for all pins.

1V, 1 mA 1V ±60 mV (0.940/1.060V) 1 mA ±60  $\mu$ A (0.940/1.060 mA)

### 4-24. -7V, -7 mA

- a. Press ADVANCE TO NEXT FAIL. The "-7V, -7 mA" printout will be produced.
- b. Examine the voltage and current parameters as in paragraph 4-22. Verify the following limits for all pins.
  - -7V, -7 mA -7V ±40 mV (-7.40/-6.60V) -7 mA ±40 μA (-7.40/6.60 mA)

#### 4-25. -1V, -1 mA

- a. Press ADVANCE TO NEXT FAIL. The "-1V, -1 mA" printout will be produced.
- b. Examine the voltage and current parameters as in paragraph 4-22.

c. Verify the following limits for all pins.

-1V, -1 mA

-1V ±6 mV (-1.060/-.940V)

-1 mA  $\pm$ 60  $\mu$ A (-1.060/-.940 mA)

## 4-26. Pin Driver C-Current Modes Check

- 4-27. This test sets up the pin driver in typical continuous current modes. The continuous current function allows for current generators to be turned on independently of the logic state of the pin under test. In each of the tests, both the Logic 1 and Logic 0 current generators are turned on simultaneously. The resultant output current is the difference between the programmed Logic 1 and Logic 0 currents.
  - a. Load "R-Pack C-Current Modes 24-Pin" or "R-Pack C-Current Modes 16-Pin" for 24-pin or 16-pin instrument, respectively.

#### 4-28. 7V, 7 mA +12, C-5

#### NOTE

+12, C-5 denotes that the Logic 1 and Logic 0 currents are +12 mA and -5 mA, respectively. C-5 means that the Logic "0" source is turned on continuously for -5 mA.

- a. Press TEST. The "7V, 7 mA +12, C-5" printout will be produced.
- b. Examine the voltage and current parameters as in paragraph 4-22. Verify the following limits for all pins.

7V ±1.1V (5.9/8.1V) 7 mA ±1.1 mA (5.9/8.1 mA)

#### 4-29. 1V, 1 mA +2, C -1

Logic 1 Current Source: +2 mA

Logic 0 Current Source: -1 mA continuous

- a. Press ADVANCE TO NEXT FAIL. The "1V, 1 mA +2, C-1" printout will be produced.
- b. Examine the voltage and current parameters as in paragraph 4-22.
- c. Verify the following limits for all pins.

1V ±0.18V (0.82/1.18) 1 mA ±0.18 mA (0.82/1.18 mA)

#### 4-30. -7V, -7 mA -12, C+5

Logic 1 Current Source: +5 mA Continuous

Logic 0 Current Source: -12 mA

- a. Press ADVANCE TO NEXT FAIL. The "-7V, -7 mA -12, C+5" printout will be produced.
- b. Examine the voltage and current parameters as in paragraph 4-22.
- c. Verify the following limits for all pins.

-7V=±1.1V (-8.1/5.9V)

-7 mA:±1.1 mA (-8.1/-5.9) mA)

#### 4-31. -1V, 1 mA -2, C+1

Logic 1 Current Source: +1 mA Continuous Logic 0 Current Source: -2 mA

- a. Press ADVANCE TO NEXT FAIL. The "-1V, -1 mA -2, C+1" printout will be produced.
- b. Examine the voltage and current parameters as in paragraph 4-22.
- c. Verify the following limits for all pins.

-1V ±.18 (-1.18/-0.82V) -1 mA ±.18 (-1.18/-0.82 mA)

#### 4-32. Failure Detection Circuitry Check

4-33. The failure detection circuitry check verifies that the tester can indicate failing conditions for IC's under test. Failing voltage and current conditions are set up with the R-Pack. Source and load parameters are tested for each pin. The four tests are as follows:

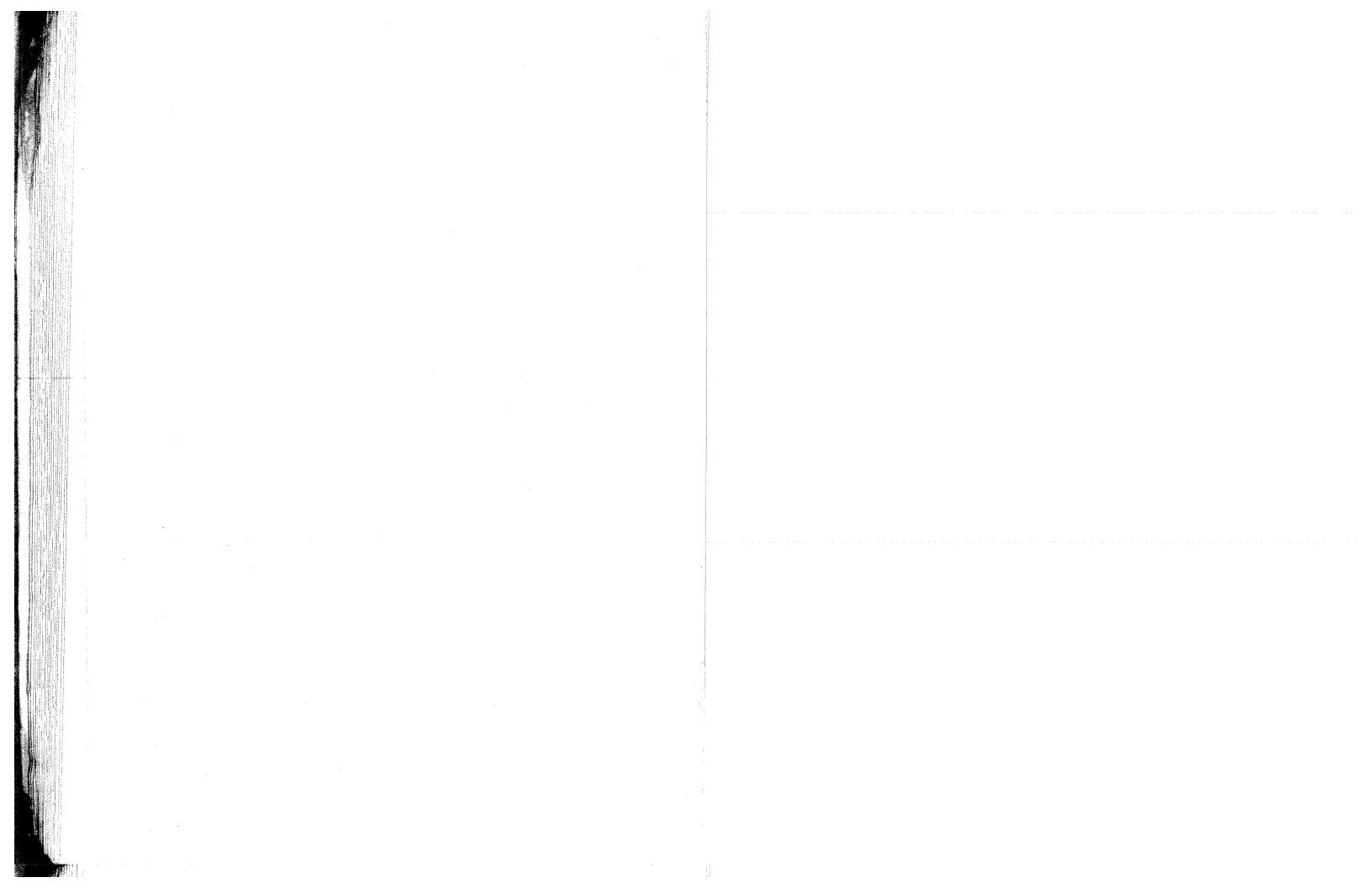
- Test 1 Even Pins "Source" Logic 1 Odd Pins "Load" Logic 0
- Test 2 Even Pins "Load" Logic 0
  Odd Pins "Source" Logic 1
- Test 3 Even Pins. "Load" Logic 1 Odd Pins "Source" Logic 0
- Test 4 Even Pins "Source" Logic 0 Odd Pins "Load" Logic 1
- a. Set 5045A front panel switches as in paragraph 4-20 except:

ON FAILURE — CONTINUE V and I RESULTS — OFF (Down)

- b. Remove R-Pack from the test socket.
- c. Load "R-Pack Fail Detect Check 24-Pin" or "R-Pack Fail Detect Check 16-Pin" for 24-pin or 16-pin instrument.
- d. Press TEST. PASS light should illuminate and no printout will be produced.
- e. Install R-Pack in test socket and connect ground lead to A30TP25 (marked 1).
- f. Press TEST. Printout should begin. For all four tests, verify that every pin is listed in the FAIL PIN information. For 16-pin instruments, pins 1-16 should fail. For 24-pin instruments, pins 1-24 should fail. If any pin is not listed in any or all of the tests, then there may be a problem with the failure detect circuitry for that pin. If this occurs, reinsert the R-Pack and run the test again. If problem still occurs refer to Troubleshooting, Section VIII.
- 4-34. Successful completion of R-Pack Tests 1, 2, and 3 along with positive self check results indicates that with high probability the 5045A Digital IC Tester is functioning properly. For a complete verification of all 5045A published specifications, the Performance Test must be executed.

# Operational Verification Test Card

HEWLETT-PACKARD MODEL 5045A IC TESTER	Test Performed Date
SERIAL NO.	
DESCRIPTION	CHECK
1. Self Check 1	
2. Self Check 2	
	-
6. R-Pack Fail Detect Check	(
NOTE: Tests 4, 5, 6 printout tapes should be	je lastened to tins rest card.
•	
사용 1	
86 (1) 8 (1)	



# 4-35. PERFORMANCE TEST

4-36. The 5045A Performance Test, outlined in Table 4-2 is used to verify that all operational modes of the IC tester are functioning correctly. In addition, all voltage and current specifications are verified. This Performance Test may be used for incoming inspection, periodic certification, troubleshooting and post-repair verification.

Table 4-2. Performance Test Outline

	1.	DAC Adjustment Check
And the state of t		DAC Reference Level V Zero, V Gain I Zero, I Gain
	11.	Analog Voltage Check
		Part I Hi, Lo Range Part II Logic Levels
	111.	Analog Current Check
		Low Range 200 mA Range Continuous Current Modes
	IV.	Cross Talk
		Part I, II
	V.	Failure Detection Circuitry Check
A A	V١	V and I Results Check
		Voltage Current V/I Offset
	VII.	Fast Edge Check
		Pos Rise Time Neg Rise Time
	VIII.	Relays Check
	1X.	Op Code Check
	X	Printer Check
	ΧI	Automatic IC Handler Signals Check (Optional)

#### 4-37. DAC ADJUSTMENT CHECK

- 4-38. The "DAC Adj Check" test verifies proper alignment of the A11 Reference Level Generator (DAC). This procedure may be deleted if an alignment has just been performed.
  - a. Remove test head cover. Tilt up the front portion of the cover (the cover hinges at the rear).
  - b. Attach DVM ground lead to A30 TP25 (marked 4). Remove R-Pack if installed.
  - c. Set front panel switches as follows:

START — MAN/HNDLR ON FAILURE — HOLD V and I RESULTS — DOWN PRINTER — ON

d. Load "DAC Adjust CHECK"

#### 4-39. Test 1: DAC REF 7.5V

- 4-40. This test verifies that the DAC reference level is correct.
  - a. Press TEST. The "DAC REF 7.5V" printout will be produced.
  - b. Measure voltage on TP8.
  - c. Verify the following limits of 7.5V 55 mV.

±15

#### 4-41. Test 2: -V Zero 2 0V

- 4-42. This test verifies correct zero offset for the -V Level Generator.
  - a. Press ADVANCE TO NEXT FAIL. The "-V Zero 2 0V" printout will be produced.
  - b. Measure voltage on TP8.
  - c. Verify the following limits of 0.00V  $\pm 10$  mV.

#### 4-43. Test 3: +V Zero 2 0V

- 4-44. This test verifies correct zero offset for the +V Level Generator.
  - a. Press ADVANCE TO NEXT FAIL. The +V Zero 2 0V printout will be produced.
  - b. Measure voltage on TP8.
  - c. Verify the following limits of 0.00V  $\pm 10$  mV.

#### 4-45. Test 4: "+6.5V Logic 1"

- 4-46. This test verifies the +6.5V Gain adjustment of the +V Level Generator.
  - a. Press ADVANCE TO NEXT FAIL. The "+6.5V Logic 1" printout will be produced.

- b. Measure voltage on TP8.
- c. Verify the following limits of  $\pm 6.5 \text{V} \pm 10 \text{ mV}$ .

# 4-47. Test 5: "+6.5V Logic 0"

- 4-48. This test verifies the +6.5V Gain adjustment of the -V Level Generator.
  - a. Press ADVANCE TO NEXT FAIL. The "+6.5V Logic 0" printout will be produced
  - b. Measure voltage on TP8.
  - c. Verify the following limits of  $\pm 6.5 \text{V} \pm 10 \text{ mV}$ .

# 4-49. Test 6: -6.5V Logic 1

- 4-50. This test verifies the -6.5V Gain adjustment of the +V Level Generator.
  - a. Press ADVANCE TO NEXT FAIL. The "-6.5V Logic 1" printout will be produced.
- b. Measure voltage on TP8.
- c. Verify the following limits of -6.5V  $\pm 10$  mV.

## 4-51. Test 7: -6.5V Logic 0

- 4-52. This test verifies the -6.5V Gain adjustment of the -V Level Generator.
  - a. Press ADVANCE TO NEXT FAIL. The "-6.5V Logic 0" printout will be produced.
  - b. Measure voltage on TP8.
  - c. Verify the following limits of -6.5V  $\pm 10$  mV.

## 4-53. Test 8: Current Gen, +10 mA

- 4-54. This test verifies proper gain for the +I Level Generator. Switch meter to current mode.
  - a. Press ADVANCE TO NEXT FAIL. The "Current Gen. +10 mA" printout will be produced.
  - **b.** Measure current at TP8.
  - c. Verify the following limits of 10 mA  $\pm$ .6 mA.

## 4-55. Test 9: Current Gen, -10 mA

- 4-56. This test verifies proper gain for the -I Level Generator.
- 2. Press ADVANCE TO NEXT FAIL. The "Current Gen. -10 mA" printout will be produced.
- **b.** Measure current at TP8.
- c. Verify the following limits of -10 mA  $\pm$ .6 mA.

- 4-57. Test 10: +1 Zero, +10 μA
- 4-58. This test verifies proper zero offset for the +I Level Generator.
  - a. Press ADVANCE TO NEXT FAIL. The "I Zero  $\pm 10~\mu A$ " printout will be produced.
  - b. Measure current at TP8.
- c. Verify the following limits of +10  $\mu$ A  $\pm$ 5  $\mu$ A.
- 4-59. Test 11: -l Zero, -10 μA
- 4-60. This test verifies proper zero offset for the -I Level Generator.
  - a. Press ADVANCE TO NEXT FAIL. The "I Zero -10  $\mu$ A" printout will be produced.
  - b. Measure current at TP8.
- c. Verify the following limits of -10  $\mu$ A  $\pm$ 5  $\mu$ A.
- 4-61. If all limits have been satisfied for all 11 tests then the A11 Reference Level Generator (DAC) is properly aligned. Perform the complete A11 adjustment procedure as described in Section V, if any of the tests failed.

## 4-62. Analog Voltage Check

- 4-63. The Analog Voltage Check is a verification of the accuracy of programmed voltage levels. The test is divided into two parts.
  - a. Part I
    - +7.5V, Pos High Range High End Logic 1
    - +1.9V Pos High Range Low End Logic 1
    - +1.8V Pos Low Range High End Logic 1
    - +0.1V Pos Low Range Low End Logic 1
    - -7.5V Neg High Range High End Logic 0
    - -1.9V Neg High Range Low End Logic 0
    - -1.8V Neg Low Range High End Logic 0
    - -0.1V Neg Low Range Low End Logic 0
- b. Part II
  - +5V Logic 1
  - +5V Logic 0
  - -5V Logic 1
  - -5V Logic 0
  - +1V Logic 1
  - +1V Logic 0
  - -1V Logic 1
  - -1V Logic 0
- 4-64. The following graph shows the breakdown of the IC Tester's High and Low Voltage Ranges. The ▲ marks denote the voltages checked in Part I. "O" marks denote voltages checked in Part II.

## 4-65. Part I

- a. Set front panel switches as in paragraph 4-38.
- b. Load "Analog Voltage Check Part 1".
- c. Press TEST.

# 4-66. Test 1: +7.5V Pos High Range, High End

- a. Measure voltage on Test Points 1-24.
- b. Verify the following limits of  $\pm 7.5 \text{V} \pm 25 \text{ mV}$  for all pins.

# 4-67. Test 2: +1.9V Pos High Range, Low End

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- . Verify the following limits of  $\pm 1.9 \text{V}$   $\pm 25$  mV for all pins.

## 4-68. Test 3: +1.8V Pos Low Range High End

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of  $\pm 1.8 \text{V} \pm 15 \text{ mV}$  for all pins.

## 4-69. Test 4: +0.1V Pos Low Range, Low End

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of  $\pm 0.1V \pm 15$  mV for all pins.

#### 4-70. Test 5: -7.5V Neg High Range, High End

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of  $-7.5V \pm 25$  mV for all pins.

## 4-71. Test 6: -1.9V Neg High Range, Low End

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- Verify the following limits of  $-1.9V \pm 25$  mV for all pins.

# 4-72. Test 7: -1.8V Neg Low Range, High End

- a. Press ADVANCE TO NEXT FAIL.
- **b.** Measure voltage on Test Points 1-24.
- c. Verify the following limits of -1.8V  $\pm 15$  mV for all pins.

#### 4-73. Test 8: -0.1V Neg Low Range, Low End

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of -0.1V  $\pm 15$  mV for all pins.

#### 4-74. Part II

- 4-75. Voltage Limit Verification for Pos and Neg Logic Modes.
  - a. Load "Analog Voltage Check Part II".

#### 4-76. Test 1: +5V Logic 1

- a. Press TEST.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of  $\pm 5V \pm 25$  mV for all pins.

#### 4-77. Test 2: +5V Logic 0

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of  $+5V \pm 25$  mV for all pins.

#### 4-78. Test 3: -5V Logic 1

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage of Test Points 1-24.
- c. Verify the following limits of -5V  $\pm$ 25 mV for all pins.

#### 4-79. Test 4: -5V Logic 0

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of -5V  $\pm$ 25 mV for all pins.

#### 4-80. Test 5: +1V Logic 1

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of  $\pm 1V \pm 15$  mV for all pins.

#### 4-81. Test 6: +1V Logic 0

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of  $\pm 1V \pm 15$  mV for all pins.

## 4-82. Test 7: -1V Logic 1

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of -1V  $\pm$ 15 mV for all pins.

# 4-83. Test 8: -1V Logic 0

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of -1V  $\pm$ 15 mV for all pins.

# 4-84. Analog Current Check

4-85. The Analog Current Check is a verification of the accuracy of programmed current levels. The test is divided into three parts.

# 4-86. Part I — Low Current Range

±20 mA

±2.6 mA

±2.4 mA

 $\pm 10 \mu A$ 

## 4-87. Part II - High Current Range

±200 mA

#### 4-88. Part III

## a. Continuous Current Modes

±100 mA

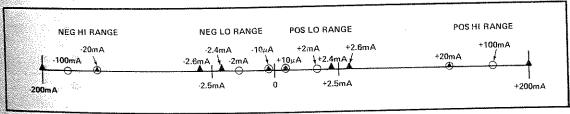
±20 mA

±2 mA

±10 μA

## b. Voltage Verification for Current Modes

4-89. The following graph shows the breakdown of the IC Testers High and Low current ranges. The "A" marks denote the currents checked in parts 1 and 2. The "O" marks are for currents checked in part 3 (continuous modes).



## 4-90. Part I — Analog Current Check Low Range

- a. Set up DVM to measure DC current.
- b. Connect ground level to TP25 (marked 4).
- c. Load "Analog Current Check Low Range".

### 4-91. Test 1: +20 mA

- a. Press TEST.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of 20 mA  $\pm 1.2$  mA for all pins.

#### 4-92. Test 2: +2.6 mA

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of 2.6 mA  $\pm 0.4$  mA for all pins.

#### 4-93. Test 3: +2.4 mA

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of 2.4 mA  $\pm$ 0.14 mA for all pins.

## 4-94. Test 4: +10 μA

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of 10  $\mu$ A  $\pm$ 10  $\mu$ A for all pins.

#### 4-95. Test 5: -20 mA

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of -20 mA  $\pm$ 1.2 mA for all pins.

#### 4-96. Test 6: -2.6 mA

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of -2.6 mA  $\pm 0.4$  mA for all pins.

#### 4-97. Test 7: -2.4 mA

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of -2.4 mA  $\pm$ 0.14 mA for all pins.

#### 4-98. Test 8: -10 μA

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of -10  $\mu$ A  $\pm$ 10  $\mu$ A for all pins.

#### 4-99. Analog Current Check 200 mA Range

4-100. The 200 mA ranges are checked with a separate test due to the maximum available current restrictions of the IC Tester. For any one pin setup condition, the total current from either positive or negative current generators may not exceed 600 mA. The test is organized so that only one pin is set up at any one time. The setup condition moves sequentially from pin 1 to 24 each time the ADVANCE TO NEXT FAIL button is pushed. Pin 1 is set up by pressing TEST.

- a. Load "Analog Current Check 200 mA Range".
- b. Press TEST.
- c. Measure current at TP1.
- d. Verify the following limits of  $\pm 200$  mA  $\pm 12$  mA on pin 1.
- e. Press ADVANCE TO NEXT FAIL to step test to pin 2. For each step, verify the following limits of  $\pm 200$  mA  $\pm 12$  mA.
- f. After TP24 has been checked, the -200 mA test begins with TP1. Again press ADVANCE TO NEXT FAIL to step through all 24-pins. The spec for the -200 mA test is -200 mA ±12 mA.

#### 4-101. Continuous Current Modes

4-102. The continuous current function allows the current generators to be turned on independent of the logic state. In each of the tests, both the Logic 1 and Logic 0 current generators are turned on simultaneously. The resultant output appearing at the test points is the difference between the positive and negative programmed current levels. The tests are divided between three program cards as follows:

- a. Card 1 Pins 1-8
- b. Card 2 Pins 9-16
  - Card 3 Pins 17-24

4-103. For any particular test checkpoint, the 8 pins will have different current setups. Refer to Table 4-3 for the expected outputs and limits.

#### NOTE

For 16-pin instruments, use the program for modes 1-8 and 17-24. Ignore references to pins 9-16.

## 4-104. Continuous Current Modes 1-8

a. Load "Pindriver C-Current Modes 1-8".

### 4-105. Test 1

- a. Press TEST.
- b. Measure current on Test Points 1-8.
- c. Verify currents according to Table 4-3 Test 1.

## 4-106. Test 2

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure current on Test Points 1-8.
- c. Verify currents according to Test 2.

4-107. Continue for remaining tests by pressing ADVANCE TO NEXT FAIL. For each test, verify the currents for Test Points 1-8 by referring to Table 4-3 and the appropriate test number.

#### 4-108. Continuous Current Modes 9-16

- a. Load "Pindriver C-Current Modes 9-16".
- b. Proceed as in paragraph 4-104 above making reference to pins 9-16 in Table 4-3.

### 4-109. Continuous Current Modes 17-24

- a. Load "Pindriver C-Current Modes 17-24".
- b. Proceed as in paragraph 4-104 above making reference to pins 17-24 in Table 4-3.

#### 4-110. Voltage Verification for Current Modes

4-111. This test is a verification of programmed voltage modes for continuous current pin driver setups.

4-112. Use the same procedure and equipment as outlined in paragraphs 4-104 through 4-109 except that voltages will be measured instead of currents. The approximate voltage magnitude is 7 volts. Refer to Table 4-4 for correct voltage levels. Note that for each program card, tests 1 through 4 are programmed for  $\pm 7V \pm 25$  mV. For tests 5 through 8, the level is  $\pm 7V \pm 25$  mV.

Table 4-3. Pindriver C-Current Modes (Current)

Pin	Numl	ber		Test Number							
Card 1-8	Card 9-16	Card 17-24	1	2	3	4	5	6	7	8	
1,2	9,10	17,18	+100 mA +/-18 mA	+20 mA +/-3.6 mA	+2 mA +/52 mA	+10 μA +20, -10 μA	-100 mA +/-18 mA	-20 mA +/-3.6 mA	-2 mA +/52 mA	-10 μA -20, +10 μA	
3,4	11,12	19,20	+20 mA +/-3.6 mA	+20 mA +/52 mA	+10 μA +20, -10 μA	-100 mA +/-18 mA	-20 mA +/-3.6 mA	-2 mA +/-,52 mA	-10 μA -20 +10 μA	+100 mA +/-18 mA	
5,6	13,14	21,22	+2 mA +/52 mA	+10 μA +20, -10 μA	-100 mA +/-18 mA	-20 mA +/-3.6 mA	-2 mA +/52 mA	-10 μA -20, +10 μA	+100 mA +/-18 mA	+20 mA +/-3.6 mA	
7,8	15,16	23,24	+10 μA +20, -10 μA	-100 mA +/-18 mA	-20 mA +/-3.6 mA	-2 mA +/52 mA	-10 μA -20, +10 μA	+100 mA +/-18 mA	+20 mA +/-3.6 mA	+2 mA +/52 mA	

Table 4-4. Pindriver C-Current Modes (Voltages)

Pin	Numl	oer				Test N	umber			
Card 1-8	Card 9-16		1	2	3	4	5	6	7	8
1,2	9,10	17,18	+7V	+7V	+7V	+7V	-7V	-7V	-7V	· -7V
3,4	11,12	19,20	+7V	+7V	+7V	-7V	-7V	-7V	-7V	+7V
5,6	13,14	21,22	+7V	+7V	-7V	-7V	-7V	-7V	+7V	+7V
7,8	15,16	23,24	+7V	-7V	-7V	-7V	-7V	+7V	+7V	+7V

Note: +/-25 mV limits for all.

#### 4-113. Cross Talk

4-114. The Cross Talk tests verify that the accuracy of programmed voltage and currents is within specification when cross talk conditions are set up on the Reference Level Generators and the individual pindrivers.

#### 4-115. Cross Talk Part I

- a. Set front panel switches as in paragraph 4-38c.
- b. Connect DVM ground lead to TP25 (marked 4).
- c. Connect DVM Positive lead to TP7.
- d. Load "Cross Talk Part I".

## 4-116. Test 1: +V -I

- a. Press TEST.
- b. Verify the following limits of 7.5V  $\pm$ 25 mV on TP7.

#### 4-117. Test 2: +V -I

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of 7.5V  $\pm$ 25 mV on TP7.

#### 4-118. Test 3: +V +I

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of 7.5V ±25 mV on TP7.

#### 4-119. Test 4: +V +I

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of 7.5V  $\pm$ 25 mV on TP7.

## 4-120. Test 5: -V +I

- a. Press ADVANCE TO NEXT FAIL.
- **b.** Verify the following limits of -7.5V  $\pm 25$  mV on TP7.

## 4-121. Test 6: -V +

- a. Press ADVANCE TO NEXT FAIL.
- **b.** Verify the following limits of  $-7.5V \pm 25$  mV on TP7.

# 4-122. Test 7: -V -I

- a. Press ADVANCE TO NEXT FAIL.
- **b.** Verify the following limits of -7.5V ±25 mV on TP7.

### 4-123. Test 8: -V -I

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of  $-7.5V \pm 25$  mV on TP7.
- 4-124. Set up DVM to measure current (approx. 2 mA).
  - a. Connect ammeter positive lead to TP7.
  - b. Ground lead remains on TP25 (marked 1).

### 4-125. Test 9: +I +V

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of 2 mA  $\pm 0.12$  mA at TP7.

### 4-126. Test 10: +I +V

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of 2 mA  $\pm$ 0.12 mA at TP7.

### 4-127. Test 11: +I -V

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of 2 mA  $\pm 0.12$  mA at TP7.

### 4-128. Test 12: +I -V

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of 2 mA  $\pm 0.12$  mA at TP7.

#### 4-129. Test 13: -I -V

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of -2 mA  $\pm 0.12$  mA at TP7.

#### 4-130. Test 14: -I -V

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of -2 mA  $\pm 0.12$  mA at TP7.

#### 4-131. Test 15: -I +V

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of -2 mA  $\pm 0.12$  mA at TP7.

#### 4-132. Test 16:-I +V

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of -2 mA  $\pm 0.12$  mA at TP7.

### 4-133. Cross Talk Part II

- a. Set DVM to measure voltage (approx. 7.5V). Connect DVM ground lead to TP25 (marked (1). Load "Cross Talk Part II".
- b. Press TEST. Printer output should be similar to that below:

TEST: 1-2
FAIL 2PASS 0
CORRECT 1111111111111
PIN
STATE 1>11111111111111
FAIL PIN: 1 4 . 7
10 13 16 19 22

- c. Measure voltage on indicated Fail Pins. Voltage should be +7.5V ±25 mV.
- d. Press ADVANCE TO NEXT FAIL. Printer output should be similar to that below:

TEST: 1-2
FAIL 2PASS 0
CORRECT 001001001001
FIN
STATE 1>100100100100100
FAIL PIN: 1 4 7
10 13 16 19 22

- e. Measure voltages on indicated Fail Pins. Voltage should be +7.5V ±25 mV.
- f<sub>8</sub> Press ADVANCE TO NEXT FAIL. Printer output should be similar to that below:

- 8. Measure voltage on indicated Fail Pins. Voltage should be  $\pm 7.5 \text{V} \pm 25 \text{ mV}$ .
- h. Press ADVANCE TO NEXT FAIL. Printer output should be similar to that below:

TEST: 2-3
FAIL 2PASS 0
CORRECT 010010010010
PIN
STATE 1>010010010010
FAIL PIN: 2 5 8
11 14 17 20 23

- i. Measure voltage on indicated Fail Pins. Voltage should be +7.5V ±25 mV.
- j. Press ADVANCE TO NEXT FAIL. Printer output should be similar to that below:

- k. Measure voltage on indicated Fail Pins. Voltage should be +7.5V ±25 mV.
- I. Press ADVANCE TO NEXT FAIL. Printer output should be similar to that below:

TEST: 3-4
FAIL 2PASS 0
CORRECT 100100100100
PIN
STATE 1>001001001001
FAIL PIN: 3 6 9
12 15 18 21 24

m. Measure voltage on indicated Fail Pins. Voltage should be  $\pm 7.5 \text{V} \pm 25 \text{ mV}$ .

#### 4-134. Failure Detection Circuitry Check

4-135. The Failure Detection Check verifies that a failing device under test can activate the 5045A's failure circuitry. The test uses a precision resistor package (HP P/N 05045-60042) to set up failing conditions for voltage and current. Source and load parameters are tested for each pin. The tests are as follows:

- Test 1 Even Pins "Source" Logic 1
  Odd Pins "Load" Logic 0

  Test 2 Even Pins "Load" Logic 0
  Odd Pins "Source" Logic 1

  Test 3 Even Pins "Load" Logic 1

  Odd Pins "Source" Logic 1
- Odd Pins "Source" Logic 0

  Test 4 Even Pins "Source" Logic 0
- Odd Pins "Load" Logic 1
- a. Set 5045A front panel switches as in paragraph 4-38 c. except:

#### ON FAILURE — CONTINUE

b. Load "R-Pack Fail Detect Check 24" or "R-Pack Fail Detect Check 16" for 24-pin or 16-pin instrument. These programs are included in the Operational Verification Card Set. Press TEST. PASS light should illuminate and no printout will be produced. Note: R-Pack is not installed for this part of the test.

Now install R-Pack in test socket and connect ground lead to TP25 (marked ↓). Secure R-Pack with locking lever. Press TEST. Printout should begin. For all four tests, verify that every pin is listed in the FAIL PIN information. For 16-pin instruments, pins 1-16 should fail. For 24-pin instruments, pins 1-24 should fail. If any pin is not listed in any or all of the tests, then there may be a problem with the failure detect circuitry for that pin. If this occurs, reinsert the R-Pack and run the test again. If problem still occurs, refer to Trouble-shooting in Section VIII.

## 4-136. V AND I RESULTS — VOLTMETER/AMMETER PRINTOUT CHECK

4-137. This test verifies that the V and I RESULTS printout feature is working properly. The voltage specification is verified by applying an external voltage standard to each of the pins and observing the computed prinout. The current specifications check uses the Resistor Pack (also used in part V). A known current is produced by applying a specified voltage across each 1K resistor in the R-Pack. The resultant current is then computed and printed by the tester. The last part of the V/I check verifies that the voltmeter circuity has minimum offset.

#### **CAUTION**

Always adjust the power supply to the approximate test range before applying to the IC tester. Damage to the 5045A may result if voltage magnitudes exceeding 7V are applied to the Test Head.

#### 4-138. Voltage Printout Feature

#### **CAUTION AGAIN**

Do not connect the power supply until the correct voltage is set up. Damage to the IC Tester may result if excessive voltage is applied to the Test Head pins.

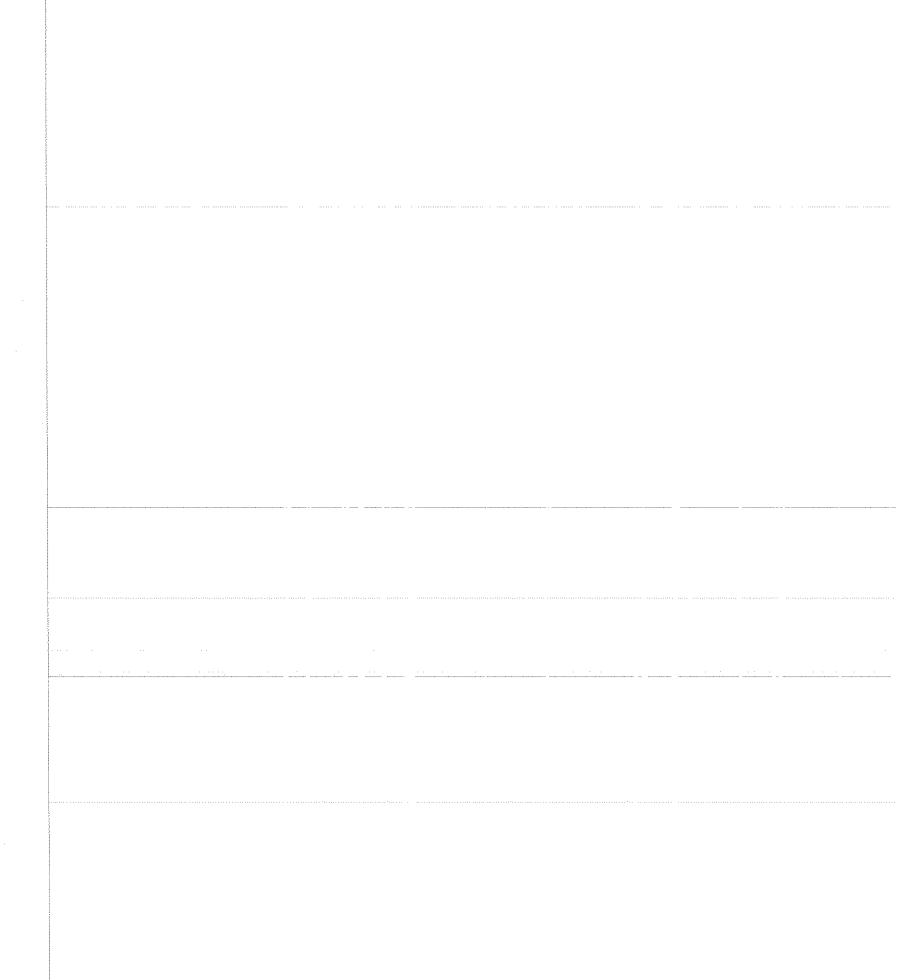
- a. Turn on power supply and set voltage to  $\pm 4.99V \pm 5$  mV. Connect negative (-) side to A30 TP25 (4).
- b. Install R-Pack in the 24 pin Test Head socket. Do not connect the black ground lead at othis time.
- c. Set Front Panel Switches as follows:

START — MAN/HNDLR
ON FAIL — Hold
V and I RESULTS — OFF (DOWN)
Printer — ON

- d. Load "V/I Results Voltage Check 16" or "V/I Results Voltage Check 24". Make sure that the correct program card is used (16-pin or 24-pin version).
- e. Press Test. The "+4.99 Setup" printout will be produced.
- f. Connect Power Supply Positive lead (+) to R-Pack black ground lead.
- **8.** Measure Voltage on TP8 and adjust Power Supply as necessary to produce  $5.000V \pm 5 \text{ mV}$ .
- h. Set V and I RESULTS ON (switch UP).

## 4-139. V/I 5V Verification

a. Press ADVANCE TO NEXT FAIL.



b. A printout similar to the following will be produced (partial printout).

TES	1 ::		jų.	VE	RIF	
		 E	ir fi	88		Ü
17		61				
17	4.5				51	
15		6L\	,l		01	
18	4.9	9 4			91	
19		6L\	,l		01	
19	4.9	ğ l			011	
29		614			<b>a</b> 1	
29	4.5			Ű,	011	_111
Z.J.		SLV	!	)B.	01	11
	4.5	9 4	ī	j.,	911	.MF
22		61.5		> -] <sub>a</sub>	81	MH
22	4.5	9 4		Ø.	011	.HA
23		属上员		ÞØ.	01	비티
	4.9				Ğij	
24				) () .	91	ΉĤ
24					011	
CORR	ELT	1	j	111	111	11
PIM						
STAT	E 1	>11	11:	111	111	11
FAIL					<u></u>	Э
ri.			15		-91 [	5
ij	<u> 1</u> t		11	1	<u></u>	1 1
	4 1		15	1	7	18
1 4	21	3	21	2	<u>"</u>	23
24						

#### NOTE

Each pin number has two listings. Voltage levels are listed on the left side of the printout. All parameters containing "L" should be ignored. In this test, only the lower printout for each pin is of importance.

c. For each pin, verify that the printout reads:

#### 4-140. V/I -5V Verification

- a. Disconnect Power Supply leads.
- b. Set:

- c. Press ADVANCE TO NEXT FAIL. The "-4.99V setup" printout will be produced.
- d. Connect Power Supply leads so that -4.99V is applied to the R-Pack black lead.
- e. Measure Voltage on  $\frac{7P24}{1P4}$ . If necessary, adjust Power Supply to produce -5.00V  $\pm 5$  mV on TP8.
- f. Set:

V and I RESULTS — ON (UP)

- g. Press ADVANCE TO NEXT FAIL wait for printout.
- h. Observe voltage printout for each pin.
- i. For each pin, verify that the printout reads:
  .o4V (-4.96V) 5.04V)
  -5V ±.03V (-4.97V, -5.03V)

## 4-141. V/I +1V Verification

- a. Disconnect Power Supply leads.
- b. Set:

V AND I RESULTS — OFF (DOWN)

Printer - OFF ON

- c. Press ADVANCE TO NEXT FAIL. The "+0.99 Setup" printout will be produced.
- d. Connect Power Supply leads so that +0.99V is applied to the R-Pack black lead.
- e. Measure voltage on TP8. If necessary, adjust Power Supply to produce  $\pm 1.00 \text{V} \pm 5 \text{ mV}$  on TP8.
- f. Set:

V AND I RESULTS — ON (UP)

- g. Press ADVANCE TO NEXT FAIL wait for printout.
- h. Observe voltage printout for each pin.
- i. For each pin, verify that the printout reads:

+1V ±.02V (+0.98, +1.02)

#### 4-142. V/I - 1V Verification

- a. Disconnect Power Supply leads.
- b. Set:

V AND I RESULTS — OFF (DOWN)

Printer — OFF

- Press ADVANCE TO NEXT FAIL. The "-0.99 Setup" printout will be produced.
- d. Connect Power Supply leads so that -0.99V is applied to the R-Pack black lead.
- **e.** Measure voltage on TP8. If necessary, adjust Power Supply to produce -1.00V  $\pm$ 5 mV on TP8.
- f. Set:

V AND I RESULTS — ON (UP)

- **g.** Press ADVANCE TO NEXT FAIL wait for printout.
- h. Observe voltage printout for each pin.
- For each pin, verify that the printout reads:

-1V ±.02V (-0.98, -1.02)

### 4-143. V/I Results Current Check

- a. Disconnect Power Supply from Test Head.
- b. Turn off 5045A.
- c. Leave R-Pack installed in test socket and connect R-Pack black lead to A30 TP25 (1).

#### 4-144. V/I 7 mA Verification

- a. Turn on 5045A.
- b. Load "V/I Results Current Check 16" or "V/I Results Current Check 24". Make sure that the correct program card is used (16-pin or 24-pin version).
- c. Set:

- d. Press TEST.
- e. A printout similar to the following will be produced (partial printout).

(6.55/7.45)
FAIL 2PASS 0
17 6.93 V 7EMA
18 7LV 7.08 MA
18 6.97 V 7LMA
19 7LV 7.04 MA
19 7.01 V 7LMA
DA ZIV ZIAR MA
20 7 V 7LMA 21 7LV 7.08 MA
21 7LV 7,08 MA
21 6,95 V 7LMA
22 7LV 7.08 MA
22 6.98 V 7LMA
23 7LV 7.12 MA
23 6.91 V 7LMA
24 7LV 7.04 MA
24 6.98 V 7LMA
CORRECT 1111111111111111
PIM
STATE 121111111111111
FAIL PIN: 1 2 3
14 15 16 17 18
19 20 21 22 23
edi, edi — Erica Sanda — E Erica Sanda — Erica Sanda Erica Sanda — Erica Sanda
visit 1

Note

Each pin has two listings. The only parameter of interest is the top current printout (right column). Ignore the information in the left column. Also, ignore the right-column current containing the "L".

Verify that the current printout for each pin reads 7 mA  $\pm 0.45$  mA (6.55/7.45).

### 4-145. V/I -7 mA Verification

- a. Press ADVANCE TO NEXT FAIL.
- b. A printout similar to that obtained in paragraph 4-144e will be produced.
- c. Observe current printout for each pin (as in paragraph 4-144e).
- d. For each pin, verify that the printout leads -7 mA  $\pm 0.45$  mA (-6.55/-7.45).

## 4-146. V/I OFFSET CHECK

- a. Load "V/I OFFSET CHECK 16" or "V/I OFFSET CHECK 24". Make sure that the correct program card is used (16-pin or 24-pin version). **REMOVE R-PACK.**
- b. For 16-pin instruments, pins 6 and 7 should be shorted together with a short length of wire. The short may be mounted in the 24-pin test socket.

## 4-147. V/I Pos Offset

- a. Press TEST.
- b. A printout similar to that in paragraph 4-144e will be produced.
- c. Observe voltage (left column) for each failed pin (as in paragraph 4-144e).
- d. For each failed pin, verify that the voltage printout reads:

 $0.00V \pm 10 \text{ mV } (-.01, .01)$ 

### 4-148. V/I Neg Offset Check

- a. Press ADVANCE TO NEXT FAIL.
- b. Observe voltage (left column) printout for each failed pin (as in paragraph 4-144e).
- c. For each failed pin, verify that the voltage printout reads:

0.00 +10 mV (-.01, .01)

#### 4-149. Fast Edge Check

4-150. The Fast Edge Check is a verification of positive and negative rise times for analog voltage levels being applied to the IC under test. If during the check, the FAIL lamp illuminates and a printout occurs, press TEST twice to continue. This is usually caused by shorting two pins together.

- 2. Set the 5045A front panel switches as in paragraph 4-38c.
- b. Load "Pos Fast Edge Check".
- c. Insert R-Pack in test socket and connect ground lead to A30 TP25 (marked 1). Also connect scope ground to A30 TP25 (marked 1).

Oscilloscope Setup:

Single Trace: CH A Trigger Slope: POS

Vertical: 0.1V Div with 10X Probe

Horizontal: 0.1 µsec/div

Not

The display for this fast waveform will be easier to examine with the use of a viewing hood.

d. Connect scope probe to A30 TP1.

Press TEST. The TEST Light should illuminate and there should be no printer output.

Observe the scope display and compare to Figure 4-2.

Rise time: -2V to +2V; 120 nsec max

Overshoot: Less than 0.8V

Move the probe to TP2 and again observe the waveform. Repeat this for all pins. Note that on 16 pin instruments, TP9 through TP16 will have no output and should not be observed.

e. Load "Neg Fast Edge Check".

Change scope trigger to Neg slope.

f. Press TEST.

Observe the waveform as done in the Positive Fast Edge Check. Compare the scope displays to Figure 4-3.

Fall Time; +2V to -2V: 120 nsec max

Overshoot: less than 0.8V

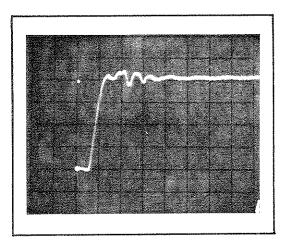


Figure 4-2. Fast Edge Check (Positive)

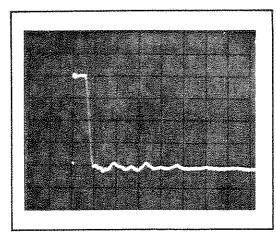


Figure 4-3. Fast Edge Check (Negative)

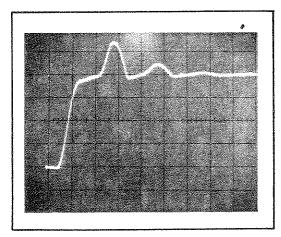


Figure 4-4. Positive Edge .1V Div/.1 μsec With Test Head Extender Cable

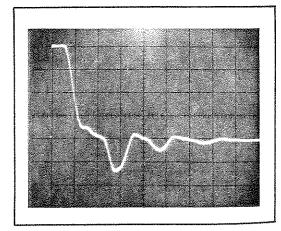


Figure 4-5. Negative Edge .1V Div/.1 μsec With Test Head Extender Cable

## 4-151. Fast Edge Signals for Extended Test Heads

4-152. The Fast Edge signals for test heads using the tongue extender cables are slightly altered. Figures 4-4 and 4-5 are typical waveforms expected after the positive and negative fast edge checks.

#### 4-153. Relays Check

- 4-154. The Relays Check insures proper operation of the test head grounding and bypass capacitor relays.
  - a. Set 5045A front panel switches as in paragraph 4-38c. Note: make sure that the ON FAIL-URE switch is in the "HOLD" position.
  - b. Load appropriate "Relays Check" magnetic card; 16-PIN for a standard instrument or 24-PIN for an Option 024 instrument. Printer output should be one of the following:

RELAYS CHECK-15 PINS

RELAYS CHECK-24 PINS

c. Press TEST. Printer output should be as follows:

(16-pin)		(24-pin)
TEST: K1 OK FAIL 1PASS CORRECT 111111111 PIN STATE 1>111111111 FAIL PIN: 12	Ø	TEST: K1 OK FAIL 1PASS 0 CORRECT 111111111111111111111111111111111111

d. Press ADVANCE TO NEXT FAIL. Printer output should be as follows:

(16-pin)		(	24-pin)
TEST: K2 OK FAIL 1PASS CORRECT 111111111 PIN STATE 1>11111111111111111111111111111111111	3	FAIL CORRECT PIN	K2 OK 1PASS 0 11111111111111 11111111111111111111

e. Press ADVANCE TO NEXT FAIL. Printer output should be as follows:

(16-pin)		(24-pin)
TEST: K8 OK FAIL 1PASS CORRECT 111111111 PIN STATE 1>1111111111 FAIL PIN: 8	3	TEST: K4 OK FAIL 1PASS 0 CORRECT 111111111111111111111111111111111111

		,		
A	 		 	
CARLO CONTRACTOR CONTR				

f. Press ADVANCE TO NEXT FAIL. Printout output should be as follows:

(24-pin) (16-pin) TEST: K7 OK TEST: K9 OK 18455 FAIL FAIL 18988 CORRECT 1111111111111111 CORRECT 11111111 PIN PIN STATE 1>1111111111111 STATE 1>111111111 FAIL PIN: 9 FAIL PIM: 7

g. Press ADVANCE TO NEXT FAIL. Printer output should be as follows:

(24-pin) (16-pin final check) TEST: K11 OK TEST: K8 OK 1PASS FAIL 1PASS 0 FAIL Ø CORRECT 111111111 FIN PIH STATE 1>11111111111111 STATE 1>11111111 FAIL PIN; 8 FAIL PIM: 1

h. Press ADVANCE TO NEXT FAIL. Printer output should be as follows:

(24-pin)

i. Press ADVANCE TO NEXT FAIL. Printer output should be as follows:

(24-pin)

i. Press ADVANCE TO NEXT FAIL. Printer output should be as follows:

(24-pin)

## 4-155. Op Code Check

- 4-156. The Op Code Check verifies program capabilities for logic and arithmetic functions within the Arithmetic Logic Unit of the 5045A's CPU.
  - a. Set front panel switches as in paragraph 4-38c.
  - b. Load "OP CODE CHECK".

Press TEST.

PASS light should illuminate and there should be no printer output.

## 4-157. Printer Check

- a. Set front panel switches as in paragraph 4-38c.
- b. Load "Printer Check".

Press TEST. The following printout will be produced:

```
TEST: @ABCDEFGHIJK
LMNOP@RSTUVWXYZ [\]^
_!"##%%'()*+,-./0123
456789:;<=>?
EEEEEEEEEEEEEEEEEE
FAIL 1PASS 0
CORRECT 11111111111111
PIN
STATE 1>111111111111111
FAIL PIN: 1
```

c. Check vertical print spacing. Ideal spacing should be about 6 characters per inch. If adjustment is necessary, refer to printer adjustments (Paragraph 8-40i).

## 4-158. Automatic IC Handler Signals Check (Optional)

- 4-159. Control signals for automatic IC handlers are generated by circuitry within the 5045A IC Tester. The following procedure is a verification of the timing relationships for these signals.
- 4-160. The test requires the use of a known good TTL IC and its corresponding Pass/Fail Program Card. The 7400 Quad Nand gate is recommended. This IC is used to test the PASS, FAIL CONTINUITY, and FAIL FUNCTION signals.
- **4-161.** In order to gain easy access to the signal lines, a test cable should be used. The test cable connector and pin-out is listed below.

#### 4-162. Cablè

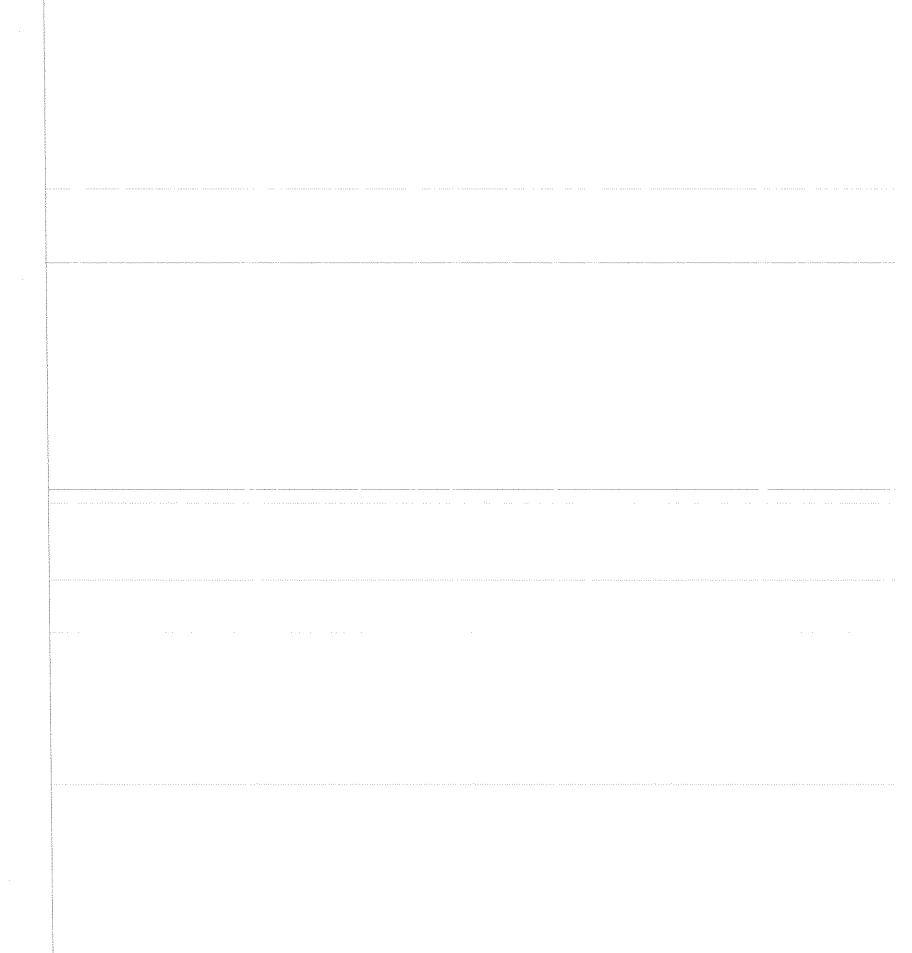
4-163. The test cable is made up of connector (HP Part Number 1251-0142) or Amphenol 5730140) with test wires connected as follows:

FAIL CONT — Pin 1

FAIL FUNCTION — Pin 11

PASS — Pin 9

GND — Pin 6, 13



#### 4-164. Procedure

a. Hook up handler control test cable to rear of 5045A. Connect scope CH A to the EOT line. Set up scope as follows:

Trigger: CH A, Negative Slope

Vertical: - 2V/div

Horizontal: - 10 msec/div

Ground: Connect to pin 6 or 13 on J15 cable

b. Set 5045A Front Panel switches as follows:

START — AUTO
ON FAILURE — END
V and I RESULTS — OFF (DOWN)
PRINTER — OFF

- c. Turn on 5045A and install 7400 IC (or equivalent) in the test head socket. (The 20-pin adapter must be used.)
- d. Load the test program.
- e. Adjust scope trigger until the EOT signal stabilizes. Using the horizontal position control, move the signal so that beginning of trace is in a convenient location. Verify that the EOT signal is low for about 65 ms (see Figure 4-6).
- f. Connect the CHB probe to the PASS line. Compare the signal to that shown in Figure 4-. Verify that the PASS signal goes high after 30 ms ±5 msec (referenced to beginning of EOT trace).
- g. Lift the test IC so that the front panel "CONT" light flashes. (The "FAIL" light will also flash.)
- h. Connect the CH B Probe to the FAIL CONT line (pin 1 on the J5 cable). Compare the signal to that shown in Figure 4-6. Verify that the FAIL CONT signal goes high after 30 msec ±5 msec (referenced to beginning of EOT Trace).
- i. Reinsert the test IC in the test head socket. Connect the CH B Probe to the FAIL FCN line (pin 11 on the J5 cable). Use a screwdriver or similar tool to short pins 1 and 2 of the test IC together. Hold the short condition throughout this portion of the test. Verify that the "FAIL" light is flashing.
- j. Compare the signal displayed to that shown in Figure 4-6. Verify that the FAIL FCN signal goes high after 65 msec ±5 msec (referenced to beginning of EOT trace).

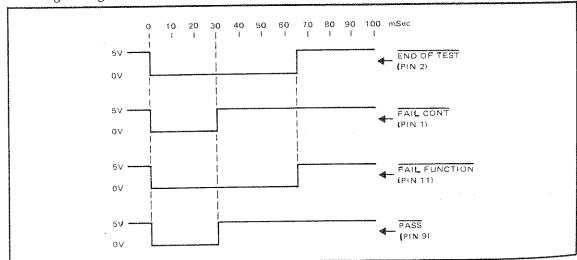
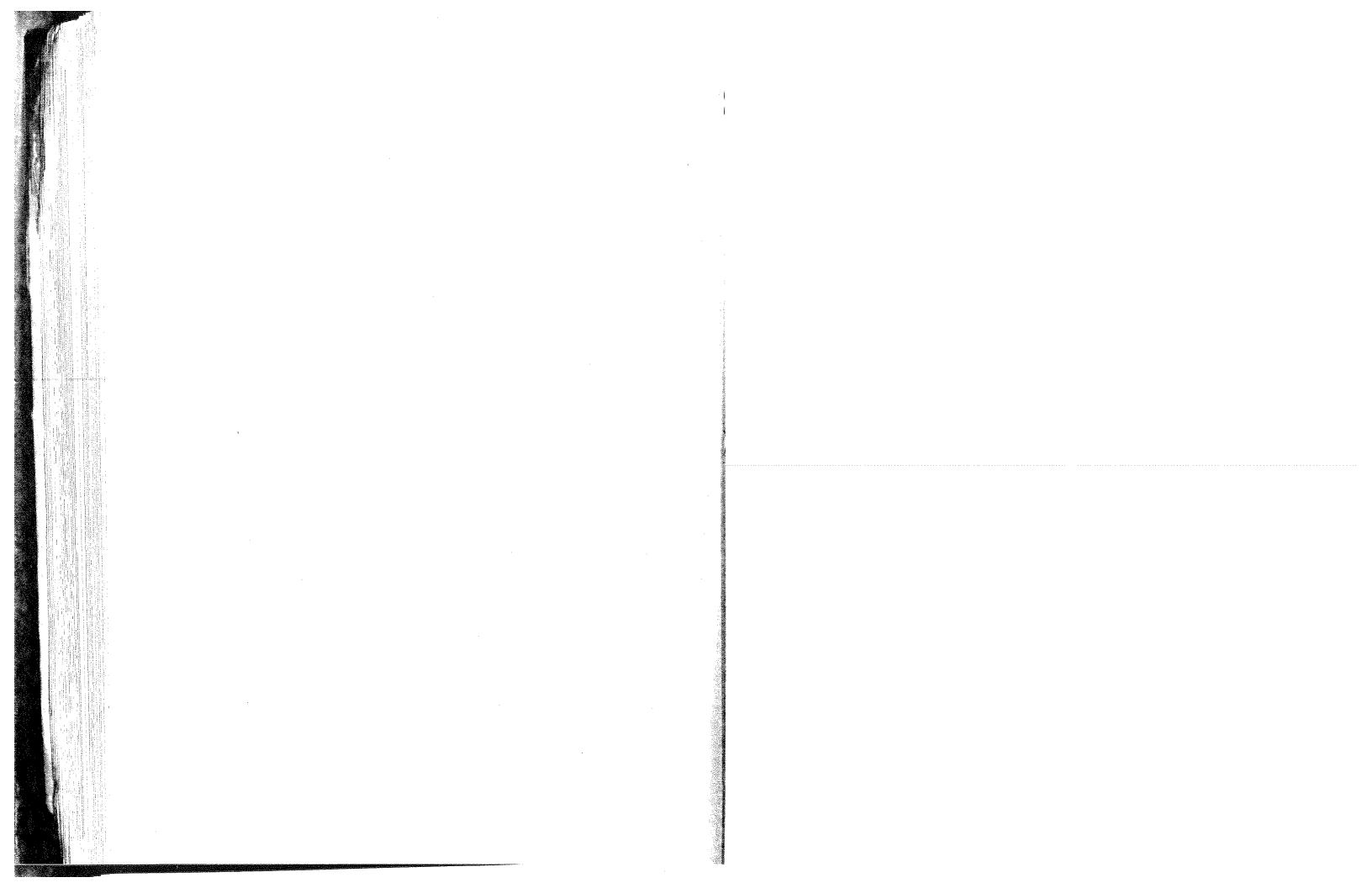


Figure 4-6. Automatic Handler Signal Timing

## Performance Test Check Card

	/LETT-PACKARD MODEL 5045A ESTER	Test Performed	
	AL NO		
JLKI			
	DESCRIPTION	СНЕСК	
1.	Reference Level Generator Check (DAC)		
2.	Analog Voltage Check	water and the second se	
3.	Analog Current Check		
4.	Cross Talk	·	
5.	Failure Detect Check	***************************************	
6.	V and I Results Check	and the state of t	
<i>7</i> .	Fast Edge Check		
8.	Relays Check		
9.	Op Code Check		
10.	Printer Check		
11.	Automatic IC Handler Signals Check		
		•	



## SECTION V ADJUSTMENTS

# 5-1. INTRODUCTION

5-2. This section contains a list of test equipment required and adjustment procedures.

#### NOTE

All of the adjustments are written for 5045A's equipped with Option 024 (24-pin). For standard instruments, disregard any reference to test points 9 through 16.

## 5-3. TEST EQUIPMENT REQUIRED

5-4. Table 5-1 lists the equipment required for adjustments. See Table 1-3 for a complete listing of test equipment required for instrument maintenance.

Table 5-1. Required Test Equipment

Instrument Type	Required Characteristics	Recommended Model No.
Oscilloscope	50 MHz	HP 1707B
Vertical	50 mV/div sensitivity, >5 ns rise time	State of the state
Horizontal	10 ns/div bandwidth	
Voltmeter/Ammeter, Digital DC	<b>Voltage:</b> 20V max 1 mV Resolution on 6.5V level	HP 3465A
	<b>Current:</b> 10 μA, 20 mA 100 μA Resolution on 10 mA level .1 μA Resolution on 10 μA level	

#### 5-5. ADJUSTMENTS

5-6. This section contains checkout and adjustment procedures for the power supplies, 4 MHz clock, printer group enable timing, and DAC alignment. These procedures should be performed in the order given, however the adjustments for the DAC should only be performed when there is an indication that an adjustment is necessary rather than on a periodic basis.

## 5-7. Standard Front Panel Switch Settings

5-8. Prior to performing adjustments or performance tests, set the front panel switches as follows:

START	MAN/HNDLR
ON FAILURE	HOLD
V AND I RESULTS	DOWN
PRINTER	ON

The state of the s		

## 5-9. POWER SUPPLY CHECK AND ADJUSTMENTS

5-10. There are four adjustable power supplies and seven supplies which are not adjustable. The supplies should be checked without a program loaded. To check and adjust the power supplies, proceed as follows:

#### WARNING

LOCATIONS AT LINE VOLTAGE ARE EXPOSED WHEN THE TOP COVER IS REMOVED AND POWER IS APPLIED. AVOID ELECTRICAL SHOCK. SERVICE AND ADJUSTMENTS SHOULD BE COMPLETED BY QUALIFIED SERVICE PERSONNEL.

- a. Disconnect primary power from the instrument. Set the front panel switches as per paragraph 5-8.
- b. Remove top cover from IC tester.
- c. Remove power supply cover.
- d. Apply power to the 5045A. Be sure the rear panel line selector settings matches the line voltage.
- e. Connect digital voltmeter and oscilloscope to each supply shown in the following table. Board assembly numbers, test points and adjustment locations for the power supplies are marked on the power supply cover. Measure each supply using the chassis in the vicinity of power supply as ground. Adjust as required.
- f. Set front panel switch to MAN/HNDLR. Load any program card **BUT DO NOT PRESS TEST**.
- g. Again measure the supplies and compare tolerances against the table shown below. When necessary, perform adjustments on the adjustable supplies.

Brown Street,	Voltage		embly and justment	Tolerances	120 Hz Ripple
	+15	A1	None	±.75V	<100 mV
	-15	A1	None	±.5V	<100 mV
	+18	A1	None	±.9V	<100 mV
	-18	A1	R2	±.2V	<100 mV
	+8	A2	R2	±.2V	<100 mV
	_	A2	R3	±.2V	<100 mV
	-	A2		±.6V	<100 mV ·
		A2		±.5V	<150 mV
	•-	A3	R3	±.05V	<200 mV
		A3		±.25V	<200 mV
	+18	A3		±2V	<200 mV
	+8 -8 +12 -12 +5 -5	A2 A2 A2 A2 A3 A3	R2 R3	±.2V ±.2V ±.6V ±.5V ±.05V ±.25V	<100 mV <100 mV <100 mV <150 mV <200 mV <200 mV

h. Using an oscilloscope, measure the ripple on each supply and verify that the tolerances are met.

#### NOTE

Re-install power supply cover before proceeding with other measurements.

## 5-11. A9 4 MHz CLOCK CHECK AND ADJUSTMENT

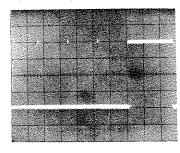
a. Connect frequency counter to A9TP4. Check that frequency is 4 MHz  $\pm$ .01 MHz, if not adjust A9R4 for proper frequency.

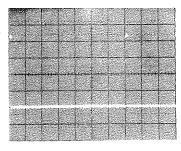
# 5-12. PRINTER GROUP ENABLE TIMING ADJUSTMENT

a. Set front-panel switches as follows:

START switch Al	JTO
ON FAILURE switch CONTI	NUE
PRINTER switch	ON

- b. Load "DAC REF CHECK" magnetic card.
- c. Using a 10:1 divider probe, connect oscilloscope to A26U2(7). Connect ground lead to A26U2(8).
- d. Set oscilloscope to .1 V/division and horizontal sweep to 1 msec/ division. Check that time between positive pulses (period) is 7 msec ±1 msec, if not, adjust A26R21 for proper period. See Figure A and B for proper waveform.





1 V/cm, 5 msec/div

1 V/cm, 1 msec/div

Figure A

Figure B

#### NOTE

The remaining adjustments should only be performed when there is an indication that adjusting is necessary rather than on a periodic basis.

# 5-13. A11 DAC VOLTAGE ADJUSTMENT

5-14. The A11 Adjustment Procedure requires the use of five pre-programmed magnetic test cards which are included in the Diagnostic Card Kit. These cards are:

"DAC REF CHECK"

"+/-V ZERO ADJUST"

"DAC V GAIN ADJUST"

"CURRENT GEN. PRESET ADJUST"

"+/- I ZERO 1-2 ADJUST"

- 5-15. Proper alignment of the A11 Reference Level Board depends on careful execution of the following procedure. During the adjustments, it will be necessary to record some measurements and make simple averaging calculations. A hand held calculator or scratch paper will be useful. This precise alignment technique is necessary to insure proper DAC offset and linearity. Note: Allow the 5045A to warm up for at least 20 minutes before making any A11 Reference Level Generator Adjustments.
- 5-16. The A11 Reference Level Generator (DAC) Adjustments are performed in 3 steps:
  - a. DAC Reference Adjustment
  - b. Voltage Generator Adjustment
  - c. Current Generator Adjustment

#### NOTE

All of the tests refer to 24-pin instruments. For 16-pin instruments, test points 9-16 will have no outputs and should not be measured.

#### 5-17. DAC REF Adjustment

a. Set 5045A Front Panel Switches:

```
START — — MAN/HNDLR
ON FAILURE — — HOLD
V and I RESULTS — — DOWN
PRINTER — — ON
```

- b. Load "DAC REF CHECK"
- c. Remove Test Head Cover.
- d. Connect DVM ground lead on A30 TP25 (labeled ‡ ).
- e. Center all pots on the A11 board.
- f. Press TEST. Measure voltage on A30 TP8. Adjust A11 "REF" pot for 7.5V ±5 mV.

#### 5-18. Voltage Generator Adjustment

- 5-19. Note: Scratch paper or a Calculator will be useful. Some of the adjustments involve splitting voltage differences with the +V ZERO 1 and -V ZERO 1 pots (located on A11). Table 5-2 serves as an aid in recording measurements and calculating these differences. Make a copy of the table and fill it in as measurements are made. (Make a blank copy because the table may have to be used more than once.)
  - a. +V ZERO 2 Adjustment

Set Front Panel Switches as in paragraph 5-17 (a).

Load "+/-V ZERO 2 ADJUST."

Connect DVM ground lead to A30 TP25.

b. Press **TEST**. The following printout will be produced:

- c. Measure +V ZERO 2 pot to produce  $0.00 \pm 5$  mV on pin 8. Then verify that all other pins measure  $0.00V \pm 10$  mV.
- d. -V ZERO 2 Adjustment

Press ADVANCE TO NEXT FAIL. The following printout will be produced:

- e. Adjust -V ZERO 2 pot to produce  $0.00 \pm 5$  mV on pin 8. Then verify that all other pins measure  $0.00V \pm 10$  mV.
- f. +V GAIN (+6.5V) Adjustment
  Load "DAC V GAIN ADJUST"
- g. Press TEST. The following printout will be produced:

- h. Adjust +V GAIN pot to produce 6.5V ±2 mV on pin 8.
- i. -V GAIN (-6.5V) Adjustment

Press ADVANCE TO NEXT FAIL. The following printout will be produced:

j. Adjust -V GAIN pot to produce -6.5V ±2 mV on pin 8.

The following measurements involve splitting voltage differences. Use Table 5-2 as an aid in making calculations. Table 5-3 is an example of typical measurements. It will be helpful to study Table 5-3 before proceeding.

k. +V ZERO 1 (-6.5V)

Press ADVANCE TO NEXT FAIL. The following printout will be produced:

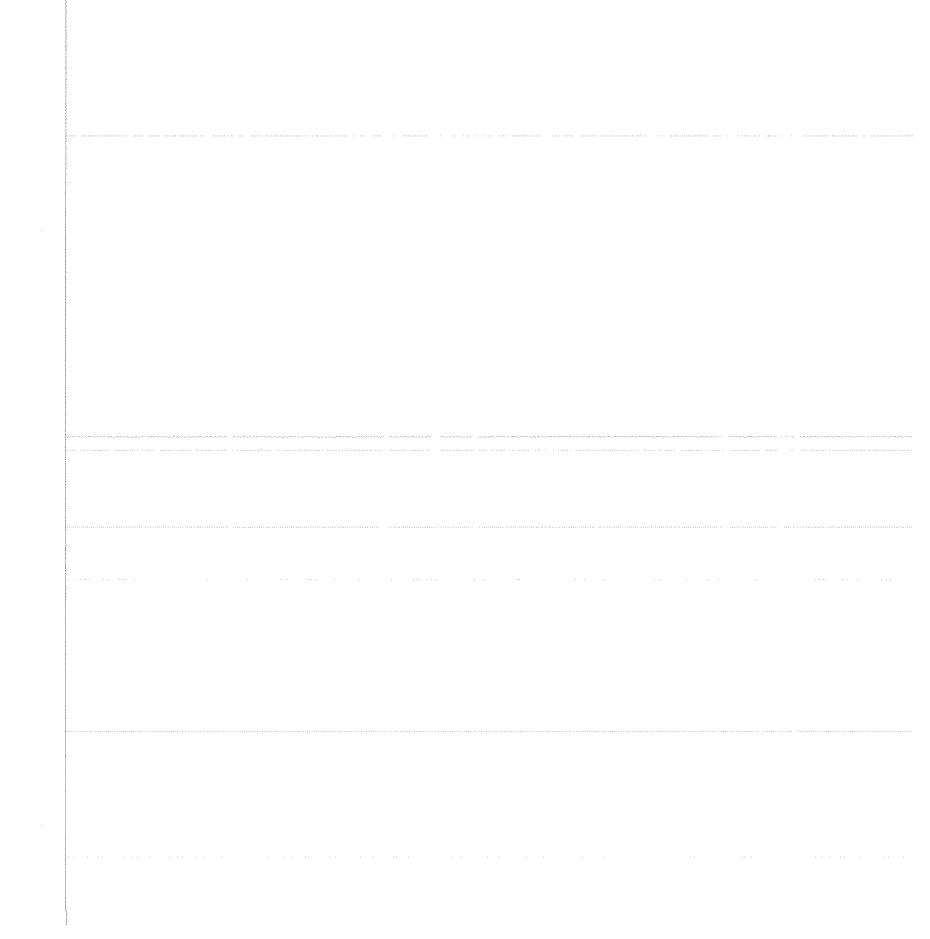
The part of the second of the	4.	i i	ZEI		1.		
(-6.5V) FAIL		l Fi		···			
CORRECT							
PIH .	at .	. d	ત્રી તો	4 4	4 4	4	1 4
STATE 12	'   .   #	1.1.	1 1 1	1. 1.		j.	J. J.
FAIL FIRE	1	i	135 145		1		l"
9 18 14 18		-5	1	1	<u></u>		10
19 28	1	1	1	di M	1		
in the							

I. Measure the voltage on pin 8 and record it under column A of Table 5-2 (line 1). Calculate the **DIFFERENCE** between -6.5V and the voltage recorded in A. For example (Table 5-3), if column A has -6.580, then the **DIFFERENCE** (.080V) is entered in column B. Next, enter 1/2 the difference in the "HALF DIFF" column. In the example this "HALF DIFF" is .040V. In the +V ZERO 1 Adjustment Column, enter the voltage from A plus the "HALF DIFFERENCE". In other words, split the difference between the voltage recorded in Column A and -6.5V by adjusting the +V ZERO 1 pot. In the example, -6.540V is entered. Note that the adjustment to +V ZERO 1 should always bring the output voltage closer to -6.5V level. If the adjustment moves the output further from -6.5V, then a sign error has been made in the calculations. Now that the desired +V ZERO 1 adjustment has been calculated, adjust the +V ZERO 1 pot for that voltage (pin 8).

### m. -V ZERO 1 (+6.5V)

Press ADVANCE TO NEXT FAIL. The following printout will be produced:

- Measure voltage on pin 8 and record in Table 5-2 column A (line 2). Use the same procedure for calculating **DIFFERENCE**, **HALF DIFFERENCE**, and **-V ZERO 1** level as was used in Paragraph 5-19 step (l). Note that in this test, the difference between the measured reading in column A and +6.5V must be calculated. After calculating the **-V ZERO 1** level, adjust **-V ZERO 1** pot for that voltage (pin 8).
- Now that +V ZERO 1 and -V ZERO 1 pots have been adjusted, it is necessary to trim the +V GAIN and -V GAIN levels. Press TEST twice. A "V GAIN (+6.5V)" printout will be produced. Measure the voltage on pin 8 and record in Table 5-2, column A (line 3). Calculate the "MAGNITUDE DIFFERENCE" and enter in column B. In the "MAGNITUDE DIFFERENCE" column, note the two arrows, 1 and 1. Do not worry about the sign of the difference. Instead, use the arrows to indicate if the adjustment should increase (1) or decrease (1) the parameter in question. An example will help: for the +V GAIN (+6.5V) test, suppose a level of 6.542V is measured. This is recorded under column A. The "MAGNITUDE DIFFERENCE" is .042V and the adjustment direction is down (1). Under column B, .042V is entered and the (1) arrow is circled. Make no adjustments at this time.
- p. Press ADVANCE TO FAIL. A "-V GAIN (-6.5V)" printout will be produced. Measure the voltage on pin 8 and record this level under column A of Table 5-2 (line 4). Determine the "MAGNITUDE DIFFERENCE" in the same manner as Paragraph 5-19 step (o). If -6.492V is measured, the "MAGNITUDE DIFFERENCE" is .008V. The direction for the "MAGNITUDE DIFFERENCE" is up (1). Therefore, .008V is recorded and the (4) arrow is circled in the "MAGNITUDE DIFFERENCE" column. Make no adjustments at this time.
- Press ADVANCE TO NEXT FAIL. A "+V ZERO 1 (-6.5V)" printout will be produced. Measure voltage on pin 8. Record level (line 5) and calculate "MAGNITUDE DIFFERENCE" as done in Paragraph 5-19 step (p). Be sure to circle the appropriate arrow. Make no adjustments at this time.
- Press ADVANCE TO NEXT FAIL. A "-V ZERO 1 (+6.5V)" printout will be produced. Measure voltage on pin 8. Record level (line 6) and calculate "MAGNITUDE DIFFERENCE" as done in Paragraph 5-19 step (o). Be sure to circle the appropriate arrow. Make no adjustments at this time.
- The four "MAGNITUDE DIFFERENCE" levels in Table 5-2 are labeled C, D, E, and F. It is now necessary to average these differences and calculate the adjustment required for trimming +V GAIN and -V GAIN.



### t. +V GAIN AVERAGE (line 7)

Take the two "MAGNITUDE DIFFERENCE" readings from C and E of Table 5-2 and add them. Take this sum and divide by 2 to find the "AVERAGE DIFFERENCE". Note that C and E should both have the same arrow direction († or ‡). The "AVERAGE DIFFERENCE" should also have the same arrow as C and E. Take the voltage recorded in column A (line 3) and add or subtract "AVERAGE DIFFERENCE" as necessary to bring this level closer to +6.5V. Press TEST twice. Measure voltage on pin 8 and adjust +V GAIN pot for the calculated level (should be close to +6.5V).

Use the following example for clarity. Refer to the sample chart, Table 5-3. Note that the "MAGNITUDE DIFFERENCES" for C and E are .042  $\downarrow$  and .040  $\downarrow$  respectively. The "AVERAGE DIFFERENCE" is .041V  $\downarrow$ . The +V GAIN (+6.5V) level recorded under column A (line 4) is +6.542V. The adjustment for +V gain is therefore 6.542V +.041V  $\downarrow$  = +6.501V (magnitude addition). In this example, after pressing TEST, the +V GAIN pot is adjusted to produce +6.501V on pin 8.

### u. -V GAIN AVERAGE (line 8)

Press ADVANCE TO NEXT FAIL and adjust the -V GAIN pot for the correct level on pin 8.

Refer to the Sample Test Record, Table 5-3 for an example. The "MAGNITUDE DIFFER-ENCE" is .009V †. The -V GAIN (6.5V) level recorded under column A (line 4) is -6.492V. The adjustment for the -V GAIN pot is therefore 6.492 + .009 † = -6.501V (magnitude addition).

v. It is now necessary to check all 4 levels to insure that the voltage generator is properly aligned. All measurements refer to pin 8.

Press **TEST** twice +**GAIN** (+6.5**V**) Measure +6.5V ±10 mV

Press ADVANCE TO NEXT FAIL -V GAIN (-6.5V)

Measure -6.5V ±10 mV

Press ADVANCE TO NEXT FAIL +V ZERO 1 (-6.5V) Measure -6.5V  $\pm$ 10 mV

Press ADVANCE TO NEXT FAIL -V ZERO 1 (+6.5V)

Measure +6.5V ±10 mV

Note: Make no adjustments at this time.

### w. +V ZERO 2 and -V ZERO 2 Check

Re-checking the  $\pm V$  Zero 2 adjustments is necessary to insure that the voltage generator still has zero offset.

Repeat Paragraph 5-19 steps (a thru e) and readjust if necessary. If the  $\pm V$  Zero 2 pots require adjustment, then, after adjusting, repeat step v above. Then proceed to step x.

x. If any of the limits measured in step v above could not be met, then a second pass at the voltage adjustments must be made. **DO NOT CENTER ANY OF THE POTS!** The second pass uses the same procedure and fine tunes the adjustments. Perform steps f through w under Paragraph 5-19 if a second pass is necessary. Use a new copy of Table 5-2 and proceed as before.

### **Verification of Voltage Adjustments**

After all adjustments have been made, a verification of performance for all pins must be executed. Use the procedure in step v and w to verify voltage levels for all pins. Make measurements on A30 test points 1-24. If necessary, repeat second pass according to Paragraph 5-19 step x.

Final limits for all pins (Test Points 1-24).\*

+V GAIN (+6.5V) +6.5V = 10 mV -V GAIN (-6.5V) -6.5V  $\pm$ 10 mV +V ZERO 1 (-6.5V) -6.5V  $\pm$ 10 mV

-V ZERO 1 (+6.5V) +6.5V ±10 mV

\*Note: For 16-pin instrument, test points 9-16 will have no outputs and should not be measured.

### 5-20. Current Generator Adjustment

### **Equipment Required:**

HP 3465A or equivalent 4-1/2 Digit Current Meter 10  $\mu$ A, 200 mA Ranges

- a. Set front panel switches according to Paragraph 5-17 step (a).
- b. Remove Test Gead cover (if not already done). Connect ammeter ground lead to A30TP25 (marked 4). Set ammeter to measure 10 mA level.
- Center ±1 ZERO 1 and ±1 ZERO 2 pots (if not already done).
- d. Load "CURRENT GEN. PRESET ADJUST". Press TEST. The following printout will be produced:

e. Measure current on pin 8. Adjust +1 ZERO 2 pot to produce 10 mA  $\pm$ 0.2 mA.

f. Press ADVANCE TO NEXT FAIL. The following printout will be produced:

TE	3	T	15 25					IJ		ft	***	in the second		eng I	E	1		free
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	, 104 , 14 5	4																

- g. Measure current on pin 8. Adjust -I ZERO 2 to produce -10 mA  $\pm$ 0.2 mA.
- h. Load "+/-I ZERO 1-2 ADJUST." Press TEST. The following printout will be produced:

- i. Measure current and adjust +I ZERO 1 pot to produce +10  $\mu$ A ±.1  $\mu$ A on pin 8. Then verify that all other pins measure +10  $\mu$ A ±5  $\mu$ A. If necessary, the spec on pin 8 maybe relaxed to +10  $\mu$ A ±5  $\mu$ A to meet tolerance on all other pins.
- j. Press ADVANCE TO NEXT FAIL. The following printout will be produced:

k. Measure current and adjust -I ZERO 1 pot to produce -10  $\mu$ A  $\pm$ .1  $\mu$ A on pin 8. Then verify that all other pins measure -10  $\mu$ A  $\pm$ 5  $\mu$ A. If necessary, the spec on pin 8 may be relaxed to -10  $\mu$ A  $\pm$ 5  $\mu$ A to meet tolerance on all pins.

Press ADVANCE TO NEXT FAIL. The following printout will be produced:

- m. Measure current and adjust +1 **ZERO 2** pot to produce +10  $\mu$ A ±.1  $\mu$ A on pin 8. Then verify that all other pins measure +10  $\mu$ A ±2.5  $\mu$ A. If necessary, the spec on pin 8 may be relaxed to +10  $\mu$ A ±2.5  $\mu$ A to meet tolerance on all pins.
- n. Press ADVANCE TO NEXT FAIL. The following printout will be produced:

- o. Measure current and adjust -I ZERO 2 pot to produce - $10\mu$ A  $\pm$ .1 on pin 8. Then verify that all other pins measure - $10\mu$ A  $\pm$ 2.5  $\mu$ A. If necessary, the spec on pin 8 may be relaxed to - $10\mu$ A  $\pm$ 2.5  $\mu$ A to meet tolerance on all pins.
- p. VERIFICATION OF CURRENT ADJUSTMENTS

Verify that limits are met for all pins.

Note: This step may be deleted if all limits were met under steps h through j above.

Press TEST +1 Zero 1 +10 -A Verify:  $10 \mu A \pm 5 \mu A$ 

Press ADVANCE TO NEXT FAIL -1 ZERO 1 -10  $\mu$ A Verify -10  $\mu$ A  $\pm$ 5  $\mu$ A for all pins.

### p. VERIFICATION OF CURRENT ADJUSTMENTS (Continued)

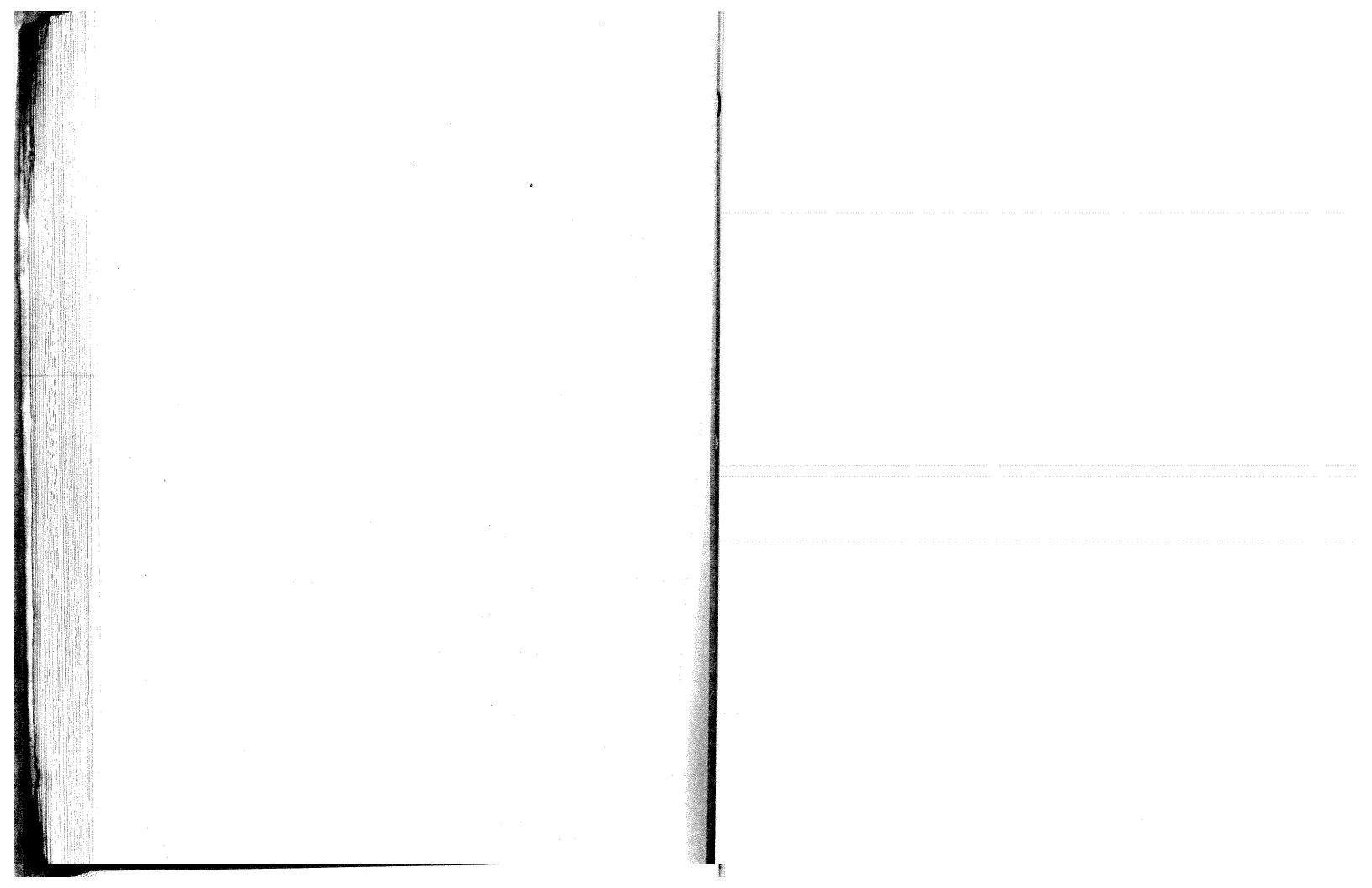
Press ADVANCE TO NEXT FAIL +1 Zero 2 +10  $\mu$ A Verify +10  $\mu$ A ±2.5  $\mu$ A for all pins.

Press ADVANCE TO NEXT FAIL -1 ZERO 2 -10  $\mu$ A Verify -10  $\mu$ A  $\pm 2.5~\mu$ A for all pins.

If all limits cannot be met, then repeat steps h through p above as many times as necessary. DO NOT center the pots when making a second pass through the adjustments.

5-21. Successful completion of the DAC Reference Adjustment, Voltage Generator Adjustment, and Current Generator Adjustment results in proper calibration of the A11 Reference Level Generator (DAC). All Performance Tests should be run in order to verify instrument specs.

Table 5-2. Blank Test Aid



## SECTION VI REPLACEABLE PARTS

### 6-1. INTRODUCTION

- 6-2. This section contains information for ordering replacement parts. Table 6-1 lists parts in alphanumerical order of their reference designators and indicates the description and HP Part Number of each part, together with any applicable notes. The table includes the following information.
  - a. Description of part (see abbreviations below)
  - b. Typical manufacturer of the part in a five-digit code; see list of manufacturers in Table 6-2.
  - c. Manufacturer's part number.
  - d. Total quantity used in the instrument (Qty column).

REFERENCE DESIGNATIONS  TP = test point mechanical part	
assembly E = micellaneous electrical mechanical part U = integrated of microcircuit termination F = fuse	
attenuator; isolator; termination F. = fuse P = electrical connector   microarical part   mechanical part   without   microarical part   mechanical part   without   microarical part   microarical part   without   microarical part   micr	
termination F: = fuse P: = electrical connector microcirculity    Example   File   Fil	cuit;
### stan: motor   FL   = filter	
BT	
capacitor Hy = circulator Q = transistor; SCR; triode breakdown thyristor waractor jack RT = thermistor X = socket path; wire socket RT = thermistor X = socket RT = thermistor Y = crystal unit-delay line. K = reisy T = transformer = transformer = transformer = thermistor RD = transformer = transformer = transformer = thermical board RD = transformer	ator;
compler	ode (
### Second Company Provided Register   Stationary Provided Reg	ission
varactor  directional coupler  delay line  annunciator; signaling	
### dispersional coupler   S	
### delay line   ### annunciator; signaling   ### device (audible or   ### wisual); lamp; LED  ### ampere   ### alternating current   ### BCD   ### binder head   ### complementary transition   ### authomatic gain: control   ### BP   ### bandpass filter   ### authomatic gain: control   ### BP   ### binder head   ### binder head   ### complementary transition   ### authomatic gain: control   ### authomatic gain: control   ### BP   ### binder head   ### binder head   ### complementary transition   ### authomatic gain: control   ### authomatic gain: control   ### authomatic gain: control   ### binder head   ### binder head   ### binder head   ### complementary transition   ### authomatic gain: control   ### binder head   ### binder head   ### complementary transition   ### authomatic gain: control   ### authomatic gain: control   ### binder head   ### binder head   ### complementary transition   ### authomatic gain: control   ### binder head   #### complementary transition   #### authomatic gain: control   #### authomatic gain: control   #### binder head   #### complementary transition   ##### complementary transition   ##### authomatic gain: control   ##### BPF   ##### binder head   ######### CM   ######################	iezo-
annunciator; signaling device (audible or visual); lamp; LED  ABBREVIATIONS  ABUTOMS COMPL = composition	
ABBREVIATIONS   ABBREVIATIONS	tuned:
ABBREVIATIONS  **ampere** **alternating current** **BCD** **accessory** **BCU** **apolition** **BCU** **apolition** **accessory** **BECU** **apolition** **BCD** **apolition** **COMPL** **complete** **DEPC** **adector** **DET** **adector** **CONN** **connector** **DET** **adector** **adium plate** **diam = diameter* **CRT** **cathode-ray tube** **DIA** **adiameter (to parts list)* **autionatic frequency** **BKDN** **binder head** **CTL** **autionatic requency** **BKDN** **binder head** **CTL** **autionatic requency** **BKDN** **binder head** **CTL** **complementary transistor logic** **sistor logic** **DIFF** **autionatic requency** **BKDN** **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**  **BP**  **autionatic gain control**	
# ampere	
######################################	
######################################	
### Stemating current BD = board COMPL = complete DEPC = deposited of complete accessory BE CU = beryllium copper CONN = connector DET = detector	ın
accessory  BE CU = beryllium copper  CONN = connector  DET = detector  addisstment BFO = beat frequency  CP = cadmium plate diam = diameter  CRT = cathode-ray tube  DIA = diameter (t  parts list)  automatic frequency  BKDN = binder head  CTL = complementary transistor logic  DIFF  control  BP = bandpass  CW = continuous wave  AMPL = differential  automatic gain control  BPF = bandpass filter  automatic gain control  BPF = bandpass filter  automatic sevel control  BPF = bandpass  D/A = digital-to-analog  DPDT = double-po  throw  automatic level control  BWO = backward-wave  BWO = backward-wave  dB = decibel  amplifier  CAL = calibrate  TimW DSB = double side  CONN = connector  DET = detector  cadmium plate diam = diameter (t  parts list)  CTL = complementary transistor logic  DIFF  control  BPF = bandpass  CW = continuous wave  AMPL = differential  div = division  div = division  To division  CAL = calibrate  DR = drive  DSB = double side	arbon
### adjustment   BFO   = beat frequency   CP   = cadmium plate   diam   = diameter	
**analog-to-digital oscillator CRT = cathode-ray tube DIA = diameter (to parts list)  **audio frequency BH = binder head CTL = complementary transistor logic DIFF  **control BP = bandpass CW = continuous wave AMPL = differential  **automatic frequency BKDN = breakdown Sistor logic DIFF  **control BP = bandpass CW = continuous wave AMPL = differential  **automatic gain control BPF = bandpass filter cw = clockwise div = division  **automatic level control BWO = backward-wave dB = decibel	
** submatic frequency BKDN = breakdown sistor logic DIFF  control BP = bandpass CW = continuous wave AMPL = differential  ** automatic gain control BPF = bandpass filter cw = clockwise div = division  ** automatic gain control BPF = bandpass filter bandpass filter bandpass filter cw = clockwise div = division  ** automatic level control BPF = bandpass filter bandpass filter cw = clockwise div = division  ** automatic fequency BKDN = bandpass CW = continuous wave AMPL = differential  ** automatic gain control BPF = bandpass filter cw = clockwise div = division  ** automatic fequency BKDN = bandpass CW = continuous wave AMPL = differential  ** automatic gain control BPF = bandpass filter cw = clockwise div = division  ** automatic gain control BPF = bandpass filter cw = clockwise div = division  ** automatic gain control BPF = bandpass filter cw = clockwise div = division  ** automatic gain control BPF = bandpass filter cw = clockwise div = division  ** automatic gain control BPF = bandpass filter cw = clockwise div = division  ** automatic gain control BPF = bandpass filter cw = clockwise div = division  ** automatic gain control BPF = bandpass filter cw = clockwise div = division  ** automatic gain control BPF = bandpass filter cw = clockwise div = division  ** automatic gain control BPF = bandpass filter cw = clockwise div = clockwise	ed in
### Sutomatic frequency BKDN = breakdown sistor logic.    Control	
control BP = bandpass CW = continuous wave AMPL = differential  **Butomatic gain control BPF = bandpass filter cw = clockwise div = division  **Butomatic gain control BPF = bandpass filter cw = clockwise div = division  **Butomatic sevel control BBS = brass D/A = digital-to-analog DPDT = double-po  **Butomatic sevel control BWO = backward-wave dB = decibel  **Butomatic sevel control BWO = braskward-wave dB = decibel  **Butomatic sevel control BWO = braskward-wave dB = decibel  **Butomatic spain control BPF = bandpass filter cw = clockwise div = division  **Butomatic spain control BPF = bandpass filter cw = clockwise div = division  **Butomatic spain control BPF = bandpass filter cw = clockwise div = division  **Butomatic spain control BPF = bandpass filter cw = clockwise div = division  **Butomatic spain control BPF = bandpass filter cw = clockwise div = division  **Butomatic spain control BPF = bandpass filter cw = clockwise div = division  **Butomatic sevel control BPF = bandpass filter cw = clockwise div = division  **Butomatic sevel control BWO = backward-wave dB = decibel  **Butomatic sevel control BPF = bandpass filter cw = clockwise div = division  **Butomatic sevel control BPF = bandpass filter cw = clockwise div = division  **Butomatic sevel control BPF = bandpass filter cw = clockwise div = clockwise division  **Butomatic sevel control BPF = bandpass filter cw = clockwise division  **Butomatic sevel control BPF = bandpass filter cw = clockwise division  **Butomatic sevel control BPF = bandpass filter cw = clockwise division  **Butomatic sevel control BPF = bandpass filter cw = clockwise division  **Butomatic sevel control BPF = bandpass filter cw = clockwise division  **Butomatic sevel control BPF = bandpass filter cw = clockwise division  **Butomatic sevel control BPF = bandpass filter cw = clockwise division  **Butomatic sevel control BPF = bandpass filter cw = clockwise division  **Butomatic sevel control BPF = clockwise division  **Butomatic sevel control BPF = clockwise division  **Butomatic seve	
# sutomatic gain control BPF = bandpass filter cw = clockwise div = division  # summum BRS = brass D/A = digital-to-analog DPDT = double-po  # sutomatic level control BWO = backward-wave dB = decibel throw  # amplitude modulation oscillator dBm = decibel referred to DR = drive  # supplifier CAL = calibrate 1 mW DSB = double side	amplifier
# automatic level control BWO = backward—wave dB = decibel throw throw dBm = decibel referred to DR = drive amplifier CAL = calibrate 1 mW DSB = double side	
# Sutomatic level control BWO = backward-wave dB = decibel throw  # Amplitude modulation oscillator dBm = decibel referred to DR = drive  # Amplifier CAL = calibrate 1 mW DSB = double side	a, double-
*** *** *** *** *** *** *** *** *** **	
CAL = calibrate 1 mW DSB = double sid	
ONL Canbrato	band
* automatic phase ccw = counterclockwise dc = direct current DTL = diode trans	istor logic
CER = correction deg = degree (temperature DVM = digital volt	
interval or difference) ECL = emitter co	
cm = centimeter ° = degree (plane angle) EMF = electromot	
Porrage Celsius EDP = electronic	iata
**************************************	
COM = common	

6-1

A ALLEGE ENACH



### ABBREVIATIONS (CONTINUED)

		in	= minute (time)	PIV	= peak inverse voltage		thin-film trans toggle	sistor
ENCAP	= encapsulated		minute (plane angle)	pk	= peak		thread	
EXT	= external		= miniature	PL.	= phase lock		through	
F	= farad = field-effect transistor		= millimeter	PLO	= phase lock oscillator = phase modulation	****	titanium	
FET	= flip-flop	.,	= modulator	PM PNP	= positive-negative-		tolerance	
F/F FH	= flat head	14(0)41	= mornentary	FINE	positive	- 1	trimmer	
FOLH	= fillister head	MOS	= metal-oxide semi-	P/O	= part of		transistor	
FM	= frequency modulation		conductor = millisecond	POLY	= polystyrene	TTL =	transistor-tran	nsistor
FP	= front panel	1110	= mounting	PORC	= porcelain	<u></u> .	logic	
FREQ	= frequency		= meter (indicating	POS	= positive; position(s)		television television inte	erference
FXD	= fixed	MITT	device)		(used in parts list)		traveling wave	
9	= gram	mV	= millivoit	POSN	= position		micro (10 <sup>-6</sup> ) (	
GE	⇒ germanium = gigahertz	mVac	= millivolt, ac	POT	= potentiometer = peak-to-peak	•	parts list)	
GHz GL	= glass	mVdc	= millivolt, dc	p-p PP	= peak-to-peak (used in	UF =	microfarad (u	ised in
GND	= ground(ed)	mVpk	= millivolt, peak	t. t.	parts list)		parts list)	
H	= henry	mVp−p	= millivolt, peak-to-peak	PPM	= pulse-position	•	ultrahigh freq	quency
h	≃ hour	mVrms	= millivolt, rms = milliwatt		modulation		unregulated	
HET	= heterodyne	mW MUX	= multiplex	PREAMPL	= preamplifier		= volt	
HEX	= hexagonal	MUX MY	= mylar	PRF	= pulse-repetition		<ul> <li>voltampere</li> <li>volts ac</li> </ul>	
HD	= head	MA	= microampere		frequency		= variable	
HDW	= hardware	μF	= microfarad	PRR	= pulse repetition rate		= voltage-cont	rolled
HF	= high frequency = mercury	μΗ	= microhenry	ps	= picosecond = point		oscillator	
HG	= high	μmho	= micromho	PT PTM	= point = pulse-time modulation	Vdc	= volts dc	
HP	= Hewlett-Packard	μs	= microsecond	PWM	= pulse-width modulation	VDCW	= volts dc, wor	king (used
HPF	= nigh pass filter	μ∨	= microvolt	PWV	= peak working voltage		in parts list)	
HR	= hour (used in parts list)	µVac	= microvoit, ac	RC	= resistance capacitance		<ul> <li>volts, filtered</li> </ul>	
HV	= high voltage	μVdc	= microvolt, dc = microvolt, peak	RECT	= rectifier	VFO	= variable-freq	uency
Hz	= Hertz	μVpk	= microvolt, peak-to-	REF	= reference	1 10 25	oscillator = very-high fre	augney .
IC	= integrated circuit	μ∨р-р	peak	REG	= regulated		= very=mgn ne = volts peak	pquency
ID	= inside diameter	μVrms	= microvolt, rms	REPL	= replaceable	. 5	= Volts peak-to	o-peak
117	= intermediate frequency	μW	= microwatt	RF	= radio frequency	* F *	= voits rms	
IMPG	= impregnated	nA	= nanoampere	RFI	<ul> <li>radio frequency interference</li> </ul>		= voltage stand	ding wave
in	= inch = incandescent	NC	= no connection	m) i	= round head; right hand		ratio	
INCD	= include(s)	N/C	<ul> <li>normally closed</li> </ul>	RH RLC	= resistance-inductance-	VTO	= voltage-tune	
INCL	= input	NE	= neoñ	NLO	capacitance	VTVM	= vacuum-tub	
INS	= insulation	NEG	= negative = nanofarad	RMO	= rack mount only	V(X)	= volts, switch	ed
INT	= internal	nF	= nickel plate	rms	= root-mean-square	W	= watt	
kg	= kilogram	NI PL N/O	= normally open	RND	= round	W/	with     working inventor     working inve	orga voltade
kHz	= kilohertz	NOM	= nominal	ROM	= read-only memory	ww ww	= wirewound	2126 101691
kΩ	= kilohm	NORM	= normal	R&P	= rack and panel	W/O	= without	
kV	= kilovolt	NPN	= negative-positive-	NWV	<ul> <li>reverse working voltage</li> <li>scattering parameter</li> </ul>	YIG	= yttrium-iron	-garnet:
lb . C	<ul> <li>pound</li> <li>inductance-capacitance</li> </ul>		negative	S	= second (time)	Zo	= characteristi	
LC LED	= light-emitting diode	NPO	<ul> <li>negative-positive zero</li> </ul>	s "	= second (plane angle)		impedance	
LF	= low frequency		(zero temperature	s-8	= slow-blow (fuse (used			
LG	= long		coefficient) = not recommended for	0.0	in parts list)			
LH	= left hand	NRFR	field replacement	SCR	<ul> <li>silicon controlled</li> </ul>		NOTE	
LIM	= limit	NSR	= not separately		rectifier; screw			
LIN	= linear taper (used in	19313	replaceable	SE	= selenium	Allabbr	eviations in the	partsiisi
	parts list)	ns	= nanosecond	SECT	= sections	will be i	in upper case.	. 3
lin	= linear SH = lockwasher	nW	= nanowatt	SEMICO	N = semiconductor = superhigh frequency			8
LK WAS	= low; local oscillator	OBD	<ul> <li>order by description</li> </ul>	SHF	= silicon			
LO LOG	= logarithmic taper	OD	<ul> <li>outside diameter</li> </ul>	SI SIL	= silver			
100	(used in parts list)	OH	= oval head	SL	= stide			
log	= logarithm(ic)	OP AMPL		SNR	= signal-to-noise ratio		ULTIPLIE	:as
LPF	= low pass filter	OPT	= option = oscillator	SPDT	= single-pole, double-	M		.,,,
LV	= low voltage	osc ox	= oxide		throw			
a m	= meter (distance)	oz	= ounce	SPG	= spring	Abbrevia	ition Prefix	Multipie
mA.	= milliampere	Ω	= ohm	SR	= split ring		tera	1012
MAX	= maximum	P	= peak (used in parts	SPST	= single-pole, single-	T G	giga	10°
MΩ	= megohm = meg (10°) (used in		list)	202	throw sideband	M	mega	10*
MEG	parts list)	PAM	= puise-amplitude	SSB SST	= single sideballd = stainless steel	k	kilo	103
MET F	•		modulation	STL	= steel	da	deka	10 10 <sup>-1</sup>
MET C		PC	= printed circuit		= square	d	deci	10 **
MF	= medium frequency;	PCM	<ul> <li>pulse-code moudulation;</li> <li>pulse-count modulation</li> </ul>	SWR	= standing-wave ratio	c	centi	10-3
1	microfared (used in	nns.	= pulse-duration	-SYNC	= synchronize	m	milli	10**
to the same of the	parts list)	PDM	= pulse-duration modulation	T	= timed (slow-blow fuse)		micro nano	10-*
MFR	= manufacturer	pF	= picofarad	TA	= tantalum	n	pico	10-12
mg	= milligram	PH BRZ	= phosphor bronze	TC	= temperature	p f	temto	10-16
MHz	= megahertz = millihenry	PHL	= Phillips		compensating	a	atto	. 10-18
mH	= millihenry = mho	PIN	= positive-instrinsic-	TD	= time delay = terminal	a	-	7696
mho	= minimum		negative	TERM	- voration		Manager of the latest of the l	

6-2

### 6-3. ORDERING INFORMATION

- 6-4. To obtain replacement parts, address order of inquiry to your local Hewlett-Packard Sales and Service Office (see lists at rear of this manual for addresses). Identify parts by their Hewlett-Packard part numbers.
  - a. Instrument model number.
  - b. Instrument serial number.
  - c. Description of the part.
  - d. Function and location of the part.

### 6-5. HP PART NUMBER ORGANIZATION

6-6. Following is a general description of the HP part number system.

### 6-7. Component Parts and Materials

6-8. Generally, the prefix of HP part numbers identifies the type of device. Eight digit part numbers are used, where the four digit prefix identifies the type of component, part, or material and the four digit suffix indicates the specific type. Following is a list of some of the more commonly used prefixes for component parts. The list includes HP manufactured parts and purchased parts.

Prefix	Component/Part/Material
0121–	Capacitors, Variable (mechanical)
0122-	Capacitors, Voltage Variable (semiconductor)
0140-	Capacitors, Fixed
0150-	Capacitors, Fixed - Non-Electrolytic
0160-	Capacitors, Fixed
0180-	Capacitors, Fixed Electrolytic
0330-	Insulating Materials
0340-	Insulators, Formed
0370-	Knobs, Control
0380-	Spacers and Standoffs
0410-	Crystals
0470-	Adhesives
0490-	Relays
0510-	Fasteners
0674- thru 0778-	Resistors, Fixed (non wire wound)
0811- thru 0831-	Resistors (wire wound)
1200-	Sockets for components
1205–	Heat Sinks
1250-	Connectors (RF and related parts)
1251–	Connectors (non RF and related parts)
1410-	Bearings and Bushings
1420-	Batteries
1820-	Monolithic Digital Integrated Circuits
1826–	Monolithic Linear Integrated Circuits
1850–	Transistors, Germanium PNP
1851–	Transistors, Germanium NPN
1853–	Transistors, Silicon PNP
1854_	Transistors, Silicon NPN
1855-	Field-Effect-Transistors
1900- thru 1912-	Diodes

Prefix	Component/Part/Material	
1920- thru 1952- 1990- 3100- thru 3106- 8120- 9100-	Vacuum Tubes Semiconductor Photosensitive and Light-Emitting Diodes Switches Cables Transformers, Coils, Chokes, Inductors, and Filters	,

6-9. For example, 1854-0037, 1854-0221, and 1851-0192 are all NPN transistors. The first two are silicon and the last is germanium.

## 6-10. General Usage Parts

6-11. The following list gives the prefixes for HP manufactured parts used in several instruments, e.g., side frames, feet, top and bottom covers, etc. These are eight-digit part numbers with the four-digit prefix identifying the type of parts as shown below:

Type of Part	Prefix
Sheet Metal	5000- to 5019-
Machined	5020- to 5039-
Molded	5040- to 5059-
Assemblies	5060- to 5079-
Components	5080- to 5099-

# 6-12. Specific Instrument Parts

6-13. These are HP manufactured parts for use in individual instruments or series of instruments. For these parts, the prefix indicates the instrument and the suffix indicates the type of part. For example, 05328-60001 is an assembly used in the 5328A. Following is a list of suffixes commonly used.

Type of Part	P/N Suffix
Sheet Metal Machined Molded Assembly Component Documentation	-00000 to -00499 -20000 to -20499 -40000 to -40499 -60000 to -60499 -80000 to -80299 -90000 to -90249

mayor and a second		

Table 6-1. Replaceable Parts

	Reference Designation	HP Part Number	C	Qty	Description	Mfr Code	Mfr Part Number
<b>-</b>	Al	05045=60001	6	1	BOARD ASSEMBLY, -15V/18V REGULATOR (SERIES 1852)	26480	ŋ <b>5</b> ყ <b>45∝6</b> ჟ∪ყ <b>1</b>
	A1G1 A1C2 A1C3 A1C4 A1C5	0180 m 0 5 7 8 0150 m 0 1 2 i 0180 m 1 7 3 5 0180 m 0 1 1 7 0180 m 0 1 1 7	20222	1 11 4 2	CAPACITOR=FXD 750UF+75=10% 40VOC AL CAPACITOR=FXD ,1UF +800=20% 50VDC CER CAPACITOR=FXD ,22UF+=10% 35VDC TA CAPACITOR=FXD 2,7UF+=10% 35VDC TA CAPACITOR=FXD 2,7UF+=10% 35VDC TA	56289 56289 56289 56289	39D757G0406L4 0150-0121 15002244903542 1500275X903582 1500275X903582
	A:C6 A:C7 A:C8 A:C9	0160*0127 0160*1735 0160*0127 0150*0121	SES	29	CAPACITOR*FXD 1UF +*20% 25VDC CEP CAPACITOR*FXD .22UF+*10% 35VDC TA CAPACITOR*FXD 1UF +*20% 25VDC CER CAPACITOR*FXD .1UF +80*20% 50VOC CER	28480 56289 28480 28480	0160*0127 1500224X9035A2 0160*0127 0150*0121
	AICRI AICRE	1901-0638 1901-0638	3	3	DIODE=FW BRDG 100V 4A DIODE=FW BRDG 100V 4A	04713 04713	MDA=970≃2 MDA=970≃2
	AIR1 AIR2	0698-0083 2100-1757	5 9	5	RESISTOR 1.96K 1% .125W F TC=0+=100 RESISTOR=TRMR 500 5% WW SIDE-40J 1-TRM	24546 28480	C4@1/8@10@1961@F 2100#1757
	A:TP: A:TP: A:TP: A:TP:	0360+1662 0360+062 0360+062 0360+062	0 0 0	00	TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG	\$8486 \$8480 \$8480 \$8480	03c0*)c5d 03c0*16d2 03c0*16d2 03c0*16d2
-	1014 102 103 103 104	1626-0233 1626-0126 1626-0169 1626-0203	4 4 5 8	1 1 1	IC V RGLTR TO=3 IC 7818 V RGLTR TO=3 IC V RGLTR TO=3 IC 7815 V RGLTR TO=3	27014 04713 27014 07263	LM220K≈15 MC7816CK LM32UK≈15 7815KC
		0340=0596 1205=0291 1480=0116 4040=0749	8 8	12 5 26 4	INSULATOR-XSTR SIL-RBR HEAT SINK TO-3-PKG PIN-GRV .062-IN-DIA .25-IN-LG STL EXTR-PC BD BRN POLYC .062-BD-THKNS	28480 28480 28480 28480	0340-0590 1205-0291 1480-0116 4040-0749
		05045-60002	7	i	BOARD ASSEMBLY, 7.5/12V REGULATOR (SERIES 1852)	28489	@5045 <b>~</b> 6U0U2
	A2C1 A2C2 A2C3 A2C4 A2C5	0160=0127 0180=0197 0180=0197 0160=0127 0180=1735	2882	(gr)	CAPACITOR-FXD 1UF +-20% 25VDC CER CAPACITOR-FXD 2,2UF+-1U% 20VDC TA CAPACITOR-FXD 2,2UF+-1U% 20VDC TA CAPACITOR-FXD 1UF +-20% 25VDC CER CAPACITOR-FXD ,22UF+-1U% 35VDC TA	26489 56289 56289 26489 86889	0160*0127 1500225X9020A2 1500225X9020A2 0160*0127 1500224X903542
	1266 1267 1268	0150=0121 0180=1735 0150=0121	5 2 5	**************************************	CAPACITOR-FXD .1UF +80-20% SOVOC CER CAPACITOR-FXD .22UF+=10% 35VDC TA CAPACITOR-FXD .1UF +80-20% 50VDC CER	28480 56289 28480	0150-0121 1500224x9035A2 0150-0121
	A2CR1	1901=0638	3		DIDDE=FW BRDG 100V 4A	64713	MDA#970=2
	4281 4282 4283 4284	0757-0284 2100-1755 2100-1755 0698-3443	0 0	2	RESISTOR 150 1% .125 W F TC#0+-100 RESISTOR-TRMR 100 5% WW SIDE-ADJ 1-TRN RESISTOR-TRMR 100 5% WW SIDE-ADJ 1-TRN RESISTUR 287 1% .125 W F TC#0+-100	24546 28480 284546	C4-1/8-70-151-F 2100-1755 2100-1755 C4-1/8-10-287*-F
	A219; A2192 A3193 A2194	0360=1682 0360=1682 0360=1682 0360=0360	0 0 0	1	TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG	26480 26480 26480 26480	U560*168d U560*168d 0560*168d 0560*168d
	4201 4202 4203 4204	1826=0160 1826=0235 1826=0117 1826=0202	6 3 7	1	IC V RGLTR TO-3 IC V RGLTR TO-3 IC 7812 V RGLTR TG-3 IC V RGLTR TO-3	07263 27014 07263 27014	1809KC LM320K-12 7612KC LM320K-13
		0340+0596 1205+0290 1205+0291 1460+0116 4040+0750	1 7 8 6 7	1	INSULATOR=XSTR SIL=RBR HEAT SINK TO-3-PKG HEAT SINK TO-3-PKG PIN-GRY .062-N1-DIA .25-IN-LG STL EXTR-PC BO RED POLYC .062-RD-IHKNS	26480 26480 26480 26480	0349=0590 1205=0290 1205=0291 1480=0115 4040+0750
	er individual de la companya de la c	1205=0381	7	1	MEAT SINK SGL TO-3-CS	1016t	5426
		05045-60003	A	5	BOARD ASSEMBLY, +5/18V REGULATOR (SERTES 1520)	58480	05045+64483
	A1C2 A1C2 A1C3 A1C4 A3C4 A3C4	0160=3456 0160=3879 0160=0127 0180=0155 0160=0574	67 2 8 3	3	CAPACITOR-FXD 1000PF +-10% 1% VOC CER CAPACITOR-FXD .01UF +-20% 100VDC CER CAPACITOR-FXD 1UF +-20% 25VDC CER CAPACITOR-FXD 2.2UF20% 20VDC TA CAPACITOR-FXD .02UF +-20% 100VDC CEF	28480 25480 28480 56289 28480	0160-3475 (t60-3479 0160-0127 1500225X0020A2 0160-0574
þ		0160=0127 0180=0116 0180=1912	1 7	4	CAPACITOPHEND THE +-20% 25VDC CER CAPACITORHEND 6. BUF++10% 35VDC 14 CAPACITORHEND 12000F+75+10% BUDG AL	20289 20586 20586	0150=0127 150D685×903582 3901286000FJ4

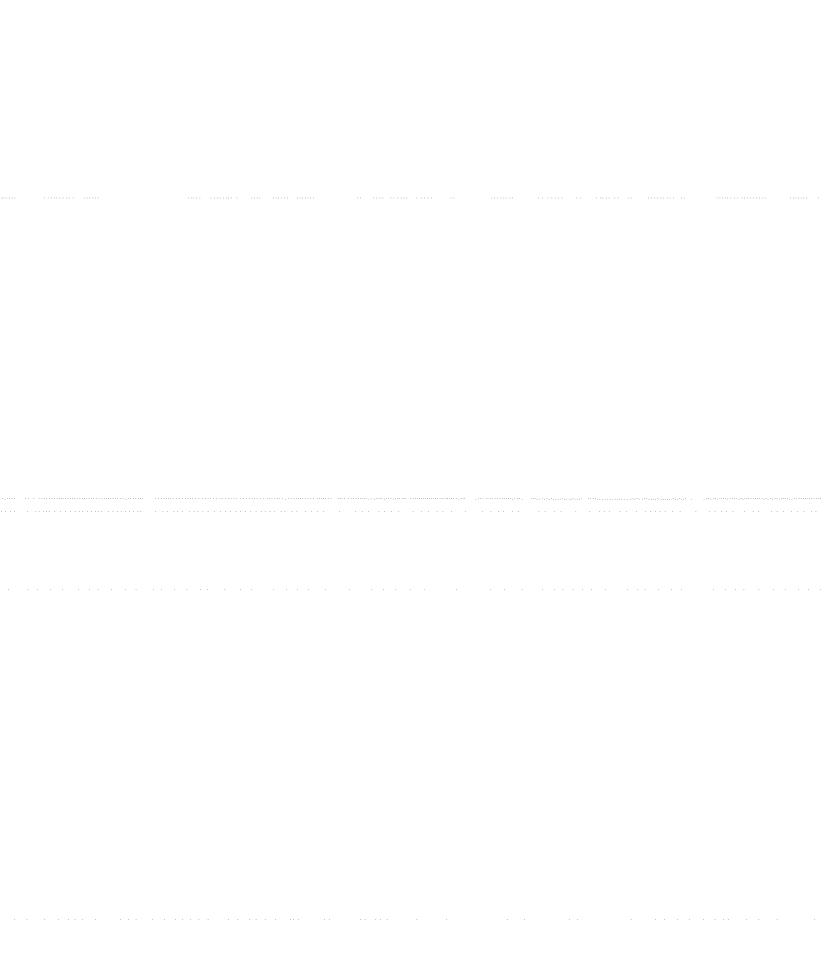


Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part Number	C	Qty		Vifr Code	Mfr Part Number
Designation  3CR1 3CR2 3CR3 3CR4	1901-0033 1902-3036 1902-3036 1902-0079 1901-0040	2 3 3 8 1	2 .	DIDDE-GEN PRP 180V 200MA U0-7 DIDDE-ZNR 3.16V 5% D0-7 PD=.4W TC=964% DIDDE-ZNR 3.16V 5% D0-1 PD=.4W TC=064% DIDDE-ZNR 20V 2% D0-14 PD=.4W TC=+.08% DIDDE-SWITCHING 30V 50MA 2NS D0-35	28480 28480 28480 28480 28480	{901=0033 {902=3030 {902=3030 {902=3036 {902=0079 {901=0040
ABG1	1884-0217	6	1	THYRISTOR-TRIAC TRANSISTOR NPN 2N6282 ST TO-3 PD=160M	04713	MAC-1004 2N6282
A 3 R 1 A 3 R 2 A 3 R 3 A 3 R 3 A 3 R 3 A 3 R 5	1854-0671 0757-0921 0757-0948 0757-0948 0757-0948 0757-0948	90204	15	RESISTOR 750 2% .125% F IC=0+=100 RESISTOR 10K 2% .125% F IC=0+=100 RESISTOR 2.2K 2% .125% F IC=0+=100 RESISTOR 10K 2% .125% F IC=0+=100 RESISTOR 10K 2% .125% F IC=0+=100	24546	Cq=1/8=F0=751=6 C4=1/8=f0=1002=6 C4=1/8=f0=201=6 C4=1/8=70=1002=6 C4=1/8=70=101=6 C4=1/8=F0=471=6
ASR6 ASR7 ASR8 ASR8 ASR10	0757-0916 0757-0916 0811-3333 0757-0961 0811-3332	2 2 9 7 8	2 1	RESISTOR 470 2% .125W F TC=0+-100 RESISTOR 470 2% .125W F TC=0+-100 RESISTOR .05 3% 2W PRW TC=0+-150 RESISTOR 36K 2% .125W F TC=0+-100 RESISTOR .025 1% 5W PW TC=0+-150	24546 28480 24546 26480	Calibaio-471-6 UB1-3333 Calibaio-8002-6 UB11-3332 E81005
A3R11 A3R12 A3R13	0686-1005 0811-3333 2100-1757 0757-0913	1 9 2 9	1	RESISTOR 10 5% .5w CC YC=0+412 RESISTOR .05 3% 2W PWW TC=0+150 RESISTOR=TRMR 500 5% WW SIDE=ADJ 1=TRN RESISTOR 360 2% .125W F TC=0++100	28480 28480 24546	0611=3333 2100=1757 C4=1/8=10=361=G
A3R14 A3TP1 A3TP2 A3TP3	0360=1682 0360=1682 0360=1682	0 0 0		TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG	28480 28480 28480	0,560=1662 0360=1662 0360=1662
A31P4 A3U3 A3U2 A3U3	1820=0439 1820=0216 1826=0202	0 1 7	4 4	IC V RGLTR 14-DIP-P OP A-P GP 8-DIP-P IC V PGLTR TO-3	07263 28480 27014 28480	723PC 1020=021b L=05 0340=0596
4343	0340=0596 1205=0266 1205=0291 1480=0118 4040=0751	1 7 8 8 8 8	1	INSULATOR-XSTR SIL-RBR HEAT SINK SGL TG-3-PKG HEAT SINK TG-3-PKG HEAT SINK TG-3-PKG PEN-GRY .062-IN-OIA .25-IN-LG STL EXTR-PC BD URN POLYC .062-BD-THKNS	28480 28480 28480 28480	1205-0200 1205-0291 1800-0116 4080-0751
A4	05045-6000	4 9	1	BOARD ASSEMBLY, ARITHMETIC LOG (SERIES 1520)	28480	05045-60004
AgCi	0180+0210	6	10		56289 24546	1500335X0U15A2 C4-1/8-10-5101-G
4481 4482	0757=0941 0757=0941 0757=0941	40, 81, 81	30	RESISTOR 5.1K 2% .125W F 1C=0+-100 RESISTOR 5.1K 2% .125W F 1C=0+-100 RESISTOR 5.1K 2% .125W F 1C=0+-100	24546 24546	C4-1/8-T0-5101-G C4-1/8-T0-5101-G
4401 4401 4402 4403 4405	1820=0077 1820=0368 1820=0368 1820=0368 1820=0328		16	IC SHP-RGTR TIL R-S PRL-IN PRL-OUT S-BIT IC SHF-RGTR TIL R-S PRL-IN PRL-OUT S-BIT IC SHF-RGTR TIL R-S PRL-IN PRL-OUT S-BIT IC GATE TIL NON GUAD Z-INP	01295 01295 01295 01295 01295	5N7474N 3N7496N 5N7496N 5N7496N 5N7402N
A4U6 A4U7 A4U8 A4U9 A4U10	1820-0545 1820-0629 1820-0606 1820-0077 1820-0782		3 2	IC CNTR TTL BIN UP/DOWN SYNCHRO IC FF TTL S J-K NEG-EDGE-TRIG IC ARITH-LGC-UN TTL 4-BIT IC FF TTL D-TYPE POS-EDGE-TRIG CLEAR IC GATE TTL NOR TPL 3-INP	01295 01295 01295 01295 01295	5N745112N 5N74181N 9N7474N 5N7427N
AQU11 A4U12 A4U13 A4U13 A4U15	1820=0301 1820=0616 1820=0174 1820=0068 1820=0640	3	5 0 1	I IC LCH TYL D=TYPE 4=817 IC MUXR/DATA=SEL TTL 2=TU=1=LINE GUAD IC INV TTL HEX . IC GATE TTL NAND TPL 3=INP IC MUXR/DATA=SEL TYL 16=TU=1=LINE 16=INP	07263 01295 01295	9322PC SN7404N SN7410N SN74150N
A4U16 A4U17 A4U18 A4U19 A4U19	1820=005 1820=028 1820=08 1820=026 1820=078	1 3 2		7 IC GATE TIL NAMD QUAD 2=INP 2 IC FF TIL J=K M/S PULSE CLEAR DUAL 1C INV TIL S HEX 1=INP 1 IC SHF=RGTR TIL R=S PRL=IN SERIAL=QUT 1C GATE TIL NOR IPL 3=INP	01295 01295 01295 01295 01295	9N74107N 9N74994N DMR590N 9N7427N
A4U21 A4U21 A4U22 A4U23	1820=062 1820=021 1820=049	4	1 9 8	IC DOOR TIL 4-TU-10-1-LINE DUAL IC DOOR TIL 4-TU-10-1-LINE IC DOOR TIL 4-TU-10-LINE 4-INP	0129	5 SN7442AN 5 SN74154N 0 1480=0115
	1480=011 4040=074	8	8	PIN-GRY .002-IN-DIA .25-IN-LG SYL EXTR-PC BD BLK POLYC .002-BD-THKNS	2846	0 4940=97A8
45	05045=60	005	0	1 BOARD ASSEMBLY, PROCESSOR MEMORY (SERIES 1520)	5848	and the time
ASR1	0757-091	17	3	18 RESISTOR 510 2% .125w F TC#0+=100	2454	0360+1682
ASTP1 ASTP2	0360=16	82 82	0	TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG	2846	

Table 6-1. Replaceable Parts (Cont'd)

	•		1 8	able 6-1. Replaceable Parts (Cont a)		
Reference Designation	I-IP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
ASU: ASU2 ASU3 ASU4 ASU5	1820 = 0716 1820 = 0373 1820 = 0656 1820 = 0694 1820 = 0380	6 1 9 0	21 1 1 2	IC CNTR ITE BIN SYNCHRU POS-EDGE-TRIG IC GATE TIL H NAND DUAL 4-INP IC GATE ITE 3 AND TPE 3-INP IC GATE ITE SECE-OR BUAD 2-INP IC GATE TE H AND-OR-INV	01295 01295 01295 01295 01295	98741618 88748118 88748118 88748868 88748868
ASU6 A5U7 A5U8 ASU9 ASU10	1820~0693 1820~0054 1820~0328 1820~0716 1816~0598	85063	8	IC FF TIL S D-TYPE POS-EDGE-TRIG IC GATE TIL NAND GUAD Z-IAP IC GATE TIL NOR GUAD Z-INP IC CNTR TIL SIN SYNCHRU PDS-EDGE-TRIG IC TIL 256-BIT RAM 3-8	01295 01295 01295 01298 01295	SN74574M SN7400N SN7402N SN74161M SN745200M
ASU11 ASU12 ASU13 ASU14 ASU15	1816-0578 1820-0716 1820-0685 1820-1107 1820-0716	3 6 8 1 6	5	IC TTL 256-BIT RAM 3-8 IC CNTR TTL BIN SYNCHRU POS-EDGE-TRIG IC GATE TIL 8 NAND TPL 3-INP IC SHF-RGTR TTL R-S PRL-IN SERIAL-OUT IC CNTR TTL BIN SYNCHRO POS-EDGE-TRIG	01295 01295 01295 01295 01295	8N748200N SN74161A SN74510N SN74166N SN74161N
A5U16 A5U17 A5U18 A5U19 A5U20	1820-0716 1820-0883 1820-0716 1820-0716 1820-0822	56663	1	IC CNTR TTL BIN SYNCHRU POS-EDGE-TRIG IC INV TTL S HEX 1-INP IC CNTR TTL BIN SYNCHRU POS-EDGE-TRIG IC CNTR TTL BIN SYNCHRU POS-EDGE-TRIG IC MUXR/DATA-SEL TTL 8-TO-1-LINE 8-INP	01295 01295 01295 01295 01295	SM74161N SN74S04N SN74161N SN74161N SN74151AN
	1480=0115 4040=0749	8		PIN-GRV .062-IN-DIA .25-IN-LG STL EXTR-PC BD BRN POLYC .062-80-THKNS	28480 28480	1480+0116 4040+0749
46	03045-40006	1	1	BOARD ASSEMBLY, MAIN MEMORY (SERIES (712)	28480	<u>ცნე45∞გ</u> (ცებ
A6C1 A6C3 A6C3 A6C4 A6C5	0160 = 0301 0180 = 0210 0180 = 0210 0180 = 0210 0160 = 3060	44465	1	CAPACITOR-FXD .012UF +-10X 200VDC POLYE CAPACITOR-FXD 3.3UF+=20X 15VDC TA CAPACITOR-FXO 3.3UF+=20X 15VDC TA CAPACITOR-FXD 3.3UF+>=20X 15VDC TA CAPACITOR-FXD .1UF +=20X 25VDC CER	28480 56289 56289 56280 28480	0160+0301 1500335x0015A2 1500335x0015A2 1500335x0015A2 0160+3060
A6C6 A6C7 A6C8 A6C9 A6C10	0180 = 0210 0180 = 0210 0160 = 0165 0160 = 0165 0180 = 1746	66885	<b>2</b> 8	CAPACITOR-FXD 3.3UF+-20% 15VOC TA CAPACITOR-FXD 3.3UF+-20% 15VOC TA CAPACITOR-FXD .056UF +-10% 200VOC POLYE CAPACITOR-FXD .056UF +-10% 200VOC POLYE CAPACITOR-FXD 15UF+-10% 20VOC TA	56289 56289 28480 28480 56289	1500335x0015A2 1500335x0015A2 0160-0165 0160-0165 1500156x902062
A6C12	0180=1746 0180=1746	55		CAPACITOR=FXD 15UF+=10% 20VDC TA CAPACITOR=FXD 15UF+=10% 20VDC TA	56289 56289	1500156x902082 1500156x902082
A6R1 A6R2 A6R3 A6R4 A6R5	0757=0941 0757=0945 0757=0941	33	20	RESISTOR 5.1k 2% .125w F TC=0+-100 RESISTOR 51k 2% .125w F TC=0+-100 RESISTOR 5.1k 2% .125w F TC=0+-100 NOT ASSIGNED NOT ASSIGNED	24546 24546 24546	C4=1/8=70=5101=G C4=1/8=70=5102=G C4=1/8=70=5101=G
A6R6 A6R9 A6R10 A6R11 A6R12	0757-0941 1810-0041 1810-0041 1810-0041 1810-0041	3 9 9 9	10	RESISTOR 5,1K 2% .125W F TC=0++100 NETWORK=RES 9-PIN-SIP .15-PIN-9PCG NETWORK=RES 9-PIN-SIP .15-PIN-9PCG NETWORK=RES 9-PIN-SIP .15-PIN-9PCG	24546 28480 28480 28480 28480	C4-1/8-79-5101-G 1810-0041 1810-0041 1810-0041
A6R13 A6R14 A6R15 A6R16 A6R17	1810=0041 1810=0041 0698=3150 0698=3150 0698=8823	99660	5	NETWORK-RES 9-PIN-SIP .15-PIN-SPCG NETWORK-RES 9-PIN-SIP .15-PIN-SPCG RESISTOR 2,37K 1% .125W F TC=0+-100 RESISTOR 2,37K 1% .125W F TC=0+-100 RESISTOR 8,25 1% .125W F TC=0+-100	28480 28480 24546 24546 28480	1810-0041 1810-0041 C4-1/88-T0-2371-F C4-1/88-T0-2371-F 0698-8823
ALRIB	0698-8823	0		RESISTOR 8.25 1% .125W F TC#0+#100	28480	0698=8823
ABUS ABUS ABUS ABUS ABUS	1820=0716 1820=0716 1820=0281 1820=0681 1820=0693	6 6 6 4 8	5	IC CNTR TTL BIN SYNCHRU POS-EDGE-TRIG IC CNTR TTL BIN SYNCHRU POS-EDGE-TRIG IC FF TTL J-K M/S PULSE CLEAR DUAL IC GATE TTL 3 NAND QUAD 2-INP IC FF TTL 3 D-TYPE POS-EDGE-TRIG	01295 01295 01295 01295 01295	SN74161N SN74161N SN74107N SN7480UN SN74874N
AAUT AAUT AAUT AAUTO	1820=1288 1820=0733 1820=0367 1820=0733 1820=0367	97.373		IC DRVR TTL CLOCK DRVR TTL-TO-MGS 1-INP IC SHF-RGTR PMGS SERIAL-IN SERIAL-DUT IC SHF-RGTR TTL R-S PRL-IN PRL-OUT 4-DIT IC SHF-RGTR PMGS SERIAL-IN SERIAL-OUT IC SHF-RGTR TTL R-S PRL-IN PRL-OUT 4-BIT	04713 27014 01295 27014 01295	MM10026CL MM1402AU SN7495AN MM1402AU SN7495AN
AGUS AGUS AGUS AGUS	1820=0328 1820=0207 1820=0693 1820=0685 1820=0693	60888	1	IC GATE TIL NOR QUAD 2-INP IC MY TIL MONOSTBL RETRIG/RESET IC FF TIL S D-TYPE POS-EDGE-TRIG IC GATE TIL S NAND TPL 3-INP IC FF TIL S D-TYPE POS-EDGE-TRIG	01295 04713 01295 01295 01295	9N7402N MC8601P 9N74974N 9N74910N 9N74974N
16016 14017 14018 14019 14020	1820-0733 1820-0733 1820-0733 1820-0054	7 3 7 3 5		IC SHF-RGIR PMOS SERIAL-IN SERIAL-OUT IC SHF-RGIR TIL R-S PRL-IN PRL-OUT 4-BIT IC SHF-RGIR PMOS SERIAL-IN SERIAL-OUT IC SHF-RGIR TIL R-S PRL-IN PRL-OUT 4-BIT IC GATE TIL NAND GUAD Z-INP	2/014	MM1402AD 8N7495AN MM1402AD 5N7495AN SN7400N
			ALL MONTHS TO THE STATE OF THE			

Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part	CD	Qty	/	Description	Mfr Cod		Mfr Part Number
Designation	Number 1820-0685 1820-0683 1820-1449	8 6 4 8		1 1	C GATE TTL S NAND TPL 3=INP C INV TTL S HEX 1=INP C GATE TTL S OR QUAD 2=INP C FF TTL S 0=IYPE POS=EDGE=TRIG C SHF=RGIR PMOS SERIAL=IN SERIAL=OUT	0129 0129 0129 0129 0129 2701	5 S 5 S	N74810N N748304N N748374N N74874N
A6U24 A6U25 A6U26 A6U27 A6U28	1820-0593 1820-0733 1820-0367 1820-1195 1820-077	7 3720		5   1	C SHF-RGTH FNOS SCHOOL PRL-OUT 4-BIT C SHF-RGTH TIL R-S PRL-IN PRL-OUT 4-BIT C FF TTL LS D-TYPE POS-EDGE-TRIG CLEAR C FF TTL D-TYPE POS-EDGE-TRIG C FF TTL H D-TYPE POS-EDGE-TRIG C GATE TTL S NAND GUAD 2-INP	0129 0129 0129 0129	5 5 75	8N7495AN N74L9175N SN7474N SN74H74N SN74H74N SN74B00N
95000 0500 1500 5500 5500	1820=0512 1820=0681 1820=1158 1820=0616 1820=0616	4 255		1	IC GATE TIL S AND UR INV DUAL 2-INP IC GATE TIL S AND UR INV DUAL 2-INP IC MUXR/DATA-SEL TIL 2-TO+1-LINE GUAD IC MUXR/DATA-SEL TIL 2-TO+1-LINE GUAD	012'0 272 270 270	63	9328PC 9328PC 9328PC 9328PC MM1408AU
A6U33 A6U34 A6U35 A6U36 A6U37	1820=0515 1820=0733 1820=0357 1820=0529 1820=0651	7			IC MUXA/DATA-SEL TIL ZETUN SERIAL-OUT IC SHF-RGTR PMOS SERIAL-IN SERIAL-OUT IC SHF-RGTR TIL R-S PRL-IN PRL-OUT 4-81' IC GATE TIL S MAND QUAD Z-INF IC GATE TIL AND QUAD Z-INP IC GATE TIL AND QUAD Z-INP	012 012 012 012	95	\$N7495AN \$N745112N \$N745UUN \$N7408N
A6U38 A6U39	1820-0511			4	PIN-GRY .062-N-10-10 .062-N-16 STL EXTR-PC BD RED POLYC .062-BD-THKNS		480 480	1480-0116 4040-0750
A7	4040-0750 05045-6000	1	2	1	BDARO ASSEMBLY, I/O MP18 (SERIES 1852)		480	05645-60007
A7C1 A7C2 A7C3	0100-0571 0150-0571 0160-0571 0160-0571		0000	4	CAPACITOR=FXD 470PF +=20% 100VDC CER CAPACITOR=FXD 070PF +=20% 100VDC CER CAPACITOR=FXD 076PF +=20% 100VDC CER CAPACITOR=FXD 070PF +=20% 100VDC CER	56 59 58	480 480 480	0160+0571 0160=0571 0160+0571 1200=0522
4751 4751 4781 4782	1200-0522 1810-0030 1810-0030 0757-0407		8 6 6 6	1 6	SOCKET-IC 24-CONT DIP-SLOR  NETWORK-RES 8-PIN-SIP .125-PIN-SPCG NETWORK-RES 8-PIN-SIP .125-PIN-SPCG NESTSTOR 200 1% .125-F f fc=0+-100 RESISTOR 200 1% .125-F fc=0+-100	NNNN	8480 8480 4546 4546	1810=0030 1810=0030 C4=1/8=10=201=F C4=1/8=10=201=F C4=1/8=10=201=F
47R3 47R4 47R5	0757=0401 0757=0401	, , 7	6 6 3	17	RESISTOR 200 1% .125% F TC=0+-100 RESISTOR 200 1% .125% F TC=0+-100 RESISTOR 1K 1% .125% F TC=0+-100		4546 4546	C4=1/8=10=201=F C4=1/8=10=1001=F 3101=1860
A7R7 A781 A7U1 A7U2	0757+028 3101=186 1820=070 1820=111	0 8	1 482	2	SWITCH-SL 5-1A DIP-SLIDE-ASSY .1A 50VI IC COMPTR TIL MAGTO 5-BIT IC FF TIL LS D-TYPE POS-EDGE-TRIG IC FF TIL JS BAR POS-EDGE-TRIG		28480 07263 01295 01295 01295	9324PC SN74LS74N SN74LS10N SN74LS10N SN74LS10N
A7US A7US A7US	1820 + 1 1 1 1820 - 1 2 6 1820 - 1 2 6 1820 - 1 2 6	5 5	7 3 3	4	IC GATE TIL LS NAND TO THE STATE OF THE LS J-K BAR PUS-EDGE-TRIG IC FF TIL LS J-K BAR PUS-EDGE-TRIG IC FF TIL LS J-K BAR PUS-EDGE-TRIG IC FF TIL LS J-K BAR PUS-EDGE-TRIG		01295 01295 01295 01295 01295	5N74LS109AN 5N74LS109AN 5N74S10N 5N7495AN
A7U7 A7U8 A7U9 A7U10	1820-05 1820-03	85 67 53	836	5	IC SCHMITT-TRIG TTL INV MEX  IC SCHMITT-TRIG TTL INV MEX  IC DCDR TTL LS 3-TO-8-LINE 3-INP  IC DCDR TTL LS 3-TO-8-LINE DUAL 2-IN	ļ	01295 01295 01295	SN74LS1344
A7U11 A7U12 A7U13 A7U14	1820-12 1820-12 1820-11 1820-01 1820-06	81 16 95	3 7 6	Ĭ	IC DCDR TIL LS 3-10-8-LINE 3-INP IC DCDR TIL LS 3-10-8-LINE 3-INP IC FF TIL LS D-TYPE POS-EDGE-TRIG CU IC INV TIL S HEX 1-INP	м	01295 01295 01295 01295	\$N74L3175N \$M74804N \$N74L580N
A7U15 A7U16 A7U17 A7U18 A7U19	1820=18 1820=00 1820=00 1820=0	528 581 716	8 9 4 6 9	1 4		[5	01295 29510 29510 29510	5 SN/489UN SN/4161N SN/489N
A7U20 A7U21 A7U22 A7U23	1820=0 1820=1 1820=1 1820=1	199 053 322	1623		IC INV TTL LS HEX 1-INP IC SCHMITT-TRIG TTL INV HEX IC GATE TTL S NOR GUAD 2-INP IC GATE TTL LS OR GUAD 2-INP IC GATE TTL LS OR GUAD 2-INP IT SAME TTL LS ROS PRL-IN PRL-O	υŤ	0129 0129 0129 0129 0129	5 SN7414N 5 SN74502N 5 SN746332N 5 SN746332N
A7U25 A7U25 A7U26 A7U27 A7U28	1820=1 1820=1 1820=1	283 283 283	7 2		IC GATE TIL LS NAND TPL 3-INP IC GATE TIL S NOR GUAD 2-INP IC SHF-RGTR TIL LS R-S PRL-IN PRL-( IC TIL 64-BIT RAM DO-NS U-C IC TIL 64-BIT RAM DO-NS U-C		0129 0129 0129 0129 0129	5
A7U29 A7U30 A7U31 A7U32 A7U33 A7U34 A7U35	1820 1820 1820 1820 1820 1820 1820	1500 1500 1510 1510 1510			IC SFR TTL NANO GUAD 2-INP IC SFR TTL NANO GUAD 2-INP IC FF TTL LS J=K BAR PUS=EDGE=TRIG IC GATE TTL NOR GUAD 2-INP IC GFR TTL NANO GUAD 2-INP IC SFR TTL NANO GUAD 2-INP IC SFR TTL NANO GUAD 2-INP		012	95   3N74L8109AN 95   3N74J8N 95   SN74J8N

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Table 6-1. Replaceable Parts (Cont'd)

Reference Designation	HP Part Number	CD	Qty	Description	Mfr Code	Mfr Part Number
A7U36	1820=1201	6	1	IC GATE TIL LS AND QUAD 2-INP IC SHF-RGTR TIL LS R-S SERIAL-IN PRL-OUT	01295 01295	SN74LS08N SN74LS184N
A7U37	1820-1433 1820-0681	6 4	5	+c cayE gti g saoD DildU 2⇒TMP	01295 01295	5N74500N 5N74L5157N
A7U38 A7U39 A7U40	1820=1470 1820=1194	1	1 1	IC MUXELDATA-SEL TIL LS 2-TO-1-LINE GUAD IC CNTR TYL LS BIN UP/DOWN SYNCHRO	01295	8N74LS143N
A7041 A7042 A7043	1820=0892 1820=1207 1820=0628	7 2 9	1 1	IC GATE TTL S AND-OR-INV IC GATE TTL LS NAND 8-INP IC TTL 64-8IT RAM 60-NS 0-C	01295 01295 01295	8N74865N 8N74L830N 8N7489N
	0360=1682 4040=0731 1200=0521	0 8	37 1	TERMINAL-STUD SGL-TUR PRESS-MTG EXTR-PC BD GRN POLYC .06-80-1HKNS LOCK-DUAL INLINE PKG INLINE PKG	28480 28480 52072	0360*1682 4640*0751 CA*24*200*DL
A6 .	05045-60008	3	1	BOARD ASSEMBLY, ROM (SERIES 1520)	28469	u\$045 <b>≈</b> 60008
	0757=0941	3		RESISTOR 5,1K 2% ,125W F TC#0++100	24546 24546	G4=1/8=10=5101=G C4=1/8=10=1001=G
ABR1 ABR2	0757=0924	5	33	RESISTOR 1K 2% 125W F TC=0+-100 NETWORK-RES 8-PIN-SIP 125-PIN-SPCG	28480	1810 - 0030
ABR4	1810-0030 1810-0030 0757-0907	6	5	NETWORK-RES 8-PIN-SIP .125-PIN-SPCG RESISTOR 200 2% .125W F IC=0+-100	28460 24546	C4+1/8=10+501+0 1810=0070
A6R5	1818-2278	4	1	IC. MOS ROM 512 x 8	28480	1818=2278 1818=2281
ABU2	1818=2281	9	1	IC, MOS ROM 512 X 8 IC, MOS ROM 512 X 8	28480 28480	1818#2284
ASU3 ASU4	1818=2284 1820=1294 1820=0661	2 7	1 3 3	IC,MUS KUM 512 X 5 IC MUXR/DATA+SEL TTL 2-TU+)-LINE QUAD IC GATE TTL GR QUAD 2-INP	27014 01295	0M8123N 8N7432N
A 6 U 5	1818-2277	3	. 1	IC.MOS ROM StZ x 8	28480	1818*2277
A6U6 . A8U7	1818-2280	8	1	IC, MOS ROM 512 X 8	28460 28460	1818*22*0 1818*2283
ABUB ABUP	1818-2283 1820-1294 1820-0077	7	1	IC, MOS ROM 512 X 8  IC MUXR/DATA-SEL TTL 2-TU-1-LINE GUAD  IC FF TTL 0-TYPE POS-EDGL-TRIG CLEAR	27014	DM8123N SN7474N
ABUIO	1818=2276		ı	IC.MOS ROM 512 X 8	28480	1818=2276
ABU12	1818-2279	5	1	IC, MOS ROM 512 x 8	28480 28480	1818-2279
A6U13 A8U14	1818~2282 1820~1294 1820~0214	7 9	,	IC MUXA/DATA-SEL TTL 2-TO-1=LINE QUAD IC DCDR TTL BCD-TO-DEC 4-TD-10-LINE	27014 01295	UM8123N 8N7442AN
46015	0360=1682	9		TERMINAL STUD SGL-TUR PRESS-MTG	28480	0360*1682
	1480-0116	8	4	PIN-GRY .082-IN-DIA .25-IN-LG STL EXTR-PC 80 YEL POLYC .062-80-THKNS	28480 28480	1480=0115 4040=0752
<b>A</b> 9	05045-60009	4	1	BOARD ASSEMBLY, ADDRESS (SERIES 1852)	58480	0≶ถ45⇔6บับบุ9
A9C1	0150=0210	6		CAPACITORMEXO 3 3UF+=20% 15VOC TA	56289	1500335×un15A2
A9C2	0180-0210	6		CAPACITOR=FXD 3.3UF+=2UX 15VOC TA CAPACITOR=FXD 43PF +=5x 300VOC MICA	56289 28480	1500335x0015A2
19C3 19C4	0160=2200 0180=0106	9	1	CAPACITOR-FXD 43PF +=5% 500000 MICH	56289	150De06x0005#2
ASCR1	1902-0125	6	t	DIODE-ZNR 2.61V 5% DO=7 PO#,4W TC#~.072% DIODE-SWITCHING 30V 50MA 2N8 DO=35	28480 28460	1902-0120
1481	1854=0071	7	27	TRANSISTOR NPW SI PD#300MW FT#200MMZ	28480	1854=0071
49R1	0757=0941	3		RESISTOR 5.1K 2% .125W F TC#0+=100	24546 24546	(4=1/8=10=5101=6 (4=1/8=10=5101=6
1983 1983	0757-0941 0757-0941	3	1	RESISTOR 5.1K 2% 125W F TC#0++100	24546	C4-1/8-10-5101-G
ARRA ARRS	2100-2633	5	3	RESISTOR-TRMR 1K 10% C SIDE-ADJ 1-TRN RESISTOR 3.16K 1% 125W F TC=0+-100	34983 24546	ETS0X102 - C4-1/8-10-3161-F
1986	0757=0940	2	1	RESISTOR 4.7K 2% 1125W F TC#04+100	24546	C4-1/8-T0-4701-G
1487 1488	0757-0940	5		I neeve-nous vivil novi 124m F (Establic)	24546	C4=1/8=10=4701=G C4=1/8=10=1001=G
1989 49810	0757±0924 0757=0976 0757#0948	8	7	RESISTOR 15 0K 2% ,125W F TC#0+#100 RESISTOR 10K 2% ,125W F TC#0+#100	24546 24546	C4-1/8-[U-1502-6 C9-1/8-[0-1002-6
49811	•			NETWORK-RES 9-PIN-SIP .15-PIN-SPCG	28480	1810-0154
19812 19813	1810=0164 0757=0940	7 2	İ	RESISTOR 4.7K 2% .125W F TC=0++100	24546 24546	C4=1/8=1U=47U1=G C4=1/8=FU=10U2=G
APRIA .	0757-0972 0757-0924	5		RESISTOR 100K 2% 125w F TC#0++100 RESISTOR 1K 2% 125w F TC#0++100	24546	C##1/8=10#1001=6
A87P1 A97P2	0360-1682	0		TERMINAL STUD SGL-TUR PRESS-MTG TERMINAL STUD SGL-TUR PRESS-MTG	26460 28460	U360+1652 U360+1652
ANTES ANTES	0360+1682 0360+1682	0	ı İ	TERMINAL -STUD SGL -TUR PRESS-MTG	28480	0360-1662
A STORY	0360=1682 0360=1682	0	• [	TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG	28480 28480	0360=1682 0360=1682
19796	0360=1682	0		TERMINAL-STUD SGL-TUR PRESS-MTG	28480	0360-1682
49U)	1820-0511	9		IC GATE TIL AND QUAD 2-INP	01295	\$N7408N \$N74133A
4901 4904	1820w0661 1820w0697	0 2		IC GATE TTL OR GUAD 2-INP IC DRVR TTL S NAND LINE DUAL 4-INP	01295 01295	8N7432N 5N74814DM
19us	1820-0068	1		IC GATE TIL NAND TPL 3-INP	01295 04713	5%7410N %C4024P
	*~E0#038/		5 1	46 MY FIR WORK		

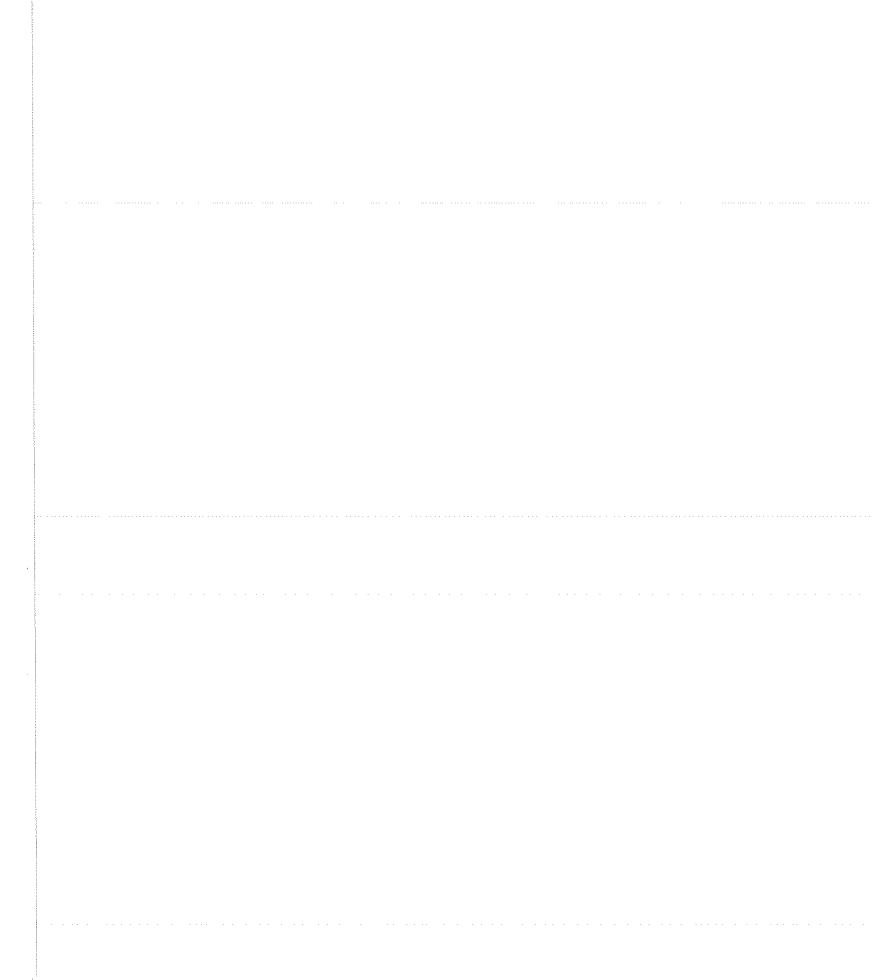


Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part	С	Qty		Description	Mfr Code		Mfr Part Number	
Designation	Number	S S D	` 1 1	1 10	GATE YTL NOR DUAL 4-INP GATE TTL NAND DUAL 4-INP FF TTL D-TYPE POS-EDGE-TRIG CLEAR	01295 01295 01295 01295	3N7 3N7	425N 420N 474N 474N	
.9U7 .9U8 .9U9 .9U10	1820-0077 1820-0077 1820-0683	9 2		IC	INV TIL S HEX 1-INP	01295 01295 01295	SN:	14804N 74753N 74161N	
11UPA 11UPA 11UPA	1820-0380 1820-0716 1820-1064 1820-0471	0 6 9 0	1 10	10	GATE TIL H AND-OR-INV CNTR TIL BIN SYNCHRU POS-EDGE-TRIG ENTRAGTR TIL SERIAL-IN PRL-OUT 8-BIT INV TIL HEX 1-INP FF TIL S D-TYPE POS-EDGE-TRIG	01295 01295 01295	5N 5N 3N	74164N 7406N 74874N	
A9U14 A9U15 A9U16	1820=0693	8 26		10	FF TTL D=TYPE POS=EDGE=TRIG CLEAR CNTR TYL BIN SYNCHRU POS=EDGE=TRIG CNTR TYL BIN SYNCHRU POS=EDGE=TRIG	01295 01295 01295 01295	SN SN	7474N 74161N 74174N 174161N	
A9U17 A9U18 A9U19	1820-0716 1820-0716 1820-0716 1820-0716	0000	5	10	CNTR TTL BIN SYNCHRO POS-EDGE-TRIG	0129	31	74161N <sub>4</sub> 74165N	
vansi Vanso	1620-1042	3	2	9	: GHF-RGTR TTL R-S PRL-IN SERIAL-OUT IN-GRV .062-IN-DIA .25-IN-LG STL XYR-PC BD GRN POLYC .062-BD-THKNS	2848 2848		480-011 <b>6</b> 040-0753	
	4040-0753 05045-6001	0 7	, a		DARO ASSEMBLY, DAG (SERIES 1520)	5848		5045*60010	
A10C1 A10C2	0140-2055	9 6	1		APACITOR=FXD .01UF +80=20% 100VDC CER APACITOR=FXD .01UF +80=20% 100VDC CER APACITOP=FXD 1000PF +=10% 1KVDC CER	284 284 284 584	30 0	.100-2055 160-2055 160-3456 1160-3456 1110B335K035AS	
A1003 A1004 A1005	0160-3456 0160-3456 0180-0161	5		1   0	APACITURATED	284 009	80	0160=2055 71108335K035AS	
A	0180-0161 0160-2055 0180-0161	6 6	1		CAPACITOR FXD 3.3UF++10% 35VDC TA	009	08 180	71108335K035A8 1902+3234 1901+0044	
A10CR1 A10CR2 A10CR3 A10CR4	1902-3234 1901-0040 1901-0044 1902-0064				DIODE-SWITCHING 30V 50MA 2N8 DG-35 DIODE-SWITCHING 30V 50MA 2N8 DG-35 DIODE-ZNR 7.5V 5X DG-7 PD#,4W TC#+,65 DIODE-ZNR 19,6V 5X DG-7 PD#,4W TC#+,0	3% 58	480 480	1901-0040 1902-0054 1902-3234 1902-0064	
A10CR6 A10CR6 A10CR7 A10CR8	1902-006 1902-006 1901-004 1901-004	u 0	1   1   1   1   1   1   1   1   1   1		DIODE-ZNR 7.5V 5% DO-7 PDE-4W ICE+.05 DIODE-ZNR 7.5V 5% DO-7 PDE-4W ICE+.05 DIODE-SWITCHING 30V 50MA 2NS DO-35 DIODE-SWITCHING 30V 50MA 2NS DO-35 DIODE-SWITCHING 30V 50MA 2NS DO-35 DIODE-SWITCHING 30V 50MA 2NS DO-35	28	480 480 480 480	1902-0064 1901-0040 1901-0040	
ALOCRIO ALOCRIO ALOCRII	1901-004	0	1		DIODE-SWITCHING 30V 50MA 2NS 00-35	2	480	1901+0040 1854-0071 1853-0020	
V1005	1854=000 1853=000		7	26	TRANSISTOR NPN SI PDB300MW FT8200MHZ TRANSISTOR PNP SI PDB300MW FT8150MHZ RESISTOR JK 2% 125W F TC80+=100	5	4546 4546	C#m1/8mT0m1001mG	
AIORI AIORZ AIORZ AIORZ	0757-09 0757-09 0757-09 0757-09	24 21 48	2 9 0 3		RESISTUR 1K 2% .125% F TC=0+-100 RESISTOR 10K 2% .125% F TC=0+-100 RESISTOR 10K 2% .125% F TC=0+-100 RESISTOR 510 2% .125% F TC=0+-100	2	4546	C4=1/8=10=151=G C4=1/8=10=1002=G C4=1/8=T0=511=G C4=1/8=T0=101=G	
ALORS ALORS ALORS ALORS	0757-09 0757-09 0757-09 0757-09	17	3 3 3 3		RESISTOR 100 2% .125W F IC#0+-100 RESISTOR 510 2% .125W F IC#0+-100 RESISTOR 510 2% .125W F IC#0+-100 RESISTOR 510 2% .125W F IC#0+-100 RESISTOR 100 2% .125W F IC#0+-100 RESISTOR 100 2% .125W F IC#0+-100		4546 24546 24546 24546	C4=1/8=10=511=6 C4=1/8=10=511=6 C4=1/8=10=101=6	
Alorio Alorii	0757=0°	900 901 931	3	7	RESISTOR 5.1K 2% .125W F TC=0+=100 RESISTOR 2K 2% .125W F TC=0+=100		24546 24546 24546	C4=1/8=10=5101=6 C4=1/8=10=2001=6 C4=1/8=10=2001=6 C4=1/8=10=5101=6 C4=1/8=10=1001=6	•
A10R12 A10R13 A10R14 A10R15	0757+0 0757=0 0757=0	941	2 2	8	RESISTOR 1K 2% ,125W F TC=0+-100		24546 24546 24546	C4=1/8=T0=3001=G C4=1/8=T0=3001=G C4=1/8=T0=3001=G	
A10R16 A10R17 A10R1B A10R19	0757+0 0757+0 0757+0 0757+0	935 935 976	55545	e e	RESISTOR 3K 2% 125W F TC#0++100 RESISTOR 150K 2% 125W F TC#0++100 RESISTOR 3K 2% 125W F TC#0+-100		54249 54249 54249 54249	C4-1/8-T0-15021-6 C4-1/8-T0-1001-6	
A10R20 A10R21 A10R23 A10R24	0757- 0757- 0757- 0757- 0757-	) 935 ) 935 ) 935 ) 935	กษตลน		RESISTOR 3K 2% .125W F TC=0+=100 RESISTOR 1K 2% .125W F TC=0+=100	***************************************	24546 24546 24546 24546 24546	Ca=1/8=10=5001=G Ca=1/8=10=5001=G Ca=1/8=70=1001=G	
A10R25 A10R25 A10R27 A10R29 A10R29 A10R30	0757- 0757- 0757- 0757- 0757-	0924 0907 0908 0976	2 1 2 4 7	q	RESISTOR 1K 2% .125W F TC=0+=100 RESISTOR 200 2% .125W F TC=0+=100 RESISTOR 1K 2% .125W F TC=0+=100 RESISTOR 150K 2% .125W F TC=0+=100 RESISTOR 300 2% .125W F TC=0+=100		24546 24546 24546 24546	C4=1/8=10=201=6 C2=1/8=10=1101=6 C4=1/8=10=1502=6 C4=1/8=10=1502=6	

Table 6-1. Replaceable Parts (Cont'd)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
A10R31 A10R32 A10R33 A10R34 A10R35	0757-0924 0757-0941 0757-0911 0757-0948 0757-0958	3702	. 3	RESISTOR 1K 2% ,125W F TCM0+=100 RESISTOR 5.1K 2% ,125W F TCM0+=100 RESISTOR 300 2% ,125W F TCM0+=100 RESISTOR 10K 2% ,125W F TCM0+=100 RESISTOR 27K 2% ,125W F TCM0+=100	24546 24246 24246 24246	C4=1/8=T0=1001=6 C4=1/8=T0=5101=6 C4=1/8=T0=511=6 C4=1/8=T0=1101 C4=1/8=T0=1042=6 C4=1/8=T0=2702=6
A10R36 A10R37 A10R38 A10R39 A10R40	0757-0924 0757-0948 0757-0967 0757-0924 0757-0941	2 0 3 2 3	****	RESISTOR 1K 2% ,125W F TCM0+=100 RESISTOR 10K 2% ,125W F TCM0+=100 RESISTOR 62K 2% ,125W F TCM0+=100 RESISTOR 1K 2% ,125W F TCM0+=100 RESISTOR 5,1K 2% ,125W F TCM0+=100	24546 24546 24546 24546 24546	C4-1/8-10-1001-6 C4-1/8-10-1002-G C4-1/8-10-1001-G C4-1/8-10-1001-G C4-1/8-10-5101-G
A10R41 A10R43 A10R44 A10R45 A10R46	0757~0972 0757~0946 0757~0958 0757~0924 0757~0924	RRROO		RESISTOR 100K 2% .125W F TCM0+=100 RESISTOR 10K 2% .125W F TCM0+=100 RESISTOR 27K 2% .125W F TCM0+=100 RESISTOR 1K 2% .125W F TCM0+=100 RESISTOR 1K 2% .125W F TCM0+=100	24546 24546 24546 24546 24546	C4=1/8=F0=1002=G C4=1/8=F0=1002=G C4=1/8=F0=2702=G C4=1/8=F0=1001=G C4=1/8=F0=1001=G
A10847 A10848 A10849	0757=0958 0757=0948 0757=0924	5 0		RESISTOR 27K 2X ,125w F TCm0+=100 RESISTOR 10K 2% ,125w F TCm0+=100 RESISTOR 1K 2% ,125w F TCm0+=100	24546 24546 24546	C4-1/6-10-2702-6 C4-1/6-10-1002-6 C4-1/8-70-1001-6
A10U1 A10U2 A10U3 A10U4 A10U5	1820-0899 1820-0716 1820-0716 1820-0716 1820-0511	5 6 6 6 9	1	IC CATE TIL DECD SYNCHMO PUB-EDGE-TRIG IC CATE TIL BIN SYNCHRU PUS-EDGE-TRIG IC CATE TIL BIN SYNCHRU PUS-EDGE-TRIG IC CATE TIL BIN SYNCHRU PUS-EDGE-TRIG IC CATE TIL AND QUAD 2-IÑP	01295 01295 01295 01295 01295	5N74160N 5N74161N 5N74161N SN74161N SN7406N
A10U6 A10U7 A10U8 A10U9 A10U10	1820-0733 1820-0693 1820-0077 1820-0054 1820-0077	78252		IC SHF-RSTR PMOS SERIAL-IN SERIAL-OUT IC FF ITL S D-TYPE POS-EDGE-TRIG IC FF ITL D-TYPE POS-EDGL-TRIG CLEAR IC GATE ITL NAND QUAD 2-INP IC FF ITL D-TYPE POS-EDGL-TRIG CLEAR	27014 01295 01295 01295 01295	MN 1402AU SN 74874N SN 7474N SN 7400N SN 7474N
A10011 A10012 A10013 A10014 A10015	1820 = 0491 1820 = 0733 1820 = 0471 1820 = 1322 1820 = 0328	7 026	4-4	IC DCDR TIL BCD=TO=DEC 4=TO=10=LINE IC BHF=RGTR PMOS SERIAL=IN SERIAL=OUT IC INV TYL HEX 1=INP IC GATE TIL S NOR GUAD Z=INP IC GATE TIL NUR GUAD Z=INP	01295 27014 01295 01295 01295	SN74145N - MM1402AU SN7406N SN74502N SN74802N
A10U16 A10U17 A10U18 A10U19 A10U20	1820=0077 1820=0716 1820=0367 1820=0368 1820=0471	26520		IC FF 1TL D-TYPE POS-EDGE-TRIG CLEAR IC CNTR TIL GIN SYNCHRU POS-EDGE-TRIG IC SHF-RGTR TIL R-S PRL-IN PRL-OUT 4-BIT IC FF TTL 0-TYPE POS-EDGE-TRIG CLEAR HEX IC INV TTL HEX 1-INP	01295 01295 01295 01295 01295	SN7474N SN74161N SN7495AN SN74174N SN7406N
A10U21 A10U22 A10U23 A10U24 A10U25	1820 - 0054 1820 - 0328 1820 - 0377 1820 - 0788 1820 - 0471	50 50 50	gasa	IC GATE TIL NAND GUAD 2=1NP IC GATE TIL NOR GUAD 2=1NP IC GATE TIL HAND-GREINV DUAL 2=1NP IC FF TIL D=TYPE POS=EDGE=TRIG CLEAR HEX IC INV TIL HEX 1=1NP	01295 01295 01295 01295 01295	3874008 3874028 38744508 38741748 3874068
	1460-0116 4040-0754	8	5	PIN-GRY .062-IN-DIA .25-IN-LG STL EXTR-PC BD BLU POLYC .062-BD-THMS	28480 28480	1480-0116 4040-0754
411	05045-60011	8	1	80ARD ASSEMBLY, REFERENCE LEVEL G (SERIES 1852)	28480	05945-69011
A11C1 A11C2 A11C3 A11C4 A11C5	0160-4279 0160-4279 0160-4279 0140-0209 0150-0121	33,95	5 23	CAPACITOR-FXO 470PF +=10% 200VDC POLYP CAPACITOR-FXO 470PF +=10% 200VDC POLYP CAPACITOR-FXO 470PF +=10% 200VDC POLYP CAPACITOR-FXO 5PF +=10% 500VDC MICA CAPACITOR-FXO ,1UF +80=20% 50VOC CER	71590 71590 71590 72136 28480	CPP-471J CPP-471J CPP-471J OM15C050K05000V1CH 0150+0121
*11C6 *11C7 *11C8 *11C9 *11C10	1510#0210 1810#0410 8155#0410 2705#0410	5 8 8 6 9	3	CAPACITOR=FXD .1UF +80-20% 50VDC CER CAPACITOR=FXD 30PF +=5% 300VDC MICA CAPACITOR=FXD 30PF +=5% 300VDC MICA CAPACITOR=FXD 1000PF +=5% 300VDC MICA CAPACITOR=FXD .01UF +80-20% 100VDC CER	26460 26460 26460 26460 28460 28460	6150=0121 9160=0161 0160=0161 9160=2216 0160=2256
A11011 A1012 A11013 A11014 A11015	0160*2197 0140*0209 0160*0161 0140*0184 0160*2055	09899	2	CAPACITOR=FXD 19PF +=5% 300VDC MICA CAPACITOR=FXD 5PF +=10% 500VDC MICA CAPACITOR=FXD 30PF +=10% 500VDC MICA CAPACITOR=FXD 8200PF +=1% 100VDC MICA CAPACITOR=FXD 8200PF +=1% 100VDC MICA CAPACITOR=FXD 801UF +80=20% 100VDC CER	28480 72136 28480 72136 28480	0160-2197 DM15C050K0500=V1CH 0160-0181 DM20F822F010UNV1CH 0160-2055
A11C16 A11C17 A11C16 A11C19 A11C20	0160-2325 0140-0184 0160-2325 0160-2055 0160-2055	50000	ţ	CAPACITOR=FXD 2000PF +=5% 300VDC MICA CAPACITOR=FXD 8200PF +=1% 100VDC MICA CAPACITOR=FXD 2000PF +=5% 300VDC MICA CAPACITOR=FXD .01UF +80=20% 100VDC CER CAPACITOR=FXD .01UF +80=20% 100VDC CER	28480 72136 28480 28480 28480	0160-2225 DM20F82E0100*V1CK 0160-2225 0160-2055 0160-2055
\$11C21 \$11C22 \$11C23 \$11C24 \$11C24	0180-0151 0140-0151 0150-0121 0150-0121 0160-0362	60557	5	CAPACITOR-FXD 3.3UF+-toX 35VOC TA CAPACITOR-FXD 820FF +-2% 300VDC MICA CAPACITOR-FXD .tUF +80-20% 50VDC CER CAPACITOR-FXD 1UF +80-20% 50VDC CER CAPACITOR-FXD 510FF +-5% 300V0C MICA	00908 72136 28480 28480 28480	71108335x035A3 DM15F821&0500xV1CR 0150-0121 0150-0121 0160-0362
		Violation			THE PART AND THE P	

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Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part		у	Description	Mfr Code	Mfr Part Number	
Designation	0140-0342 7 0180-0116 1		CA CA	PACITOR=FXO 510FF +=5x 300VDC MICA PACITOR=FXO 6.8UF+=10x 35VOC TA PACITOR=FXO 5.8UF+=10x 35VOC TA PACITOR=FXO 1000FF +=5x 300VDC MICA PACITOR=FXO 1000FF +=5x 300VDC MICA	28480 56289 56289 28480 72136	0160-0362 150065X903582 1500665X903502 0160-8216 DM15F821G03004V1CR	
A11C29 A11C30 A11C31 A11C32	0140×0151 0180×1746 0150×0121	55	CA	PACITOR=FXD 15UF+=10% 20VDC TA  PACITOR=FXD 15UF+80=20% 50VDC CER PACITOR=FXD 1UF +80=20% 50VDC CER PACITOR=FXD 2PF += 25PF 500VDC CER	56289 28480 28480 00908	1500156x902082 0150=0121 0160=2240 11108335K035AS 1500156x902082	
A11033 A11034 A11035	0100000000	5 5	6,	APACITOR=FXD 3.3UF+=10% 35VDC TA APACITOR=FXD 15UF+=10% 20VDC TA APACITOR=FXD 3.3UF+=10% 35VDC TA	56289 00908	71108335K035AS	
A 1 1 C 3 6	0180=0161	1	٥	IGDE SWITCHING 30V 50MA 2NS DD#35	28480 28480 28480	1901-0040 1901-0040 1901-0040	
ALICRI ALICRE ALICRI ALICRI	1901=0040 1901=0040 1901=0040 1901=0040	1	000	IODE-SWITCHING 30V 50MA 2NS DO=35 IODE-SWITCHING 30V 50MA 2NS DO=35	26480 28480 28480	1901~0040 1901~0040	
A110R5 A110R6 A110R7 A110R8	1901=0040 1901=0040 1901=0040 1901=0040		1 0	DIODE-SWITCHING 30V 50MA 2NS D0+35 DIODE-SWITCHING 30V 50MA 2NS D0-35 DIODE-SWITCHING 30V 50MA 2NS D0-35 DIODE-SWITCHING 30V 50MA 2NS D0-35 DIODE-SWITCHING 30V 50MA 2NS D0-35 DIODE-SWITCHING 30V 50MA 2NS D0-35	59480 58480 58480 58480	1901=0040 1901=0040 1901=0040 1901=0040	
Alicre Alicrio	1901-0040	0	. 1	DIODE-ZNR 9V 5% DO-14 PDE.5W TCB+.001%	28480 0848c	1902-0071	
ALICRII ALILI	9140=0144 9140=0144	0		COIL-MLD 4.7UH 10% Q#45 .0950%.25LG-NOM COIL-MLD 4.7UH 10% Q#45 .0950%.25LG-NOM	28480 01295	9140=0144	
A1101 A1102 A1103	1855-0051 1853-0020 1854-0071 1853-0020	1 4 7 a	3	TRANSISTOR JOFET NOCHAN DOMODE SI TRANSISTOR PNP SI POWJOOMW FTW.50MMZ TRANSISTOR NPN SI POWJOOMW FTW.500MMZ TRANSISTOR PNP SI POWJOOWW FTW.50MMZ TRANSISTOR JOFET NOCHAN DOMODE SI	28480 28480 28480 01295	1	
A11GA A11GA A11GA A11GA A11GB	1855-0081 1855-0081 1854-0071 1854-0071	1 7 7		TRANSISTOR J-FET N=CHAN D=MODE SI TRANSISTOR NPN SI PD#300MW FT#200MMZ TRANSISTOR NPN SI PD#300MW FT#200MMZ TRANSISTOR NPN SI PD#300MW FT#200MMZ TRANSISTOR NPN SI PD#300MW FT#200MMZ TRANSISTOR NPN SI PD#300MW FT#200MMZ	01295 28480 28480 28480		
Alig9 Aligio	1854-0071 1854-0071 1853-0020	7 4		TRANSISTOR PNP SI PDW300MW FTW150MHZ	28480 28480 28480	1853-0020	
A11011 A11012 A11013	1853-0020	4 4		RESISTOR 100 2% -125% F TC#0++100	24544 2454	Cd=1/8=Tueluluu	
A11R1 A11R2 A11R3 A11R4	0757-0900 0757-0900 0757-0904 0757-0900 0757-0900	3 4 6 4 4	6	RESISTOR 100 2% .125W F TC=0+=100 RESISTOR 6.8K 2% .125W F TC=0+=100 RESISTOR 100 2% .125W F TC=0+=100 RESISTOR 100 2% .125W F TC=0+=100	2454 2454 2454 2454	6 C4=1/8=70=101=6 C4=1/8=70=101=6	
A1185 A1186 A1187 A1188	0757-0945 0757-0946 0757-0944 0757-0941	7 0 6 3	3	RESISTOR 7.5K 2% ,125W F TC=0+-100 RESISTOR 10K 2% ,125W F TC=0+-100 RESISTOR 6.8K 2% ,125W F TC=0+-100 RESISTOR 5.1K 2% ,125W F TC=0+-100 RESISTOR 15K 2% ,125W F TC=0+-100	2454 2454 2454 2454	6 C4=1/8=10=100==6 6 C4=1/8=10=5:01=6 C4=1/8=10=1502=6	
A:1R10 A:1R11 A:1R11 A:1R12	0757-0952 0757-0955 0757-0948 0757-0944	6 9 0 6	15	RESISTOR 20K 2% 125W F TCR0+=100 RESISTOR 10K 2% 125W F TCR0+=100 RESISTOR 6.8K 2% 125W F TCR0+=100 RESISTOR 6.8K 2% 125W F TCR0+=100	245 245 245 245	46	
A11R13 A11R14 A11R15	0757-0900 0757-0941			RESISTOR 3.17 CA 144	245	46 C4-1/8-T0-101-G	
ATTRIC ATTRIC ATTRIC ATTRIC	0757~0900 0757~0900 0757~0900 0757~0900	4		RESISTOR 100 2% 125W F 1C=0+=100 RESISTOR 100 2% 125W F TC=0+=100 RESISTOR 100 2% 125W F TC=0+=100 RESISTOR 100 2% 125W F TC=0+=100	245 245 245	46	-
A11R21 A11R21 A11R22 A11R23	0757-097 0757-093 0757-095	2 0 1 1 2 6		RESISTOR 100K 2% .125W F TC=0+-100 RESISTOR 2K 2% .125W F TC=0+-100 RESISTOR 15K 2% .125W F TC=0+-100 RESISTOR 6.6K 2% .125W F TC=0+-100 RESISTOR 51K 2% .125W F TC=0+-100	24°	C4=1/8=10=2001=6 C4=1/8=10=1502=6 C4=1/8=10=6801=6 C4=1/8=10=5102=6	
A11R24 A11R25 A11R26 A11R27	0757-096 0757-098 0757-098 0698-325	5 1 3 2 12	2 2	RESISTOR 2.4K 2% .125W F TC#0+=100 RESISTOR 1K 2% .125W F TC#0+=100 RESISTOR 450 1% .125W F TC#0+=50 RESISTOR 450 1% .125W F TC#0+=50	28 24	546	
A11R28 A11R29 A11R30	0757-099 0757-099	52	6	RESISTOR 20K 2X ,125% F TCM0+=100	24	546	
A11R31 A11R32 A11R33 A11R34 A11R35	0757=09 0757=09 0757=09 0757=09 0757=09	24	2 4 0	RESISTOR 20K 2% .125w F TC=0+=100 RESISTOR 10K 2% .125w F TC=0+=100 RESISTOR 1K 2% .125w F TC=0+=100 RESISTOR 100 2% .125w F TC=0+=100 RESISTOR 100K 2% .125w F TC=0+=100	l a	1546 C4-1/8-10-1014-5 C4-1/8-10-1002-5 C4-1/8-10-1002-5	

Table 6-1. Replaceable Parts (Cont'd)

					able 6-1. Replaceable Parts (Cont'd)		
	erence ignation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
ALLESS ALLESS ALLESS ALLESS	7 6	0757-0940 0757-0957 0757-0394 0757-0416 0757-0957	2 1 0 7 1	# 22	RESISTOR 4,7K 2% ,125W F TC#0++100 RESISTOR 24K 2% ,125W F TC#0++100 RESISTOR 51,1 1% ,125W F TC#0++100 RESISTOR 511 1% ,125W F TC#0++100 RESISTOR 24K 2% ,125W F TC#0++100	24546 24546 24546 24546 24546	C4w1/8wTuw4701mG C4w1/8wTuw2402wG C4w1/8wTuw21x1wF C4w1/8wTuw2402mG
A11R4 A11R4 A11R4 A11R4	2 3 4	0757-0911 0757-0924 0757-0965 0757-0933 0757-0957	7 2 1 3 1	AAAAAAAAAAAAAAAA	RESISTOR 300 2% .125% F TC#0+=100 RESISTOR 1K 2% .125% F TC#0+=100 RESISTOR 51% 2% .125% F TC#0+=100 RESISTOR 2,4% 2% .125% F TC#0+=100 RESISTOR 24% 2% .125% F TC#0+=100	24546 24546 24546	C4m1/8m10m301mG C4m1/8m10m101mG C4m1/8m10m5102mG C4m1/8m10m2401mG C4m1/8m10m2402mG
A11844 A1184 A1188 A1188	7 8 9	0698-3252 0757-0957 0757-0416 0757-0965 0757-0394	9 1 7 1 0	in the state of th	RESISTOR 450 1% .125W F TC=0+-50 RESISTOR 294 27 .125W F TC=0+-100 RESISTOR 511 1% .125W F TC=0+-100 RESISTOR 51k 1% .125W F TC=0+-100 RESISTOR 51k 1% .125W F TC=0+-100	28480 24546 24546 24546 24546	6698-3252 C4-1/8-10-2402-G C4-1/8-10-511R-F C4-1/8-10-5102-G C4-1/8-10-5181-F
A1185 A1185 A1185 A1185 A1185	3 4	0757-0965 0757-0965 0757-0965 0757-0965 0757-0965	1 1	Constant	RESISTOR 51K 2% .125M F ICmo+=100 RESISTOR 51K 2% .125M F ICmo+=100 RESISTOR 51K 2% .125M F ICmo+=100 RESISTOR 51K 2% .125M F ICmo+=100 RESISTOR 51K 2% .125M F ICmo+=100	24546 24546 24546 24546	C4-1/8-10-5102-6 C4-1/8-10-5102-6 C4-1/8-10-5102-6 C4-1/8-10-5102-6 C4-1/8-10-5102-6
A11RS A11RS A11RS A11RS	7 8 9	0757-0941 0757-0941 0757-0941 0757-0931 0757-0941	3313		RESISTOR 5.1K 2% ,125w F TC#0+-100 RESISTOR 5.1K 2% ,125w F TC#0+-100 RESISTOR 5.1K 2% ,125w F TC#0+-100 RESISTOR 3K 2% ,125w F TC#0+-100 RESISTOR 5K 2% ,125w F TC#0+-100	24546 24546 24546 24546	C4-1/8-10-5101-G C4-1/8-10-5101-G C4-1/8-10-5101-G C4-1/8-10-5101-G C4-1/8-10-5101-G
A1196 A1196 A1196 A1196 A1196	2 3 4	0757=0941 0757=0920 0757=0941 0757=0911 0698=6977	38371	1	RESISTOR 5.1% 2% .125W F TC=0+-100 RESISTOR 680 2% .125W F TC=0+-100 RESISTOR 5.1% 2% .125W F TC=0+-100 RESISTOR 300 2% .125W F TC=0+-100 RESISTOR 30% 2% .125W F TC=0+-25	24546 24546 24546 24546 28480	C4-1/8-10-5101-G C4-1/8-10-681-G C4-1/8-110-101-G C4-1/8-10-301-G 0698-6977
A11R6 A11R6 A11R6 A11R6	.7 .8 .♥	0757#0945 0698#6977 0757#0945 0698#6360 0698#6360	7 1 7 6 6	2	RESISTOR 7.5K 2% .125W F TC%0+~100 RESISTOR 30K .1% .125W F TC%0+~25 RESISTOR 7.5K 2% .125W F TC%0+~100 RESISTOR 10K .1% .125W F TC%0+~25 RESISTOR 10K .1% .125W F TC%0+~25	24546 28460 24546 28480 28480	C4+1/8+10-1501-G 0698+6977 < C4-1/8-10-7501-G 0698-6360 0698-6360
A1181 A1181 A1181 A1181 A1181	72 73 74	0757-0915 0757-0915 0757-0915 0757-0915 0757-0907	1 1 1 1 1 1	ti.	RESISTOR 430 2% .125W F TC=0+=100 RESISTOR 430 2% .125W F TC=0+=100	24546 24546 24546 24546 24546	C4=1/8=10=431=G C4=1/8=10=431=G C4=1/8=10=431=G C4=1/8=10=431=G C4=1/8=10=231=6
Alir Alir Alir Alir Alir	77 78 79	1810=0202 0757=0972 0757=0944 0757=0926 2100=2632	40644	1 2	NETWORK-RESISTOR 12 BIT BIN LADDER NTWK RESISTOR 100K 2% .125W F TCE0++100 RESISTOR 6.8K 2% .125W F TCE0++100 RESISTOR 1.2K 2% .125W F TCE0++100 RESISTOR-TRWR 100 10% C SIDE+AOJ 1-TRN	73138 24546 24546 24546 30983	812-411-R50k C4-1/8-T0-1002-G C4-1/8-T0-0801-G C4-1/8-T0-1201-G ET50X101
Alin Alin Alin Alin Alin Alin	62 63 84	2100-2514 2100-2632 2100-2514 2100-2514 2100-2522	1.4	4	RESISTOR-TRMR 20K 10% C SIDE-ADJ 1-THN RESISTOR-TRMR 100 10% Č SIDE-ADJ 1-TRN RESISTOR-TRMR 20K 10% Č SIDE-ADJ 1-TRN RESISTOR-TRMP 20K 10% Č SIDE-ADJ 1-TRN RESISTOR-TRMP 10K 10% Č SIDE-ADJ 1-TRN RESISTOR-TRMP 10K 10% Č SIDE-ADJ 1-TRN	30983 30983 30983 30983 30983	£750x205 £750x101 £750x205 £750x205 £750x105
Alir Alir Alir Alir Alir	67 86 89	2100=2514 2100=2522 2100=2633 2100=2489 2100=2633	11595	1	RESISTON-TRMR 20K 10% C SIDE-ADJ 1-TRN RESISTOR-TRMR 10K 10% C SIDE-ADJ 1-TRN RESISTOR-TRMR 1K 10% C SIDE-ADJ 1-TRN RESISTOR-TRMR 5K 10% C SIDE-ADJ 1-TRN RESISTOR-TRMR 1K 10% C SIDE-ADJ 1-TRN RESISTOR-TRMR 1K 10% C SIDE-ADJ 1-TRN	30963 30963 30963 30983 30983	ET50w205 ET50X103 ET50X102 ET50X502 ET50X102
4111	. *	0757-0924	5	-	RESISTOR 1K 2% ,125W F TC≖0+~100	24546	C4=1/8=T0=1001=6
A111 A111 A111 A111 A111 A111	II;  2  3	0360+1682 1826+0208 1826+0207 1826+0207 1826+0207	0 33222	11	TERMINAL-STUD SGL-TUR PRESS-MTG  OP AMP GP 8-DIP-P  OP AMP WE 8-DIP-P  OP AMP WE 8-DIP-P  OP AMP WE 8-DIP-P  OP AMP WE 8-DIP-P	27014 27014 27014 27014 27014 27014	0360~1682 LM310N LM318N LM318N LM318N
	17 18 18 110	1820=0493 1826=0208 1826=0208 1820=1938 1820=1617	5 6 8	8 5	OP AMP GP 8-DIP-P OP AMP GP 8-DIP-P OP AMP GP 8-DIP-P II CMOS GUAD BILATERAL SWITCH IC CMOS DUAL D.F-F POS EDGL CLOCK	27014 27014 27014 28480 04713	LM307N LM310N LM310N 1H20=1958 MC14U15HCP
	U[1 U12 U13 U14 U15	1826=0208 1826=0208 1826=0208 1826=0208 1820=1938	3 3 3 6		OP AMP GP 8=DIP=P OP AMP GP 8=DIP=P OP AMP GP 8=DIP=P OP AMP GP 8=DIP=P IC CMOS QUAD BILATERAL SWITCH	27014 27014 27014 27014 28480	LM310N LM310N LM310N LM310N
	V(7 V(8 V(9 V26	1820=1617 1820=1936 1826=0208 1820=1617 1826=0208	8 3 3		IC CMOS DUAL D F=F POS EDGE CLOCK IC CMOS DUAD BILATERAL SWITCH OP AMP GP 8=DIP=P IC CMOS DUAL D F=F POS EDGE CLOCK OP AMP GP 8=DIP=P	04713 28480 27014 04713 27014	MC14013BCP 1620-1938 LM310N MC14013BCP LM310N

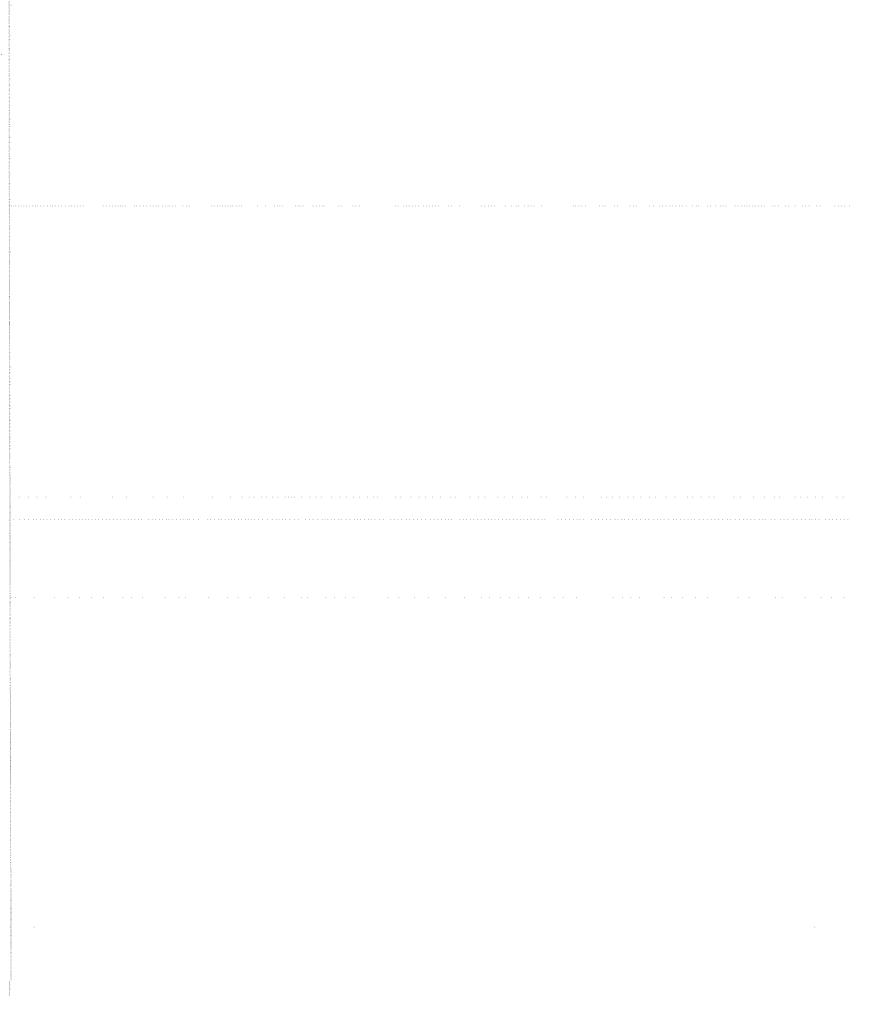


Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part	С	Qty		Description	Mfr Coc		Mfr Part Number
Designation	Number	D		<u> </u>	CMOS QUAD SILATERAL SWITCH	2848	i 3   M	 620-1938 C14013BCP
A11U21 A11U22 A11U23 A11U24	1820=1938 1820=1917 1820=1928 1820=1922 1820=1922	58255	i 4	IC	CMOS QUAD BILATERAL CMOS QUAD SHF-RGTR CMOS QUAL SHF-RGTR CMOS DUAL 4-BIT SHF-RGTR CMOS DUAL 4-BIT	019 284 284 270	28 C 80 1 80 1	04041AE 620-1622 620-1622 M310N
A11U26 A11U26 A11U27	1820=1822 1820=1822 1820=0471	3 5 0		IC	AMP GP 8-DIP-P SHF-RGIR CMGS DUAL 4-BIT INV ITL HEX 1-INP BFR CMGS HEX 1-INP	284 012 019	80 95 28	B20-1622 107406N 104010AF 1620-1622
A:1128 A:1129 A:1130	1820-0980	5 8		IC PI	BFR CMUS ONAL 4-817 SHF-RGTR CMOS DUAL 4-817 SHF-RGTR CMOS DUAL 4-817 N-GRV .062-IN-DIA .25-IN-LG STL TR-PC 8D VIO POLYC .062-80-THKNS	284		1 480 = 0 1 1 5 1 480 = 0 1 5 5
	4040=0755	5			ARD ASSEMBLY, PIN DRIVE C	26	480	05045-60412
412	05045=6001	5   3	1		(SERIES 1520)		480 480	0160-3456 0180-3456
41201 41202 41203 41204	0160-3456 0160-3456 0160-3456 0160-3456			000	PACITOR=FXD 1000PF +=10% 1KVDC CER APACITOR=FXD 1000PF +=10% 1KVDC CER APACITOR=FXD 1000PF +=10% 1KVDC CER APACITOR=FXD 1000PF +=10% 1KVDC CER	25	1480 1480	0160-3456 0160-3456 0160-3456
A12CS A12Ce	0160-3456	- 1	6	c	APACITOR=FXD 1000PF +=10% 1KVDC CER APACITOR=FXD 01UF +80=20% 100VDC CER	2	8480 8480 8480	0160-2055 0160-2055 0160-2055
A12C7 A12C8 A12C9	0180=2055 0180=2055 0180=2055 0180=2055		9	000	APACITOR=FAU .010F +80=20% 100VDC CER APACITOR=FAD .010F +80=20% 100VDC CER APACITOR=FAO .010F +80=20% 100VDC CER	"	8480   8480	0160-2055
A12C15 A12C15 A12C13	0150-0250 1055-0410 1055-0410 1055-0410		7 7 7 7 7	15   8	APACITOR-FXO 01UF +80-20% 10UVOC CER APACITOR-FXD 51PF +-5% 30UVOC MICA APACITOR-FXD 51PF +-5% 30UVOC MICA APACITOR-FXD 51PF +-5% 30UVOC MICA APACITOR-PXD 51PF +-5% 30UVOC MICA	8	8480 8480 8480	0160-2201 0160-2201 0160-2201 0160-2201
A12C14 A12C15 A12C16 A12C17	0160-2201 0160-2201 0160-220	i i	7 7 7 7		CAPACITOR=FXD 51PF +=5% 300VDC MICA CAPACITOR=FXD 51PF +=5% 300VDC MICA CAPACITOR=FXD 51PF +=5% 300VDC MICA		28480 28480 28480 28480 28480	0160-2201 0160-2201 0160-2201 0150-0121
A12C19 A12C19 A12C20	0160=220 0150=012	1	5	- 1	CAPACITOR-FXD .1UF +80-20% 50VDC CER CAPACITOR-FXD .1UF +80-20% 50VDC CER		28480	0150=0121
#18C51	0150=012		5 4	7	RESISTOR 51 2% .125% F TC#04=100		24546 24546 24546	C4m1/8mT0m51R0mG C4m1/8m70m2001mG C4m1/8m70m2001mG
A12R1 A12R2 A12R3 A12R4	0757=093 0757=093 0757=089	1 1 3	1 4		RESISTOR 51 2% 125% F TC=0+=100 RESISTOR 2K 2% 125% F TC=0+=100	er en en en en en en en en en en en en en	24546 24546 24546	C4=1/8=10=51R0=G C4=1/8=10=2001=G C4=1/8=10=2001=G C4=1/8=10=1002=G C4=1/8=10=1002=G
A12R5 A12R6 A12R7 A12R8	0757-09 0757-09 0757-09 0757-09	72 72	0 0 0		RESISTOR 100K 2% .125W F TCm0+=100 RESISTOR 100K 2% .125W F TCm0+=100 RESISTOR 100K 2% .125W F TCm0+=100 RESISTOR 100K 2% .125W F TCm0+=100 RESISTOR 100K 2% .125W F TCm0+=100		24546 24546 24546 24546	C4=1/8=TU=1002=G C4=1/8=TU=1002=G C4=1/8=T0=1002=G
A12R10	0757=09	72	0		RESISTOR LOOK 2% 125W F TC#0+=100		24546 54546 54546	C4-1/8-T0-1002-G 1810-0041 C4-1/8-10-51R0-G
412R12 412R12 412R13 412R14	1810-00 0757-00 0757-00	141 193 193	9 4 4		NETWORK-RES GAPINOS F TC=0+-100 RESISTOR 51 2% 125W F TC=0+-100 RESISTOR 51 2% 125W F TC=0+-100 RESISTOR 51 2% 125W F TC=0+-100		24546 24546	C4=1/6=10=31×0=0
A12R15 A12R16 A12R17	0757=0	814 972	9 0 9	4	RESISTOR 511 1% .5W F TC=0+-100 RESISTOR 100K 2% .125W F TC=0+-100 RESISTOR 511 1% .5W F TC=0+-100		54246 58480 54246 54480	C4=1/8=10=1002=G 0757=0814 C4=1/8=10=1002=G
A12R18 A12R19 A12R20	0757=0 0757=0 0757=0	972	0 4		RESISTOR 100 2% 125W F TC=0+=100		24546 28486 2454	0757-0814 C4-1/8-10-1002-G
A12R21 A12R22 A12R21 A12R24	0757=0 0757=0 0757=0 0757=0 0757=0	972 814 972	90909		RESISTOR 100 2% .5N F TC#0+=100 RESISTOR 100 2% .125% F TC#0+=100 RESISTOR 20K 2% .125% F TC#0+=100		2848 2454 2454 2454	0 0757=0814 6 C4=1/8=[0+1002=G 6 C4=1/8=[0=2002=G
A12R25	0757-	0917 0955	3		RESISTOR 510 2% 125% F JC=0+=100 RESISTOR 20% 2% 125% F JC=0+=100 RESISTOR 20% 2% 125% F JC=0+=100 RESISTOR 20% 2% 125% F JC=0+=100		2454 2454 2454	66
A12R27 A12R28 A12R29 A12R30	0757- 0757- 0757-	0955	3		RESISTOR 5.1K 2X .125W F TC=0+=100		2454 2454	46 C4=1/8=[0=2002=G
A12R31 A12R32 A12R33 A12R34	0757- 0757- 0757- 0757-	089 094 094	3		RESISTOR 5: 12 . 125W F TC=0+-10' RESISTOR 5:1K 2% .125W F TC=0+-10' RESISTOR 5:1K 2% .125W F TC=0+-10' RESISTOR 5:1K 2% .125W F TC=0+-10'	Q	245 245	46 C4=1/8=[0=5]01=6 46 C4=1/8=T0=5101=6 46 C4=1/8=T0=5101=6
A12R35 A12R36 A12R37	0757- 0757- 0757- 0757- 0757	⊷095 ≈095	5 9		RESISTOR 20K 2X .125W F 1C=0+=100 RESISTOR 20K 2X .125W F 1C=0+=100 RESISTOR 20K 2X .125W F 1C=0+=100		245 245 245 245 245	46 C4-1/8-10-2002-6 46 C4-1/8-10-2002-6 46 C4-1/8-10-1601-6
A12R38 P2R39 A12R40	0757 0757		5 2	e				

Table 6-1. Replaceable Parts (Cont'd)

***************************************	Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
	A12R41 A12R42 A12R43 A12R44 A12R44	0757~0924 0757~0937 0757~0924 0757~0955 0757~0931	27291		RESISTOR 1K 2% ,125% F TC#0+=100 RESISTOR 1,6K 2% ,125% F TC#0+=100 RESISTOR 1K 2% ,125% F TC#0+=100 RESISTOR 20K 2% ,125% F TC#0+=100 RESISTOR 2K 2% ,125% F TC#0+=100	24546 24546 24546 24546	C4=1/8=10=1001=6 C4=1/8=10=3601=6 C4=1/8=10=1001=6 C4=1/8=10=2002=6 C4=1/8=10=2001=6
	A12US A12US A12US A12US A12US	1820=0616 1820=1028 1820=0519 1820=0471 1820=0639	5 1 0 4	in a and	IC MUXR/DATA-SEL TTL 2-TO-1-LINE QUAD IC (MISC ITEM) IC SFR TIL NAND GUAD 2-INP IC INV TTL HEX 1-INP IC FF TIL 0-TYPE POS-EUGE-TRIG CLEAR	07263 01295 01295 01295 01295	9322PC 877489N 847437N 877446N 8774175N
	A12U6 A12U7 A12U8 A12U9 A12U10	1820=0716 1820=0782 1820=0782 1820=0683 1820=0693	8888	777.77	IC CNTR TIL BIN SYNCHRU POS-EDGE-TRIG IC CNTR TIL BIN SYNCHRO POS-EDGE-TRIG IC GATE TIL NOR TPL 3-INP IC INV TIL S HEX 1-INP IC FF TIL S D-TYPE POS-EDGE-TRIG	01295 01295 01295 01295 01295	8N74161N SN74161N SN7427N SN7480GN SN74874N
	A12U11 A12U13 A12U14 A12U15	1820-0367 1820-1164 1820-0665 1820-0328 1826-0055	M 42 40 40	1	IC SHF-RGTR TTL R-S PRL-IN PRL-OUT W-BIT IC SFR TTL NOR QUAD 2-INP IC GATE TTL S NAND TPL 3-INP IC GATE TTL NOR QUAD 2-INP COMPARATOR GP DUAL 14-DIP-C	01295 01295 01295 01295 07263	3N7495AN 3N745ION 3N745ION 3N7402N 711DC
Contract Consequence	A12U16 A12U17 A12U18 A12U19 A12U20	1826-0055 1820-1615 1820-0468 1826-0055	នាក់ស្ន	1	COMPARATOR GP DUAL 14-DIP-C IC IC DCDR TTL BCD-TO-DEC 4-TO-10-LINE COMPARATOR GP DUAL 14-DIP-C COMPARATOR GP DUAL 14-DIP-C	07263 04713 01295 07263 07263	711DC MC:46449BCP 8N7445N 711DC 711DC
CANADA AND AND AND AND AND AND AND AND AN		1250±1368 1480±0116 4040±0747	7 8 2	6	CONNECTURERF SM8 M PC 50=0HM PIN=GRV _062=IM=DIA _25=IM=LG STL EXTR=PC BD GRA POLYC _062=BD=IHKNS	28480 28480 28480	1250=1368 1480=0116 4940=0747
Salara House	A13	05045=60013	0	i	SOARD ASSEMBLY, PIN DRIVER (SERIES 1916)	28480	85045m60013
	A13C1 A13C2 A13C3 A13C4 A13C5	0180-2201 0170-0074 0170-0074 0160-2201 0160-3456	7 3 7 6	8	CAPACITOR-FXD 51PF +-5% 300VOC MICA CAPACITOR-FXD 047UF +-20% 50VDC POLYE CAPACITOR-FXD 047UF +-20% 50VDC POLYE CAPACITOR-FXD 51PF +-5% 300VDC MICA CAPACITOR-FXD 1000PF +-10% 1KVDC CER	28480 84411 84411 28480 28480	0160-2201 602-4730R5M2 6160-2201 0160-23056
Company of the second	A13C6 A13C7 A13C8 A13C9 A13C10	0160~3456 0160~1456 0160~3456 0160~3456 0160~2201	5 5 5 7		CAPACITOR=FXD 1000PF +=10% 1KVDC CER CAPACITOR=FXD 1000PF +=10% 1KVDC CER CAPACITOR=FXD 1000PF +=10% 1KVDC CER CAPACITOR=FXD 1000PF +=10% 1KVDC CER CAPACITOR=FXD 51PF +=5% 300VDC MICA	28480 28480 28480 28480 28480	0150-3456 0150-3456 0150-3456 0160-3456 0160-2201
Notice and the second s	4;3C;1 4;3C;2 4;3C;3 4;3C;4 £;3C;5	0170*0094 0170*0094 0160*2201 0160*3456 0160*3456	3 7 6 6		CAPACITOR=FXD .047UF +=20% 50VDC POLYE CAPACITOR=FXD .047UF +=20% 50VDC POLYE CAPACITOR=FXD 51PF +=5% 300VDC MICA CAPACITOR=FXD 1000PF +=10% 1KVDC CER CAPACITOR=FXD 1000PF +=10% 1KVDC CER	84411 84411 86480 28480 28480	602-4730R5w2 602-4730R5w2 0160-2201 0160-3056 0160-3456
And the Second Assessment of the Second	At 3016 At 3017 At 3018 At 3019 At 3020	0160=3456 0160=3456 0160=3456 0160=2204 0160=3454	6 6 0 4	10 4	CAPACITOR-FXD 1000PF +=10% 1KVDC CER CAPACITOR-FXD 1000PF +=10% 1KVDC CER CAPACITOR-FXD 1000PF +=10% 1KVDC CER CAPACITOR-FXD 100PF +=5% 300VDC MICA CAPACITOR-FXD 220PF +=10% 1KVDC CER	28480 28480 28480 28480 28480	0160-3456 0160-3456 0160-3456 0160-3254 0160-3454
	413C21 413C22 413C23 413C24 413C25	0160-3454 0160-3454 0160-2204 0150-0071 0160-3454	4044	4	CAPACITOR=FXD 220PF +=10% 1KVDC CER CAPACITOR=FXD 220PF +=10% 1KVDC CER CAPACITOR=FXD 100PF +=5% 300VDC MICA CAPACITOR=FXD 400PF +=5% 1KVDC CER CAPACITOR=FXD 220PF +=10% 1KVDC CER	28480 28480 28480 28480 28480 28480	0160-5454 0160-2454 0160-2204 0150-0071 0160-3454
	A13C26 A13C27 A13C28 A13C29 A13C30	0150-3456 0160-3456 0160-3456 0160-3456 0160-2199	29999	ð	CAPACITOR-FXD 1000PF +=10% 1KVDC CER CAPACITOR-FXD 1000PF +=10% 1KVDC CER CAPACITOR-FXD 1000PF +=10% 1KVDC CER CAPACITOR-FXD 1000PF +=10% 1KVDC CER CAPACITOR-FXD 30PF +=5% 100VDC MICA	28480 28480 28480 28480 28480	0160=3456 0160=3456 0160=3456 0160=3456 0160=2179
	A13C31 413C32 413C33 413C34 413C35	0160~2199 0160~2204 0160~2204 0160~2199	2002	enale vicama productiva propriate productiva propriate productiva propriate productiva propriate productiva propriate productiva pro	CAPACITOR-FXO 30PF +-5% 300VOC MICA CAPACITOR-FXO 100PF +-5% 300VOC MICA CAPACITOR-FXD 100PF +-5% 300VOC MICA CAPACITOR-FXD 30PF +-5% 300VDC MICA CAPACITOR-FXD 30PF +-5% 300VDC MICA	28480 28480 28480 28480	0160-2199 0160-2204 0160-2204 0160-2199 0160-2199
	A13C36 413C37 413C38 413C39 413C30	0170=0094 0170=0094 0160=2199 0160=2199 0170=0094	33223	and analysis of the same of th	CAPACITOR-FXO .047UF +-20% 50VDC POLYE CAPACITOR-FXD .047UF +-20% 50VDC POLYE CAPACITOR-FXD 30PF +-5% 300VDC MICA CAPACITOR-FXD 30PF +-5% 300VDC MICA CAPACITOR-FXD _047UF +-20% 50VDC POLYE	84411 28460 28460 28460	602-4730K5x2 602-4730K5x2 0160-2199 0160-2199 602-4730R5%2
	A13Ca1 413Ca2 A13Ca3 A13Ca4 A13Ca4	0170*0094 0150=0071 0150=0071 0150*0071 0150*2204	34440	The second secon	CAPACITOR-FXO 0047UF +-20% 50VOC POLYE CAPACITOR-FXO 400PF +-5% 1KVOC CEH CAPACITOR-FXO 400PF +-5% 1KVOC CEH CAPACITOR-FXO 400PF +-5% 1KVOC CER CAPACITOR-FXO 100PF +-5% 300VOC MICA	\$8480 \$8480 \$8480 \$8481	602-473085%2 0150-0071 0150-0071 0150-0071 0160-2204
	<u> </u>	\$100 market					

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Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part	c	000	Description	Mfr Code	Mfr Part Number
Designation	Number	D	Qty			2199
13046	0160-2199 0160-2199 0160-2204	0 N N		CAPACITOR=FXD 30PF +=5% 380VDC MICA CAPACITOR=FXD 30PF +=5% 380VDC MICA CAPACITOR=FXD 100PF +=5% 380VDC MICA	28480 28480 28480	0160=2199 0160=2199 0160=2204 1901=0040
13048 1130R1 1130R2 1130R3 1130R3	1901=0040 1901=0040 1901=0040 1901=0040 1901=0040	11 +1 94 +4 94		DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35	58490 58490 58480 58460 58490	1901-0040 1901-0040 1901-0040 1901-0040
113043 413087 413088 413089 413089	1901-0040 1901-0040 1901-0040 1901-0040	1 1 1 1 1		DIODE-SWITCHING 30V 50MA 2NS D0-35 DIODE-SWITCHING 30V 50MA 2NS D0-35 DIODE-SWITCHING 30V 50MA 2NS D0-35 DIODE-SWITCHING 30V 50MA 2NS D0-35 DIODE-SWITCHING 30V 50MA 2NS D0-35	28480 28480 28480 28480 28480	1901-0040 1901-0040 1901-0040 1901-0040
A:SCR11 A:SCR12 A:SCR13 A:SCR13	1902+3193 1902+3193 1902+3193 1902+3193 1901+0040	3 3 3 1	4	DIODE-ZNR 13.3V 5% DO-7 PDB.4W TCS+.059% DIODE-ZNR 13.3V 5% DO-7 PDB.4W TCS+.059% DIODE-ZNR 13.3V 5% DO-7 PDB.4W TCS+.059% DIODE-ZNR 13.3V 5% DO-7 PDB.4W TCS+.059% DIODE-ZNR 13.3V 5% DO-7 PDB.4W TCS+.059% DIODE-SWITCHING 30V SOMA 2NS DO-35	26460 26460 26460 28460	1902-3193 1902-3193 1902-3193 1901-0040
A13CR15 A13CR16 A13CR17 A13CR19 A13CR20	1901=0040 1901=0518 1901=0518 1901=0040 1910=0034	1 8 8 1 2		DIODE-SWITCHING 30V 50MA 2NS DO-35 DIODE-SCHOTTKY DIODE-SCHOTTKY DIODE-SWITCHING 30V 50MA 2NS DO-35 DIODE-SE 30V 80MA 8NS DO-7	28480 28480 28480 28480	1901-0518 1901-0518 1901-0518 1901-0040 1910-0034
A13CR21 A13CR22 A13CR23 A13CR24 A13CR25	1901+0040 1901=0050 1901=0050 1901=0050	3 3 3 3	108	DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 80V 200MA 2NS 00-35 DIODE-SWITCHING 80V 200MA 2NS 00-35 DIODE-SWITCHING 80V 200MA 2NS 00-35 DIODE-SWITCHING 80V 200MA 2NS 00-35	28480 28480 28480 28480 28480	1901-0050 1901-0050 1901-0050
A13CR26 A13CR27 A13CR28 A13CR29 A13CR30	1901-0050 1901-0050 1901-0050 1901-0050 1910-0034	A. C. M. C. M.	, ]	DIODE-SWITCHING 80V 200MA 2NS 00-35 DIODE-SWITCHING 80V 200MA 2NS 00-35 DIODE-SWITCHING 80V 200MA 2NS 00-35 DIODE-SWITCHING 80V 200MA 2NS DC-35 DIODE-SWITCHING 80V 200MA 2NS DC-35 DIODE-GE 30V 80MA 8NS DC-7	28480 28480 28480 28480 28480	1901=0050 1901=0050 1901=0050 1910=0034
A13CR31 A13CR32 A13CR33 A13CR34 A13CR35	1910-0034 1901-0518 1901-0518 1901-0518 1901-0518		2 8 8 8	DIODE-SCHOTTKY DIODE-SCHOTTKY DIODE-SCHOTTKY DIODE-SCHOTTKY DIODE-SCHOTTKY	28480 08485 08485 08485	1910-0054 1901-0518 1901-0518 1901-0518
A:30:4 A:30:4 A:30:2 A:30:3 A:30:4	1854-0071 1854-0634 1854-0071 1854-0071		7 8 7 7	TRANSISTOR NEW SI PD#300MM FT#200MHZ TRANSISTOR NEW SI PD#300MM FT#200MHZ TRANSISTOR NEW SI PD#300MM FT#200MHZ	28480 04713 28480 28480 28480	1854-0071
A:305 A:306 A:307 A:308 A:307	1854-0071 1854-0534 1854-0071 1853-0620 1853-0326		7 8 7 4	TRANSISTOR NPN SI PD#300MW FT#200MHZ TRANSISTOR NPN SI PD#1W FT#50MHZ TRANSISTOR NPN SI PD#300MW FT#200MHZ TRANSISTOR PNP SI PD#300MW FT#150MHZ TRANSISTOR PNP SI PD#300MW FT#150MHZ TRANSISTOR PNP SI PD#1W FT#50MHZ	28480 04713 28480 28480 04713	MPS=U01 1854-0071 1853-0020 MPS=U51
A13011 A13012 A13013 A13014	1853-0020 1853-0020 1853-0020 1853-0326	) )	4 4 3 4	TRANSISTOR PNP SI PD#300MW FT#150MMZ TRANSISTOR PNP SI PD#300MW FT#150MMZ TRANSISTOR PNP SI PD#300MW FT#150MMZ TRANSISTOR PNP SI PD#30 PN FT#50MMZ TRANSISTOR PNP SI PD#300MW FT#150MMZ TRANSISTOR PNP SI PD#300MW FT#150MMZ	28480 28480 28480 04713 28480	1853-0020 1853-0020 MPS-U51 1853-0020
A13015 A13016 A13017 A13018 A13019	1853-0020 1854-0670 1854-007 1854-007	0 0 1	2 7 7	TRANSISTOR PNP SI PDE300MW FTE150MMZ TRANSISTOR NPN SI DARL PDE300MM FTE200MMZ TRANSISTOR NPN SI DARL PDE300M FTE200MMZ TRANSISTOR NPN SI DARL PDE300M FTE200MMZ TRANSISTOR NPN SI PDE300MW FTE200MMZ	2848 0129 2848 0129 2848	TIP110 0 1854-0071 TIP110 0 1854-0071
A13020 A13021 A13022 A13023 A13024	1853+002 1853-037 1853-037 1853+002	0 7 7	4 4 4	TRANSISTOR PNP SI PD#309MW FT#150MHZ TRANSISTOR PNP SI DARL PD#50W TRANSISTOR PNP SI DARL PD#50W TRANSISTOR PNP SI PD#300MW FT#150MHZ	2848 0129 0129 2848	5 TIP 115 5 TIP 115 1851-0020
A13R1 A13R2 A13R3 A13R4	0757-090 0757-090 0757-090 0757-028	) 9 ) 7 3 3	3164	2 RESISTOR 240 2% .125W F 1C=0+=100 RESISTOR 240 2% .125W F 1C=0+=100 RESISTOR 200 2% .125W F 1C=0+=100 RESISTOR 2% 1% .125W F 1C=0+=100 RESISTOR 2% 1% .125W F 1C=0+=100 RESISTOR 25 1% 3W PW 1C=0+=20	2454 2454 2454 2454	C4=1/8=10=201=F C4=1/8=10=2001=F C4=1/8=10=2001=F 0811=3451
A13R6 A13R7 A13R8 A13R8	0757-026 0757-091 0811-349 0757-09	53 74 74	# P P P P P	RESISTOR 2K 1% .(25M F TC=0+-100 RESISTOR 126K 2% .125M F TC=0+-100 RESISTOR 25 1% 3M PM TC=0+-20 RESISTOR 126K 2% .125M F TC=0+-100 RESISTOR 560 2% .125M F TC=0+-100	245/ 245/ 245/ 245/ 245	46
A13R10 A13R11 A13R12 A13R13 A13R14 A13R15	0757=09 -0757=09 -0757=09 -0757=09 -0757=09	65 18 65 67	1 1 1 2	RESISTOR 51K 2X .125% F TC=0++100 RESISTOR 560 2X .125% F TC=0++100 RESISTOR 51K 2X .125% F TC=0+-100 RESISTOR 200 2X .125% F TC=0+-100 RESISTOR 120K 2X .125% F TC=0++100	245 245 245	46

Table 6-1. Replaceable Parts (Cont'd)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
A13816 A13817 A13818 A13819 A13820	0757-0974 0811-3453 0757-0283 0757-0263 0811-3453	ក្នុង ក្ស ស្ន		RESISTOR 120K 2% .125W F TC=0+-100 RESISTOR 25 1% 3W PW TC#0+-00 RESISTOR 2K 1% .125W F TC=0+-100 RESISTOR 2K 1% .125W F TC=0+-100 RESISTOR 2K 1% .125W F TC=0+-20	24546 28480 24546 24546 28480	C4=1/8+10+1202=G 0811=3453 C4=1/8+10=2001+F C4=1/8+10=2001+F 0811=3453
A13R21 A13R22 A13R23 A13R24 A13R25	0757-0918 0757-0965 0757-0965 0757-0918 0757-0948	4		RESISTOR 560 2x .125% F TC*0+-100 RESISTOR 51% 2x .125% F TC*0+-100 RESISTOR 51% 2x .125% F TC*0+-100 RESISTOR 560 2x .125% F TC*0+-100 RESISTOR 10% 2x .125% F TC*0+-100	24546 24546 24546 24546	C4-1/8-Tu-561-6 C4-1/8-Tu-5102-6 C4-1/8-Tu-5102-6 C4-1/8-Tu-561-6 C4-1/8-10-1002-5
A:3R26 A:3R27 A:3R28 A:3R29 A:3R30	0757-0948 0757-0948 0757-0946 0757-0937 0757-0923	0 0 7	q	RESISTOR 10% 2% .125W F TC#0++100 RESISTOR 10% 2% .125W F TC#0++100 RESISTOR 10% 2% .125W F TC#0++100 RESISTOR 3.6% 2% .125W F TC#0++100 RESISTOR 910 2% .125W F TC#0++100	24546 24546 24546 24546 24546	C4-1/8-10-1002-G C4-1/8-70-1002-G C4-1/8-70-1002-G C4-1/8-70-901-G C4-1/8-70-911-6
A13R31 A13R32 A13R33 A13R34 A13R35	0757~0923 0757~0923 0757~09283 0757~0955 0757~0976	11594		RESISTOR 910 2% ,125w f TC=0++100 RESISTOR 910 2% ,125w f TC=0++100 RESISTOR 2k 1% ,125w f TC=0++100 RESISTOR 2k 2% ,125w f TC=0++100 RESISTOR 150k 2% ,125w f TC=0++100	24546 24546 24546 24546 24546	C4-1/8-70-911-G C4-1/8-70-911-G C4-1/8-70-2001-P C4-1/8-70-2002-G C4-1/8-70-1502-G
A13836 A13837 A13836 A13839 A13840	0757-0924 0757-0976 0757-0955 0757-0283 0757-0911	24967		RESISTOR 1K 2X 125W F TC#0++100 RESISTOR 150K 2X 125W F TC#0++100 RESISTOR 26K 2X 125W F TC#0++100 RESISTOR 2K 1X 125W F TC#0++100 RESISTOR 300 2X 125W F TC#0++100	24546 24546 24546 24546 24546	C4=1/8=f0=1001=G C4=1/8=f0=1502=G C4=1/8=f0=202=G C4=1/8=f0=201=F C4=1/8=f0=301=G
A13841 A13842 A13843 A13844 A13845	0757-0937 0757-0924 0698-3457 0757-0976 0698-3457	7 2 6 4 6	4	RESISTOR 3.6K 2% .125W F TC=0+-100 RESISTOR 1K 2% .125W F TC=0+-100 RESISTOR 316K 1% .125W F TC=0+-100 RESISTOR 150K 2% .125W F TC=0+-100 RESISTOR 316K 1% .125W F TC=0+-100	24546 24546 28480 24546 24546 28480	C4+1/8-TU-5601-G C4+1/8+T0-1001-6 0698-3457 C4-1/8-TU+1502-G 0698-3457
A13R46 A13R47 A13R48 A13R49 A13R50	0757+0937 0757+0924 0757+0924 0757+0976 0757+0937	7 2 2 4 7		RESISTOR 3.6K 2% .125W F TC=0+-100 RESISTOR 1K 2% .125W F TC=0+-100 RESISTOR 1K 2% .125W F TC=0+-100 RESISTOR 150K 2% .125W F TC=0+-100 RESISTOR 3.6K 2% .125W F TC=0+-100	24546 24546 24546 24546	C4=1/8=f0=3001=G C4=1/8=f0=1001=G C4=1/8=f0=1001=G C4=1/8=f0=1502=G C4=1/8=f0=3601=G
A13851 A13852 A13853 A13854 A13855	0757-0911 0757-0911 0757-0923 0757-0924 0698-3457	7 7 1 2 6		RESISTOR 300 2X .125W F TC=0+=100 RESISTOR 300 2X .125W F TC=0+=100 RESISTOR 910 2X .125W F TC=0+=100 RESISTOR 1K 2X .125W F TC=0+=100 RESISTOR 316K 1% .125W F TC=0+=100	24546 24546 24546 24546 28480	C4=1/8=10-301=6 C4=1/8=10-301=6 C4=1/8=10-911-6 C4=1/8=10-1001=6 0698-3457
A13856 A13857 A13858 A13859 A13860	0757-0924 0698-3457 0757-0911 0757-0955 0757-0955	2 67 9 9		RESISTOR 1K 2% ,125W F TC=0+-100 RESISTOR 316K 1% ,125W F TC=0+-100 RESISTOR 300 2% ,125W F TC=0+-100 RESISTOR 20K 2% ,125W F TC=0+-100 RESISTOR 20K 2% ,125W F TC=0+-100	24546 2888 24546 24546 24546	C4-1/8-10-1001-6 0598-3457 C4-1/8-10-501-6 C4-1/8-70-2002-6 C4-1/8-70-2002-6
413861 413862	0757-0283 0757-0283	6		RESISTOR 2K 1% .125W F TC#0++100 RESISTOR 2K 1% .125W F TC#0++100	24546 24546	C4=1/8+1U=2001=F C4=1/8+1U=2001=F
A1301 A1302 A1303 A1304 A1305	1826=0311 1820=1619 1826=0311 1820=1618 1820=1620	90993	8 2 3	OP AMP GP 8-01P-P IC GATE CMOS EXCL-OR/NOR TPL 3-INP OP AMP GP 8-01P-P IC GATE CMOS NAND IPL 3-INP IC GATE CMOS NOR GUAD 2-INP	04713 04713 04713 04713 04713	MC14001RCL MC14057RCL MC14057RCL MC14052CRCL MCM2014P1
A:3106 A:307 A:308 A:309 A:3010	1820=1621 1826=0311 1826=0311 1826=0311	49999	1	IC GATE CMOS NANO GUAO 2-INP OP AMP GP 8-DIP-P OP AMP GP 8-DIP-P OP AMP GP 8-DIP-P OP AMP GP 8-DIP-P	04713 04713 04713 04713 04713	MC 1401108CP MLM201AP1 MLM201AP1 MLM201AP1 MLM201AP1
A13U11 A13U12 A13U13 A13U14 A13U15	1826=0311 1820=1619 1826=0311 1820=1618 1820=1620	9 0 9 5		OP AMP GP 8=01P=P IC GATE CMUS EXCL=OR/NUR TPL 3=INP OP AMP GP 8=D1P=P IC GATE CMOS NAND TPL 3=INP IC GATE CMOS NOR GUAD 2=INP	04713 04713 04713 04713 04713	MEM201AF1 MC14025UBCP MC14023UBCP MC14023UBCP
A13016 413017 A13018 A13018 A13020	1820-1938 1820-1938 1820-1614 1820-1614 1820-1620	66553	5	IC IC, CMOS, 40168 4D IC, CMOS, 40168 4D IC GATE CMOS NOR QUAD 2×1NP	28480 28480 28480 28480 04713	1820-1938 1820-1938 1820-1614 1820-1614 MC14001U8CP
AF3U21 AF3U22 AF3U23 AF3U24 AF3U25	1820-1614 1820-1617 1820-1614 1820-1614 1820-1938	58556		IC, CMOS, 40168 40 IC CMOS DUAL D F-F POS EDGE CLOCK IC, CMOS, 40168 4D IC, CMOS, 40168 4D IC	28480 28480 28480 28480 28480	1850=1870 1850=1614 WC110138Cb 1850=1914
At Suga	1820-1938	6		re .	54480	1620 <b>-</b> 1936

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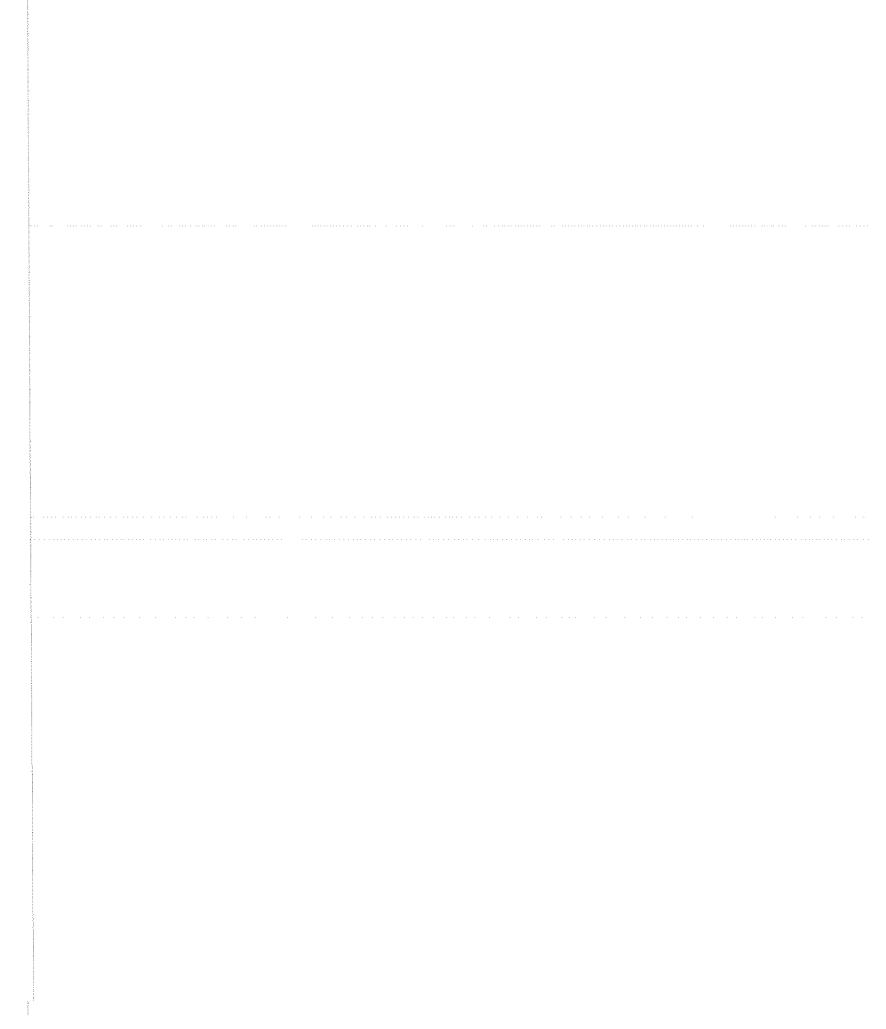


		Table	6-1. Replaceable Parts (Cont'd)	Mfr Code	Mfr	Part Number
Reference	HP Part c	Qty	Description	28480	0340-0579 0360-1682	2077730N
Designation	0340=0579 0360=1682 0570=0125 1480=0116 4040=0710 2360=0055 05045=20202	1 TE SC PI	SULATOR RUBBER RED SMINAL-STUD SGL-TUR PRESS-MTG SMINAL-STUD SGL-TUR PRESS-MTG REM-MACH 4-40, 188-IN-LG BOG-HO-SLT REM-MACH 4-40, 188-IN-LG BOG-HO-SLT XTR-PC BD BLK POLYC, 07-80-THKNS XTR-PC BD BLK POLYC, 07-80-THKNS CREW-MACH 6-32, 188-IN-LG BOG-HO-SLT EAT SINK	28480 00000 28480 00000 28480	08058 BY 1480#0115 4040#0715	DESCRIPTION
	020t3#50sor		SAME AS A13, USE PREFIX A14			
4 5 4		1 1	SAME AS A13, USE PREFIX A15			
A15		A Company of the Comp	SAME AS A13. USE PREFIX A15			
410			SAME AS A13, USE PREFIX A17(OPTION 024)			
AST			SAME AS A13, USE PREFIX A18 (UPTION 024			
å16			SAME AS A13, USE PREFIX A19(OPTION 024	4)		
A19			SAME AS A13, USE PREFIX A20(OPTION 02			
05A			SAME AS A13, USE PREFIX A2)		l l	
wat			SAME AS A13, USE PREFIX A22			
#55			SAME AS A13, USE PREFIX A23			
¥53			SAME AS A13, USE PREFIX A24	} a	8480 098	10-6552
A25  A25C3 A25C3 A25C3 A25C4 A25C3 A25C4 A25C7	0150= 1901= 1901= 1901= 2 1901 0 1901 2 1901 2 1901 1901 1901 1901 1901	063339 99966 509650 96503 5 111 4444780 1	SENSOR ASSEMBLY ARE AN EXCHAPGE  SENSOR ASSEMBLY ARE AN EXCHAPGE  ORDERED BY PART NUMBER 19810-6796  THE REPLACEMENT PARTS ARE LISTED  BELOW FOR REFERENCE ÜNLY.  BELOW FOR REFERENCE ÜNLY.  BELOW FOR REFERENCE ÜNLY.  BELOW FOR REFERENCE ÜNLY.  BELOW FOR REFERENCE ÜNLY.  BELOW FOR REFERENCE ÜNLY.  BELOW FOR REFERENCE ÜNLY.  BELOW FOR REFERENCE ÜNLY.  BELOW FOR REFERENCE ÜNLY.  BELOW FOR REFERENCE ÜNLY.  BELOW FOR REFERENCE ÜNLY.  BELOW FOR REFERENCE ÜNLY.  BELOW FOR REFERENCE ÜNLY.  SOUDC CAPACITOR-FXD 22UF+-10X 15VDC TA  CAPACITOR-FXD .01UF +80-20X 100VDC  CAPACITOR-FXD .01UF +100-0X 50VDC  CAPACITOR-FXD .00FF +-1X .500VDC  CAPACITOR-FXD .00FF +-1X .00VDC  CAPACITOR-FXD .00FF1X .	RRCCERRCCER CCERRCCER ICACER I	56289 51 528480 61 61 628480 61 628480 61 628480 61 628480	00226×901582 00226×901582 60=0128 60=0174 150=0084 150=0084 150=0084 150=2001 160=2001 160=2001 1500226×901582 0160=2001

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N. C. C. C. C. C. C. C. C. C. C. C. C. C.				

Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part	C D	Qty		_	Mfr Code	Mfr Part Numbe	, <b>K</b>
Designation	Number 1901-0040 1901-0040	1 1 1 4	a	0100	DE-SWITCHING SOV 50MA 2NS DD-35 DE-SWITCHING SOV 50MA 2NS DD-35 DE-SWITCHING SOV 50MA 2NS DO-35 DE-ZNR 5.11V 5% DD-7 PDB.4W TCS#.009% DE-SWITCHING SOV 50MA 2NS DD-35	28480 28480 28480 28480 28480	1901-0040 1901-0040 1901-0040 1902-0041 1901-0046	
A25CR102 A25CR103 A25CR105 A25CR105	1902=0041 1901=0040 1901=0040 1901=0040 1901=0040	1		0100	DE-SWITCHING 30V 50MA 2NS DD=35 DE-SWITCHING 30V 50MA 2NS DD-35 DE-ZNR 5,11V 5% DD-7 PDm,4W TCm=,009%	28460 26460 28480 28480 28480	1901=0040 1901=0040 1901=0040 1901=0040 1902=0041	
A25CR200 A25CR201 A25CR203 A25CR203 A25CR206	1902=0041 1901=0040 1901=0040 1901=0040	4 444		010	DDE-SWITCHING 30V 50MA 2NS 00~35 DDE-SWITCHING 30V 50MA 2NS 00~35 DDE-SWITCHING 30V 50MA 2NS 00~35 DDE-SWITCHING 30V 50MA 2NS 00~35 DDE-SWITCHING 30V 50MA 2NS 00~35 DDE-SWITCHING 30V 50MA 2NS 00~35 DDE-ZNR 5,11V 5% 00~7 PD#, 4% TC#-,009%	28480 28480 28480 28480 28480	1901-0040 1901-0040 1901-0040 1902-0041	
A25CR300 A25CR301 A25CR302 A25CR303 A25CR306	1902=0041 1901=0040 1901=0040 1901=0040 1901=0040	4		DIC	ODE-SWITCHING 30V 50MA 2NS DO-35 ODE-SWITCHING 30V 50MA 2NS DO-35 ODE-SWITCHING 30V 50MA 2NS DO-35 ODE-SWITCHING 30V 50MA 2NS DO-35 ODE-SWITCHING 30V 50MA 2NS DO-35 ODE-ZNR 5.11V 5% DO-7 PDB-4W ICH-009%	28480 28480 28480 28480	1902~0041 1901~0040 1901~0040	
A25CR400 A25CR401 A25CR402 A25CR403 A25CR403 A25CR405	1902=0041 1901=0040 1901=0040 1901=0040	1 1 1		01 01 01	ODE-SWITCHING BOV 50MA 2NS 00-35 ODE-SWITCHING 30V 50MA 2NS 00-35 ODE-SWITCHING 30V 50MA 2NS 00-35 ODE-SWITCHING 30V 50MA 2NS 00-35	28480 28480 28480 28480	1901-0040 1901-0040 1901-0040 1901-0040	
A250; A250; A250; A250; A250;	1854-0404 1853-0404 1854-0404 1854-0404	0 2 0 0		7 F	RANSISTOR NPN SI TO=16 PD=360MW RANSISTOR PNP SI TO=18 PD=360MW RANSISTOR NPN SI TO=18 PD=360MW RANSISTOR NPN SI TO=18 PD=360MW RANSISTOR NPN SI TO=18 PD=360MW RANSISTOR NPN SI TO=18 PD=360MW	28480 28480 28480 28480	1853-0010 1854-0404 1854-0404 1854-0404	
25021 25022 25023 425031 425032	1824~0404 1822~0010 1824~0404			7	RANSISTOR NPN SI TO-18 PD=360MW RANSISTOR NPP SI TO-18 PD=360MW RANSISTOR NPN SI TO-18 PD=360MW RANSISTOR NPN SI TO-18 PD=360MM RANSISTOR NPN SI TO-18 PD=360MM RANSISTOR NPN SI TO-18 PD=360MM	28480 8480 8488 8488 8488 8488 8488	1853=0010 1854=0404 1854=0404	
A25001 A25042 A25003 A25044 A25045	1854-0404 1853-001 1853-001 1854-040		202	1	TRANSISTOR NPN SI TO-16 PD=360M* TRANSISTOR PNP SI TO-18 PD=360M* TRANSISTOR PNP SI TO-16 PD=360M* TRANSISTOR NPN SI TO-16 PD=360M* TRANSISTOR PNP SI TO-18 PD=360M* TRANSISTOR PNP SI TO-18 PD=360M*	28480 28480 28480 28480	1853-0010 1853-0010 1853-0010	
A250101 A250103 A250104 A250105 A250106	1853-001 1854-040 1854-040	4 4	0000		TRANSISTOR NPN SI TO-18 PD#360MW TRANSISTOR NPN SI TO-18 PD#360MW TRANSISTOR NPN SI TO-18 PD#360MW TRANSISTOR PNP SI TO-18 PD#360MW TRANSISTOR NPN SI TO-18 PD#360MW TRANSISTOR NPN SI TO-18 PD#360MM	2848 2848 2848 28486	1854-0404 1854-0404 1853-6010 0 1854-0404	
A250107 A250201 A250203 A250204 A250205	1854=040 1853=0040 1854=041 1854=041	.0 )4 )4	2000		TRANSISTOR PNP SI TO-18 P00360MW TRANSISTOR NPN SI TO-18 P00360MW TRANSISTOR NPN SI TO-18 P00360MW TRANSISTOR NPN SI TO-18 P00360MW TRANSISTOR PNP SI TO-18 P00360MM	2848 2848 2848 2848	0 1654=0404 1854=0404 1854=0404 1853=0010	
4250207 4250207 4250301 4250303 4260304	1853-00 1854-04 1853-00 1854-04	04 10 04	8 0 2 0 0		TRANSISTOR NPN SI TO-18 PD=360 MW TRANSISTOR PNP SI TO-18 PD=360 MW TRANSISTOR NPN SI TO-18 PD=360 MW TRANSISTOR NPN SI TO-18 PD=360 MW TRANSISTOR NPN SI TO-18 PD=360 MW TRANSISTOR NPN SI TO-18 PD=360 MW	2844 2844 2844	1853=0010 1854=0404 60 1854=0404 1854=0404	
A250305 A250306 A250307 A256401 A256403	1854-04 1853-0 1853-0 1853-0	104 104 104 010	0 20020		TRANSISTOR PNP SI TG-18 POR360*W TRANSISTOR NPN SI TO-18 POR360*W TRANSISTOR PNP SI TO-18 POR360*W TRANSISTOR NPN SI TO+18 POR360*W TRANSISTOR NPN SI TO+18 POR360*W TRANSISTON NPN SI TO-18 POR360*W TRANSISTON NPN SI TO-18 POR360*W	284 284 284 284 284	80 1854-0404 1853-0010 1854-0404 1854-0404	
AZSGADA AZSGADA AZSGADA AZSGADA	1854=0 1854=0 1853=0 1854=0	404 404 010	0 0 0 0		TRANSISTOR NPN SI TO-18 PD#350MM TRANSISTOR PNP SI TU-18 PD#350MM TRANSISTOR NPN SI TO-18 PD#350MM	28:	480 1853=0010 480 1854=0404 121 CB1031	
A2501 A2502 A2504 A2504 A2507	064- 0684- 1684- 1684- 0684-	021 031 4711	97087	18 7 1 1	RESISTOR 10K 10% .25% FC TC=-400/+700 RESISTOR 1K 10% .25% FC TC=-400/+600 RESISTOR 470 10% .25% FC TC=-400/+600 RESISTOR 1K 10% .25% FC TC=-400/+600	01	121 CB1021 1684-1051 121 CB4711 121 CB1021	
Apres Marie Apres Apres Apres	0684- 0684- 0684- 0684- 0684-	2231 5101 2241	3 15 9 2	6 4 4	RESISTOR 22K 10% .25% FC TC=-400/+80 RESISTOR 33 10% .25% FC TC=-400/+500 RESISTOR 220K 10% .25% FC TC=-400/+70 RESISTOR 10% 10% .25% FC TC=-400/+80 RESISTOR 47K 10% .25% FC TC=-400/+80	00 01	121 CB3301 121 CB2241 1121 CB1031 1121 CB4731	
	0698, 0684, 0684, 0684		1 5 9 2	8	RESISTOR 13 10% 25% FC 1C==400/+500 RESISTOR 220K 16% 25% FC 1C==400/+50 RESISTOR 10K 10% 25% FC 1C==400/+60 RESISTOR 47K 16% 25% FC 1C==400/+60 RESISTOR 100K 10% 25% FC 1C==400/+60	0 0	1121 CB2241 1121 CB1031 1121 CB4731 1121 CB1041	

Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part	C D	Qty	Description	Mfr Code	Mfr Part Number
Designation 25R25 25R30 25R31 25R32	Number  0684=1031 0698-5101 0684-2241 0684-1031	9 1 5 9		RESISTOR 10K 10X _25W FC TCR=400/+700 RESISTOR 33 10X _25W FC TCR=400/+500 RESISTOR 220X 10X _25W FC TCR=400/+900 RESISTOR 10X 10X _25W FC TCR=400/+700 RESISTOR 47K 10X _25W FC TCR=400/+800	01121 01121 01121 01121 01121	CB1031 CB3301 CB2241 CB1031 CB4731
23833 23840 23841 23842 23842 25843	0684-4731 0698-5101 0684-2241 0684-1031 0684-4731	2 15021		RESISTOR 33 10% .25W FC TC=-400/+500 RESISTOR 220K 10% .25W FC TC=-600/+900 RESISTOR 10K 10% .25W FC TC=-400/+700 RESISTOR 47K 10% .25W FC TC=-400/+800 RESISTOR 100K 10% .25W FC TC=-400/+800	01121 01121 01121 01121 01121	CB3501 CB2241 CB1031 CB1041
a25R44 a25R44 a25R44 a25R47 a25R48	0684-1031 0684-13331 0684-2231 0684-2231	9 6 7 9 3	ţ	RESISTOR 10K 10X .25W FC TC==400/+700 RESISTOR 33K 10X .25W FC TC==400/+800 RESISTOR 22K 10X .25W FC TC==400/+800 RESISTOR 10K 10X .25W FC TC==400/+700 RESISTOR 22K 10X .25W FC TC==400/+800	01121 01121 01121 01121	CB1031 CB3331 CB2231 CB1031 CB2231
A25R49 A25R50 A25R101 A25R102 A25R103	0684-4721 0684-1031 0684-1031 0684-2721 0684-2221	00000	4	RESISTOR 4.7K 10% .25W FC TC=-400/+700 RESISTOR 10K 10% .25W FC TC=-400/+700 RESISTOR 10K 10% .25W FC TC=-400/+700 RESISTOR 2.7K 10% .25W FC TC=-400/+700 RESISTOR 1.2K 10% .25W FC TC=-400/+700 RESISTOR 1.2K 10% .25W FC TC=-400/+700	01121 01121 01121 01121 01121	C#1031 C#1031 C#2721 C#1221 C#1221
425R106 425R106 425R107 425R108 425R109	0757-0280 0757-0280 0698-4519 0698-4500 0757-0280	3 3 3	4	RESISTOR 1K 1% .125W F TC=0++100 RESISTOR 1K 1% .125W F TC=0++100 RESISTOR 140K 1% .125W F TC=0++100 RESISTOR 57.0K 1% .125W F TC=0++100 RESISTOR 1K 1% .125W F TC=0++100 RESISTOR 1K 1% .125W F TC=0++100	24546 24546 24546 24546	C4=1/8=10=1001=F C4=1/8=10=1103=F C4=1/8=10=5762=F C4=1/8=10=1001=F C4=1/8=10=3012=F
A25R111 A25R111 A25R112 A25R113 A25R114	0757-0453 0757-0280 0684-1051 0698-4211 0684-1041		7	RESISTOR 30.1K 1% .125W F TCm0+-100 RESISTOR 1K 1% .125W F TCm0+-100 RESISTOR 1M 10% .25W FC TCm=800/+900 RESISTOR 1M 10% .25W F TCm0+-100 RESISTOR 100K 10% .25W FC TCm+400/+600 RESISTOR 100K 10% .25W FC TCm+400/+600	24546 24546 01121 24546 01121	C=-1/8-(01001-F CB1041 C4-1/8-(01583-F CB1041 C4-1/8-(0-8002-F
A25R115 A25R116 A25R117 A25R118 A25R119	0684-1041 0698-4505 0694-4505 0664-2231 0684-4731			RESISTOR 71.5% 1% 1629 1 10 10 10 10 10 10 10 10 10 10 10 10 1	24546 24546 01121 01121 01121	C4-1/8-TU-7152-F C81051 C82231 C84731
A 25 R 1 20 A 25 R 1 21 A 25 R 1 23 A 25 R 20 1 A 25 R 20 2	0684-4721 0684-4721 0684-1031 0684-1031 0684-2721		07096	RESISTOR 4.7K 10% .25% FC TC=+490/+700 RESISTOR 1K 10% .25% FC TC=+400/+600 RESISTOR 10K 10% .25% FC TC=+400/+700 RESISTOR 10K 10% .25% FC TC=+400/+700 RESISTOR 2.7K 10% .25% FC TC=+400/+700	01121 01121 01121 01121 2110	CB1031 CB1031 CB1031 CB2721
A25R204 A25R204 A25R206 A25R207 A25R208	0684-1221 0757-0280 0757-0280 0698-451	)	3333	RESISTOR 1.2K 10% .25% FC TC%-400/+700 RESISTOR 1K 1% .125% F TC%0+-100 RESISTOR 1K 1% .125% F TC%0+-100 RESISTOR 140K 1% .125% F TC%0+-100 RESISTOR 57.6K 1% .125% F TC%0+-100	0112 2454 2454 2454 2454	6 C4=1/8=TU=1001=F C4=1/8=T0=1001=F C4=1/8=T0=1001=F 6 C4=1/8=T0=1403=F 6 C4=1/8=[0=5782=F
A25R210 A25R211 A25R211 A25R212 A25R213	0498-4500 0757-028 0757-045 0757-028 0684-105	0 3 0	NENGN	RESISTOR 1K 1% .125W F TC=0+-100 RESISTOR 30.1K 1% .125W F TC=0+-100 RESISTOR 1K 1% .125W F TC=0+-100 RESISTOR 1M 10% .25W F TC=-800/+900 RESISTOR 158K 1% .125W F TC=0+-100	2454 2454 0112 2454	C4-1/8-10-3012-F C4-1/8-10-1001-F CB1051 C4-1/8-10-1583-F
A25R214 A25R215 A25R216 A25R217 A25R215	0698-421 0684-104 0698-450 0698-450 0684-108	1 9 5	7	RESISTOR 100K 10X .25W FC TC=-400/+800 RESISTOR 80.0K 1X .125W F TC=0+100 RESISTOR 71.5K 1X .125W F TC=0+100 RESISTOR 71.5K 1X .125W FC TC=-800/+900 RESISTOR 71.5K 10X .25W FC TC=-400/+800	011 245 245 011 011	46 C4-1/8-10-0082-F 46 C4-1/8-10-7152-F 21 C81051 21 C82231
A25R219 A25R221 A25R221 A25R223 A25R301	0684-223 0684-477 0684-477 0684-10	31 21 21	20799	RESISTOR 47K 10% .25W FC TCE-400/+800 RESISTOR 4.7K 10% .25W FC TCE-400/+700 RESISTOR 1K 10% .25W FC TCE-400/+500 RESISTOR 10K 10% .25W FC TCE-400/+700 RESISTOR 10K 10% .25W FC TCE-400/+700	011	21 CB4721 21 CB1031 21 CB1031
A25R302 A25R303 A25R304 A25R304 A25R306 A25R307	0684-10 0684-27 0684-12 0757-02 0757-02	21 21 80 80	69 3	RESISTOR 2.7K 10% .25W FC TC=-400/+70 RESISTOR 1.2K 10% .25W FC TC=-400/+70 RESISTOR 1K 1% .125W F TC=0+-100 RESISTOR 1K 1% .125W F TC=0+-100 RESISTOR 140K 1% .125W F TC=0+-100	0 01:	21 C82721 21 C81221 46 C4-1/8-T0-1001-F 546 C4-1/8-f0-1001-F 546 C4-1/8-f0-1403-F
A25R309 A25R310 A25R311 A25R311	0698-45 0698-45 0757-02 0757-02 0757-02	00 80 153	3 23233	RESISTOR 37.6K 1% .125W F TC=0+-100 RESISTOR 1K 1% .125W F TC=0+-100 RESISTOR 30.1K 1% .125W F TC=0+-100 RESISTOR 1K 1% .125W F TC=0+-100 RESISTOR 1K 1% .125W F TC=0+-100 RESISTOR 1M 10% .25W FC TC=-800/+900	24 24 24	C4=1/8=T0=5762=F C4=1/8=T0=1001=F C4=1/8=T0=3012=F C4=1/8=T0=1001=F C4=1/8=T0=1001=F C81051 C4=1/8=T0=1883=F
A25R313 A25R314 A25R315 A25R316 A25R317 A25R318	0 pg q m 1 0 p d g m q 0 p d g m q 0 p d g m q 0 p d g m q	211 041 509	7 2 1 1 7 3	RESISTOR 158K 1% 125W F TC#0+=100 RESISTOR 100X 10% 25W FC TC#+400/46 RESISTOR 80,6K 1% 125W F TC#0+=100 RESISTOR 71,5K 1% 125W F TC#0+=100 RESISTOR 11,5K 1% 125W F TC#0++100 RESISTOR 1M 10% 25W FC TC#-800/+909	25 10 00	

Table 6-1. Replaceable Parts (Cont'd)

			1	able 6-1. Replaceable Parts (Cont'd)		
Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
A25R319 A25R320 A25R321 A25R323 A25R401	0684=2231 0684=4731 0684=4721 0684=1021 0684=1031	52079		RESISTOR 22K 10% .25W FC TCm=400/+800 RESISTOR 47K 10% .25W FC TCm=400/+800 RESISTOR 4,7K 10% .25W FC TCm=400/+700 RESISTOR 1K 10% .25W FC TCm=400/+600 RESISTOR 10K 10% .25W FC TCm=400/+700	01121 01121 01121 01121 01121	CH2231 CH4731 CH4721 CH1021 CH1031
A258402 A258403 A258404 A258406 A258407	0684-1031 0684-2721 0684-1221 0757-0280 0757-0280	9 6 9 3 3		RESISTOR 10K 10% ,25% FC TCm=400/+700 RESISTOR 2.7K 10% ,25% FC TCm=400/+700 RESISTOR 1.2K 10% ,25% FC TCm=400/+700 RESISTOR 1K 1% ,125% F TCm+100 RESISTOR 1K 1% ,125% F TCm+100	01121 01121 01121 24546 24546	CB1031 CB2721 CB1221 C4=1/8=fU=1001=F C4=1/8=fU=1001=F
A25R408 A25R409 A25R410 A25R411 A25R412	0698-4519 0698-4500 0757-0280 0757-0453 0757-0280	Sen service		REBISTOR 140K 1% .125W F TC=0+=100 RESISTOR 57,6K 1% .125W F TC=0+=100 RESISTOR 1K 1% .125W F TC=0+=100 RESISTOR 30,1K 1% .125W F TC=0+=100 RESISTOR 1K 1% .125W F TC=0+=100	24546 24546 24546 24546	C4=1/8=10=1403=F C4=1/8=10=5702=F C4=1/8=10=10010=F C4=1/8=10=5012=F C4=1/8=10=1001=F
A25R414 A25R415 A25R416 A25R416 A25R418 A25R418	0698-4211 0684-1041 0698-4509 0698-4505 0684-1031 0684-1051	211793		RESISTOR 158K 1% .125W F TC=0+-100 RESISTOR 100K 10% .25W FC TC=-400/+600 RESISTOR 80,6K 1% .125W F TC=0+-100 RESISTOR 71.5K 1% .125W F TC=0+-100 RESISTOR 10K 10% .25W FC TC=-400/+700 RESISTOR 1M 10% .25W FC TC=-600/+900	24546 01121 24546 24546 01121 91121	C4=[/8=T0=1583=F C81041 C4=1/8=T0=8062=F C4=1/8=T0=7152=F CB1031 CB1051
A25R419 A25R420 A25R421 A25R422 A25R423	0684-1041 0684-1071 0684-1041 0684-1031 0684-1021	1 7 9 7		RESISTOR 100K 10% ,25W FC TC==400/+800 RESISTOR 1K 10% ,25W FC TC==400/+600 RESISTOR 1K 10% ,15W FC TC==400/+600 RESISTOR 1K 10% ,25W FC TC==400/+600 RESISTOR 1K 10% ,25W FC TC==400/+600	01121 12110 1121 01121 01121	C81021 C81021 C81021 C81031
A25U1 A25U2 A25U3 A25U4 A25U5	1820=0077 1820=0077 1820=0471 1820=0077 1820=0175	- 40 & R	1	IC FF TTL Detype POSEDGESTRIG CLEAR IC FF TTL DETYPE POSEDGESTRIG CLEAR IC INV TTL HEX 1-INP IC PF TTL DETYPE POSEDGESTRIG CLEAR IC INV TTL HEX 1-INP	01295 01295 01295 01295 01295	SN7474N SN7406N SN7406N SN7474N SN7475N
A25U4 A25U7 A25U100 A25U200 A25U300	1820-0077 1820-0077 1820-0203 1820-0203 1820-0203	ው ዑ ዑ የ የ የ የ	α	IC FF TIL D=TYPE PUS=EDGE=TRIG CLEAR IC FF TIL D=TYPE POS=EDGE=TRIG CLEAR OP AMP GP TO=99 OP AMP GP TO=99 OP AMP GP TO=99	01295 01295 01928 01928 01928	8 7 4 7 4 N 8 7 7 4 7 4 N C 4 7 4 1 C T C 4 7 4 1 C T C 4 7 4 1 C T
A25U400	1820=0201	6		OP AMP GP T0+99	01928	CATAICT
A2524	1251=1636 4040=0750 09820=24761	4 7 6	1	MISCELLANEOUS PARTS CONNECTOR-SGL CONT SKT .gu-In-BSC-SZ RND EXTR-PC BD RED POLYC .062-B0-THKNS SPACER, CAPTIVE	28460 28460 28480	1251-1636 4440-0750 9820-24761
¥59	05045-60015	5		CARD READER/PRINTER INTERFACE ASSEMBLY (SERIES 1852)	28480	n5045-60015.
A26C1 A26C2 A26C3 A26C3 A26C3	0180=0291 0180=0373 0180=0210 0180=0195 0180=0195	90000	1 1	CAPACITOR=FX0 1UF+=10% 35VDC TA CAPACITOR=FX0 .68UF+=10% 35VDC TA CAPACITOR=FX0 3.3UF+=20% 15VDC TA CAPACITOR=FX0 3.3UF+=20% 35VDC TA CAPACITOR=FX0 ,33UF+=20% 35VDC TA	56289 56289 56289 56289 56289	15u0105×9035A2 15g0b84×9035A2 15g0335×4015A2 15g0334×0035A2 15g0334×0035A2
A26C6 A26C7	0180+0195 0180-0210	6 6		CAPACITOR-FXD .33UF+-2UX 35V0C TA CAPACITOR-FXD 3.3UF+-2UX 15V0C TA	56269 56269	1500334×0035A2 1500335×0015A2
AZBORTI AZBORZ AZBORZ AZBORZ AZBORZ AZBORZ AZBORZ AZBORZ AZBORZ	1901-0040 1901-0040 1901-0029 1901-0040 1901-0040 1901-0040	1 1 1 1 1 3	1	DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-PWR RECT 600V 750MA D0-29 DIODE-SWITCHING 30V 50MA 2NS D0-35 DIODE-SWITCHING 30V 50MA 2NS D0-35 DIODE-SWITCHING 30V 50MA 2NS D0-35 DIODE-SWITCHING 30V 50MA 2NS D0-35 DIODE-ZNR 1N5363B 30V 5% 90*5W 10#+29MV	28480 28480 28480 28480 28480 28480	1901-0040 1901-0040 1901-0029 1901-0040 1901-0040 1901-0040 1902-0644
13931	1251-3025	Ģ	1	CONNECTOR 34+PIN M RECTANGULAR	28460	1251=3025
#2601 #2602 #2603 #2604 #2605	1853-0318 1854-0449 1853-0058 1853-0058	3 8 8 8	1 1 4	TRANSISTOR PNP SI PD#S00MW FT#60MHZ TRANSISTOR NPN SI TO#39 PD#5W FT##MHZ TRANSISTOR PNP SI PD#300MW FT#200MHZ TRANSISTOR PNP SI PD#300MW FT#200MHZ TRANSISTOR PNP SI PD#300MW FT#200MHZ	04713 28480 07263 07263 07263	MPS6562 1854-0449 532248 532248 532248
*2096 ************************************	1853=0058	8		TRANSISTOR PNP SI PD#300Mm FT#200MHZ	07263	\$32248
12602 12603 12604 12604 12605	0757-0941 1810-0041 0757-0970 0757-0960	3 9 8 6	1	RESISTOR 5.1K 2% .125w F IC#0+=100 NETWORK-RES 9==[n-81P .15=PIN-SPCG RESISTOR 82K 2% .125w F IC#0+=100 RESISTOR 33K 2% .125w F IC#0+=100 NOT ASSIGNED	S4249 S4249 S4249 S4249	C4-1/8-10-5101-G 1810-0041 C4-1/8-10-8202-G C4-1/8-10-5302-G
Attany Attany Attany Attany Attany	1810-0041 1810-0041 0757-0897 0757-0900 0811-2822	9 9 B 4 9	1	NETWORK-RES 9-PIN-SIP ,15-PIN-SPCG NETWORK-RES 9-PIN-SIP ,15-PIN-SPCG RESISTOR 75 2% ,125% F TC=0+-100 RESISTOR 100 2% ,125% F TC=0+-100 RESISTOR 5.8 5% ,75% PM TC=0+-50	28480 28480 24546 24546 91637	1810-0041 1810-0041 C4-1/8-10-75KU-6 C4-1/8-10-101-6 PS1/2-72-086-J

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Model 5045A Replaceable Parts

Table 6-1. Replaceable Parts (Cont'd)

umber  57-0893 57-0924 57-0930 57-0924 586-2015 586-2015 586-2015 757-0930 757-0924 100-2517 757-0930 757-0930 757-0930	O shows whom anoon	Oty 4	RESITER RESIDENCE RESIDENC	ISTOR 51 2% .125W F TCm0+=100 ISTOR 1K 2% .125W F TCm0+=100 ISTOR 1.8K 2% .125W F TCm0+=100 ISTOR 1.8K 2% .125W F TCm0+=100 ISTOR 200 5% .5W CC TCm0+529 ISTOR 200 5% .5W CC TCm0+529 ISTOR 200 5% .5W CC TCm0+529 ISTOR 200 5% .5W CC TCm0+529 ISTOR 200 5% .5W CC TCm0+529 ISTOR 1.8K 2% .125W F TCm0+=100 ISTOR 1.8K 2% .125W F TCm0+=100	24546 24546 24546 01121 01121 01121 24546	C4=1/8=70=5180=G C4=1/8=70=1001=G C4=1/8=70=1001=G C4=1/8=70=1001=G E82015 E82015 E82015 E82015 C4=1/8=70=1801=G C4=1/8=70=1801=G C4=1/8=70=1801=G
57-0924 57-0924 56-2015 56-2015 56-2015 56-2015 57-0930 757-0924 100-2517 757-0924 1757-0930 757-0930	SONE ROUGH SNOW	43	RESITER RESIDENCE RESIDENC	1870R 18 2 125 F 7C20+100  1870R 18 2 125 F 7C20+100  1870R 18 2 125 F 7C20+100  1870R 200 5 5 5 5 CC 7C20+529  11870R 200 5 5 5 CC 7C20+529  11870R 200 5 5 5 5 CC 7C20+529  11870R 200 5 5 5 5 CC 7C20+529  11870R 200 5 5 5 5 CC 7C20+529	24546 01121 01121 01121 01121 24546	C4-1/8-70-1001-0 E82015 E82015 E82015
086 = 2015 086 = 2015 086 = 2015 757 = 0924 100 = 2517 757 = 0924 757 = 0930 757 = 0930	OONE ROUGH	1	RES RES RES	11810R 200 5% 5% CC TC=0+529	01121 01121 24546	E82015
100=2517 757-0924 757-0930 757-0930 757-0932	0000	1	1	113(UK 16 % % ***	24546	C4m1\8 + iouloniae
757-0930 757-0932			RES	SISTOR-TRMR 50K 10% C SIDE-ADJ 1-TRN SISTOR 1K 2% ,125W F TC=00-100 SISTOR 1.8K 2% ,125W F TC=00+-100	30983 24546 24546 24546 24546	C4-1/8-10-2201-G C4-1/8-10-1801-G C4-1/8-10-1801-G
757-0965		I	I KE	SISTOR 1.8K 2% .125W F TC#0+=100 SISTOR 2.2K 2% .125W F TC#0+=100	24546	C4-1/8-T0-5102-G
360-0124	1	S	i i	STOPHEN OF THE STOPHEN OF THE STOPHEN ONE CTOR-SGL CONT PIN . U4-IN-85C-5Z RND ONE CTOR-SGL CONT PIN . U4-IN-85C-5Z RND	28460 28460	0560-0124 0560-0124 9N7474N
0360-0124 1820-0077	3		1,,	T SE TIL DETYPE PUSEENGE TRIG CLEAR	01295 07263 07263	966020C 7416APC 1618=2103
1820-0294	5	} 3	10	C SHF-RGTR TIL R-S PRL-IN PRL-OUT 5-817 C SHF-RGTR TIL R-S PRL-IN PRL-OUT 5-817	01295	8N7496N 8N74161N
1820=0715 1820=0730 1820=0294	5	ļ	1	C SHF-RGTR TTL SERIAL IN PRL-OUT 8-811	07263	74164PC 8474964
1820-0077 1820-0077 1820-1017			1 1	IC FF TTL D-TYPE POS-EDGE-TRIG CLEAR IC DCDR TTL L 2-TD-4-LINE OUAL 2-INP IC DCDR TTL L 2-TD-4-LINE OUAL 2-INP	07263	3 93L21FC 5 9N7496N 5 9N7432N
1820+0661		5	1	IC GATE TIL MAND QUAD Z-INP	0129	5 8N7407N 5 8N7498N
1820=0368 1820=0176 1820=036	7	4   0   3	•	IC SHFERGIK IIL AND THE AND THE MEST	0129	5 SN7495AN 5 SN7496N
1205-001 1480-011	i 6	0 8		HEAT SINK TO-5/TO-39-CS PIN-DRY .062-IN-DIA .25-IN-LG STL PIN-DRY .062-IN-DIA .25-IN-LG STL EXTR-PC BD YEL POLYC .062-BD-THKNS	284	1460=0116 80 4040=0752
		0	,	BOARD ASSEMBLY, FRONT PANEL SWITCH		
0150m016 0180m174 0160m016	51 46 61	3 5 4	3	CAPACITOR=FXD .01UF +=10% 200VDC POLYE CAPACITOR=FXD 15UF+=10% 200VDC POLYE CAPACITOR=FXD .01UF +=10% 200VDC POLYE	556 284	150D156X902UBC 180
0180=01	97 <del>9</del> 7	8		CAPACITOR-FXD 2.2UF+-10% 20VDC TA	56. 50	289 150D225X9020A2 289 150D225X9020A2 150D685X9035B2
0180=01	16	()		RESISTOR 51K 2% .125W F TC00+-100 RESISTOR 51K 2% .125W F TC00+-100 RESISTOR 51K 2% .125W F TC00+-100 RESISTOR 51K 2% .125W F TC00+-100	54	546
1810=0	965 132 132	9 9 5	5	NETWORK-RES 9-PIN-SIP .15-PIN-SPCG NETWORK-RES 9-PIN-SIP .15-PIN-SPCG RESISTOR 5.1K 2X .125W F TC=0+-100	5.	1637 C5P09C=07-501J 4546 C4-1/8=70-5101=6 4546 C4-1/8=70-5102=6
0757=0 0757=0 0757=0	965	1 7 7	e	RESISTOR 51K 2% .125W F TC=0+-100 RESISTOR 500 2% .125W F TC=0+-100 RESISTOR 300 2% .125W F TC=0+-100	2	4546 C4-1/8-10-301-0 8480 3101-1910 3101-0647
3101=0 3101=0 3101=0	1916	8 0 8 9	2 3 1	SWITCH-PB SPOT MOM 1A SWITCH-PB SPOT MOM 1A SWITCH-TGL SUBMIN SPOT .02A 20VAC/OI SWITCH-TGL SUBMIN SPOT .02A 20VAC/OI	PC PC	28480 1101-1917 28480 3101-1915
3101 m 3101 m 3101 m 3101 m	1916 0647 1916	50896		SWITCH-PB SPOT MOM 14 120VAC STICK-PB SPOT MOM 14 120VAC SWITCH-PB SPOT MOM 14 SWITCH-BLE UBMIN SPOT .024 20VAC/D SWITCH-TGL SUBMIN SPOT .024 20VAC/D SWITCH-TGL SUBMIN SPOT .024	c PC	28480 3101-0647 28480 3101-1916 28480 3101-1917 3101-1917
1 1	820-0730 820-0294 818-2103 820-0294 818-220-0368 1820-0368 1820-0369 1820-0369 1820-0369 1820-0077 1820-1017 1820-0054 1820-0054 1820-0054 1820-0054 1820-0054 1820-0054 1820-017	820-0730 820-0730 820-0730 820-0736 1820-0736 1820-0730 1820-0736 1820-077 1820-0077 1820-0056 1820-0056 1820-0056 1820-0056 1820-0056 1820-0056 1820-0056 1820-0056 1820-0056 1820-0056 1820-0056 1820-0056 1820-0056 1820-0056 1820-0056 1820-0056 1020-	820-0730	820-0730	820-0730   S   2   IC MY TIL SONGELIN PRI-OUT S-81   IC MY TIL SONGELIN PRI-OUT S-81   IC MY TIL SERIAL-IN PRI-OUT S-81   IC MY TIL MONOSTER RETRIO-RESET DUAL IS MY-ACTION-PRI-OUT S-81   IC MY TIL MONOSTER RETRIO-RESET DUAL IS MY-ACTION-PRI-OUT S-81   IC MY TIL MONOSTER RETRIO-RESET DUAL IS MY-ACTION-PRI-OUT S-81   IC MY TIL MONOSTER RETRIO-RESET DUAL IS MY-ACTION-PRI-OUT S-81   IC MY TIL MONOSTER RETRIO-RESET DUAL IS MY-ACTION-PRI-OUT S-81   IC MY-ACTI	## 200-0730   5   2   1   1   2   2   1   2   2   2   2

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2=G 2=G 2=G 1 1=G 2=G 2=G 2=G	en en en en en en en en en en en en en e	
2=G 2=G 2=G 1 1=G 2=G 2=G 2=G	en en en en en en en en en en en en en e	
2=G 2=G 2=G 1 1=G 2=G 2=G 2=G	en en en en en en en en en en en en en e	

Model 5045A Replaceable Parts

Table 6-1. Replaceable Parts (Cont'd)

			T	able 6-1. Replaceable Parts (Cont'd)	Mfr	
Reference Designation	HP Part Number	C	Qty	Description	Code	Mfr Part Number
A27811	3101=1916	8		SWITCH-PB SPDT MOM .1A	28480	3101-1910 9N74123N
	1820-0579	9	3	IC MY TTL MONOSTEL RETRIG DUAL IC MY TYL MONOSTEL RETRIG DUAL	01295	3147412314
#5405 #5405	1820-0579	9		t was tall the tall t	01295	8N74U6N SN74123M
A27U3 A27U0	1820=0579	9		IC MY TTL MONOSTOL RETHIG DUAL IC GATE TTL AND GUAD 2-INP	01295	5N7408N
A2703	1620-0511	9		THE THE CO. O. THE POSITIONE TRIG	01295	8N74L874N
427U6	1820=1112	B	1	I we achimist this it was busined and the	01295	8N74132N 8N7402N
A27U7 A27U8	1820-0326	6		IC GATE TTL NOR QUAD 2-110	01295	8M74L8164N 8M7400N
42749	1820-1433	5		IC GATE ALT NOVO GRAD CATAL		SN74165N
A27U10	1820=1002	3		IC SHF-RGYR TTL RAS PRLAIN SERIAL-OUT IC FF TTL LS DATYPE POSABORE-TRIG	01295	3N74L374N
117751 11754	1820-1112	8		IC FF TIL LS D-TYPE POS-EDGE-TRIG	01295	8%741.374%
A27U13	1820-1112	1	_	STANDOFF-RYT-ON .625-1N-LG 6-321HD	28480	0360-0771
	0380=0771	В	4	Stateoort		
	15205-10017	4	1	BOARD ASSEMBLY, SOCKET DRIVER	58490	<b>∪</b> \$045=60017
158	05045-60017	"		(8ERIES 1916)	28460	U160=3676
isāri	0160=1876	4	24	CAPACITOR=FXD 47PF +=20% 200VDC CER CAPACITOR=FXD -04TUF +=20% 20VDC CER	28480	U160-0575
428C2	0160-0575 0160-3876	4	25		28480 28480	0160=3876 -0160=0575
458C2	0160=0575	4		CAPACITOR=FXO 47FF +-20% 50VDC CER CAPACITOR=FXD 47FF +-20% 200VDC CER	58480	0160-3876
428C5	0160-3576			SOVOC CER	58480	0150=0575
45806	0160-0575	4		CAPACITUREFXD 47PF +=20% 200VDC CER CAPACITOR=FXD 47PF +=20% 50VDC CER	58480 58480	0160-0575
42807 42808	0160-0575	4			28480 28480	0160-3876
42854 013844	0160=3876 0160=0575	4		CAPACITOR-FXD .047UF 40204 30400 021		0160=3676
	0160-3876	4	1	CAPACITOR-FXD 47PF +=20% 200VDC CER CAPACITOR-FXD .047UF +=20% 56VDC CER	28480 28480	0160-0575
113924 A2615	0100-0575 0160-3876	4			28480 28460	0160=3876 0160=0575
428C13	0160-0575	4		CAPACITOR=FXO _047UF +=20% 50VDC CER CAPACITOR=FXO 47PF +=20% 200VDC CER	28480	0160=3876
A28015	0160-3876	4		0.011F 4020% 50VOC CER	28480	0160=0575
150C19	0160=0575 0160=3876	4			28480 28480	0160-3876
A28C17	0150-0575	4	i	CAPACITUR#FXD -047UF +=20% 50VDC CER CAPACITUR#FXD -047UF +=20% 200VDC CER	28480 28480	0160~3876 0160~0575
428C20	0160-3876 0160-0575			CAPACITOR-FXD .0470F +-204 30425 5CF	1	0160-3876
450CS1	0160=3876	١.	,	CAPACITOR=FXD 47FF +=20% 200VDC CER CAPACITOR=FXD .047UF +=20% 50VDC CER	28480 28480	0160=0575
158055	0160-0575		4		28480	0160=3875 0160=0575
A28C23 A28C24	0160-3876 0160-0575	-	4	CAPACITOR=FXD 4/PF +=20% 50VDC CER CAPACITOR=FXD 47PF +=20% 200VDC CER	58480	U160-3876
128525	0160-3876		4	THE THE THE THE SHOPE SOVOC GER	28480	0160#0575
A28C26 A28C27	0160+0575		4	CAPACITOR=FXD 47PF +=20% 200VDC CER CAPACITOR=FXD 047UF +=20% 50VDC CER	28480 28480	0160-3870 0160-05/5
425C26	0160-0575		4		28480 26480	0160-3876
428CZ9	0160-3876 0160-0575	1	4	CAPACITUR-FXD -047UF +-20% 50VDC CER CAPACITOR-FXD -047UF +-20% 50VDC CER	28480	0160-0575
A28C30	0160=0575		4	CAPACITOR-FXO 47PF +=20% 200VDC CER	28480	0164#3870
128621 428631	0160-3876	4	4		28480 28480	0160=3870
1 426033	0160-3876		4	CAPACITOR FXD 47PF +=20% 20000 CER	28480 28480	0160-0575
458C22	0160=0575 0160=3876		4	CAPACITOR#FXD 47PF +#20% 200700 524	-	1
¥58C39	0160=0575	.	4	CAPACITOR#FXD #847UF ##20% 50VDC CER CAPACITOR#FXD #7PF ##20% 200VDC CER	28480 28480	U160=3876
A28C37 A28C38	0160=3876 0160=0575	.	4		28480 28480	U160=3876
428C19 428C20	0160-3876	,	4	CAPACITOR=FXD 47PF +=20% 200VDC CER CAPACITOR=FXD .047UF +=20% 50VDC CER	28480	
	0160-0575			AND SOUNDS AND STAFF AND SOUNDS CEP	28480	
428C41 428C42	0160-3876 0160-0579		4	CAPACITOR-FXD 047UF ++20% 50VDC CER	28486 28486	) U160≈3876
458C41	0160=3676	5	a B	CAPACITOR-FXD 47FF +=20% 20000 CER	28480 28480	0160-0575
*28C45	0160-3576		4	CAPACITOR MPXU 47PF 4#20% 200100	-	
128546	0160-057		4	CAPACITOR-FXD .047UF +-20% 50VDC CER CAPACITOR-FXD 47PF20% 20UVDC CER	28481	0160=3676
458C44 458C44	0160-387		q u	CAPACITOR-FXD 47FF +=20% 2000C CER	2848	
Azecni	1			SEED BUTTOUTHE TOU SOME SNS DOWS	2848 2848	
A&&CR2	1901-004 1901-004	0	1	DIODE-SWITCHING 30V 50MA 2NS DO-35	28#B	n 1901∞0040
1 4260,00	1901~004 1901~004		1		2548 2548	
A28CR5	1901-004		i	DIDDE-SWITCHING 30V 50MA 2NS DO-35		*
71						
						1

See introduction to this section for ordering information \*Indicates factory selected value

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Table 6-1. Replaceable Parts (Cont'd)

				Tal	ble 6-1. Replaceable Parts (Cont d)	· · · · · · · · · · · · · · · · · · ·	
Reference	HP Part Number	c D	Qty	/	Description	Mfr Code	Mfr Part Number
Designation A28CR6 A28CR7 A28CR8	1901-0040 1901-0040 1901-0040	1			DIODE-SWITCHING 30V 50MA 2N8 DO-35 DIODE-SWITCHING 30V 50MA 2N8 DO-35 DIODE-SWITCHING 30V 50MA 2N8 DO-35 DIODE-SWITCHING 30V 50MA 2N8 DO-35	28480 28480 28480 28480 28480	1901-0040 1901-0040 1901-0040 1901-0040
A28CR9 A28CR10	1901=0040 1901=0040	1			DigDE-Switching Adv Some and DO-15	28480 28480	1901=0040 1901=0040
A28CR11 A28CR12 A28CR13 A28CR14 A28CR15	1901=0040 1901=0040 1901=0040 1901=0040 1901=0040	1 1 1 1			DIDDE-SWITCHING 30V 50MA 2NS D0-35 DIDDE-SWITCHING 30V 50MA 2NS D0-35 DIDDE-SWITCHING 30V 50MA 2NS D0-35 DIDDE-SWITCHING 30V 50MA 2NS D0-35	28480 28480 28480	1901=0040 1901=0040 1901=0040 1901=0040
A28CR16 A28CR17 A28CR18 A28CR19	1901-0040 1901-0040 1901-0040 1901-0040 1901-0040	1 1 1 1			DIODE-SWITCHING 38V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35	28480 28480 28480 28480 28480	1901=0040 1901=0040 1901=0040 1901=0040
A28CR20 A28CR21 A28CR22 A28CR21 A28CR24	1901-0040 1901-0040 1901-0040 1901-0040	1 1 1		į	DIODE-SWITCHING 30V 50MA 2NS DO-35 DIODE-SWITCHING 30V 50MA 2NS DO-35 DIODE-SWITCHING 30V 50MA 2NS DO-35 DIODE-SWITCHING 30V 50MA 2NS DO-35	26480 26480 26480 28480 28480	1901-0040 1901-0040 1901-0040 1901-0040
A28L1 A28L2 A28L3 A26L4	9100=2247 9140=0144 9140=0144 9140=0144	0 0 0			COIL-MLD 100NH 10% GM34 .095D%,25LG-NUM COIL-MLD 4.7UH 10% GM45 .095D%,25LG-NUM COIL-MLD 4.7UH 10% GM45 .095D%,25LG-NUM COIL-MLD 4.7UH 10% GM45 .095D%,25LG-NUM COIL-MLD 4.7UH 10% GM45 .095D%,25LG-NUM	\$8480 \$8480 \$8480 \$8480	3140=0144 3140=0144 3140=0144
A26L5 A26L6 A26L7 A26L8 A26L8 A26L9	9140=0144 9140=0144 9140=0144 9140=0144	000			COIL-MLD 4.7UM 10% Q#45 .0950x.25LG-NOM COIL-MLD 4.7UH 10% Q#45 .0950x.25LG-NOM COIL-MLD 4.7UH 10% Q#45 .0950x.25LG-NOM COIL-MLD 4.7UH 10% Q#45 .0950x.25LG-NOM COIL-MLD 4.7UH 10% Q#45 .0950x.25LG-NOM	28480 28480 28480 28480 28480	9140=0144 9140=0144 9140=0144
A28L10 A28L11 A28L12	9140+0144 9140+0144				COIL-MLD 4.70H 10% Q#45 .095DX.25LG-NOM	26480 26480	9140-0144 9140-0144
45845 45845	1251+3283 1251+0101			2	CONNECTOR 24-PIN F MICHORIBBON CONNECTOR 50-PIN F MICHO RIBBON	28480 28480 28480	1851-0101
10857 42807 42824 42824	1853-0020 1853-0071 1853-0020 1853-0020		7 7 7 4 7 4 7 4 7 4 7 4 7 4 7 4 7 4 7 4		TRANSISTOR PNP SI PD=300MM FT#150MHZ TRANSISTOR NPN SI PD=300MM FT#200MHZ TRANSISTOR PNP SI PD=300MM FT#150MHZ TRANSISTOR NPN SI PD=300MM FT#200MHZ TRANSISTOR NPN SI PD=300MM FT#150MHZ TRANSISTOR PNP SI PD=300MM FT#150MHZ	28480 28480 28480 28480	1854-0071 1853-0040 1854-0071 1853-0020
# 5804 # 5808 # 5809 # 5804	1854-0071 1853-0020 1854-0071 1851-0020 1854-0071	ı	7 4 7		TRANSISTOR NPN SI PD#300MW FT#200MMZ TRANSISTOR PNP SI PD#300MM FT#150MMZ TRANSISTOR NPN SI PD#300MM FT#200MMZ TRANSISTOR NPN SI PD#300MM FT#150MMZ TRANSISTOR NPN SI PD#300MM FT#1200MMZ TRANSISTOR NPN SI PD#300MM FT#200MMZ	28480 28480 28480 28480 28480	1854-0071 1853-0020 1854-0071 1853-0020 1854-0071
A28G11 A28G11 A28G12 A26G13 A28G14	1853-0020 1854-0071 1853-0020 1854-0071 1853-0020		4 7 4 7		TRANSISTOR PMP SI PD=300MW FT=150MHZ TRANSISTOR MPN SI PD=300MW FT=200MHZ TRANSISTOR PMP SI PD=300MW FT=150MHZ TRANSISTOR MPN SI PD=300MW FT=200MHZ TRANSISTOR PMP SI PD=300MW FT=150MHZ TRANSISTOR PMP SI PD=300MW FT=150MHZ	28480 28480 28480 28480 28480	1853-0020
A28015 A28016 A28017 A28018 A28019	1854-0071 1853-0020 1854-0071 1853-0020 1854-0071	;	7 7 7		TRANSISTOR NPN SI PD#300MW FT#200MHZ TRANSISTOR PNP SI PD#300MW FT#150MHZ TRANSISTOR NPN SI PD#300MW FT#150MMZ TRANSISTOR NPN SI PD#300MW FT#150MMZ TRANSISTOR NPN SI PD#300MW FT#200MHZ TRANSISTOR NPN SI PD#300MW FT#200MHZ	28480 28480 28480 28480 28480	1853-0020 1854-0071 1853-0020 1854-0071
A 28020 A 28021 A 28022 A 28023 A 28024	1853=0020 1854=0071 1853=0020 1854=0071	1	4 7 4 7		TRANSISTOR PNP 81 PO=300MW FT=150MHZ TRANSISTOR NPN 91 PO=300MW FT=260MHZ TRANSISTOR PNP 91 PO=300MW FT=150MHZ TRANSISTOR NPN 91 PD=300MW FT=200MHZ TRANSISTOR NPN 91 PD=300MW FT=200MHZ	2848: 2848: 2848: 2848:	1854-0071 1853-0020 1854-0071
A 26R1 A 26R2 A 26R3 A 26R4 A 25R5	0683~105 0683~105 0757~091 0653~105 0683~105	5 7 5	5 5 3 5 5	54	RESISTOR 1M 5% .25% FC TC==800/+900 RESISTOR 1M 5% .25% FC TC==800/+900 RESISTOR 510 2% 125% F TC=0+000 RESISTOR 1M 5% .25% FC TC==800/+900 RESISTOR 1M 5% .25% FC TC==800/+900	0112 0112 0112	6 C81055 1 C81055 1 C81055
A 28R6 A 28R7 A 28R9 A 28R9 A 28R10	0757-091 0663-105 0663-105 0757-091 0683-105	7 5 5 7	35535		RESISTOR 510 2X .125% F TC=0+=100 RESISTOR 1M 5X .25% FC TC==800/+900 PESISTOR 1M 5X .25% FC TC==800/+900 RESISTOR 510 2X .125% F TC=0+=100 RESISTOR 1M 5X .25% FC TC==800/+900	2454 0112 0112 2454 0112	1 C81055 1 C81055 6 C#=1/8=10=5:1=6 11 C81055
A26R11 A26R12 A26R13 A26R14 A26R15	0683-105 0757-091 0683-105 0683-105 0683-105	17 55 55	ម្មានមាន		RESISTOR 1M 5% .25W FC TC#-800/+900 RESISTOR 510 2% .125W FC TC#-800/+900 RESISTOR 1M 5% .25W FC TC#-800/+900	0116 0116 0116 0116	C4=1/A=70=511=6 C51055 C51055 C51055
A28R16 A28R17 A28R18 A28R19 A26R20	0683=105 0757=09 0757=09 0663=10 0683=10	17 17 55	53355		RESISTOR 1M 5% ,25% FC TC=-800/+900 RESISTOR 510 2% ,125% F TC=0+100 RESISTOR 510 2% ,125% FC TC=-800/+900 RESISTOR 1M 5% ,25% FC TC=-800/+900 RESISTOR 1M 5% ,25% FC TC=-800/+900	245 245 011 011	46

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Model 5045A Replaceable Parts

Table 6-1. Replaceable Parts (Cont'd)

Reference Designation	HP Part Number	C	Qty	Description	Mfr Code	Mfr Part Number
26821 A26822 A26823 A26824 A26824 A26825	0757-0917 0463-1055 0463-1055 0757-0917 0663-1055	35535		RESISTOR 510 2% .125w F TC=0+-100 RESISTOR 1M 5% .25w FC TC==800/+900 RESISTOR 1M 5% .25w FC TC==800/+900 RESISTOR 510 2% .125w FT TC=04-100 RESISTOR 1M 5% .25w FC TC=800/+900	24546 01121 01121 24546 01121	C4=1/8=10=511=6 C81055 C4=1/8=70=511=6 C81055
A28R20 A26R27 A26R28 A26R29 A26R30	0683-1055 0757-0917 0683-1055 0603-1055 0757-0917	53553	ii Louis and an an an an an an an an an an an an an	RESISTOR iM 5% .25% FC IC=+800/+900 RESISTOR 510 2% .125% F IC=0++100 RESISTOR 1M 5% .25% FC IC=+800/+900 RESISTOR 1M 5% .25% FC TC=+800/+900 RESISTOR 510 2% .125% F IC=0+-100	01121 24546 01121 01121 24546	C81055 C841/8-70+511-G C81055 C81055 C4-1/8-10-511-G
A28R31 A28R33 A28R33 A28R34 A28R35	0463~1055 0463~1055 0463~1055 0463~1055 1810~0030	ស្រុសស្ស		RESISTOR 1M 5% ,25W FC TCH=800/+900 RESISTOR 1M 5% ,25W FC TCH=800/+900 RESISTOR 1M 5% ,25W FC TCH=800/+900 RESISTOR 1M 5% ,25W FC TCH=800/+900 NETWORK-RES 6-PIN-SIP ,125-PIN-SPCG	01121 01121 01121 01121 28480	CB1055 CB1055 CB1055 CB1055 CB1055
A28R36 A28R37 A28R38 A28R39 A28R40	0483-5125 0483-5125 0483-5125 0757-0917 0757-0917	88833	18	RESISTOR 5.1K 5% .25W FC TC#=4007+700 RESISTOR 5.1K 5% .25W FC TC#=4007+700 RESISTOR 5.1K 5% .25W FC TC#=4007+700 RESISTOR 5.10 2% .25W F TC#0+-100 RESISTOR 5.10 2% .125W F TC#0+-100	01121 01121 01121 24546 24546	C05125 C05125 C05125 C4-1/8-10-511-6 C4-1/8-10-511-G
A 2 6 R 4 E A 2 6 R 4 E A 2 6 R 4 U A 2 6 R 4 U A 2 6 R 4 U A 2 6 R 4 U	0483~5125 0463~5125 0483~5125 1810~0030 0483~5125	8 8 8 6 8		RESISTOR 5.1K 5% 25% FC TC=-400/+700 RESISTOR 5.1K 5% 25% FC TC=-400/+700 RESISTOR 5.1K 5% 25% FC TC=-400/+700 NETWORK-RES 8-PIN-SIP 125-PIN-SPCG RESISTOR 5.1K 5% 25% FC TC=-400/+700	01121 01121 01121 28480 01121	C85125 C85125 1810=0050 C85125
#59848 #59848 #59848 #59849	0683-5125 0683-5125 0683-5125 0683-5125	8 8 8 8		RESISTOR 5.1K 5% .25W PC TC=+400/+700 RESISTOR 5.1K 5% .25W PC TC=+400/+700 RESISTOR 5.1K 5% .25W PC TC=+400/+700 RESISTOR 5.1K 5% .25W PC TC=-400/+700 RESISTOR 5.1K 5% .25W PC TC=-400/+700	01121 01121 01121 01121 01121	C#5125 C#5125 C#5125 C#5125
426851	0757-0924	2		RESISTOR 1K 2% .125M F TC=0+=100	54246	C4=3/H=10=1001=5
A28U1 A28U2 A28U3 A28U4 A28U4	1820-0367 1820-0471 1820-0471 1820-0788 1820-0788	3 0 0 2 2		IC SHF-RGIR TIL R-S PRL-IN PRL-OUT 4-811 IC INV TTL HEX 1-INP IC INV 1TL HEX 1-INP IC FF TTL D-TYPE POS-EUGE-TRIG CLEAR HEX IC FF TTL D-TYPE POS-EDGE-TRIG CLEAR HEX	01295 01295 01295 01295 01295	5N7495AN 5N7405N 5N74174N 5N74174N 8N74174N
428U6 428U7 428U8	1820=0367 1820=0903 1820=0903	3 3 3	5	IC SHP-RGTR ITL R-S PRL-IN PRL-QUT 4-BIT IC SHP-RGTR ITL L R-S SERIAL-IN PRL-QUT IC SHF-RGTR ITL L R-S SERIAL-IN PRL-QUT	01295 01295 01295	50749540 30741.1640 30741.1640
429				SAME AS A28, USE PREFIX A29		
430	05045-60019	6	1	BDARO ASSEMBLY, SUCKET (SERIES 1520)	28480	65045=00019
A30CB A30CC A30CC A30CCB	0160=3677 0160=3677 0160=3877 0160=3877 0160=3877	ម្តីមាន		CAPACITOR=FXO 100PF +=20% 200VDC CER CAPACITOR=FXD 100PF +=20% 200VDC CER CAPACITOR=FXD 100PF +=20% 200VDC CER CAPACITOR=FXD 100PF +=20% 200VDC CER CAPACITOR=FXD 100PF +=20% 200VDC CER	28480 28480 28480 28480 28480	0160=3877 0160=3877 0160=3877 0160=3877 0160=3877
A30C6 A30C7 A30C8 A30C9 A30C10	0160=3877 0160=3877 0160=3877 0160=3877 0160=3877	55555		CAPACITOR-FXD 100PF +=20% 200VDC CER CAPACITOR-FXD 100PF -=20% 200VDC CER CAPACITOR-FXD 100PF +=20% 200VDC CER CAPACITOR-FXD 100PF +=20% 200VDC CER CAPACITOR-FXD 100PF +=20% 200VDC CER	28480 28480 28480 28480	0160-3877 0160-3877 0160-3877 0160-3877 0160-3877
A30C11 A30C12 A30C13 A30C14 A30C15	0160-3877 0160-3877 0160-3877 0160-3877 0160-3877	95555		CAPACITOR-FXD 100PF +-20% 200VDC CER CAPACITOR-FXD 100PF +-20% 200VDC CER CAPACITOR-FXD 100PF +-20% 200VDC CER CAPACITOR-FXD 100PF +-20% 200VDC CER CAPACITOR-FXD 100PF +-20% 200VDC CER	28480 28480 28480 28480 28480	0160+3877 0160+3877 9160+3877 0160+3877 0160+3877
A30C16 A30C17 A30C18 A30C19 A30C20	0150=3877 0150=3877 0150=3877 0160=3877 0160=3877	55555		CAPACITOR-FXD 100PF +-20% 200VOC CER CAPACITOR-FXD 100PF +-20% 200VOC CER CAPACITOR-FXD 100PF +-20% 200VOC CER CAPACITOR-FXD 100PF +-20% 200VOC CER CAPACITOR-FXD 100PF +-20% 200VOC CER	28480 28480 28480 28480	0160-3677 0160-5677 0160-3677 0160-3677 0160-3877 0160-3877
A30C21 A30C22 A30C24 A30C24	0160~3877 0160~3877 0160~3877 0160~3877 0160~0127	5555		CAPACITOR-FXD 100PF +=20% 200VDC CER CAPACITOR-FXD 100PF +=20% 200VDC CER CAPACITOR-FXD 100PF +=20% 200VDC CER CAPACITOR-FXD 100PF +=20% 200VDC CER CAPACITOR-FXD 100F +=20% 25VDC CER	26460 26460 26460 28460 28460	0150=3877 0160=3877 0160=3877 0160=3877 0160=9127
A30C26 A30C27 A30C28	0160=3879 0160=0127 0160=0127	7	!	CAPACITOR-FXO .01UF +-20X 100V0C CER CAPACITOR-FXO 1UF +-20X 25V0C CER CAPACITOR-FXO 1UF +-20X 25V0C CER	26480 26480 26480	0150=3679 0150=0127 0150=0127
			THE PROPERTY OF THE PROPERTY O			



Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part Number	CD	Qty	Description	Mfr Code	Mfr Part Number
Designation	1200-0610 1200-0650	5	1 1	SOCKET-IC-TS 24-CONT (BASE) DIP-SLDR SOCKET, TEST 24-PIN	28480 28480	1200=0610
A30K1 A30K2 A30K3 A30K4	0490=1079 0490=1079 0490=1079 0490=1079 0490=1079	4 4 4 4	·	RELAY-REED 1A 500MA 100VDC SVDC-COIL RELAY-REED 1A 500MA 100VDC SVDC-COIL RELAY-REED 1A 500MA 100VDC SVDC-COIL RELAY-REED 1A 500MA 100VDC SVDC-COIL RELAY-REED 1A 500MA 100VDC SVDC-COIL	28480 26480 26480 26480 26480	0490=1079 0490=1079 0490=1079 0490=1079 0490=1079
A30K6 A30K6 A30K6 A30K6	0490-1079 0490-1079 0490-1079 0490-1079 0490-1079	44444		RELAY-REED 14 500MA 100VDC 5VDC-COIL RELAY-REED 1A 500MA 100VDC 5VDC-COIL RELAY-REED 1A 500MA 100VDC 5VDC-COIL RELAY-REED 1A 500MA 100VDC 5VDC-COIL RELAY-REED 1A 500MA 100VDC 5VDC-COIL	28480 28480 28480 28480 28480	0490=1079 0490=1079 0490=1079 0490=1079 0490=1079
ABOK10	0490=1079	4		RELAY-REED IA 500MA 100VDC 5VDC-COIL RELAY-REED IA 500MA 100VDC 5VDC-COIL	28480 28480	0490*1079 0490*1079
A30K12 A30L1 A30L2 A30L3 A30L4 A30L5	9100=1791 9100=1791 9100=1791 9100=1791 9100=1791	111111	A CONTRACTOR A CON	COIL 290NH 20% .23D%.375LG=NOM COIL 290NH 20% .23D%.375LG=NOM COIL 290NH 20% .23D%.375LG=NOM COIL 290NH 20% .23D%.375LG=NOM COIL 290NH 20% .23D%.375LG=NOM	28480 28480 28480 28480 28480	9100=1791 9100=1791 9100=1791 9100=1791 9100=1791
A30L6 A30L7 A30L8 A30L9	9100-1791 9100-1791 9100-1791 9100-1791 9100-1791	11111		COIL 290NH 20% .23D%.375LG=NOM COIL 290NH 20% .23D%.375LG=NOM COIL 290NH 20% .23D%.375LG=NOM COIL 290NH 20% .23D%.375LG=NOM	28480 28480 28480 28480	9100-1791 9100-1791 9100-1791 9100-1791 9100-1791
A30L10 A30L12 A30L13 A30L14	9100-1791 9100-1791 9100-1791 9100-1791 9100-1791	1111111		COIL 290NH 20% .23D%.375LG=NOM COIL 290NH 20% .23D%.375LG=NOM COIL 290NH 20% .23D%.375LG=NOM COIL 20NH 20% .23D%.375LG=NOM COIL 290NH 20% .23D%.375LG=NOM	28480 28480 28480 28480 28880	9100=1791 9100=1791 9100=1791 9100=1791 9100=1791
A30L16 A30L17 A30L18 A30L19 A30L20	9100-1791 9100-1791 9100-1791 9100-1791 9100-1791	1		COIL 290NH 20% .23D%.375LG=NOM COIL 290NH 20% .23D%.375LG=NOM COIL 290NH 20% .23D%.375LG=NOM COIL 290NH 20% .23D%.375LG=NOM COIL 290NH 20% .23D%.375LG=NOM	28480 28480 28480 28480 28480	9100=1791 9100=1791 9100=1791 9100=1791
A30L21 A30L22 A30L23 A30L23	9100=1791 9100=1791 9100=1791 9100=1791			COIL 290NH 20% .230%.375LG=NOM COIL 290NH 20% .230%.375LG=NOM COIL 290NH 20% .230%.375LG=NOM COIL 290NH 20% .230%.375LG=NOM	28480 28480 28480 28480	9100=1791 9100=1791 9100=1791 9100=1791 882765
A3081 A3082	0698=8369 0698=8369 0698=8369		9 9	RESISTOR 2.7 5% .125W CC TCB=120/+400 RESISTOR 2.7 5% .125W CC TCB=120/+400 RESISTOR 2.7 5% .125W CC TCB=120/+400	12110 12110 12110	8827G5 8827G5
A307P1 A307P2 A307P3 A307P3	0300 - 0077 0300 - 0077 0360 - 0077 0360 - 0077 0360 - 0077		ระเพลา	TERMINAL STUD SGL TUR SWGFRM-MTG TERMINAL STUD SGL TUR SWGFRM-MTG TERMINAL STUD SGL TUR SWGFRM-MTG TERMINAL STUD SGL TUR SWGFRM-MTG TERMINAL STUD SGL TUR SWGFRM-MTG	28480 28480 28480 28480 28480	0360-0077 0360-0077 0360-0077 0360-0077
A307P5 A307P6 A307P7 A307P8 A307P9	0360-0077 0360-0077 0360-0077 0360-0077		W 2 1 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2	TERMINAL STUD SGL=TUR SWGFRM=MTG TERMINAL STUD SGL=TUR SWGFRM=MTG TERMINAL STUD SGL=TUR SWGFRM=MTG TERMINAL STUD SGL=TUR SWGFRM=MTG TERMINAL STUD SGL=TUR SWGFRM=MTG	28485 28486 28486 28486 28486	0360-0077 0360-0077 0360-0077 0360-0077
A30TP10 A30TP11 A30TP12 A30TP13 A30TP14 A30TP15	0360-0077 0360-0077 0360-0077 0360-0077	7	មាមមាម	TERMINAL-STUD SGL-TUR SWGFRM-MTG YERMINAL-STUD SGL-TUR SWGFRM-MTG TERMINAL-STUD SGL-TUR SWGFRM-MTG TERMINAL-STUD SGL-TUR SWGFRM-MTG YERMINAL-STUD SGL-TUR SWGFRM-MTG	2848 2848 2848 2848	0 0360=0077 0360=0077 0360=0077 0 0360=0077
A307P16 A307P17 A307P18 A307P19 A307P20	0360=007 0360=007 0360=007 0360=007	7 7 7	ម្នាប់ព្យ	TERMINAL-STUD SGL-TUR SWGFRN-MTG TERMINAL-STUD SGL-TUR SWGFRN-MTG TERMINAL-STUD SGL-TUR SWGFRN-MTG TERMINAL-STUD SGL-TUR SWGFRN-MTG TERMINAL-STUD SGL-TUR SWGFRN-MTG TERMINAL-STUD SGL-TUR SWGFRN-MTG	2848 2848 2848 2848	0 0360=0077 0 0360=0077 0 0360=0077 0 0360=0077
A30TP22 A30TP22 A30TP23 A30TP24 A30TP25	0360+007 0360+007 0360+007 0360+007 0360+007	7 7 7	U U U U U	TERMINAL STUD SGL TUR SWGFRMMIG TERMINAL STUD SGL TUR SWGFRMMIG TERMINAL STUD SGL TUR SWGFRMMIG TERMINAL STUD SGL TUR SWGFRMMIG TERMINAL STUD SGL TUR SWGFRMMIG TERMINAL STUD SGL TUR SWGFRMMIG	2846 2846 2846	0360=0077 0360=0077 0360=0077 0360=0077 0360=0077
	0380-074	5	6	4 STANDOFF=RVI=UN .187=IN=LG 6=32THO		

Replaceable Parts

Table 6-1. Replaceable Parts (Cont'd)

Reference Designation		C	Qty	Description	Mfr Code	Mfr Part Number
						g5g45 <u>~</u> 60020
A31	05045-60020	9	1	BOARD ASSEMBLY, TEST HD INT	28480	
2317428	1251-1365	6		CONNECTOR-PC EDGE 22-CONT/ROW 2-ROWS CONNECTOR-PC EDGE 22-CUNT/ROW 2-ROWS	28480 28480	1251-1365
ASIXA29 AOCAXICA	1251=1365 1251=0472	6	1	CONNECTOR-PC EDGE 6-CONT/ROW 2-ROWS	28480	1251-0472
			1	BOARD ASSEMBLY, MOTHER INTERFACE	28480	05045*60016
A32	05045-60016	3		CAPACITOR=FXD 22UF+=20% 35VOC TA	56289	150D220x0035H2
A32C1	0180-0160	5	1	RESISTOR 5.1K 2% .125W F TCB0+=100	24546	C4-1/8-TU-5101-G
ASER	0757=0941	3		TOWERTOON DE SOCS 15-CONTIRON 20ROWS	28480	1251-2035
esakse Osakse	1251-2035	9	1	CONNECTOR-PC EDGE 22-CUNT/ROW 2-ROWS	28480	1251-1365
A33	05045-60014	1	i	BOARD ASSEMBLY, MAIN MUTHER (BERIES 1628)	28480	05045=60014
10771	0180=0161	6		CAPACITOR-FXD 3.3UF+=10% 35VDC TA	00908 28450	T1108335K035A8 0160-0127
433C1 433C2	0160-0127	2		CAPACITOR=FXD 1UF +=20% 25VDC CER CAPACITOR=FXD 1UF +=20% 25VDC CER	28480 00905	0160-0127 T1108335K035AS
A33C3 A33C4	0180=0161	6		CAPACITOR-FXD 3.3UF+-10% 35VDC TA CAPACITOR-FXD 15UF+-10% 20VDC TA	56289	1500156x902082
43305	0180=0161	6		CAPACTTOOMEND & SHEEPELOX 35VDC TA	00908	T110B335K035A8
A33C7	0180=0161	8		CAPACITOR FXD 3.3UF+=10% 35VDC TA	56289 26480	1500156x902082 0160=0127
433C9	0160=0127	5 5		CAPACITOR-FXD 1UF +=20% 25VDC CER CAPACITOR-FXD 1UF +=20% 25VDC CER	59490	0160=0127
k33C10		2		CABACTING_EXD LIF ##20% 25VDC CER	28480	0160-0127 71106335K035AS
433C12	0160=0127	6		CAPACITOR*FXD 3.3UF+*10% 35VDC 1A	0090B 26480	0160-0127
433C14	0160=0127 0160=0127 0160=0127	5		CAPACITOR-FXD 1UF +-20% 25VDC CER CAPACITOR-FXD 1UF +-20% 25VDC CER	58480 58480	0160=0127 0160=0127
433C15	0100-0127	5		CAPACITOR FXD 1UF +=20% 25VDC CER CAPACITOR FXD 1UF +=20% 25VDC CER	28480 28480	0160=0127 0160=0127
A33C17	0160-0127	2		RESISTOR 10 1% .125W F 7C80+=100	24546	Cu=1/8=10=1080=F
ASSRI	0757=0346	2	1	CONSTRUCTOR OF FROM SOMEUNIAROW ZEROWS	28480	1251-1365
433X44 24X224	1251=1365 1251=1365	6		CONNECTOR-PC EDGE 22-CONT/ROW 2-ROWS CONNECTOR-PC EDGE 22-CONT/ROW 2-ROWS	28480 28480	1251=1365 1251=1365
435x46 433x47	1251-1365	9		L as carea . ac thai 22 m Chall /800 2 m Chall	28480 28480	1251=1365
ASEXAS	1251-1365	6		CONNECTOR=PC EDGE 22=CONT/ROW 2=ROWS	28480	1251=1365
ASSXA9 ASSXA10	1251=1365	6		CONNECTOR-PC EDGE 22-CUNT/ROW 2-ROWS CONNECTOR-PC EDGE 22-CUNT/ROW 2-ROWS	28480 28480	1251-1365
433X411	1251-1365	6		CONNECTOR-PC EDGE 22-CUNT/ROW 2-ROWS CONNECTOR-PC EDGE 22-CUNT/ROW 2-ROWS	28480 28480	1251-1305
A33X413	1251-1365	6		CONNECTOR-SC EDGE 55-EDMINGS 5-4040	28480	1251-1365
ASSXA14 ASSXA15	1251~1365 1251~1365	ti ći		CONNECTOR-PC EDGE 22-CONT/ROW 2-ROWS CONNECTOR-PC EDGE 22-CONT/ROW 2-ROWS	28480 28480 28480	1251-1305
433X816 433X817	1251-1365	6		CONNECTOR=PC EDGE 22=CONT/ROW 2=ROWS	28480	1251=1365
#33XA18	1251-1365	ė		CONNECTOR-PC EDGE 22-CUNIVRUM C-ROMO	28480	1 ,
ASSXA19	1251-1365	5		CONNECTOR-PC EDGE 22-CONT/ROW 2-ROWS CONNECTOR-PC EDGE 22-CONT/ROW 2-ROWS	26480 26480	1251-1305
ASSEASE	1251-1365 1251-1365	6	į	CONNECTOR-PC EDGE CC-CUNIVROW 2-ROWS	28480 28480	1251-1365
933×952 923×155	1251-1365	5		CONNECTOR-PC EDGE 22*EUNIVAUN 2**U**	58480	1251~1305
* ABBK#S#	1251-1365	6	· [	CONNECTOR-PC EDGE 22-CONT/ROW 2-ROWS	28480	1251=1305
	1251-1119	4	15	POLARIZING KEY-PC EDGE CONN	28480	1251-1115
A34	05150-6001	1 6	, , ,	PRINTER MECHANICAL ASSEMBLY	28480	05150-60011
ASSAL	5060-9051	4	1 1	PRINT HEAD	28460	5080=9051
#34L1	9100=3515	1		PAPER ADV CUIL	28480	9100+3515
A35	09810-6796	2	,   ,	SENSOR ASSEMBLY (ORDERED AS PART OF 425)	28480	(19810-67962
435CR1000	1901-0050	[ ;	3	DIGDE SWITCHING BOV ZOUMA ZNS DG-35	28480	1901-0050
A350811 A350821	2140=0092		7	LAMP-INCAND 685 SVDC 60MA T-1-8ULB	10000	
435081 435081 435084	2140=0092 2140=0092		0	LAMP-INCAND 685 SVDC 60MA T-1-8ULB LAMP-INCAND 685 SVDC 60MA T-1-8ULB	L0000 L0000	685 TIP END
-340841	2140-0092		o	LAMP-INCAND 685 SVDC BOMA T-1-BULB	30000	
			***************************************			
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Table 6-1. Replaceable Parts (Cont'd)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
35M1	09820~29761	6	1	MOTOR ASSEMBLY	28480	09820-29761
35010 35020 35030 35040	1990=0306 1990=0306 1990=0306 1990=0306	9999	44	PHOTOTRANSISTOR VAXE40V ID=100NA PHOTOTRANSISTOR VAXE40V ID=100NA PHOTOTRANSISTOR VAXE40V ID=100NA PHOTOTRANSISTOR VAXE40V ID=100NA	28480 28480 28480 28480	1990=0306 1990=0306 1990=0306 1990=0306
	1450=0153 09810=23301 09810=25501 09810=26564	0 6 4 9	\$ 1 1	MISCELLANEOUS PARTS LAMPHOLDER MOGT-SC-FLG-SKI TUR-TERM LAMP, RETAINER NUT, RETAINING PC BOARD, SENSOR MOUNTING	28480 28480 28480 28480	1450=0153 09810=23301 09810=25701 09810=26564
436	05045+60041	ä	1	BOARD ASSEMBLY, ONE SHUT (SERIES 1746)	28460	05045-60041
13601	0160-3762 0160-3762	7	5	CAPACITOR=FXD .680F +=5% SOVDC MET*PULYC CAPACITOR=FXD .680F +=5% SOVDC MET*POLYC	28460 28480	0160=3762 0160=3762
136C2 136C3	1200=0559	6	1	SOCKET TEST 20-PIN	28480	1200=0851
-3671 A3672	1200=0557 1251=4259	9	1	SOCKET-IC 20-CONT DIP DIP-SLOW (BASE) CONNECTOR=SGL CONT PIN .U11=IN=BSC=SZ	19613 28480	1521-4528 550-0334-60-0005
A36R1	0757=0449	6	5	RESISTOR 20K 1% ,125W F TC=0+-100 RESISTOR 20K 1% ,125W F TC=0+-100	24546 24546	C4=1/8=T0=2002=F C4=1/8=T0=2002=F
A 3 6 R 2 A 3 6 B 2 A 3 6 B 3 A 3 6 B 4 A 3 6 B 4 A 3 6 B 4 A 3 6 B 4 A 3 6 B 4 B 4 B 6 B 6 B 7 B 6 B 7 B 7 B 7 B 7 B 7 B 7 B 7 B 7 B 7 B 7	3101-1860 3101-1841 3101-1841 3101-1841	1.888	3	SWITCH-SL 5-1A DIP-SLIDE-ASSY 1A 50VDC SWITCH-SL 4-1A DIP-SLIDE-ASSY 1A 50VDC SWITCH-SL 4-1A DIP-SLIDE-ASSY 1A 50VDC SWITCH-SL 4-1A DIP-SLIDE-ASSY 1A 50VDC	28480 28480 28480 28480	3:01=1800 3:01=1841 3:01=3841 3:01=1841
A 3 7	05045+60043	6	1	STATIC PROTECTION BOARD (SERIES 1916)	28484	05045-60043
A37C1 A37C2 A37C3 A37C3	0160-4557 0160-4557 0160-0228 0180-0228	0066	2	CAPACITOR-FXD 10F +-20% 50VDC CER CAPACITOR-FXD 10F +-20% 50VDC CER CAPACITOR-FXD 22UF+-10% 15VDC TA CAPACITOR-FXD 22UF+-10% 15VDC TA	28480 28480 55289 55289	0160-4557 0160-4557 1500226X901562 1500226X901582
A37CR1+ A37CR192	1901-0050	3		DIODE-SWITCHING 86V 200MA 2NS 00-35	28480	1901-0050
A37P1	1251+2658	2	1	CONNECTOR-PC EDGE 50+CUNT/ROW 2+ROWS	28480	1251=2658
A38	05045-60037	8	,	BOARD ASSEMBLY, HP-IB INTERFACE (SERIES 1712)	28480	05045=60037
ASSCRI	1901+0040	1		DIODE-SWITCHING BOY SUMA 2NS DO-35	28480	1901-0040
ASSJI	1200=0433	0	1	SOCKET-IC 24-CONT CONNECTOR 24-PIN F MICRORIBBON	28480 28480	1200+0453 1251=3283
A38J3 A38R1	1251-3263 1810-0134	3		NETWORK-RES 10-PIN-SIP .1-PIN-SPCG NETWORK-RES 10-PIN-SIP .1-PIN-SPCG	28480 28480	1810-0136 1810-0136
A36R2	0698-6362 1251-4364 1400-0995	24 2 1	VARIATION AND AND AND AND AND AND AND AND AND AN	PRECISION RESISTOR PACK BOARD (05045-60042) RESISTOR 1K 0.1% .125W CONNECTOR 12-PIN HEADER CABLE GRABBER		0698-6362 1251-4384 1400-0995
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		***************************************			e de la constitución de la const	
	And the state of t	A A A A A A A A A A A A A A A A A A A	The state of the s			
	Available to the state of the s	AND THE PERSON NAMED IN COLUMN TWO IS NOT THE OWNER.				<i>x</i>
	AND THE RESIDENCE OF THE PERSON OF THE PERSO	×	A-1-1-1-1-1-1-1-1-1-1-1-1-1-1-1-1-1-1-1			

See introduction to this section for ordering information \*Indicates factory selected value

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Table 6-1. Replaceable Parts (Cont'd)

		,	l.	able 6-1. Replaceable Parts (Cont d)		, i
Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
<b>A1</b>			L.	CHASSIS PARTS		-
81 82	3160-0287 3160-0287	8	8	FAN=TBAX 45=CFM 115V 50/60=H2 1.5=THK FAN=TBAX 45=CFM 115V 50/60=HZ 1.5=THK	28480 28480	3160=0287 3160=0287
C1 C1	0150=0119 0180=2179	1	. 1	CAPACITOR=FX0 .01UF/.01UF +-20% CAPACITOR=FX0 0600UF+75=10% 15VDC AL (PART OF J1)	26480 00853	0150-0119 500462UU15AA2A
CS CS	0180=0580 0180=0580	3	a	CAPACITOR-FXD .04F+75-10% 15VDC AL CAPACITOR-FXD .04F+75-10% 15VDC AL	56289 56289	602040340158124 60204034015812A
C4 C5 C6 C7	0180-2277 0180-2277 0180-0579 0180-0579 0180-0577	9 0 0 0 8	2 2 1	CAPACITOR=FX9 8200UF+75=10% 25VDC AL CAPACITOR=FX0 8200UF+75=10% 25VDC AL CAPACITOR=FX0 7200UF+75=10% 30VDC AL CAPACITOR=FX0 7200UF+75=10% 30VDC AL CAPACITOR=FX0 028F+75=10% 40VDC AL	56269 56269 00853 00853	3608226025AC2A 3608226025AC2A 5007220030AC2A 5007220030AO2A 5002830040C£2A
C9 C10 C11 C12 C13	0160=3094 0160=3094 0160=3094 0160=3094 0160=0127	80882	4	CAPACITOR=FXO .1UF +=10% 100VDC CER CAPACITOR=FXO .1UF +=10% 100VDC CER CAPACITOR=FXO .1UF +=10% 100VDC CER CAPACITOR=FXD .1UF +=10% 100VDC CER CAPACITOR=FXD 1UF +=20% 25VDC CER	28480 28480 28480 28480 28480	0160-3094 0160-3094 0160-3094 0160-3094 0160-0127
CR1 CR2 CR3	1906-0058 1902-0986 1902-0986	5	1 2	DIODE=FW BRDG 1000 30A VF DIFF#1.1MV . DIODE-ZNR 9.1V 5% PD#1W IR#1UA DIODE-ZNR 9.1V 5% PD#1W IR#1UA	04713 04713 04713	M0490=2 144526201 144526011
D81 D82 D83 O84 D85	2140-0025 2140-0025 2140-0025 2140-0025 2140-0025	9999	5	LAMP=INCAND 327 28VDC 40MA T-1=3/4-8UL8 LAMP=INCAND 327 28VDC 40MA T-1=3/4-8ULB LAMP=INCAND 327 28VDC 40MA T-1=3/4-8ULB LAMP=INCAND 327 28VDC 40MA T-1=3/4-8ULB LAMP=INCAND 327 28VDC 40MA T-1=3/4-8ULB	28480 28480 28480 28480 28480	2140-0025 2140-0025 2140-0025 2140-0025 2140-0025
Ei	2110=0381	7	1	FUSE 3A 250V SLO-BLO 1.25%.25 UL (PART OF JI)	28480	2110-0381
Fi	2110-0304	4	1	FUSE 1.5A 250V SLOWBLO 1.25X.25 UL (PART OF J1)	28480	2110-0304
F2	2110-0054	1	5	FUSE 154 250V MDM-8LO 1.25X.25 UL	28486	2110-0054
<b>#3</b>	2110-0054	1		FUSE 154 250V MOM-8LO 1,25x,25 UL	28480	2110=0054
Ji Ji	0490-0444	ê	1	POWER MODULE, UNFILTERED	28480	
L1 L2	9140=0136 9140=0136	0	s	COIL-MLD 22UH 10% Q=50 .281D%,938LG-NOM (PART OF J1) COIL-MLD 22UH 10% Q=50 .281D%,938LG-NOM (PART OF J1)	28480 28480	9140=0136
4P1 402 4P3 4P4 4P5	5040-7219 5040-7220 5060-9805 05045-00023 5040-7201	8 1 4 6	A N N R	STRAP, HANDLE, CAP-FRONT STRAP, HANDLE, CAP-HEAH COVER, SIDE FOOT(STANDARD)	25480 25480 28480 28480 28480	5040-7219 5040-7220 5060-9605 05045-00023 5040-7201
MP6 MP7 MP8 MP9 MP10	5001+0440 5040=7202 5060+9848 5060+9836 05045=20201	5 1 4	THE STATE STATE	TRIM, SIDE TRIM, TOP PANEL, FRONT EXTRACTOR	58480 58480 58480 58480 58480	5001-0040 5060-9848 5060-9836 05045-20201
MP11 MP12 MP13 MP14 MP15	3131 = 0367 3131 = 0369 3131 = 0370 3131 = 0371 3131 = 0368	40905	44	CAP, SWITCH, LOAD CAP, SMITCH, PASS CAP, SWITCH, CONT CAP, SWITCH, FAIL CAP, SWITCH, TEST	28480 28480 28480 28480 28480	3131=0367 3131=0369 3131=0370 3131=0371 3151=0366
HATA HATA HATA HATA HATA	05045=60112 05045=60112 05045=20205 05045=60111 05045=20206	0 8 9	1 1 1	SUB-PANEL, CONTROLS ODOR ASSY, PRINTER PIN, HINGE C.D. DOOR ASSY, CONTROL PIN, HINGE, P.D.	28480 28480 28480 28480 28480	05045-00016 05045-601162 05045-20205 05045-60111 05045-20206
4921 4923 4924 4925 4926	05045-20203 05045-40003		1	AXLE, PAPER ROLL NOT ASSIGNED COVER, TEST HEAD NOT ASSIGNED NOT ASSIGNED	28480 28480	05045-20203
#P27 4P28 4P29 4P31 4P32	05045=20204 05045=200027 05045=00021 05045=40001 05045=40002	4	1	SCREW, TONGUE GUIDE, BOARD, SOCKET DRIVE TRAY, TEST HEAD GUIDE, MAG CARD, BUTTOM GUIDE, MAG, CARD, TOP	28480 28480 28480 28480 28480	05045-20204 05045-00027 05045-00021 05045-00001
#933 #936 #935 #936 #937	0403-0150 05045-00004 5020-8805 05045-00014 05045-00015	8	1	GUIDE-PC BD GRA POLYC .062-BD-THKNS COVER, POWER SUPPLY FRAME, FROM READER BRACKET, CARD READER BRACKET, CARD READER	58490 58490 58490 58490 58490	0403+0150 05045+00004 5020+6805 05045+00014 05045+00015
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See introduction to this section for ordering information \*Indicates factory selected value

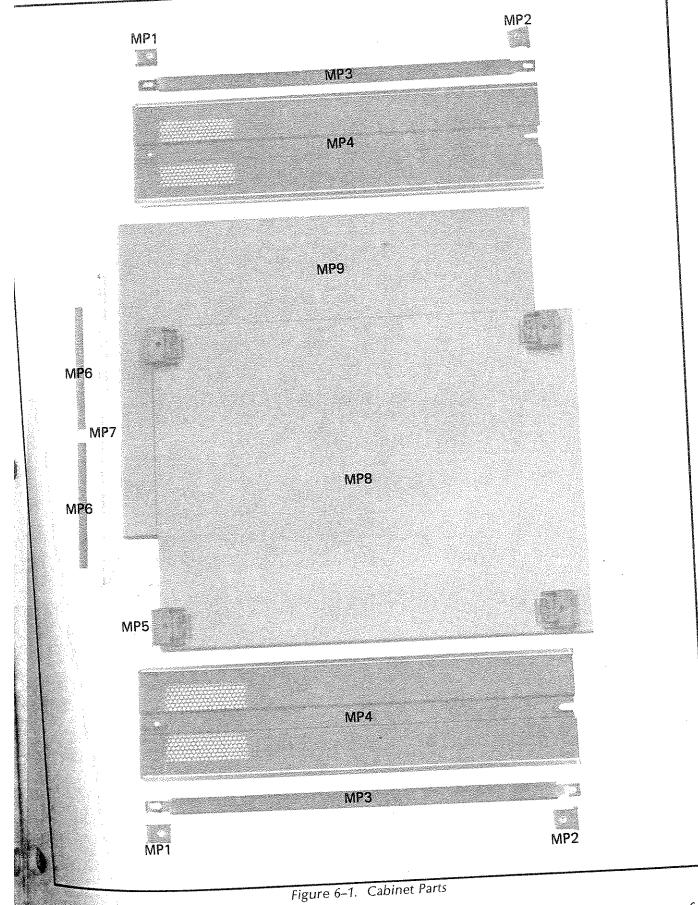
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Table 6-1. Replaceable Parts (Cont'd)

F . E	HP Part	c	O+•	$\overline{\mathcal{J}}$	Description	Mfr Code	Mfr Part Number
Reference Designation	Number	ם	Qt	<u> </u>	INTERFACE M.B.	28480 28480 28480	05045~00013 05045~00010 05045~00011
жр40 Мр36 Мр38	02042-00019 02042-00011 02042-00013	1 2 7		2	SUPPORT STATE STAT	28480 28489	05045=00008 5020=8858
MP41 MP42 MP43	5020-8838 05045-00009 05045-00007	9		1	STIFFENER, BLOCK HEAD BULKHEAD, REAR GUIDE, BOARD, FRONT, P.S.	28480 28480 28480 28480	05045=00007 05045=00005 05045=00006 5020=8806
Nb42 Nb40 Nb42 Nb44	05045-00005 05045-00006 5020-6806	a		1 1	GUIDE, BUARD, REAR, P.S. GUIDE, BOARD, REAR, P.S. FRAME, REAR SUPPORT, P.S. COVER	28480 28480 28480	05045*00029 928*0401 05045*00012
жр48 мр49 мр50	05045-00029 9281-0401 05045-00018	1 9	1	3	BRACKET, MOTHER BD	28480 04713 04713	509595 509595
61	1854-0671 1854-0671	,		1	PERISTOR 220 1% SW PW TC=0+-20	28480 28480	0811-2640
<b>R1</b>	0811-2640			1	TRANSFORMER-POWER PRI: 115/230V: W/100V	28480	n5045=60106
9° 1 19 2	9100=3044 05045=6010 05045=6010	6	2	1 1 1	CABLE ASSY, MAIN MOTHER CABLE ASSY, BM TO SM CABLE ASSY, FRONT PANEL CONTROL CABLE ASSY, LM HANDLR CABLE ASSY, LM PANERMER	28480 28480 28480	05045-60105 05045-60103 05045-60104 05045-60102
M2 M2	05045-6016 05045-601	2	0 8	1 1	CABLE ASSY, TRANSFORMER  CABLE ASSY, AC POWER MODULE  CABLE ASSY 18AWG 3-CNDCT JGK-JKT	28480 28480	u5045=69101 8120=1378
1 46	05045-601 8120-1378	· .	1	1	MISCELLANEOUS PARTS		4586=28
	0180-0076 0340-0486 0340-0596	)	4 6	5	CLAMP=CAP 2.062=DIA STL INSULATOR=COVER NYLON INSULATOR=XSTR SIL=RBR INSULATOR=XSTR SIL=RBR	56289 28480 28480 79963 00000	0 02058 BA DF3CHIbilou
	0360=062	9	5 9	16	STANDOFF-RVI-ON 125-IN-LG 6-32THO STANDOFF-RVI-ON 125-IN-LG 6-32THO STANDOFF-RVI-ON 125-IN-LG 6-32THO	00000 2848 0000	0 0510-0102 0 ORDER BY DESCRIPTION
	0510=018 0590=111 0900=001 1200=045	2 6 7	2297		NUT-SHMET=UNI O-RING .208=IN=ID .07-IN-XSECT=0IA NTRU 30CKET=XSTR 2-CDNY TO-3 30CKET=XSTR 2-CDNY TO-3	2848	0 1205-0293
	1200-0559 1205-025 1200-055	3	09	:	HEAT BINK TUBSHING (BASE) SOCKET, IC 20-CONT DIP TEST 20-PIN (BASE) PART OF SUCKET ADAPTER)	1961 2845 2846	1210-0013
	1210-00 1251-01	59	34 4		CLAMP-CAP 1.375-DIA STL CONNECTOR-PC EDGE 15-CGNT/ROW 2-ROWS POLARIZING KEY-PC EDGE CONN FUBEHOLDER-BLOCK 15A 250V 1-FU	284 284 284	80   1400=0000 80   1400=0598
	1251=11 1400=00 1400=05 2680=01	08 98 72	2 - 2 - 2		FUSEHOLDER-SLOPE 2.5-01A STL  CLAMP-CAP 2.5-01A STL  SCREW-MACH 10-32 .375-IN-LG 100 DEG  CAP-PUSHBUTTON BLACK; .375-IN DIA	284 284	80 2680 × 01/2 3101 = 16/1
And the state of t	3101-16 4208-00 7120-1	984 98	2 1 8		FOAM STRIP, 1/4 X 2" NAMEPLATE .112=IN=WD .5d=IN=LG AL NAMEPLATE .112=IN=WD 1.6=IN=L ABEL=INFORMATION 1.32=IN=WD 1.25=IN=LG AL PLATE=SERIAL .5=IN=WD 1.25=IN=LG AL	G 284	
	7120-4 7122-0 8660-0	097 463	7		1 5007	28 28	480 05035-40004 05045-00002 05045-00003
	05035= 05045= 05045= 05045=	000 000 000	02 1		PAMEL, REAR PAM, FLOOR COVER, BOTTOM INSULATOR COVER, RECEPTACLE	28 28	05045+00024 05045+00024
	05045- 05045-	-000	36	1 2	SMIELD, PROCESSOR	58	8480 05045-80019 8480 05045-80019 8480 05045-60032
	05045 05045 05045 05045	ශලිරි! ශලිරි ශලිරි	250	3	SOCKET ADAPTER CONTINUES OF REPACK PRECISION RESISTOR OLAGNOSTIC CARD KIT	2	8480 05045=80020 05045=80020
	05045	A0	050	1 2	1 DUMMY IC, 24-PIN 1 CLIP, PAPER RETURN	5	8480 05045+00051

See introduction to this section for ordering information \*Indicates factory selected value

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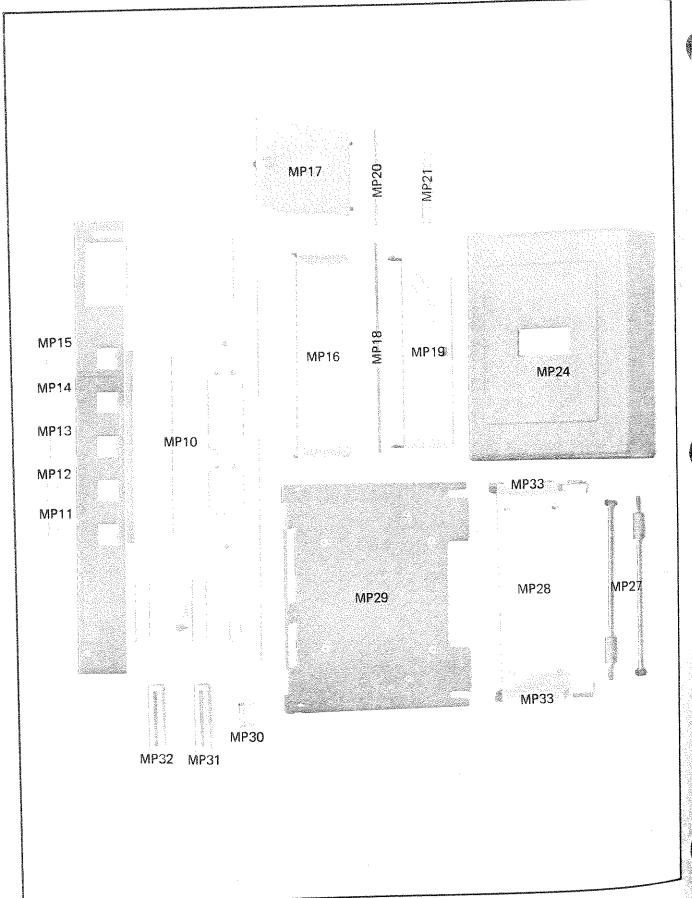


Figure 6-1. Cabinet Parts (Continued)

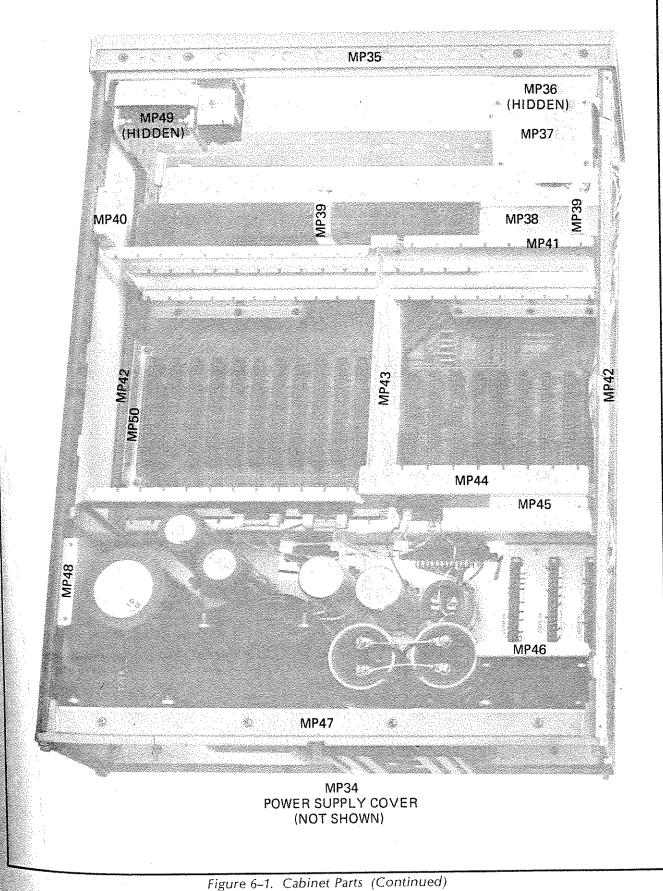
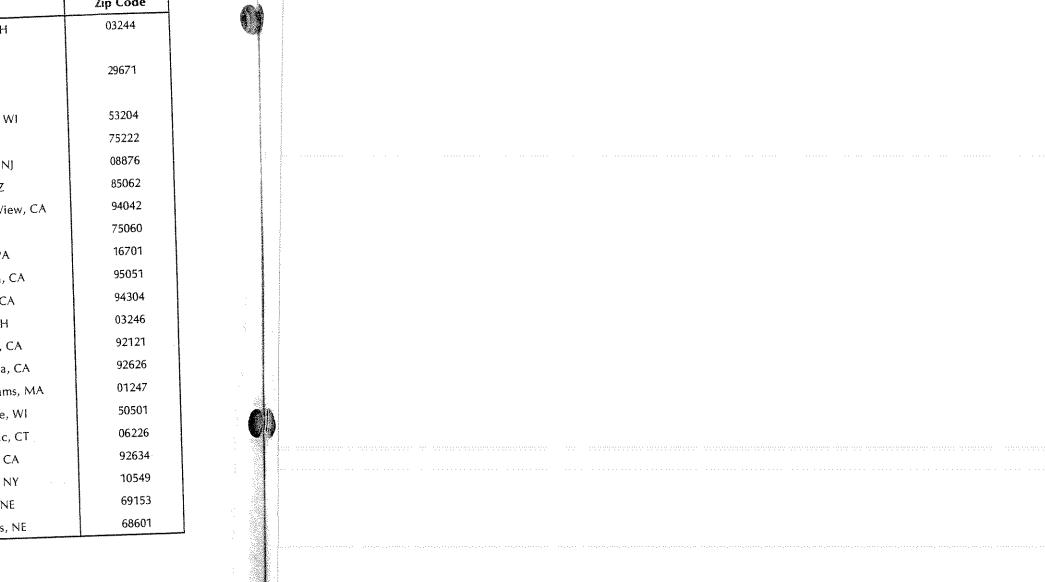


Table 6-2. Manufacturers Code List

1 46- No	Manufacturer Name	Address	Zip Code
Mfr No.	GTE Sylvania Miniature LT Prod	Hillsboro, NH	03244
0000]	· · · · · · · · · · · · · · · · · · ·		
00000	Any Satisfactory Supplier	Pickens, SC	29671
00853	Sangamo Elec Co S. Carolina Div	r ionolist o	
0090B	Kemet	Milwaukee, WI	53204
01121	Allen-Bradley Co	1	75222
01295	Texas Instr Inc Semicond Cmpnt Div	Dallas, TX	08876
0192B	RCA Corp Solid State Div	Somerville, NJ	85062
04713	Motorola Semiconductor Products	Phoenix, AZ	
07263	Fairchild Semiconductor Div	Mountain View, CA	94042
19613	Textool Products Inc	Irving, TX	75060
24546	Corning Glass Works (Bradford)	Bradford, PA	16701
27014	National Semiconductor Corp	Santa Clara, CA	95051
28480	Hewlett-Packard Co Corporte HQ	Palo Alto, CA	94304
	Aavid Engineering Inc	Laconia, NH	03246
30161	Mepco/Electra Corp	San Diego, CA	92121
30983	<b>,</b>	Costa Mesa, CA	92626
52072	Circuit Assembly Corp	North Adams, MA	01247
56289	Sprague Electric Co	Milwaukee, WI	50501
71590	Centralab Elek Div Globe-Union Inc	Willimantic, CT	06226
72136	Electro Motive Corp Sub IEC	Fullerton, CA	92634
73138	Beckman Instruments Inc Helipot Div		10549
79963	Zierick Mfg Co	Mt Kisco, NY	69153
84411	TRW Capacitors Div	Ogallala, NE	68601
91637	Dale Electronics Inc	Colúmbus, NE	00001



# SECTION VII MANUAL CHANGES

#### 7-1. INTRODUCTION

7-2. This section contains information necessary to adapt this manual to older instruments. This manual applies directly to 5045A instruments having serial prefix 1932A.

# 7-3. NEWER INSTRUMENTS

7-4. As changes are made, newer instruments may have a serial prefix not listed in this manual. Manuals for these instruments are supplied with a manual change sheet, containing the required information. Contact the nearest Hewlett-Packard Sales and Service Office for information if this sheet is missing.

# 7-5. OLDER INSTRUMENTS

7-6. To adapt this manual to instruments having a serial prefix prior to 1932A, perform the backdating that applies to your instrument's serial prefix as listed in Table 7-1 below.

Table 7-1. Manual Backdati	n
----------------------------	---

If Your Instrument has Serial or Serial Number Below	Make the Following Changes to Your Manual
1916	1
<b>1</b> = :	1,2
1852	1,2,3
1712A	1,2,3,4
1704A	1,2,3,4,5
1628A176 thru 185	1,2,3,4,5,6
1628A156 thru 175	
1620A	1,2,3,4,5,6,7
1520A	1,2,3,4,5,6,7,8

#### CHANGE 1

Page 6-23, Table 6-1, A28 Replaceable Parts:

Change A28 from Series 1916 to 1520A.

Page 8-147, Figure 8-31, A28 Schematic Diagram:

Change A28 Series from 1916 to 1516 and 1520.

Delete a connection between the shell and pin 17 (circuit common) of 24-pin dual inline connector P2 and connection between shell and pin 36 (circuit common) of 50-pin dual inline connector P4.

Page 6-15, Table 6-1, A13 (05045-60013) Replaceable Parts:

Change A13 Series from 1916 to 1712.

Change HP Part Numbers for A13U16, 17, 25 and U26 from 1820-1938 to 1820-1614.

Page 8-135, Figure 8-27 (Sheet 1 of 2), A13-A24 Schematic Diagram: Change A13-A24 from Series 1916 to 1712.

Page 6-29, Table 6-1, Replaceable Parts:

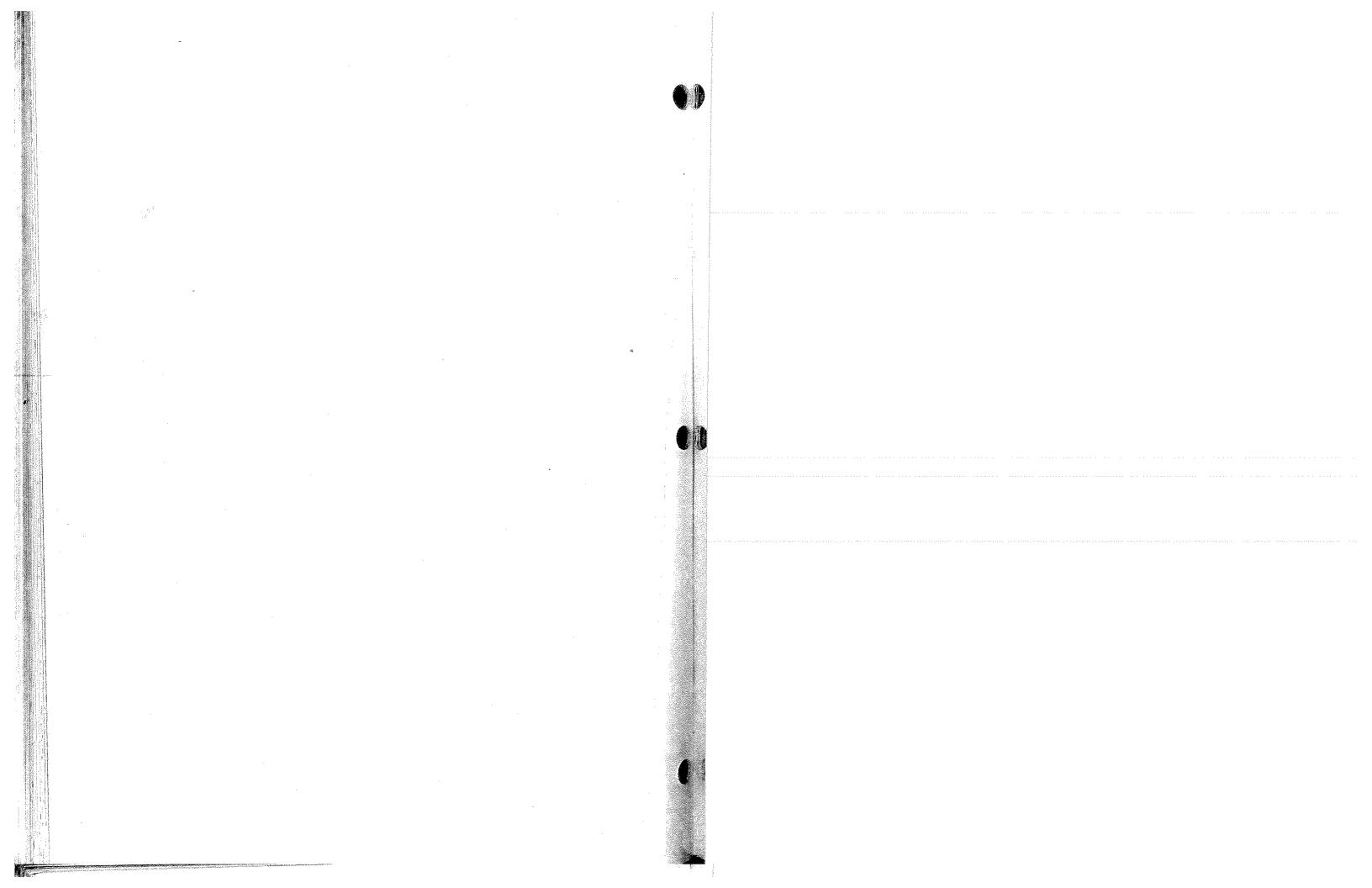
Delete CR3 1902-0986.

Page 8-113, Figure 8-17, A2 Schematic Diagram:

Delete 9.1V breakdown diode (CR3) between terminal 15 and terminals 11, 11.

Page 6-29, Replaceable Parts:

Delete complete A37 parts list.



# SECTION VIII MAINTENANCE AND TROUBLESHOOTING

#### 8-1. INTRODUCTION

8-2. This section contains maintenance, troubleshooting, theory of operation, component locators and schematic diagrams. The maintenance information includes a table for identification of assemblies and a table of test equipment required. Removal and disassembly procedures, in addition to repair and cleaning procedures, are included. Troubleshooting covers the CPU, the pin drivers and self check. A troubleshooting flow chart, and operation flow chart and a ROM listing are included.

## 8-3. ASSEMBLY IDENTIFICATION

8-4. Table 8-1 lists the designations, name and Hewlett-Packard part number of the assemblies that comprise the 5045A.

Table 8-1. Assembly Identification

Assembly	Description	HP Part No.
A1	±15V and ±18V Regulator	05045-60001
A2	±8V and ±12V Regulator	05045-60002
A3	±5V and +18V Regulator	05045-60003
A4	Arithmetic Logic Unit	05045-60004
A5	Processor Memory	05045-60005
A6	Main Memory	05045-60006
A7	I/O Board (HP-IB)	05045-60007
A8	ROM	05045-60008
A9	Address	05045-60009
A10	D/A Control	05045-60010
A11	Reference Level Generator	05045-60011
A12	Pin Driver Control	05045-60012
A13 thru A24	Pin Driver	05045-60013
	(A17 thru A20 comprise Option 024)	
A25	Card Reader Interface Assembly	09810-66562
A26	Card Reader/Printer Interface	05045-60015
A27	Front Panel Switch Board	05045-60021
A28 or A29	Socket Driver	05045-60017
A30	Socket Assembly	05045-60019
A31	Test Head Interconnect	05045-60020
A32	Interface Motherboard	05045-60016
A33	Main Motherboard	05045-60014
A34	Thermal Printer	05150-60011
A35	Magnetic Card Reader	09810-67962
A36	One-Shot Multivibrator	05045-60041
A37	Static Protection	05045-60043
A38	HP-IB Interface	05045-60037

#### 8-17. Card Reader Removal

- a. Disconnect power from 5045A.
- b. Remove top cover of 5045A by loosening screw on rear of cover.
- c. Remove top trim strip using flat-blade screwdriver inserted into slots in strip to lift strip out.
- d. Remove A25 Card Reader Interface board by lifting board up until it is out of connector, then push board down and to the rear of the connector until the left end of the board passes through the board guide. Pull left side of board forward, sliding the board under the guide. When clear of the guide lift the board up until the side edge connector can be removed. Remove the connector in the center of the board, making sure not to bend the pins. Remove board from instrument.
- e. Turn 5045 on its side and remove bottom cover by loosening the screw at rear of cover.
- f. Remove the screw second in from left end of the instrument on the front flange (bottom portion). (A nut on the inside of the instrument on this screw must be held to allow removal of the screw.)
- g. Remove the two screws on the left top of the front flange. This will allow the card reader assembly to be removed.
- h. Reverse the preceding procedure to reinstall the card reader assembly. The nut and screw attaching the lower bracket and lower front flange should be loosened and the lower portion of the card reader moved if the card does not feed smoothly into and out of the reader. The nut and screw should then be retightened.

#### 8-18. Cleaning Solvents

8-19. Recommended freon cleaning solvents listed below can be used for the card driving wheels and the commutator contacts.

# CAUTION Do not use freon on Magnetic Read/Write head.

Manufacturer's Name	Manufacturer's Part No.	HP Part No.
Sprayon Products	#2002	8500-0232
Miller-Stephenson	MS-180	
Jesta	TFA 1135	
CRC Chemicals	2016	

#### CAUTION

Do not use solvents which are not recommended. Some solvents will leave a harmful residue which will seriously affect the operation of the card reader.

# 8-20. Cleaning the Card Driving Wheels

8-21. The magnetic card reader must be removed as described above. Remake the electrical circuit connections to the card reader and start the card reader running. Spray a moderate amount of solvent on a kimwipe and wipe the driving surface of the two drive wheels which are shown in Figure 8-1. Repeat this procedure until no more dirt can be removed from the drive wheels.

#### **CAUTION**

Do not spray solvent directly onto the drive wheels. Solvent will destroy adjacent plastic parts.

# 8-22. Cleaning the Motor Commutator Contacts

8-23. The magnetic card reader must be removed as described above. Loosen the two hex headed screws which fasten the end cap to the motor shown in Figure 8-1. Pull the end cap back to expose the commutator contacts. Remake the electrical circuit connections to the card reader and start the card reader running. Spray moderate amounts of solvent directly on the commutator contacts, until the motor runs smoothly at the normal speed. Do not wipe the commutator contacts with a cloth or tissue.

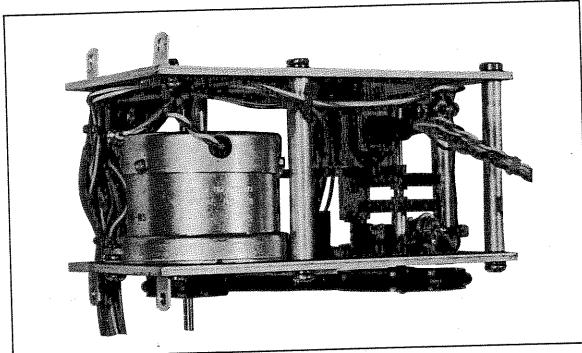


Figure 8-1. A35 Card Reader

# 8-24. Cleaning the Read/Write Head

8-25. Clean the card reader Read/Write head with cleaning card, HP Part Number 8660-0463. Instructions for use of this cleaning card are listed in the following paragraph. Cards are available from HP Customer Service Center, in Mountain View, California and Parts Center Europe, Boeblingen, Germany.

#### **CAUTION**

See warning on card.

# 8-26. Use of Cleaning Card for Magnetic Card Reader

8-27. This card should be used only as often as is necessary. Use when the reader gives erratic results, such as when loading a program card results in a "RELOAD" being printed by the thermal printer. It should also be used after approximately every 750 program card loadings or every 2 months, whichever comes first. If the reader continues to give erratic results after two passes of the cleaner card and these results are not restricted to a few cards, the problem may be in another part of the tester. Maintenance procedure for cleaning the card drive wheels (paragraph 8-20) should be performed if the card seems to be slipping.

#### 8-28. Lamp Replacement

- 8-29. To replace a defective lamp in the card reader, proceed as follows:
  - a. Remove the card reader as described above.
  - b. Remove the lamp assembly by pulling it out with a pair of pliers.
  - c. Loosen brass nut on the front (Lamp) end of the assembly with a  $\sqrt[3]{16}$ " wrench. (See Figure 8-2.)
  - d. Remove the brass nut and lamp holder.
  - e. Replace the defective lamp, HP Part Number 2140-0092.
  - f. Screw the lamp holder back into place and replace the  $^3\!/_{16}"$  brass nut.
  - g. Press the lamp assembly into the assembly holder.
  - h. Check to assure that the magnetic card reader is performing properly by loading a known good program from a magnetic card into the tester and verify that the program in memory and the program on the card are identical.

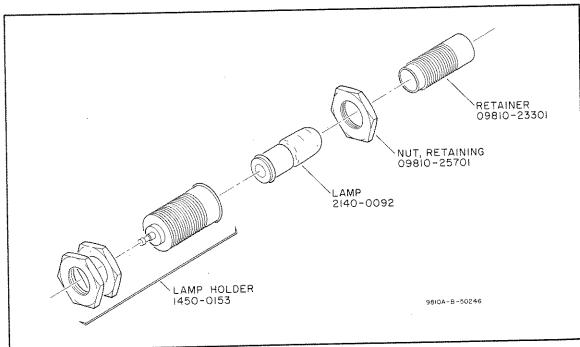


Figure 8-2. Lamp Replacement

- 8-30. If the card reader still malfunctions after performing the above cleaning and lamp replacement procedures, exchange it via your HP Service Office (listed at the rear of this manual).
- 8-31. There are two versions of magnetic card readers, as follows:

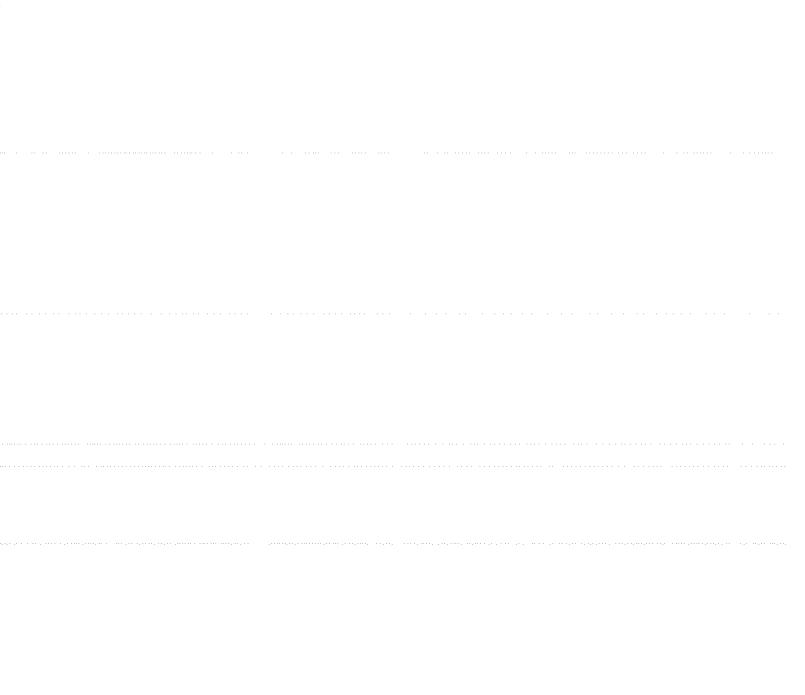
#### Version A:

This has a teflon guide on the motor shaft. The motor mounting nuts are the aircraft type with rubber inserts. The motor is purposefully left loose on its mounting bolts.

#### CAUTION

Do not tighten the motor mounting nuts. To do so will bind the motor shaft.





#### Version B:

This version does not have a teflon guide on the motor shaft. The motor mounting nuts have lock washers and hold the motor tight against its mounting surface.

#### **CAUTION**

Do not loosen the motor mounting nuts. To do so will cause the card reader to malfunction.

#### 8-32. A34 THERMAL PRINTER MAINTENANCE

8-33. The following procedures are provided for maintenance of the thermal printer. To insure that the print head is not damaged by a possibly defective A26 Card Reader/Printer Interface board, the board should be checked per paragraph 8-40.

#### 8-34. Printer Removal and Disassembly

- 8-35. Remove the printer as follows:
  - a. Disconnect gray cable and the red and blue wires from control board.
  - b. Remove A26 Card Reader/Printer Interface board.
  - c. Remove print mechanism by removing front casting top trim strip. Remove two top screws and mechanism will be loose and can be removed. Note that lower lip of paper guide overhangs the front panel and the upper paper guide is free to move and does not touch panel.
  - d. Remove mounting bracket by removing only the four screws on the rear of the assembly that hold the bracket to the side plates.
  - e. Remove the spring clip that holds the head in place by pressing down and sliding it towards the left side of the mechanism, then up and out.
  - f. Loosen the cam hold screws at rear of heat sink. Head and heat sink are ready to be removed. Note that there is a spring between the upper plastic paper guide and the heat sink. Remove heat sink by pressing the rear down and back.
- 8-36. PRINT HEAD REPLACEMENT. Remove the head from the heat sink by pressing a blunt tool through hole in the heat sink. There should be enough heat sink compound in heat sink to hold the new head in place. Install the new head in the heat sink.
- 8-37. ROLLER REPLACEMENT. Remove the thumbwheel. Then remove the right side plate only. Do not loosen any screws on the solenoid side of the mechanism other than the two on the mounting bracket. This will insure some mechanical alignment.
- 8-38. Remove the retaining ring holding the armature onto the shaft. Slide the armature/clutch assembly off the roller shaft. Slide the roller shaft out of the left side plate.
- 8-39. Install the new roller shaft and reassemble the mechanism. Do not oil the armature or side plate bearings. The right side plate should be adjusted so that the bearing drag is minimized.



# 8-40. A26 Card Reader/Printer Interface Board Checkout

- a. Check all power supplies. (Refer to paragraph 5-9.)
- b. Load card in (card title should print), place AUTO/MAN switch to MAN.
- c. Check current drawn by A26U5, U9, U13, U17 and U20 in the following manner: Connect a 1/4 Watt 200  $\Omega$  resistor between +5 volts and:

U5 — pin 10,11,13,14,15

U9 — pin 10,11,13,14,15

U13 — pin 10,11,13,14,15

U17 — pin 10,11,13,14,15

U20 — pin 10,11,13,14,15

Measured voltage at each indicated pin should be less than 0.4V with load resistor applied.

d. Check the Group Enable lines (pins 19,33,16,32 of gray connector on the A26 board). Connect  $\frac{1}{2}$  Watt 200  $\Omega$  resistor from ground to each pin and measure voltage.

pin 19 -- >+9.5V

pin 33 -- >+9.5V

pin 16 -- ~0V

pin 32 — ~0V

- e. Check the voltage at U12A pins 4,5,6,7. Voltage should be greater than 2.4V.
- f. Reinstall mechanism into the instrument and connect the gray cable, the red and blue wires to the A26 board. Mechanism should be positioned, using four screws on mounting bracket so that lip on lower paper guide rests on front panel and upper guide is free.
- Check "Printer Group Enable Timing" per paragraph 5-12. Make adjustments as necessary.
- h. Run "Printer Check" per paragraph 4-157.
- Print spacing is controlled by an adjustable stop screw located between the solenoid and armature. The hex end is 3/16 inch. To reduce print spacing, turn the screw clockwise. To increase spacing, turn the screw counter-clockwise. Vertical spacing should be approximately 6 characters per inch.
- Press STEP button to obtain a printout and repeat measurement and adjustment as necessary.

# 8-41. PC Boards Requiring Special Handling and Cleaning

- 8-42. The following PC boards require special handling and cleaning.
  - A11 Reference Level Generator, Part No. 05045-60011
  - A13-A24 Pin Driver, Part No. 05045-60013
  - A33 Main Motherboard, Part No. 05045-60014
  - A28 or A29 Scoket Driver, Part No. 05045-60017
  - A30 Socket Assembly, Part No. 05045-60019
  - A31 Test Head Interface, Part No. 05045-60020

#### **CAUTION**

The A11 DAC and A13 thru A24 pin driver boards contain CMOS circuits which are highly susceptible to static discharge damage. Handle these boards only by the large black heat sink or the board extractor.

- 8-43. HANDLING. The boards listed above should be handled only by the edges. Finger prints on the board surface may cause high resistance leakage and degrade instrument performance.
- 8-44. CLEANING. After repairs are made on the boards listed above, the contaminated areas should be washed with a special detergent such as Alcohol. The areas should be dried and sprayed with a coating (approximately 0.001 inch) of GE Dri-Film (or equivalent). Old film can be stripped from the board when necessary by using freon.

#### 8-45. REPAIR

#### 8-46. Printed Circuit Component Replacement

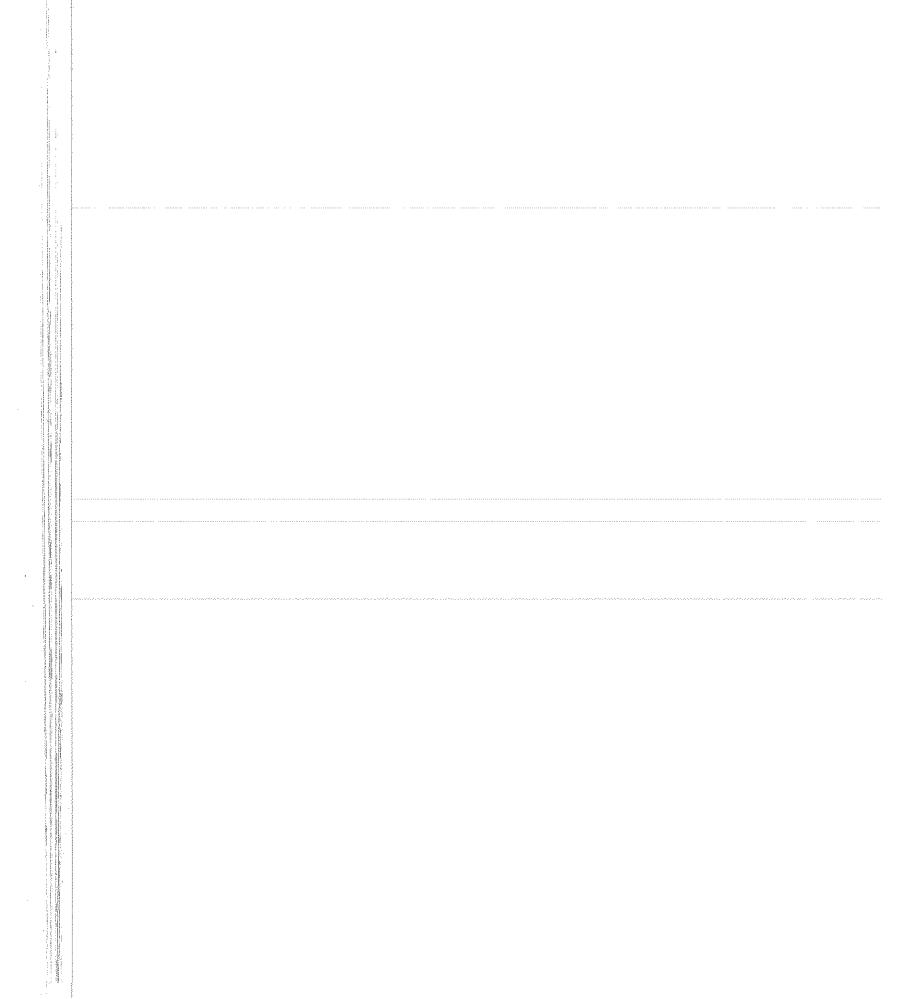
8-47. Component lead holes in the circuit boards have plated-through walls to ensure good electrical contact between conductors on opposite sides of the board. To prevent damage to the plating and the replacement component, apply heat sparingly, and work carefully.

#### 8-48. Replacing Integrated Circuits

- 8-49. Following are two recommended methods of replacing integrated circuits:
  - a. SOLDER GOBBLER. This is the best method. Solder is removed from board by a soldering iron with a hollow tip connected to a vacuum source. MUST NOT PRODUCE STATIC CHARGES WHEN OPERATING!
  - b. CLIP-OUT. This method should be used as a last resort only. Clip the leads as close to the base as possible. With a soldering iron and long nose pliers, carefully remove the wires from each hole. Then clean the holes.

#### 8-50. TROUBLESHOOTING

- 8-51. Troubleshooting the 5045A is divided into two sections: (1) the CPU and its peripherals, and (2) Pin Drivers and associated circuitry.
- 8-52. CPU troubleshooting covers the following circuits:
  - a. A35 Card Reader and interface
  - b. A34 Printer and interface
  - c. A4 Arithmetic Logic Unit (ALU)
  - d. A5 Processor Memory Board
  - e. A6 Main Memory Board
  - f. A8 ROM Board
  - g. A9 ROM Address Board
- 8-53. Pin Driver troubleshooting covers the following circuits:
  - a. A13-A24 Pin Drivers Boards
  - b. A28, A29 Socket Driver Boards (Fast Edge circuits)
  - c. A10 D/A and A12 Pin Driver Control Logic
  - d. A11 Reference Level Generators
  - e. A12 Pin Driver Control
  - f. A30 Socket Board
  - g. Relays



- 8-54. Troubleshooting the 5045A requires an understanding of the sequence of operation within the instrument. This sequence is divided into three levels of documentation: (1) general overall operations; (2) Firmware flow diagram; (3) ROM listing (mnemonic and hexcode).
- 8-55. The overall operational flow of information is as follows:
  - a. Power on.
  - b. Wait for LOAD button to be pressed.
  - c. Turn card reader and LOAD light on.
  - d. Read information from card.
  - e. Turn card reader motor and LOAD light off.
  - f. Perform checksum on data read in from card versus information stored on the card.
  - g. If checksum error, then print "RELOAD" and return to step b. If checksum is correct, print IC Type information.
  - h. Press TEST button (TEST light comes on).
  - i. Test Circuit (PASS, FAIL, or CONT light comes on).
  - j. Press LOAD button (go back to step c).
  - k. Press TEST (In MAN/HANDLR mode).
  - 1. TEST light goes out.
- 8-56. Figure 8-4 is a troubleshooting flow diagram showing areas of concern when a particular step is not executed correctly. This is based on the use of the Self Check 1 & 2 Programs covered in paragraphs 4-13 and 4-14.

#### CAUTION

NEVER operate the 5045 with any of the Pin Driver boards (A13 to A24) installed while A10 or A11 or A12 are removed. It is all right to operate the 5045A with A13 to A24 removed if A10 or A11 or A12 are installed. A11 will not operate without A10 while A12 will operate independently of A10 and A11.

#### NOTE

Before proceeding further, perform clock adjustment per paragraph 5-11a.

### 8-57. CPU Troubleshooting

- 8-58. Check the symptoms listed and perform the appropriate procedure:
- a. Instrument will not operate when LOAD button is pressed.
  - 1. Remove boards A10 through A24.
  - Check power supplies per paragraph 5-9.
  - 3. Check clock per paragraph 5-11a.
  - 4. Check program flow in operational flow diagram, Figure 8-3.
  - 5. Connect 1601L and 10250A per Table 8-3 and perform the following steps.

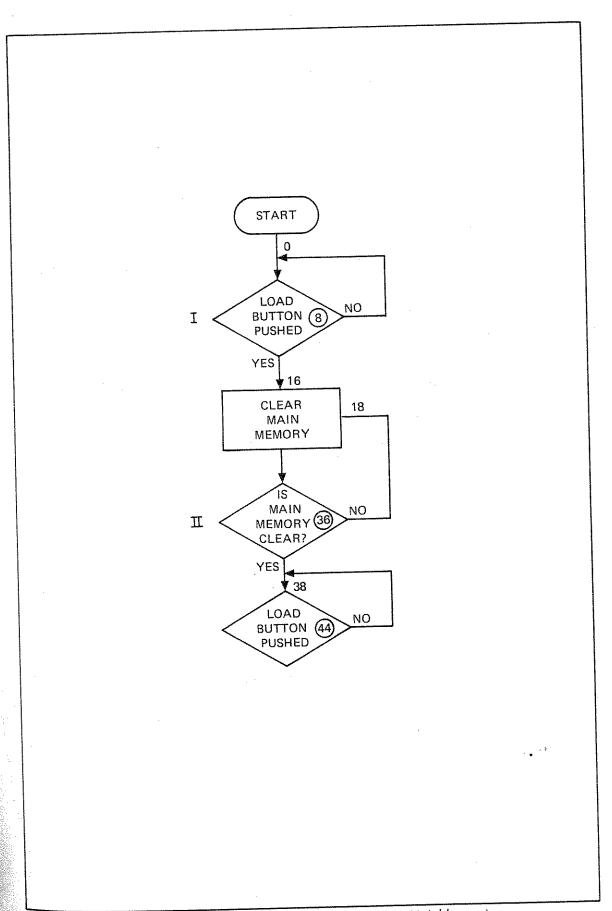
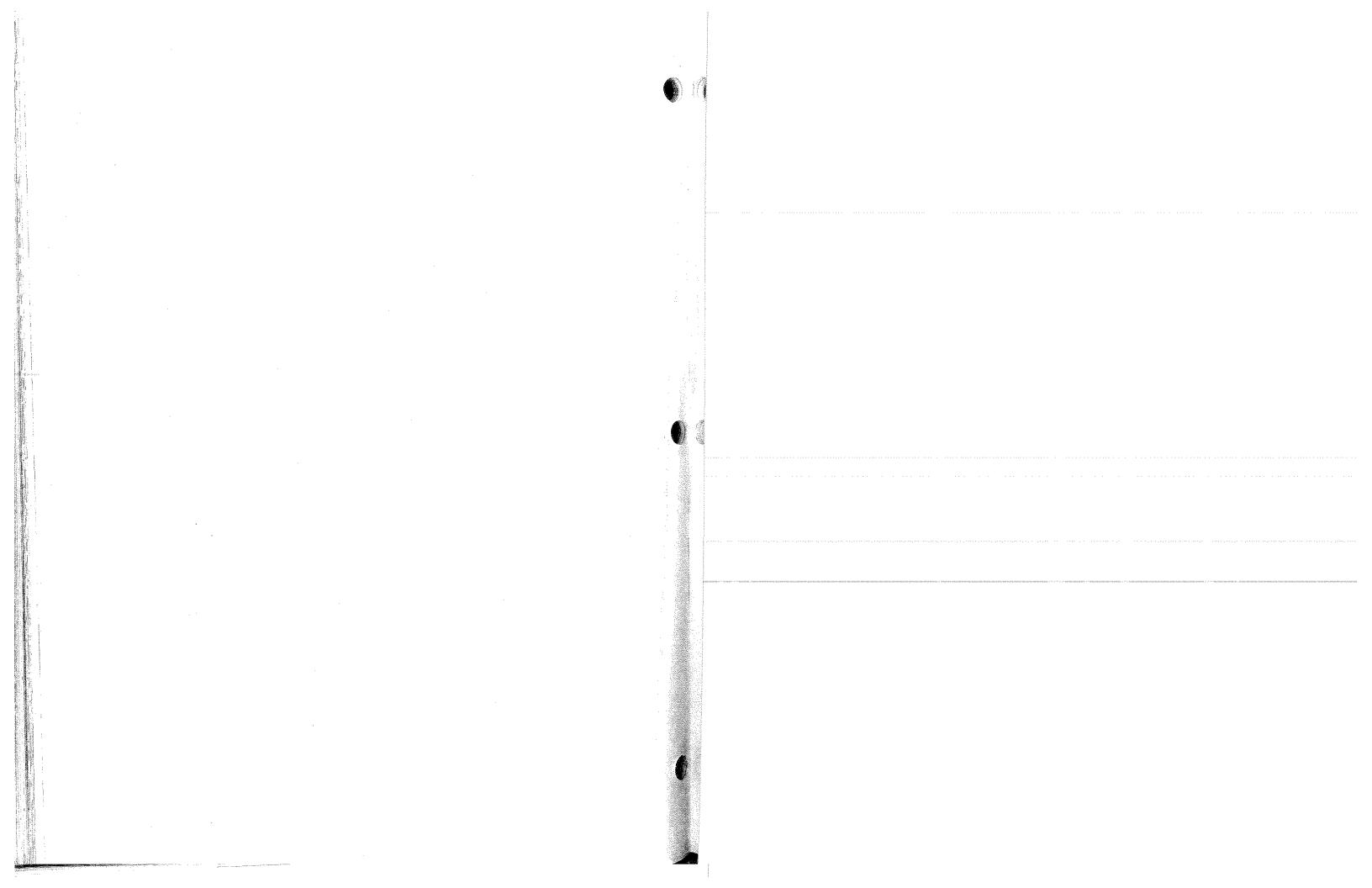


Figure 8-3. Operational Flow Diagram (First 44 Addresses)

Table 8-3. HP 1601L and HP 10250A Connections

Connect 1601L Data Inputs	To 5045A Test Points
0	A8TP1
1	A8TP2
2	A8TP3
3	A8TP4
4	A8TP5
5	A8TP6
6	A8TP7
7	A8TP8 A8TP9
8	A8TP10
9 10	Connect to 10250A output
11	A9TP3 (serial data)
Clock	A9TP1
GND	Chassis
Connect 10250A	To 5045A Test Points
1 2 3	A8TP11 A8TP12 A9TP6 A8TP13 (if 5045A is equipped with 05045-60030 connect to A9U2(12)
4 +5V GND	A8TP13 (if 5045A is equipped with 05045-50050 commerces of a California Chassis
10250A:	settings for 1601L and 10250A (Positive True Logic):
<b>10250A:</b> 1 & 2	settings for 1601L and 10250A (Positive True Logic): per address to be checked
10250A: 1 & 2   3 HI	
10250A: 1 & 2   3 HI 4 HI	
10250A: 1 & 2   3 HI 4 HI 1601L:	per address to be checked
10250A: 1 & 2   3 HI 4 HI 1601L:	
10250A: 1 & 2   3 HI 4 HI 1601L: 0-9 pe	per address to be checked er address to be checked
10250A:  1 & 2    3 HI  4 HI  1601L:  0-9 pe	per address to be checked er address to be checked
10250A:  1 & 2    3 HI  4 HI  1601L:  0-9 per  10 HI  11 OF	per address to be checked er address to be checked F
10250A:  1 & 2    3 HI  4 HI  1601L:  0-9 pe  10 HI  11 OF  LOGIO	per address to be checked  er address to be checked  F C — POS
10250A:  1 & 2    3 HI  4 HI  1601L:  0-9 per  10 HI  11 OF  LOGIO  DISPL  BYTE	per address to be checked  er address to be checked  F C — POS AY MARK — ON
10250A:  1 & 2    3 HI  4 HI  1601L:  0-9 pe  10 HI  11 OF  LOGIO  DISPL  BYTE  CLOC	per address to be checked  er address to be checked  F C — POS AY MARK — ON — 3 Bit (OCT)
10250A:  1 & 2 ;  3 HI 4 HI 1601L:  0-9 per 10 HI 11 OF LOGIO DISPL BYTE CLOC THRE	per address to be checked  F C — POS AY MARK — ON — 3 Bit (OCT) CK —
10250A:  1 & 2 p 3 HI 4 HI 1601L:  0-9 pe 10 HI 11 OF LOGIO DISPL BYTE CLOC THRE SAME	per address to be checked  F C — POS AY MARK — ON — 3 Bit (OCT) CK — SHOLD — TTL





- 6. Set the 1601L and 10250A TRIGGER switches as follows:
  - 0-9 on 1601A and 1-2 on 10250A for Address 1. (All address related switches LO except 0 on 1601L to HI.)
- 7. Display should be as shown in Figure 8-6. (See explanation of how to read the ROM listing and flow diagrams, paragraph 8-71.)
- 8. Using the flow diagram and listing determine if the flow is correct. If not, determine where it starts to deviate.

#### NOTE

The basic operation of the CPU is best checked using the first 8 addresses. Check that this loop is correct before proceeding further. Boards included in this basic operation are the Power Supplies, A1, A2 and A3, A4 ALU, A5 Processor Memory, A6 Main Memory, A8 PROM and A9 Address, Front Panel.

- b. Instrument operates properly until LOAD button is pressed.
  - 1. Check the power supply while the unit is inoperative after LOAD button is pressed. If the power supplies are being loaded it is an indication that the pin driver boards may be loading the power supplies. Turn the power off and remove the pin driver boards. Repeat the test without pin driver boards. The instrument will operate without the pin drivers although failure will be registered.
  - 2. Check that LOAD button data is being transferred from the A27 Front Panel board to A5U20 when the front panel transfer line is LOW as follows: sync scope of A27U11(1) (+ edge). On the first clock pulse (positive edge) after U11(1) goes high, a low should be shifted out, check that on A5U20(6) a high is also clocked out on the first clock pulse. Keep scope triggered on U11(1).
  - 3. Check that the Main Memory is cleared *prior* to data loading by triggering on the Refresh line A6U27(5). Press the LOAD button but don't load the card. Check that the outputs of U36, U26, U19, U10, U8 and U17 are low for all 256 memory locations.
  - 4. To check that the information is being loaded into the memory from the mag card, sync the scope on A6U20(3). Check that the data input at the following points A6U31(13 & 9) and check that U31 (1, 10) are alternately high. If there is no data at A6U31(9) the shift register may not be working properly.
- 5. Check that Data is also shifted out on  $A6(\overline{3})$  during the load operation.
- 6. Check that data is being shifted from the memories to the parallel/serial input shift register and back to the memory. Check all 24 outputs of U36, U26, U19, U10, U8 and U17.
- 7. Check the Main Memory to insure that the program is being stored. While waiting for the TEST button to be pressed the Main Memory should be periodically refreshed. Trigger scope off the Refresh line A6U27(5). Check that there is one Clock 2 for each of the two Ø clocks.
- 8. Use 1601L to check that the ROM address is cycling through addresses 464 to 584 prior to the TEST button being pressed. If not, check the CPU flow using the flow diagram.
- 9. Check that when A6(4) goes low, A6U28(5) also goes low. (This condition indicates that the ROM program has reached the logic model execution state and the main memory is the program source.) If in refresh mode, A26U28(5) will remain high until completion of refresh cycle.



# 8-59. Non-sequential Troubleshooting Hints for 5045A That Fails After TEST Button is Pressed.

8-60. With A12(4) shorted to the chassis all programs should be executed with no failure (except Self Check 1). This allows checking the Main Memory Program and ROM program flow. All controls should operate properly. In AUTO START mode the PASS and TEST lights should stay on or may flash. While in MAN START mode the tester should cycle once each time the TEST button is pressed. Pressing the TEST button while the program is being executed should stop execution and the TEST button light should turn off. If not, check the A21 Front Panel board and the ROM program flow.

8-61. To check the parameter storage on the A10 board, remove A11-A24 and load the Self Check 1 Card.

a. Set front panel switches as follows:

START — MAN/HANDLR ON FAILURE — HOLD V AND I RESULTS — ON PRINTER — ON

The printout should be as follows (see page 8-17).

# Maintenance and Troubleshooting

	TEST: 1-2
FAIL 1PASS 0 1	TEST: 1-2 FAIL (PASS 0 1 -5LV -10LMA 2 -5LV -10LMA 3 -5LV -10LMA 4 -5LV -10LMA 5 -5LV -10LMA 6 -5LV -10LMA 6 -5LV -10LMA 7 -5LV -10LMA 7 -5LV -10LMA 10 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 11 -5LV -10LMA 12 -7.5 V -15LMA 13 (-7.5 V -15LMA 15 (-7.5 V -15LMA 16 (-7.5 V -15LMA 17 (-7.5 V -15LMA 18 (-7.5 V -15LMA 19 (-7.5 V -15LMA 19 (-7.5 V -15LMA 19 (-7.5 V -15LMA 19 (-7.5 V -15LMA 20 (-7.5 V -15LMA 21 (-7.5 V -15LMA 22 (-7.5 V -15LMA 23 (-7.5 V -15LMA 24 (-7.5 V -15LMA 25 (-7.5 V -15LMA 26 (-7.5 V -15LMA 27.5 V -15LMA 28 (-7.5 V -15LMA 29 (-7.5 V -15LMA 20 (-7.5 V -15LMA 21 (-7.5 V -15LMA 22 (-7.5 V -15LMA 23 (-7.5 V -15LMA 24 (-7.5 V -15LMA 25 (-7.5 V -15LMA 26 (-7.5 V -15LMA 27.5 V -15LMA 28 (-7.5 V -15LMA 29 (-7.5 V -15LMA 20 (-7.5 V -15LMA 21 (-7.5 V -15LMA 22 (-7.5 V -15LMA 23 (-7.5 V -15LMA 24 (-7.5 V -15LMA 25 (-7.5 V -15LMA 26 (-7.5 V -15LMA 27.5 V -15LMA 28 (-7.5 V -15LMA 29 (-7.5 V -15LMA 20 (-7.5 V -15LMA 21 (-7.5 V -15LMA 21 (-7.5 V -15LMA 22 (-7.5 V -15LMA 23 (-7.5 V -15LMA 24 (-7.5 V -15LMA 25 (-7.5 V -15LMA 26 (-7.5 V -15LMA 27 (-7.5 V -15LMA 28 (-7.5 V -15LMA 29 (-7.5 V -15LMA 20 (-7.5 V -15LMA 20 (-7.5 V -15LMA 21 (-7.5 V -15LMA 21 (-7.5 V -15LMA 22 (-7.5 V -15LMA 23 (-7.5 V -15LMA 24 (-7.5 V -15LMA 25 (-7.5 V -15LMA 26 (-7.5 V -15LMA 27 (-7.5 V -15LMA 28 (-7.5 V -15LMA 29 (-7.5 V -15LMA 20 (-7.5
CPU RDR PRNTR OK	

8-17

- b. If overall printout is incorrect, in format and/or wording, the problem is either in the printer interface or A8 ROM.
- c. If limits are incorrect (i.e., 5LV, 10 LMA), problem is on A10 or A5, A6 boards. Check the A10 2K storage element and the output on A10(17) (serial data out to RAM). If limits are correct but non L values are incorrect then problem is in the A8 ROM (A11 and A12 must be installed and A12(4) shorted).

8-62. To check the A11 Reference Level Generator operation use V/I R-Pack Program Card. Figure 8-5 shows a typical waveform for A11TP1 triggered by A11U25(13).

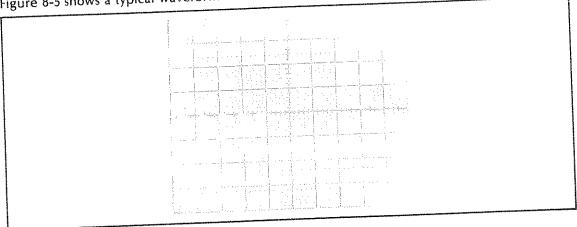


Figure 8-5. Typical Waveform for A11TP1

- a. Check that the four reference output voltages at A11(11, 12, 13, 14) agree with the programmed voltages and currents as shown in Table 8-4, and current equations described in paragraph 8-131.
- b. If the V and I printout is correct from the previous step but waveform or output voltages are incorrect, then the problem is on the A11 DAC converter or the A11 Sample and Hold circuit.

A11 Output	A13 Waveform
	A13TP1
A11(12)	A13U24(8)
A11(13)	A13U24(4)
A11(11)	A13U18(11)
A11(14)	A13U19(11)

- c. Check that A11U25 outputs 15, 13, 12, 11, 2, 5, 4, 3 and 10 and U24 outputs 5, 7, 3, 10 are sequentially shifting a low pulse out.
- 8-63. Failure pin grouping may be used to troubleshoot as follows:
  - a. 1 or 2 adjacent pins failed means that pin driver or socket driver board is bad.
  - b. Failure of every fourth pin is seven pin groups starting with pin 1 on test socket means A12 board or one of the pin drivers in the group is bad.
  - c. If a group of four pins fail, then set 5045A front panel to:

START Auto
ON FAILURE — Continue
V/I RESULTS — OFF (down)
PRINTER — Off
Load "Self Check 2" card.

Then using an oscilloscope (this may require the use of a viewing hood) check for series of pulse at A12 U17 pins 2, 4, 6, 10, 12, 15.

#### 8-64. Printer Problems

- 8-65. Check the symptoms listed and perform the appropriate procedure:
  - a. Paper advances but no printing.
    - 1. Check the A26 interface board group enable (paragraph 5-12).
    - 2. Check A26 character storage register clock.
    - 3. Check A26 print data register.
  - b. If printer prints but does not advance paper, check A26 paper advance circuit.
  - c. If overall printout format is incorrect but characters printed and spacing is correct, the problem is with the A8 ROM board.
  - d. If characters are not printed correctly but overall format spacing is correct, problem is on A26 board.

#### 8-66. Card Reader Problems

- 8-67. Check the symptoms listed and perform the appropriate procedure:
  - a. LOAD button pushed and light comes on but reader motor does not come on.
    - 1. With instrument power off, remove A26 board from its socket and turn the power on. The reader motor should come on. If not, check A25 card reader interface and A35 card reader assembly.
  - b. With LOAD button pushed, LOAD light on, card runs through but "RELOAD" printed.
    - 1. Check for TTL data streams at A26U19(2,3,4), A26U1(13), U19(10,11,12) (while U19(6) is low) and U1(9).
    - 2. Use head cleaner card if the operation seems intermittent (paragraph 8-26).
    - 3. If activity is correct at above points the problem is associated with the A5 processor memory board.

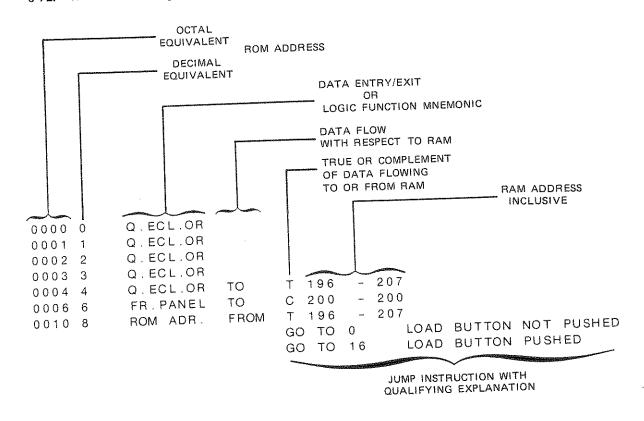
## 8-68. Troubleshooting Using Flow Diagram and ROM Listing

- 8-69. Troubleshooting using flow diagram (Figure 8-4) and firmware (ROM) listing (paragraph 8-149) is performed as follows:
  - a. Connect 1601L/10250A per Table 8-3.
  - b. Set address of first decision point (i.e., address 8) and check that the instrument cycles through address 8 until the LOAD button is pressed.
  - c. Repeat step (b) using further check points designated by roman numerals on flow diagram. (Decimal numbers indicate ROM addresses.) When it is found that a check point has not been reached the previous check point should be checked and then the ROM listing used to step sequentially through the intervening program flow. Check that the program reaches each of the designated "GO TO" addresses until a deviation from normal flow is encountered. The test program may have to be reloaded several times to accomplish this isolation procedure. Turn power off then ON or momentarily ground A4(5) to regain control. Then use the normal card loading procedure to load the card.

# 8-70. Example of How to Interpret 1601L versus ROM Listing

8-71. Figure 8-6 shows the ROM addresses being incremented, starting at ROM address 1. Note that the address holds at address 5 for 12 clock cycles. This corresponds to the implementation of ROM Address 1-5 as shown in Figure 8-6. Figure 8-7 corresponds to the implementation of the last clock of Address 5 and address 6-9 and ending with address 0. This operation is shown in flow diagram, Figure 8-3.

# 8-72. The ROM Listings (paragraph 8-149) are read as follows:



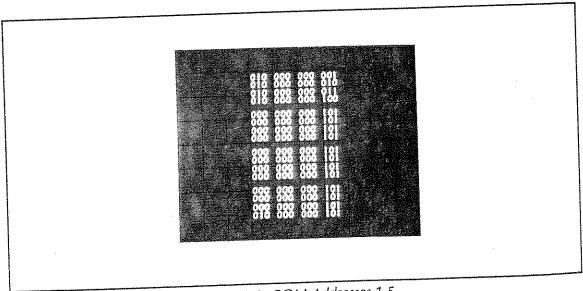


Figure 8-6. ROM Addresses 1-5

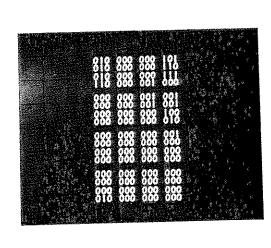


Figure 8-7. ROM Addresses 6-9

8-73. Figure 8-8 shows the implementation of ROM Address 8 and 9 when the LOAD button was pressed.

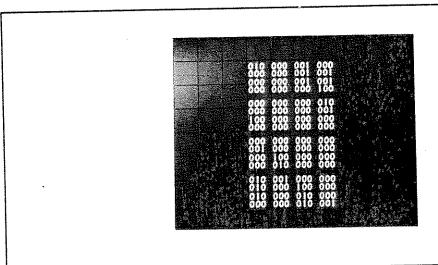


Figure 8-8. ROM Address 8 and 9

8-74. Note that in all cases the leftmost bit displayed is the serial data being transmitted to or from the RAM.

#### NOTE

Momentarily shorting A9(6) should cause the reset on pin 5 of A4, A5, A6, A8 and A9 to go low for approximately 3 seconds. Check that this resets the RAM and ROM address registers on the A5 and A9 boards to Ø. This can also be used to reset the ROM program if it jumps the loop. The logic element used is the quad exclusive OR (op code 03<sub>8</sub>) on the A4 board. This should be checked to insure that it is decoded at the ALU as 11<sub>8</sub> at U8 S<sub>0-3</sub>. Check that data transfered from the front panel is high until the LOAD button is pushed and then one low bit is transfered via A5U20.

## 8-75. ROM Contents Allocation

8-76. Content allocation for the ROM and PROM boards is described in the following paragraphs:

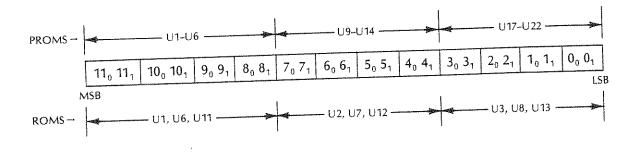
a. PROM boards (05045-60030) are sectioned as follows:

Address	IC No.
0-511 512-1023 1024-1535 1536-2047 2048-2559 2560-3071	U1,9,17 U2,10,18 U3,11,19 U4,12,20 U5,13,21 U6,14,22
Z300-307 i	- , ,

b. ROM boards (05045-60008) are sectioned as follows:

Address	IC No.
0-1023 1024-2047	U1, 6, 1 U2, 7, 1
2048-3071	U3, 8, 13

c. Within each group of 3 PROMs or ROMs the bits are allocated as follows:



# 8-77. SELF CHECK TROUBLESHOOTING PROCEDURES

8-78. The operating procedures for performing the Self Check are described in Section III. the following paragraphs provide troubleshooting procedures to use when a failure occurs during the Self Check. The three-part Self Check (Self Check 1, 2 and 3) is described for both the standard 5045A (up to 16-pin ICs) and for Option 024 (up to 24-pin ICs).

# 8-79. Self Check 1 (Standard 5045A)

8-80. Self Check 1 (16 Program) has four tests which verify the ability to detect and register a failure on each of the pins.

- a. Test 1-1: Checks pins 9-16 in the '1' state.
- b. Test 1-2: Checks pins 1-8 in the '0' state.
- c. Test 1-3: Checks pins 1-8 in the '1' state.
- d. Test 1-4: Checks pins 9-16 in the '0' state.

8-81. If the failure detect circuitry is operating properly, the tester should register a pass each time, the four tests are performed, and the data is being set properly.

8-82. The program requires that the 16 pin Dummy IC (05045-80019) be installed in the 20 pin test socket. In the case of a handler, the IC should be in the handler test socket.

8-83. The switch settings recommended for running the Self Check 1 program are:

AUTO/MAN/HANDLR — Either position ON FAILURE — HOLD V AND I — Off (down) PRINTER — ON

8-84. TROUBLESHOOTING. When a failure is printed, the two interconnected pins may both be printed as failed pins. The failure may be on either of the two pin driver boards and therefore further tests should be run to isolate the failed pin.

8-85. The general procedure for isolating a failure is listed below:

#### CAUTION

Turn off power before removing or installing printed-circuit boards. The A11 DAC and A13 thru A24 pin driver boards contain CMOS circuits which are highly susceptible to static discharge damage. Handle these boards only by the large black heat sink or the board extractor.

- a. Interchange the pin driver boards associated with the failed pin with a pin driver board that did not register a failure, one board at a time. Rerun the program and see if the failure is registered on the same pin or has moved to the pin where the suspect board was moved to. If the failure has moved, then the problem is associated with the moved board and the troubleshooting procedure in paragraph 8-118 should be used.
- b. If the failure has not moved, then the fault may be associated with the driver interconnected to the failed pin, the fast edge circuitry, or the control circuitry on A10, A11, or A12.
- c. Interchanging boards should be used where possible to isolate the failure. This can be done on the pin driver and socket driver boards.
- d. Where more than one group of pins is registered as failed and the grouping is every fourth pin (i.e., 1,5,9, etc.) the failure is probably associated with the failure detect circuitry on the A12 board or one of the pin driver boards listed as failed.

20001120000	
Application of the last	
-	

8-98. TROUBLESHOOTING. The tests in this program complements the tests in Self Check 2 and they are configured in such a way that they exercise the overall pin driver section of the tester in all modes. This program or the programs listed in paragraph 4-12 may be used to isolate the failure to the board and component. See paragraph 8-92 for a general procedure to isolate a failure.

# 8-99. Self Check 1 (Option 024)

8-100. Self Check 1 (24 Program) has four tests which verify the ability to detect and register a failure on each of the pins.

- a. Test 1-1: Checks pins 13-24 in the '1' state.
- b. Test 1-2: Checks pins 1-12 in the '0' state.
- c. Test 1-3: Checks pins 1-12 in the '1' state.
- d. Test 1-4: Checks pins 13-24 in the '0' state.

8-101. If the failure detect circuitry is operating properly, the tester should register a pass each time the four tests are performed.

8-102. The program requires that the 24-pin dummy IC (05045-80020) be installed in the 24-pin test socket. In the case of a handler, the IC should be installed in the handler test socket. The switch setting recommended for running the Self Check 1 program are:

AUTO — MAN/HNDLR — Either position ON FAILURE — HOLD V AND I — Off (down) PRINTER — ON

8-103. TROUBLESHOOTING. When a failure is printed, the two interconnected pins may both be printed as failed pins. The failure may be on either of the two pin driver boards and therefore further tests should be run to isolate the failed pin.

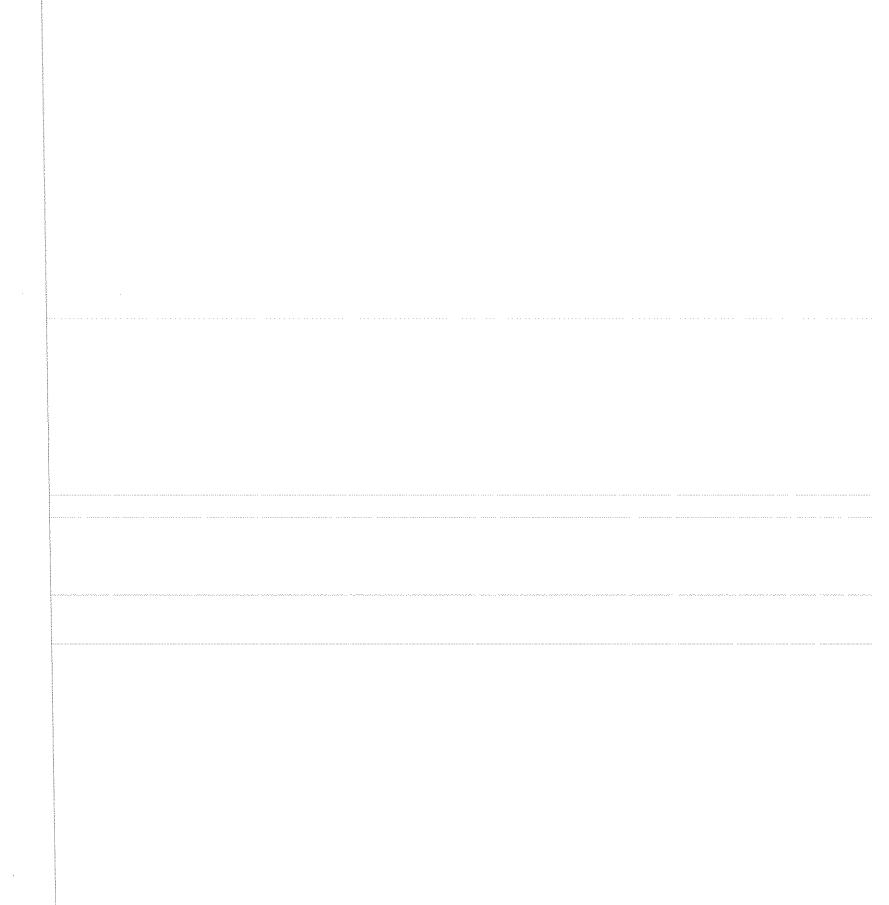
8-104. The general procedure for isolating a failure is listed below:

- a. Interchange the pin driver boards associated with the failed pin with a pin driver board that did not register a failure, one board at a time. Rerun the program and see if the failure is registered on the same pin or if it has moved to the pin where the suspect board was moved to. If the failure has moved, then the problem is associated with the moved board and the troubleshooting procedure in paragraph 8-118 should be used.
- b. If the failure has not moved, then the fault may be associated with the driver interconnected to the failed pin, the fast edge circuitry, or the control circuitry on A10, A11 or A12.
- c. Interchanging boards should be used where possible to isolate the failure. This can be done on the pin driver and socket driver boards.
- d. Where more than 1 group of pins is registered as failed and the grouping is every fourth pin (i.e., 1,5,9, etc.), the failure is probably associated with the failure detect circuitry on the A12 board or one of the pin driver boards listed as failed.

# 8-105. Self Check 2 (Option 024)

8-106. Self Check 2 (pin drivers 24 program) contains ten tests that test the overall operation of the pin driver boards, the reference generator, the sample and hold circuits, and related circuitry.

- 8-107. A description of each test is as follows:
  - a. Test 2-1: Checks all pin drivers at the maximum voltages (7.5V) and at the crossover point on the low current range (250  $\mu$ A). Pins 13-24 monitor and load pins 1-12. '0' and '1' states are exercised.
  - b. Test 2-2: Checks all pin drivers at maximum voltages (7.5V) and at the crossover point on the low current range. Pins 1-12 monitor and load pins 13-24. '0' and '1' states are exercised.
  - c. Test 2-3: Checks all pin drivers at the voltage crossover point (1.875V) and at the crossover point between Hi and Lo current ranges (2.5 mA). Pins 13-24 monitor and load pins 1-12. '0' and '1' states are exercised.
  - d. Test 2-4: Checks all pin drivers at the voltage crossover point (1.875V) and at the crossover point betwene Hi and Lo current ranges (2.5 mA). Pins 1-12 monitor and load pins 13-24. '0' and '1' states are exercised.
  - e. Test 2-5: Checks continuous current control on pin drivers 13-24. Pins 1-12 monitor pins 13-24. '0' and '1' states are exercised.
  - f. Test 2-6: Checks continuous current control on pin drivers 1-12. Pins 13-24 monitor pins 1-12. '0' and '1' states are exercised.
  - g. Test 2-7: Checks all pin drivers at the maximum voltage (7.5V) and maximum current (200 mA). Pins 13-24 monitor and load pins 1-12. Each pin combination (e.g., 1 and 24) is separately checked.
  - h. Test 2-8: Checks all pin drivers at the maximum voltage (7.5V) and maximum current (200 mA). Pins 1012 monitor and load pins 13-24. Each pin combination (e.g., 1 and 24) is separately checked.
  - i. Test 2-9: Checks all pin drivers at the maximum voltage (7.5V) and low current (20  $\mu$ A). Pins 1-12 monitor and load pins 13-24. '0' and '1' states are exercised.
  - j. Test 2-10: Checks all pin drivers at the maximum voltage (7.5V) and low current (20  $\mu$ A). Pins 13-24 monitor and load pins 1-12. '0' and '1' states are exercised.
- 8-108. When the pin driver circuitry is operating properly, the tester should cycle and register a pass each time the ten tests are performed.
- 8-109. The test program requires the 24-pin dummy IC (05045-80020) to be installed in the test socket (in the case of a handler, the IC should be installed in the handler test socket).
- 8-110. TROUBLESHOOTING. The tests in this program are configured in such a way that they exercise the overall pin driver section of the tester in all modes. This program or the programs listed in paragraph 4-12 may be used to isolate the failure to the board and component.
- 8-111. The general procedure for isolating a failure is listed below:
  - a. Interchange the pin driver board associated with the failed pin with a pin driver board that did not register a failure. Rerun the program and see if the failure is registered on the same pin or if it has moved to the pin to where the suspect board was moved.
  - b. If the failure has moved then the problem is associated with the moved board and the troubleshooting procedure in paragraph 8-118 should be used.
  - c. If the failure has not moved then the faulty circuit may be associated with the driver interconnected to the failed pin driver, the fast edge circuitry or the control circuitry on A10, A11 or A12. Interchanging boards should be used where possible to isolate the failure. This can be done on the pin driver and socket driver boards.



8-126. For all tests in both the V/I R-Pack and the R-Pack C-Current Modes program, the odd and even pins for any pin driver board are set up with the same parameters. Comparison trouble-shooting may be done with these programs.

8-127. Failing pins should be isolated by running the R-Pack Tests described in paragraph 4-16. Also, with the R-Pack removed from the test socket, actual programmed voltages and currents may be measured by probing the test points on the Test Head. Scopes, DVMs or other test equipment must be grounded to A30 TP25. The tolerances for voltages and currents when measured with the DVM is listed in Table 8-4.

Table 8-4. Tolerances for R-Pack Parameters

V/I R-Pack		R-Pack C-Current Modes	
Test 1	7V +/- 25 mV 7 mA +/42 mA	Test 1	7V +/- 25 mV 7 mA +/- 1.12 mA
Test 2	1V +/- 15 mV 1 mA +/06 mA	Test 2	1V +/- 15 mV 1 mA +/18 mA
Test 3	-7V +/- 25 mV -7 mA +/42 mA	Test 3	-7V +/- 25 mV -7 mA +/- 1.12 mA
Test 4	-1V +/- 15 mV -1 mA +/06 mA	Test 4	-1V +/- 15 mA -1 mA +/18 mA

Measurements made on A30 test points with DVM.

# 8-128. Current Source Troubleshooting

#### NOTE

All circuits on the pin driver boards are suspectible to loading and therefore high input impedance ( $10~\text{M}\Omega$ ) oscilloscopes and DVMs should be used to monitor this circuitry. A large portion of the circuitry on the pin driver boards is CMOS with very high input impedances and low output driver currents. The operational amplifiers are also high input impedance devices.

Leads which are strobed onto pin driver boards via bilateral switches should be measured using an oscilloscope unless otherwise specified. These levels should be measured during valid strobe in intervals only. Bilateral switches turn on when U20 pin 3 is high for odd pins and when U20 pin 11 is high for even pins. The high state is approximately +8V.

8-129. The correct (+) op amp voltage for current sources may be calculated by using the formulas below.

Positive Current Sources (+) inputs
Odd U13(16)
Even U3(6)

Negative Current Sources (+) inputs
Odd U11(6)
Even U1(6)

8-130. Each current source has a high and low range. For each test, refer to Table 8-5 for this information.

8-131. Calculation of (+) op amp voltage.

I is programmed level in mA.

+I Hi Range V(+) = 15 - .025I

-I Lo Range V(+) = 15 - 2.025I)

-I Hi Range V(+) = -|15 - .025I|

-I Lo Range V(+) = -|15 - 2.025I|

Note: |a| = absolute value of "a".

(see Figure 8-9)

Example:

A programmed current level of +7 mA is set up. 7 mA is in the Hi range; therefore the  $+\dot{I}$  Hi Range equation is used.

The expected (+) op amp voltage is then:

$$15 - .025 \times 7 = 14.83V$$

8-132. When the current source is operating properly the (-) op amp voltage (pin 2) should be within 20 mV of the (+) input (pin 3). The output of the op amp (pin 6) should be approximately two diode drops above or below the (+) input depending on the polarity of the current source.

8-133. When troubleshooting a current source, also check the following:

- a. Make sure that only 1 of the 3 gates in the current source is ON. The "A" gates are for the low current range and the "B" gates are for the high range. For positive current sources, the "ON" gates output voltage is within a few millivolts of the Vss pin (pin 7). The other two gate outputs should be near +18V. For negative current sources, the "ON" gate's output voltage is within a few millivolts of the VDD pin (pin 14). The two other negative current source gates should have outputs near -18V.
- b. The continuous current bit is set high or low depending on the programmed mode. When continuous current is specified, a current source will produce current independent of the logic state. These levels should be measured with an oscilloscope only. The levels are strobed onto the pin driver boards via bilateral switches. Bilateral switches turn on when U20 pin 3 is in the high state (approximately 8V) for odd pins and U20 pin 11 for even pins. Measure the continuous bit voltage level during the valid strobe period. The expected logic states for the Resistor Pack programs are listed in Table 8-5.

+ Continuous I U23(2) Odd Pins U23(3) Even Pins

-Continuous I U23(10) Odd Pins U23(9) Even Pins

Logic H Level 2.5 to 5V (approx.) Logic L Level -2.5 to -5V (approx.)

c. The logic state for a pin is determined by the "Odd Pin Test Pattern Setup" or the "Even Pin Test Pattern Setup" control lines.

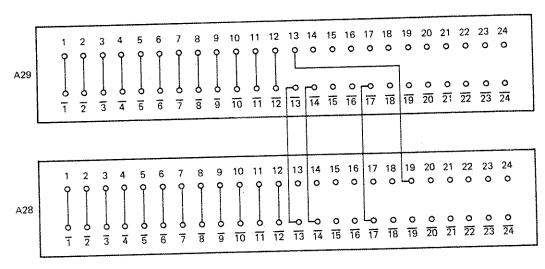
The logic levels should be measured on U22(12) for odd pins and U22(2) for even pins. Refer to Table 8-5 for expected levels.

Logic H Level +8V (approx.)
Logic L Level -8V (approx.)

- d. Turn on the 5045A and load Self Check 2. Do not use dummy IC.
- e. The PASS light should flash at a consistent rate. This indicates that the processor and memory are functioning correctly.
- f. If the FAIL light flashes then the processor or memory and associated control has a malfunction. Refer to processor troubleshooting paragraph 8-57.
- g. If the pass light flashes then one of the pindriver boards is bad.
- h. Turn the power off. Set "START" to "MAN/HANDLR."
- i. Insert one pindriver board and load Self Check 3. DO NOT USE THE DUMMY IC. Press TEST. Pass light should illuminate. Verify front panel operation by pressing TEST several times and then try to reload the card. If these front panel controls function correctly then turn off the 5045A and insert another pindriver board. Again verify correct operation. Continue this procedure until the bad board is found. When the bad pindriver is isolated, remove all of the others. Remove the ground jumper from A12 and troubleshoot the bad board by using the Current Source Troubleshooting procedure.

# 8-145. Troubleshooting the Fast Edge (Socket Driver) Circuitry

8-146. Positive and negative fast edge magnetic card program (05045-18009) and the procedure listed in paragraph 5-9 should be used to check each circuit.



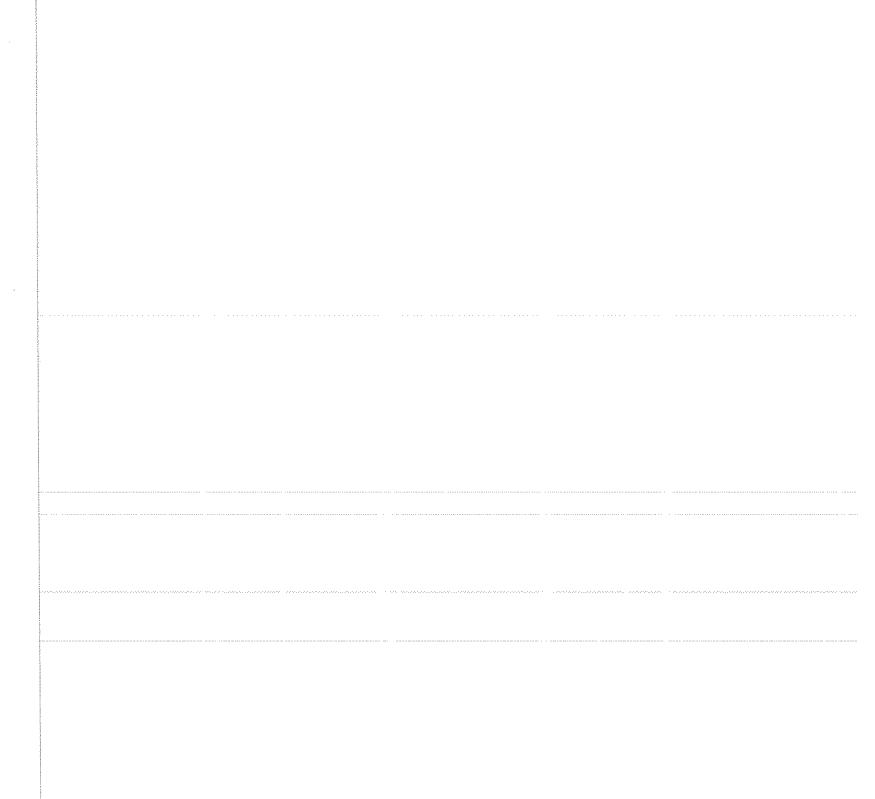
8-147. To gain access to the failed board use above procedure and isolate the failed pin. Interchange the boards if necessary to place the failed board in the A29 position (upper board). Remove the A30 Socket board and the A31 Interconnect board. Connect the A28 and 29 boards together using two 24-pin connectors wired as follows:

- 8-148. Checks to be performed on the failed board using the fast edge program cards:
  - a. Check that data is shifted into circuits U7 and U8.
  - b. The control and generation of information to the fast edge circuitry is controlled by the A12 Pin Driver Control U1-U3, U6-U9. Information designating which pin drivers are driving inputs and which are monitoring outputs is contained in U2. This information is ANDed with the next logic state information in U3D. This information is fed to the A28 and A29 socket driver (fast edge) boards via U3(11) and connector J6. This data is fed in parallel to both boards. Data is clocked onto the A28 board using the output of U3(8) via connector J4 and to the A29 board using the U3(6) via connector J5 output.

- c. Check that the data is transfered from U7 and U8 to U4 and U5.
- d. The transfer from A28/A29 U7 and U8 to U4 and U5 is controlled by the signal generated at U3(3) and output via connector J5.
- e. Check that the transistors are turned on for at least 3  $\mu$ s.
- f. Check that the '1' state storage capacitor for each fast edge circuit is charged to the '1' state level while the test socket pin is in the '0' state and the '0' state storage capacitor is charged to the '0' state level while the test socket pin is in the '1' state. These capacitors are charged from the voltage source on the corresponding pin driver circuit.

#### 8-149. A8 ROM LISTINGS

8-150. The ROM listing in connection with the ROM flow chart and an HP 1601 Logic State Analyzer can be used to verify the information flow in the instrument.



```
-(0-8) INITIAL
         -WAIT FOR LOAD BUTTON TO BE PRESSED
0 0 0 0 0
        Q.ECL.OR
0001 1
        Q.ECL.OR
0002 2
       Q.ECL.OR
0003 3
       Q.ECL.OR
0004 4
       Q.ECL.OR TO
                     T 196 - 207
        FR. PANEL TO C 200 - 200
0006 6
        ROM ADR. FROM T 196 - 207
0010 8
                      GO TO 0 LOAD BUTTON NOT PUSHED
                      GO TO 16 LOAD BUTTON PUSHED
        -(16-36) CLEAR MM
        -LOOP 255 TIMES
0020 16 Q.ECL.OR TO T 187 - 199
0022 18 A-ONE
                 FROM C 187 - 190
0024 20 A-ONE
                 TO C 187 - 190
                                  , C 195
                 FROM C 191 - 195
0027 23 A-ONE
                 TO C 191 - 194 , C 198
0031 25 A-ONE
                 FROM C 198 - 198 ,T 198
        COPY
0034 28
                 TO T 200 - 225 ,C 197
0037 31
        COPY
0042 34 M.MEM.
                 FROM T 202 - 225
0044 36 ROM ADR. FROM T 196 - 207
                      GO TO 18 MAIN MEM CLEAR LOOP LESS THAN 255
                      GO TO 38 MAIN MEM CLEAR LOOP FINISHED
         -(38-44) WAIT FOR LOAD BUTTON
       FR.PANEL TO
                     C 199 - 199
0046 38
                      T 33 - 60 , C 56 , T 2
0050 40
        Q.ECL.OR TO
        ROM ADR. FROM T 196 - 207
0054 44
                      GO TO 38 LOAD BUTTON NOT PUSHED
                      GO TO 46 LOAD BUTTON PUSHED
                    T 499 - 510 ,STORE ROM ADR: 47
        ROM ADR. TO
0056 46
        ROM ADR. FROM T 49 - 60
0060 48
                      GO TO 128 RTN 50 GO TO MAG CARD SUB
         -(50-90) INITIAL D/A SET UP
0062 50 CONSTANT TO T 285 - 286
         ( 33 ) TO T 287 - 294
         ( 30 ) TO T 295 - 302
         ( 277 ) TO T 303 - 310
         ( 11 ) TO T 311 - 318
         ( 200 ) TO T 319 - 326
         ( 4 ) TO T.327 - 334
         ( 10 ) TO T 335 - 342
         ( 0 ) TO T 343 - 350
               TO T 404 - 408 , T 404
0074 60 A-ONE
0077 63 Q.ECL.OR TO T 212 - 223 ,C 221
                      T 375 - 391
0102 66 DECODER TO
                      T 499 - 510 , STORE ROM ADR: 69
0104 68 ROM ADR. TO
0106 70 ROM ADR. FROM T 380 - 391
                       GO TO 2048 RTN 72 GO TO D/A IN/OUT SUB
                      T 302 - 311 ,C 289 ,T 329
0110 72 DECODER
                TO
                      T 499 - 510 , STORE ROM ADR: 77
0114 76
       ROM ADR.
                TO
0116 78 ROM ADR. FROM T 315 - 326
                       GO TO 2048 RTN 80 GO TO D/A IN OUT SUB
```

```
0120 80 A-ONE
                  FROM C 289 - 289
0122 82 A-ONE
                  TO C 289 - 289 , T 294
0125 85
                  FROM C 290 - 294
        A -ONE
0127 87
                  TO C 290 + 293 ,C 300
         A -ONE
0132 90 ROM ADR. FROM T 296 - 307
                      GO TO 76 PIN SET-UP NOT FINISHED
                      GO TO 92 FINISHED '0' ING PIN SET-UP
         -(94-100) CHECK SUM COMPARE 4LSB
0134 92 M.M. ADV FROM T 343 - 350
         COPY FROM T 128 - 131
0136 94
0140 96
         COPY
                 TO T 94 - 98
         COMPARE FROM T 94 - 102
0142 98
0144 100 COMPARE TO T 94 - 94
0146 102 COPY
              FROM T 132 - 135
0150 104 COPY
               TO T 98 - 102
0152 106 CONSTANT TO T 382 - 383
        ( 50 ) TO T 384 - 391
         (2) TO T 392 - 399
         (164) TO T 400 - 407
         ( 100 ) TO T 408 - 415
         ( 11 ) TO T 416 - 423
        ( 0 ) TO T 424 - 431
        ( 245 ) TO T 432 - 439
         ( 44 ) TO T 440 - 447
         ( 142 ) TO T 448 - 455
         (1 ) TO T 456 - 463
        ( 22 ) TO T 464 - 471
        ( 2 ) TO T 472 - 479
        ( 200 ) TO T 480 - 487
        ( 167 ) TO T 488 - 495
        ( 140 ) TO T 496 - 503
        ( 12 ) TO T 504 - 511
0174 124 M.MEM. FROM T 28 - 51
0176 126 ROM ADR. FROM T 464 - 475
                      GO TO 530 RTN 336 GO TO TITLE SEARCH SUB IN MM
        -(128-335) CARD READER SUBROUTINE
0200 128 Q.ECL.OR TO T 96 - 122
0202 130 Q.ECL.OR TO T 128 - 156
0204 132 COPY
                 FROM T 500 - 509
0206 134 COPY
                 TO C 214 - 243
0210 136 ROM ADR. TO
                    T 499 - 510 ,STORE ROM ADR: 137
0212 138 A-ONE
                 TO C 499 - 503
0214 140 DECODER TO T 3 - 32 ,C 18 ,C 19
0220 144 EXT.CONT FROM T 2 - 9
0222 146 EXT.CONT TO C 502 - 502
        -WAIT FOR CARD IN
0224 148 CARD RDR FROM C 4 - 7
0226 150 ROM ADR. FROM T 499 - 510
                    GO TO 144 CARD NOT IN
                     GO TO 152 CARD IN
        -(152-166) SET UP FOR TIME DELAY
        -16MS DELAY
0230 152 Q ECL.OR TO
                    C 26 - 28
0232 154 ROM ADR. FROM T 9 - 20
                     GO TO 1536 RTN 156 8 MSEC DELAY
```

```
FROM C 2 - 2
                     C 504 - 506 ,T 507 ,T 500 ,T 503
0234 156 A-ONE
               TO
0236 158 A-ONE
T 505 ,T 501 ,T 511
0246 166 ROM ADR. FROM T 9 - 20
                      GO TO 1536 RTN 174 DO 8 MSEC DELAY THEN READ
                                        CARD SUB
                                     268 RTN TO WRITE CARD SUB
0250 168 CARD RDR TO T 95 - 98
0252 170 ROM ADR. FROM T 21 - 32
                      GO TO 224 RTN 172 24 BIT WORD FROM CRD RDR
                                         COMPLETE
                                      174 24 BIT WORD FROM CRD RDR
                                         NOT COMPLETE
        -(174) READ CARD SUBROUTINE
                FROM T 99 - 122
0254 172 M.MEM.
0256 174 CARD RDR FROM C 4 - 7
0260 176 Q.ECL.OR TO T 500 - 501
0262 178 EXT.CONT TO C 504 - 505
0264 180 QUAD OR FROM C 504 - 505 ,C 504 ,C 505 ,C 504
                      C 502 - 502 , T 503 , T 505
0271 185 QUAD OR TO
         -WAIT FOR MFL
0275 189 ROM ADR. FROM T 499 - 510
                       GO TO 176 NO CLOCK
                       GO TO 168 CARD AND CLOCK
                       GO TO 208 END OF CARD
                      T 501 - 501
 0300 192 EXT.CONT TO
0302 194 ROM ADR. FROM T 499 - 510
                       GO TO 192 CARD NOT IN
                       GO TO 196 CARD IN
 0304 196 M.M. ADV FROM T 9 - 16
                  FROM T 154 - 154
 0306 198 COPY
                  TO T 90 - 90
 0310 200 ROM ADR. TO T 499 - 510 ,STORE ROM ADR: 203
 0314 204 ROM ADR. FROM T 9 - 20
                       GO TO 1536 RTN 206 DO 8 MSEC DELAY
 0316 206 ROM ADR. FROM T 9 - 20
                       GO TO 1536 RTN 210 DO 8 MSEC DELAY
 0320 208 NOP
 0321 209 NOP
                  FROM C 214 - 223
 0322 210 COPY
                  TO T 500 - 510
 0324 212 COPY
                  FROM C 90 - 90
 0326 214 A-ONE
                  TO T 233 - 233 ,C 231 ,C 226
 0330 216 A-ONE
 0334 220 EXT.CONT FROM T 9 - 16
 0336 222 ROM ADR. FROM T 224 - 235
                        GO TO 132 NO END CODE FOUND
                        GO TO 512 END CODE FOUND
```

```
-(224-235) CALCULATE CHECK SUM
        -(237-239 + 258-264) CHECK FOR END CODE
                 FROM T 128 - 131 ,T 511 ,T 120 ,T 121
0340 224 A+B
T 122
                 TO T 128 - 131 ,T 136
0346 230 A+B
                 FROM T 132 - 136
0351 233 A+B
                 TO T 132 - 135
0353 235 A+B
                 FROM C 120 - 122
0355 237 OR
                 TO C 140 - 140
0357 239 OR
0361 241 COPY
                 FROM T 110 ~ 119
                 TO T 113 - 122
0363 243 COPY
                 FROM T 100 - 109
0365 245 COPY
                 TO T 103 - 112
0367 247 COPY
                 FROM T 96 - 99
0371 249 COPY
0373 251 COPY
                 TO T 99 - 102
0375 253 A-ONE
                 FROM C 137 - 139
0377 255 A-ONE
                 TO C 137 - 139 ,C 500
                 FROM T 140 - 149
0402 258 COPY
                 TO T 141 - 150
0404 260 COPY
         -CHECK IF 1 IN S.R. - END CODE FOUND
                 FROM C 141 - 148
0406 262 OR
                 TO C 90 - 90
0410 264 OR
0412 266 ROM ADR. FROM T 224 - 235
                       GO TO 512
        -(268-335) WRITE SUBROUTINE
0414 268 CARD RDR FROM C 4 - 7
0416 270 ROM ADR. FROM T 9 - 20
                      GO TO 1536 DO 8 MSEC DELAY RTN 272
0420 272 M.MEM.
                     T 99 - 122
0422 274 ROM ADR. FROM T 9 - 20
                       GO TO 1536 DO 8 MSEC DELAY RTN 276
0424 276 CARD RDR FROM C 4 - 7
0426 278 CARD RDR FROM T 120 - 123
                      T 236 - 243 ,C 240 ,C 240
0430 280 Q.ECL.OR
                 TO
                      T 499 - 510 , STORE ROM ADR: 285
0434 284 ROM ADR.
                 TO
                 FROM T 9 - 20
0436 286 ROM ADR.
                       GO TO 1536 DO 8 MSEC DELAY RTN 288
0440 288 CARD RDR FROM T 120 - 123
0442 290 ROM ADR. FROM T 21 - 32
                       GO TO 224 RTN 292 GET NEW WORD FROM MAIN MEM
                                        IF FINISHED OLD WORD
                                     294 STILL PROCESSING OLD WORD
0444 292 M.MEM.
                 TO
                     T 99 - 122
0446 294 QUAD OR FROM T 500 - 500 ,C 90 ,C 500
0452 298 QUAD OR TO
                      T 502 - 502 , T 155
0455 301 Q.ECL.OR TO
                      T 238 - 243
0457 303 Q.ECL.OR TO
                      T 500 - 501 ,C 503
0462 306 ROM ADR. FROM T 9 - 20
                       GO TO 1536 RTN 308 HAVE END CODE
```

316 NO END CODE

```
0742 482 EXT.CONT FROM C 492 - 499
0744 484 A-ONE FROM C 192 - 192
0746 486 A-ONE
                 TO C 456 - 456 .C 464
0751 489 ROM ADR. FROM T 455 - 466
                       GO TO 530 RTN 492 TEST BUTTON PRESSED
                                   494 WRITE BUTTON PRESSED
                       GO TO 16 LOAD BUTTON PRESSED
0754 492 ROM ADR. FROM T 461 - 472
                       GO TO 1352 GO TO TEST PROG PREPERATION SUB
0756 494 Q.ECL.OR TO T 467 - 484
0760 496 ROM ADR. FROM T 455 - 466
                       GO TO 530 RTN 498 LOOK FOR TITLE CODE FFFBEF
0762 498 DECODER FROM T 193 - 193
0764 500 DECODER TO C 219 - 219 ,C 221 ,C 2 ,T 204
0771 505 M.M. ADV FROM T 464 - 471
0773 507 A-ONE
                 TO T 499 - 504 , T 500
0776 510 ROM ADR. FROM T 212 - 223
                       GO TO 512 RTN SUB
                       GO TO 128 RTN 464 WRITE MAG CARD SUB
        -(512-528) RETURN SUBROUTINE
1000 512 A-ONE
               FROM C 501 - 502
                 TO C 501 - 502 , T 511
1002 514 A-ONE
                 FROM T 503 - 506 , T 511
1005 517 A+B
1010 520 A+B
                 TO T 503 - 506 , T 511
                 FROM T 507 - 511
1013 523 A+B
                 TO T 507 - 511 , T 499
1015 525 A+B
1020 528 ROM ADR. FROM T 499 - 510
                      GO TO RETURN ADDRESS
        -(530-584) TITLE SEARCH SUBROUTINE
1022 530 Q.ECL.OR TO T 212 - 223 ,C 221 ,C 485
1026 534 M.MEM.
                 TO T 256 - 279
1030 536 COMPARE FROM T 256 - 259 ,T 511 ,T 487 ,T 488
T 489 T 490
1037 543 COMPARE TO T 280 - 280
1041 545 COMPARE FROM T 260 - 263 ,T 511 ,T 491 ,T 492
T 493 T 494
                 TO T 263 - 263
1050 552 COMPARE
1052 554 OR
                 FROM C 271 - 277
1054 556 OR
                 TO C 266 - 266
1056 558 OR
                 FROM C 263 - 270
                 TO C 277 - 277
1060 560 OR
1062 562 A-ONE
                 FROM C 477 - 480 , T 485
1065 565 A-ONE
                 TO C 477 - 480 ,C 485
1070 568 A-ONE
                 FROM C 481 - 485
1072 570 A-ONE
                 TO C 481 - 485
1074 572 OR
                 FROM C 277 - 280
1076 574 OR
                 TO C 486 - 486
1100 576 QUAD OR
                 FROM T 485 - 486 , T 485 , T 486
1104 580 QUAD OR TO
                     C 215 - 216
                      T 256 - 279
1106 582 M.MEM.
                 TO
1110 584 ROM ADR. FROM T 212 - 223
                      GO TO 536 TITLE CODE NOT FOUND
                      GO TO 512 TITLE CODE FOUND, GOTO RTN ADDRESS
                                 OR LOOPED 256 TIMES
```

```
-BLANK LOADER FOR PRINTER SUBROUTINE
1112 586 Q.ECL.OR TO T 212 - 223
1114 588 Q.ECL.OR TO C 217 - 218 ,C 215 ,C 222
1120 592 CONSTANT TO T 228 - 229
         ( 40 ) TO T 230 - 237
        ( 10 ) TO T 238 - 245
         ( 202 ) TO T 246 - 253
         (40 ) TO T 254 - 261
              ) TO T 262 - 269
         ( 10
         ( 202 ) TO T 270 - 277
             ) TO T 278 - 285
         ( 40
              ) TO T 286 - 293.
         ( 10
              ) TO T 294 - 301
         ( 202
              ) TO T 302 - 309
         ( 40
         ( 10
              ) TO T 310 - 317
         ( 202 ) TO T 318 - 325
         ( 40 ) TO T 326 - 333
              ) TO T 334 - 341
         ( 10
         ( 202 ) TO T 342 - 349
1141609 ROM ADR. FROM T 212 - 223
                       GO TO 1128 IF STARTED 586
                       GO TO RETURN ADDRESS IF STARTED 592
         -(612-744) REFERENCE GENERATOR
         -SET UP SUBROUTINE
1144 612 M.MEM.
                TO T 280 - 303
1146 614 A-ONE
                 TO T 438 - 443
                TO T 410 - 433
1150 616 M.MEM.
1152 618 COPY
                 FROM C 266 - 267 ,C 416 ,C 290 ,T 291
1157 623 COPY
                 TO C 404 - 431 , T 266 , T 267 , T 290
.C 291
1165 629 CONSTANT TO T 500 - 501
        ( 116 ) TO T 502 - 509
1170 632 COPY
                 FROM T 303 - 303
                 TO T 491 - 493 , T 489 , C 494
1172 634 COPY
1176 638 ROM ADR. FROM T 487 - 498
                       GO TO 640 NEED TO DO '1' COMPLEMENT OF SETUP
                       GO TO 656 '1' COMPLEMENT NOT NEEDED
1200 640 A-ONE
                 FROM T 293 - 294
1202 642 A-ONE
                 TO C 293 - 294 ,T 350
1205 645 A-ONE
                 FROM T 295 - 298 ,C 350
                 TO C 295 - 298 ,T 350
1210 648 A-ONE
1213 651 A-ONE
                 FROM. T 299 - 302 ,T 350
1216 654 A-ONE
                 TO C 299 - 303
1220 656 A-ONE
                 FROM T 427 - 428
1222 658 A-ONE
                 TO T 427 - 438
1224 660 COPY
                 FROM T 303 - 303 , T 302 , T 301 , T 300
T 299
T 298 T 297 T 296 T 295 T 294
1237 671 COPY
               TO T 296 - 305
                 FROM T 293 - 293 ,T 292
1241 673 COPY
1244 676 COPY
                 TO T 306 - 307
                FROM C 431 - 431
1246 678 A-ONE
1250 680 A-ONE
                 TO C 501 - 502 ., T 503 , T 505 , T 506
,C 501
1256 686 ROM ADR. FROM T 432 - 443
                      GO TO 896 RTN 632 DATA RFG FROM MM TO D/A NOT
                                         FINISHED
                                  688 DATA RFG FINISHED
```

```
1260 688 M.M. ADV FROM T 212 - 219
                 TO T 232 - 255
1262 690 M.MEM.
                    T 375 - 391
1264 692 DECODER
                 TO
                 TO T 256 - 279
1266 694 M.MEM.
                 FROM C 232 - 239
1270 696 COPY
                 TO T 288 - 295 ,T 287
1272 698 COPY
                 FROM C 236 - 237
1275 701 OR
1277 703 OR
                 TO T 494 - 494
                 FROM C 494 - 494
1301 705 A-ONE
1303 707 A-ONE
                 TO
                     C 435 - 435 ,T 433
                      T 499 - 510 , STORE ROM ADR: 711
1306 710 ROM ADR. TO
1310 712 ROM ADR. FROM C 424 - 435
                      GO TO 2048 PARAMETRIC INFO IN MM SENT TO/
                                  FROM D/A
                       GO TO 512 RTN 714 TRANSFER COMPLETED
                 FROM C 375 - 376
1312 714 A-ONE
                 TO C 375 - 377
1314 716 A-ONE
1316 718 DECODER FROM C 239 - 239 ,T 494
1321 21 DECODER TO C 492 - 492 ,T 493
1324 724 QUAD OR FROM C 493 - 493 ,C 493 ,C 494 ,C 377
,C 494
                 TO C 489 - 491
1332 730 QUAD OR
                 FROM T 241 - 250
1334 732 COPY
                 TO T 233 - 242
1336 734 COPY
                 FROM T 251 - 255
1340 736 COPY
                    T 243 - 255
1342 738 COPY
                 TO
1344 740 CONSTANT TO C 500 - 501
        ( 121 ) TO C 502 - 509
1347 743 ROM ADR. FROM T 487 - 498
                       GO TO 696 END LIST OF PIN NO. NOT REACHED
                      GO TO 688 NEED TO INPUT ANOTHER WORD FROM MM
                      GO TO 612 SET-UP DATA FOR NEW PARAMETRIC INFO
                       GO TO 512 END OF PAMETRIC INFO SET-UP
         -(746-821) SUBROUTINE
         -(A+-B)A
         -AB
         -(A+-1)B
         -AB)
         -(A+-16)B
         -(B-A)
                     T 409 - 413 , T 415
1352 746 Q.ECL.OR TO
1355 749 Q.ECL.OR TO T 421 - 429
                 FROM T 417 - 418
1357 751 COPY
                 TO C 430 - 430 , C 425
1361 753 COPY
1364 756 QUAD OR FROM C 410 - 410 ,C 412 ,T 420 ,C 402
T 4021372 762 QUAD OR TO T 214 - 214 ,C 431 ,T 432
1376 766 A-ONE
                FROM C 409 - 412
                     C 409 - 412
                 TO
1400 768 A-ONE
1402 770 COMPARE FROM T 409 - 416
1404 772 COMPARE TO T 426 - 426
1406 774 Q.ECL.OR FROM C 426 - 426 ,T 418 ,T 417 ,C 431
T 288 T 419
1415 781 Q.ECL.OR TO T 426 - 426 ,T 431 ,T 421
               FROM T 278 - 287
1421 785 COPY
                     T 279 - 288
                 TO
1423 787 COPY
```

```
FROM T 421 - 426
1425 789 A+B
                 TO T 426 - 426 ,T 425
1427 791 A+B
                 FROM T 426 - 431
1432 794 A+B
                      T 426 - 426 ,T 430
1434 796 A+B
                 TO
                                   ,C 433 ,T 426
                 FROM T 432 - 433
1437 799 AND OR
                      T 278
                             - 278
1443 803 AND OR
                 TO
1445 805 COPY
                 FROM T 392 - 401
                             - 402
                  TO
                       T 393
1447 807 COPY
                                   T 426 ,T 434 ,T 432
                 FROM C 434 - 434
1451 809 AND OR
                      T 392 - 392
1456 814 AND OR
                 TO
                 FROM C 214 - 214
1460 816 A-ONE
                      T 216 - 219
1462 818 A-ONE
                 TO
1464 820 ROM ADR. FROM T 212 - 223
                       GO TO 756 TRANSFER DATA NOT COMPLETED
                       GO TO 512 TRANSFER DATA COMPLETED
         -PASS/FAIL ANALYSIS
         -RETURN FROM MM LOGIC PROGRAM SOURCE
1466 822 PIN DRV FROM T 1 - 30
1470 824 M.M. ADV FROM C 272 - 279
                      C 457 - 462
                                   T 202 C 461
1472 826 FR. PANEL TO
                 FROM T 447 - 447 ,C 460 ,C 203
1476 830 OR
                       C 275 - 275
                  TO
1502 834 OR
                      T 457 - 459
1504 836 OR
                  FROM
                       C 508 - 508
1506 838 OR
                  TO
                      T 507 - 511 , T 511 , T 508
1510 840 COPY
                  FROM
1514 844 COPY
                  TO
                       C 500 - 506
                                    ,C 508
                 FROM T 449 - 449
1516 846 DECODER
1521 849 DECODER TO
                       T 503 - 504
1523 851 CONSTANT TO T 303 - 304
         ( 271 ) TO T 305 - 312
         ( 201 ) TO T 313 - 320
         ( 11 ) TO T 321 - 328
         ( 132 ) TO T 329 - 336
1531 857 ROM ADR. FROM T 325 - 336
                       GO TO 1440 RTN 464 LOAD, WRITE OR TEST
                                           BUTTON PUSHED
                                       860 LOAD, WRITE OR TEST BUTTON
                                           NOT PUSHED AND STOP ON FAIL
                                       876 CONTINUE ON FAIL
1534 860 PIN DRV TO T 241 - 271
                  FROM T 248 - 255
1536 862 OR
                  TO T 272 - 272
1540 864 OR
                  FROM T 256 - 263
1542 866 OR
                  TO T 273 - 273
1544 868 OR
                  FROM T 264 - 271
1546 870 OR
                  TO T 274 - 274
1550 872 OR
                  FROM T 272 - 275
1552 874 OR
                  TO
                      T 307 - 307
1554 876 OR
1556 878 ROM ADR. FROM T 304 - 315
                       GO TO 882 CONTINUE TESTING
                        GO TO 890 FAILURE OCCURED
1560 880 M.M. ADV FROM T 477 - 484
                     T 497 - 498
1562 882 CONSTANT TO
         ( 66 ) TO T 499 - 506
1565 885 ROM ADR. FROM T 436 - 447
                        GO TO 1470 (NEXT TEST) MAIN MEM AS PROG SOURCE
```

```
1570 888 M.M. ADV FROM C 272 - 279
1572 890 Q.ECL.OR TO
                      C 203 - 204 , T 206 , T 458
1576 894 ROM ADR. FROM T 314 - 325
                       GO TO 1216 FAILURE OCCURED
        -(896-958) 6 BIT PER PASS
         -RIGHT SHIFT SUBROUTINE UP TO
        -16 PASSES PROGRAMMABLE
                  FROM T 344 - 349
1600 896 COPY
                  TO T 224 - 229
1602 898 COPY
                  FROM T 334 - 343
1604 900 COPY
                  TO T 340 - 349
1606 902 COPY
                  FROM T 324 - 333
1610 904 COPY
                  TO T 330 - 339
1612 906 COPY
                  FROM T 314 - 323
1614 908 COPY
                  TO T 320 - 329
1616 910 COPY
                  FROM T 304 - 313
1620 912 COPY
                  TO T 310 - 319
1622 914 COPY
                  FROM T 294 - 303
1624 916 COPY
                  TO T 300 - 309
1626 918 COPY
                  FROM T 284 - 293
1630 920 COPY
                  TO T 290 - 299
1632 922 COPY
                  FROM T 274 - 283
1634 924 COPY
                  TO T 280 - 289
1636 926 COPY
                  FROM T 264 - 273
1640 928 COPY
                  TO T 270 - 279
1642 930 COPY
                  FROM T 254 - 263
1644 932 COPY
                  TO T 260 - 269
1646 934 COPY
                  FROM T 244 - 253
1650 936 COPY
                  TO T 290 - 2990
1632 922 COPY
                  FROM T 274 - 283
1634 924 COPY
                  TO T 280 - 289
1636 926 COPY
                  FROM T 264 - 273
1640 928 COPY
                  TO T 270 - 279
1642 930 COPY
1644 932 COPY
                  FROM T 254 - 263
                  TO T 260 - 269
1646 934 COPY
                  FROM T 244 - 253
1650 936 COPY
1652 938 COPY
                  TO T 250 - 259
                  FROM T 234 - 243
1654 940 COPY
                  TO T 240 - 249
1656 942 COPY
1660 944 COPY
                  FROM T 224 - 233
1662 946 COPY
                  TO T 230 - 239
1664 948 A-ONE
                  FROM T 431 - 434
                  TO T 431 - 434 , T 219
1666 950 A-ONE
                  FROM T 219 - 219
1671 953 COPY
                  TO T 220 - 220
1673 955 COPY
1675 957 ROM ADR. FROM T 212 - 223
                       GO TO 896 ROTATE DATA
                       GO TO 512 END ROTATION OF DATA
         -(960-1099) FAILURE PRINTOUT FORMATTERO BE
         -(208-211) NUMBER OF PIN IN IC
         -STORED IN NODES
                TO C 441 - 446 , T 241
1700 960 A-ONE
1703 963 A-B-ONE FROM T 208 - 213 ,C 511
1706 966 A-B-ONE
                  TO T 494 - 510
1710 968 FR. PANEL FROM T 204 - 207
1712 970 ROM ADR. TO T 448 - 459 , STORE ROM ADR: 971
```

```
FROM T 366 - 375
1714 972 COPY
1716 974 COPY
                  TO T 367 - 375 , T 351
1721 977 COPY
                  FROM T 356 - 365
1723 979 COPY
                  TO T 357 - 366
                  FROM T 350 - 355
1725 981 COPY
1727 983 COPY
                  TO T 351 - 356
1731 985 A-B-ONE
                  FROM T 494 - 498 .T 441
1734 988 A-B-ONE
                  TO T 494 - 510 .C 509
                  FROM T 442 - 446
1737 991 DECODER
                  TO T 422 - 427 ,C 500
1741 993 DECODER
                  FROM T 441 - 442
1744 996 A-ONE
                  TO T 441 - 442 , T 350
1746 998 A-ONE
                    FROM T 443 - 446 ,C 350
           A -ONE
1751 1001
                     TO T 443 - 446 ,T 350
           A -ONE
1754 1004
                    FROM C 350 - 350 ,C 352
1757 1007
           QUAD OR
                     TO T 492 - 493
1762 1010
           QUAD OR
                     FROM T 493 - 497
1764 1012
            COPY
                     TO T 410 - 440
1766 1014
            COPY
                     FROM T 414 - 414 , T 414
1770 1016
            COPY
                     TO T 382 - 404 , T 448
1773 1019
            COPY
           ROM ADR. FROM T 499 - 510
1776 1022
                       GO TO 1.024 DETERMINATION OF OF PINS NOT
                                    FINISHED
                       GO TO 1026 DETERMINATION FINISHED
            A-ONE
                     TO T 493 - 498
2000 1024
                     FROM T 444 - 446
2002 1026
            AND OR
                                       , T 446
                         C 503 - 503
2005 1029
            AND OR
                     TO
2007 1031
            DECODER
                    FROM T 492 - 492 ,C 351
            DECODER
                     TO
                          C 500 - 500
                                       T 502
2012 1034
2015 1037
           QUAD OR
                    FROM C 502 - 503
           QUAD OR
                    TO
                         T 501 - 501 ,C 503 ,C 387
2017 1039
           CONSTANT TO
                          C 430 - 431
2023 1043
         ( 317 ) TO C 432 - 439
           ROM ADR. FROM T 429 - 440
2026 1046
                        GO TO 390 RTN 1048 NO FAILURE
                                       1050 NO MORE INFO FOR PRINTER
                                       1054 FULL LINE READY TO BE
                                           PRINTED
                                       1058 FAILURE INFO
            ROM ADR. FROM T 448 - 459
2030 1048
                        GO TO 970 NO FAILURE
2032 1050
            DECODER
                     TO T 463 - 465
2034 1052
            ROM ADR.
                    FROM T 462 - 473
                       GO TO 1746 NO MORE INFO FOR PRINTER
2036 1054
            COPY
                     FROM T 382 - 387 , C 337 , C 441
2042 1058
            COPY
                         T 327 - 329 ,T 332 ,T 333 ,T 330
T 214 T 326
2051 1065
           QUAD OR
                     FROM T 332 - 333 ,T 337 ,T 214 ,T 214
2056 1070
                          T 336 - 337 ,T 215
           QUAD OR
                     TO
2061 1073
                     FROM C 346 - 350 ,T 501 ,T 501 ,C 350
           QUAD OR
2066 1078
           QUAD OR
                     TO
                          T 431 - 434
                     FROM C 214 - 214
2070 1080
           A-ONE
2072 1082
           A -ONE
                          C 219 - 221 ,T 222 ,C 218
                     TO
2076 1086
                          C 501 - 505
           A-ONE
                     TO
2100 1088
                          T 448 - 459 , STORE ROM ADR: 1089
           ROM ADR. TO
2102 1090
            ROM ADR. FROM T 212 - 223
                       GO TO 896 RTN 1094
                        GO TO 1100 RTR 1092
```

```
TO T 415 - 424
           COPY
2427 1303
                    FROM T 429 - 433
           COPY
2431 1305
                    TO T 425 - 433
           COPY
2433 1307
                    FROM T 401 - 409
           A + B
2435 1309
                    TO T 401 - 409
           A + B
2437 1311
                                - 406 ,T 472 ,T 472
                    FROM T 402
           A + B
2441 1313
                    TO T 402 - 404 , T 473
2445 1317
           A + B
                    FROM T 402 - 405 ,C 511 ,C 473 ,C 473
           A-B-ONE
2450 1320
                    TO T 402 - 405
           A -B -ONE
2455 1325
                    FROM T 464 - 466
           A -ONE
2457 1327
                    TO T 464 - 466 ,C 222
           A -ONE
2461 1329
                    FROM T 472 - 473
           OR
2464 1332
                    TO T 221 - 221
           OR
2466 1334
                    FROM T 221 - 222
           DECODER
2470 1336
                   TO T 213 - 213 , T 221
           DECODER
2472 1338
                    FROM T 213 - 213 ,T 213 ,T 213 ,T 511
           COPY
2475 1341
,C 221
                    TO T 216 - 220
2503 1347
           COPY
            ROM ADR. FROM T 212 - 223
2505 1349
                       GO TO 1280 LOOP OP NOT FINISHED
                       GO TO 512 LOOP OP FINISHED
                       GO TO 372 DECIMAL SUBSTRACT OP
         -(1352-1487) START OF TEST PROGRAM
         -START HERE WHEN TEST BUTTON PUSHED
         -INITIALIZE TO TEST
2510 1352 Q.ECL.OR TO T 481 - 498
           Q.ECL.OR TO T 204 - 207 ,C 206
2512 1354
           RELAYS FROM C 256 - 275
2515 1357
           NOP
2517 1359
            CONSTANT TO T 466 - 467
2520 1360
        ( 11 ) TO T 468 - 475
              ) TO T 476 - 483
            ROM ADR. TO T 499 - 510 , STORE ROM ADR: 1365
2524 1364
            ROM ADR. FROM T 467 - 478
2526 1366
                       GO TO 530 RTN 1368 TITLE SEARCH SUB
                     FROM T 502 - 508 , T 485 , T 485
            A + B
2530 1368
                     TO T 502 - 506
            A +B
2534 1372
            ROM ADR. FROM T 499 - 510
2536 1374
                        GO TO 1376 LAST TEST OF PROGRAM NOT COMPLETED
                        GO TO 1472 LAST TEST OF PROGRAM COMPLETED
                     FROM T 487 - 490
            COPY
2540 1376
                     TO T 448 - 451
            COPY
2542 1378
                     FROM T 256 - 263
            COPY
2544 1380
                     TO T 487 - 494
            COPY
2546 1382
                     FROM T 268 - 275
            COPY
2550 1384
                     TO T 452 - 459
            COPY
2552 1386
                          T 477 - 484
            Q.ECL.OR TO
2554 1388
                          T 499 - 510 ,STORE ROM ADR: 1391
            ROM ADR. TO
 2556 1390
            ROM ADR. FROM T 467 - 478
 2560 1392
                        GO TO 530 TITLE SEARCH SUB
            CONSTANT TO T 485 - 486
 2562 1394
          ( 144 ) TO T 487 - 494
          ( 302 ) TO T 495 - 502
```

```
Q.ECL.OR TO C 309 - 309
2566 1398
            ROM ADR. FROM T 487 - 498
2570 1400
                       GO TO 612 REF GEN SET-UP SUB
                         T 465 - 484 ,C 466 ,C 469 ,C 474
           Q.ECL.OR TO
2572 1402
T 203
                     FROM T 452 - 459
2600 1408
            COPY
                         T 487 - 494
                     TO
            COPY
2602 1410
                                        ,STORE ROM ADR: 1413
                         T 499 - 510
            ROM ADR. TO
2604 1412
            ROM ADR. FROM T 465 - 476
2606 1414
                        GO TO 530 RTN 1416 TITLE SEARCH SUB
           Q.ECL.OR TO
                         T 155 - 185
2610 1416
           M.M. ADV FROM T 155 - 162
2612 1418
                          T 0 - 30
            Q.ECL.OR TO
2614 1420
            Q.ECL.OR TO
                          T 31 - 61
2616 1422
            Q.ECL.OR TO
                          T 62 - 92
2620 1424
            Q.ECL.OR TO
                          T 93 - 123
2622 1426
            Q.ECL.OR TO
                          T 124 - 154
2624 1428
            PIN DRV FROM T 1 - 30
2626 1430
                     FROM T 448 - 451
2630 1432
            COPY
                          T 487 - 494
                                        ,C 180
            COPY
                     TO
2632 1434
                           C 498 - 499
            CONSTANT TO
2635 1437
         ( 54 ) TO C 500 - 507
                          T 224 - 239
            Q.ECL.OR TO
2640 1440
                           C 233 - 234
            Q.ECL.OR TO
2642 1442
                     FROM C 498 - 498
2644 1444
            A -ONE
                          T 240 - 243
                     TO
            A -ONE
2646 1446
            ROM ADR. FROM T 224 - 235
2650 1448
                        GO TO 1536 IF ENTERED FROM 858 RTN 860 LOAD,
                                   WRITE OR TEST BUTTON NOT PUSHED,
                                   STOP ON FAIL
                                   876 CONTINUE ON FAIL
                                    464 LOAD, WRITE OR TEST BUTTON PUSHED
                                   IF ENTERED FROM 1448 RTN 1450
            EXT.CONT FROM T 177 - 184
 2652 1450
                           T 180 - 199 , T 205
            Q.ECL.OR TO
2654 1452
                           T 434 - 435
            CONSTANT TO
 2657 1455
         ( 276 ) TO T 436 - 443
         ( 5 ) TO T 444 - 451
                          C 350 - 375
 2663 1459
            Q.ECL.OR TO
                          C 500 - 501
            CONSTANT TO
 2665 1461
         ( 231 ) TO C 502 - 509
           FR. PANEL FROM C 437 - 440
 2670 1464
            ROM ADR. FROM C 437 - 448
 2672 1466
                        GO TO MAIN MEMORY AS PROGRAM SOURCE
                      FROM C 487 - 490
 2676 1470
            A -ONE
                                        T 509 T 484
 2700 1472
                           C 487 - 490
                      TO
            A -ONE
 2704 1476
            CONSTANT TO
                           T 499 - 500
          ( 124 ) TO T 501 - 508
                      FROM C 509 - 509
 2707 1479
            A -ONE
 2711 1481
                      TO
                           C 504 - 506
                                        ,T 505
            A-ONE
            EXT.CONT FROM T 499 - 502
 2714 1484
 2716 1486
          ROM ADR. FROM T 499 - 510
                        GO TO 432 ALL TESTS COMPLETED
                        GO TO 1360 MORE TESTS TO BE DONE
```

```
-(1488-1533) WALKING '1' AND '0'
2720 1488 CONSTANT TO T 218 - 219
        ( 342 ) TO T 220 - 227
        ( 137 ) TO T 228 - 235
        ( 24 ) TO T 236 - 243
                    FROM T 31 - 32
           COPY
2725 1493
                    TO C 291 - 291 ,C 32
           COPY
2727 1495
                    FROM C 33
                               - 36
                                      , Т 32
2732 1498
           A -ONE
                    TO C 33
                               - 37
           A -ONE
2735 1501
           DECODER FROM T 32
                               - 36
2737 1503
                   TO T 0
                               - 15
           DECODER
2741 1505
                   FROM T 32 - 35
                                      ,C 36
           DECODER
2743 1507
                   TO T 16 - 31
           DECODER
2746 1510
                    TO C 280 - 285 , T 501 , C 447
           A -ONE
2750 1512
                    TO T 304 - 327
           M.MEM.
2754 1516
           ROM ADR. FROM T 280 - 291
2756 1518
                       GO TO MAIN MEMORY AS PROGRAM SOURCE
                       GO TO 1520 CONTINUE
                   FROM T 32 - 36
           DECODER
2760 1520
                    TO C 0 - 15
2762 1522
           DECODER
                    FROM T 32 - 35 ,C 36
2764 1524
           DECODER
                    TO C 16 - 24 ,C 447 ,C 31 ,C 291
2767 1527
           DECODER
           ROM ADR. FROM T 280 - 291
2774 1532
                       GO TO MAIN MEMORY AS PROGRAM SOURCE
         -(1536-1551) TIME DELAY SUBROUTINE
         -MAX 8MS 30MS PER LOOP MAX 256 LOOPS
2776 1534 PIN DRV FROM T 1 - 30
           Q. ECL.OR TO T 224 - 235
3000 1536
                   FROM T 236 - 239
           A -ONE
3002 1538
                    TO T 236 - 239 , T 233
           A -ONE
3004 1540
                     FROM T 240 - 243 ,T 233
           A -ONE
3007 1543
                     TO T 240 - 243 ,T 234 ,C 233
           A -ONE
3012 1546
           ROM ADR. FROM T 224 - 235
 3016 1550
                       GO TO 512 END OF DELAY SUB
                       GO TO 1536 8MSEC DELAY SUB
         -(1552-1745) TRUTH TABLE AND TRUTH TABLE
         -MEMORY SUBROUTINE
3020 1552 CONSTANT TO T 314 - 315
         ( 0 ) TO T 316 - 323
         ( 140 ) TO T 324 - 331
           M.MEM. TO T 296 - 319
 3024 1556
            M.M. ADV FROM C 121 - 128
 3026 1558
                     FROM C 199 - 199 ,T 199
            COPY
 3030 1560
                     TO T 325 - 326
            COPY
 3033 1563
            DECODER FROM C 102 - 102 ,C 325
 3035 1565
            DECODER TO T 323 - 324
 3040 1568
            Q.ECL.OR TO C 283 - 284 ,C 287
 3042 1570
            ROM ADR, FROM T 320 - 331
 3045 1573
                       GO TO 1576
                        GO TO 1584
                        GO TO 1600
            Q.ECL.OR TO T 325 - 330
 3050 1576
            M.M. ADV FROM T 323 - 330
 3052 1578
                     FROM T 129 - 152
            M . M EM .
 3054 1580
```

3056 158 3060 158 3062 158 3064 158 3067 159 3072 159 3074 159 3100 160 3102 160 3104 160 3106 160 3113 163 3115 163 3117 163 3121 163 3121 163 3123 163 3125 163 3127 163 3131 163 3131 163 3133 163 3133 163 3135 163 3137 163 3141 163	34 M 36 A 38 A 38 A 39 1 A 39 4 A 39 6 G 30 0 C 30 2 G 30 4 G 30 6 G 30 7 G 30 8 G 30	I.MEM. A-ONE A-ONE A-ONE A-ONE A-ONE A-ONE A-ONE A-OPY AOPY AOPY AOPY AOPY AOPY AOPY AOPY A	TO FROM TO FROM TO	T C C C C C T T T T T T T T T T T T T T	3 2 3 1 7 6 1 2 1 1 2 2 5 1 2 2 5 1 3 0 1 4 0 1 3 9 1 4 0 1 5 3 1 6 4 1 7 3 1 8 4 1 7 3 1 8 3 1 9 4 1 9 3 1 9 3 1 0 3		330 199 124 128 1039 138 148 151 163 172 183 193 198 198 103	, c , c	199 199 106	, C	330		
3143 16	3 5 A	A-ONE	TO	С	103 104		103 107		199 199				
3146 163 3151 163		A -ONE	FROM TO		104		107		199				
3154 16		A-ONE	FROM	Т	296	_	296						
3156 16	46 A	A-ONE	TO	T	296		296		332				
3161 16		A-ONE	FROM		297		300		332				
3164 16		A -ONE	TO	T	297		300 327	, C , C	327 327				
3167 16 3172 16		COPY COPY	FROM TO	C T	327		326		329				
3172 16 3175 16		ROM ADR.	FROM	Ť	320	_	331	, -	*				
0170 10		10,111	GO	ТО									
			GO	ТО	166	4							
3200 16		A-B-ONE	FROM	T	312	***	315	, C	511	, T	121	, т	122 .
3207 16		. → A -B -ONE	ТО	Т	332		3 3 5	, т	320				
3212 16		A-B-ONE	FROM				320	, T	125	, T	126	, T	127
, T 1.									0.00	_	0.04		
3220 16		A -B -ONE	TO		336			, 1	320	, C	331		
3224 16 3226 16		M.M. ADV ROM ADR	FROM FROM		320								
0220 10	,		GO					sou	RCE		•		
				_	400		100						
3230 16 3232 16		OR	FROM TO		122 102								
3234 16		CONSTANT	TO		318-		319						
		02 ) TO	T 320		- 327								
3237 16		A +B	FROM		332		335		511	, C	511		
3243 16		4 + B	TO		332			, T	340				
3246 17 3250 17		4 + B	FROM TO		336 332		340	_	331				
3253 17		A+B DECODER			224		243		233	, т	235		
3257 17		NOP	. •	_									

8-53

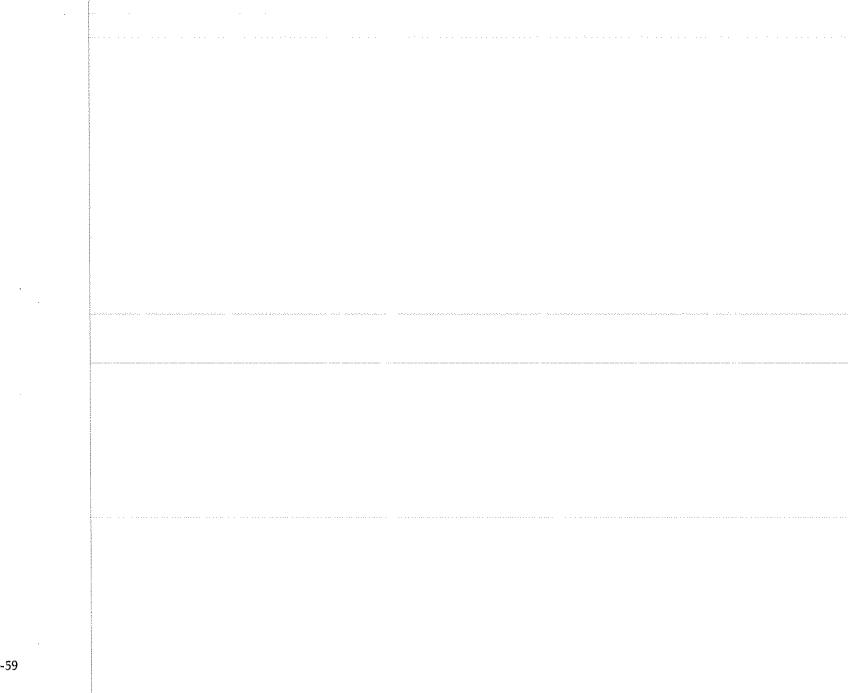
```
ROM ADR. TO T 499 - 510 , STORE ROM ADR: 1713
3260 1712
           ROM ADR. FROM T 224 - 235
3262 1714
                      GO TO 1534
3264 1716
          Q. ECL. OR TO C 1 - 24
3266 1718
          PIN DRV TO T 506 - 536
           Q. ECL. OR TO C 281 - 282 , C 285 , T 511
3270 1720
           ROM ADR. FROM T 320 - 331
3274 1724
                      GO TO MAIN MEMORY AS P. ROGRAM SOURCE
                      GO TO 1730
           M.M. ADV FROM C 304 - 311
3276 1726
           ROM ADR. FROM T 320 - 331
3300 1728
                      GO TO MAIN MEMORY AS PROGRAM SOURCE
          CONSTANT TO T 150 - 151
3302 1730
        ( 276 ) TO T 152 - 159
          65 ) TO T 160 - 167
         ( 371 ) TO T 168 - 175
         ( 363 ) TO T 176 - 183
         (5) TO T 184 - 191
        ( 0 ) TO T 192 - 199
3312 1738 M.M. ADV FROM T 192 - 199
3314 1740
          M. MEM. FROM T 164 - 187
3316 1742 Q. ECL. OR TO C 507 - 507
3320 1744 ROM ADR. FROM T 152 - 163
                     GO TO 1470 (NEXT TEST)
        -( 1746-1761) PRINT OUT "FAIL PIN ---"
3322 1746 CONSTANT TO T 292 - 293
        ( 352 ) TO T 294 - 301
         ( 116 ) TO T 302 - 309
         ( 2 ) TO T 310 - 317
         ( 201 ) TO T 318 - 325
         ( 114 ) TO T 326 - 333
         ( 22 ) TO T 334 - 341
        ( 30 ) TO T 342 - 349
3333 1755 CONSTANT TO T 499 - 500
        ( 23 ) TO T 501 - 508
3336 1758 ROM ADR. TO T 448 - 459 , STORE ROM ADR: 1759
3340 1760 ROM ADR. FROM T 499 - 510
                      GO TO 1100
        -( 1762-1807) PIN STATE PRINTOUT SUBROUTINE
3342 1762 CONSTANT TO T 230 - 231
        ( 344 ) TO T 232 - 239
        ( 307 ) TO T 240 - 247
        ( 140 ) TO T 248 - 255
        ( 101 ) TO T 256 - 263
        ( 5 ) TO T 264 - 271
        ( 324 ) TO T 272 - 279
        ( 304 ) TO T 280 - 287
       ( 162 ) TO T 288 - 295
3354 1772 ROM ADR. TO T 448 - 459 , STORE ROM ADR: 1773
3356 1774 ROM ADR. FROM T 284 - 295
                     GO TO 1836
```

```
3360 1776 CONSTANT TO T 230 - 231
        ( 0 ) TO T 232 - 239
        ( 202 ) TO T 240 - 247
        ( 40 ) TO T 248 - 255
        ( 10 ) TO T 256 - 263
     (72) TO T 264 - 271
        ( 11 ) TO T 272 - 279
        ( 344 ) TO T 280 - 287
   ( 162 ) TO T 288 - 295
3372 1786 ROM ADR. TO T 448 - 459 , STORE ROM ADR: 1787
3374 1788 ROM ADR. FROM T 284 - 295
                     GO TO 1838
3376 1790 CONSTANT TO T 230 - 231
      ( 0 ) TO T 232 - 239
        ( 122 ) TO T 240 - 247
        ( 103 ) TO T 248 - 255
        ( 41 ) TO T 256 - 263
     ( 111 ) TO T 264 - 271
        ( 317 ) TO T 272 - 279
        ( 300 ) TO T 280 - 287
        ( 162 ) TO T 288 - 295
3410 1800 A-ONE FROM C 460 - 460
3412 1802 A-ONE TO T 448 - 455 , C 456 , T 350
3416 1806
          ROM ADR. FROM T 284 - 295
                     GO TO 1836 RTN 1810 CONTINUE ON FAIL
                     RTN 1812
        -( 1808-1834) CHECK FOR V. I. PRINT OUT
        -TITLE SEARCH FOR PASS/FAIL INFORMATION
        -PRINT OUT
3420 1808 M.MEM.
                  TO T 230 - 253
3422 1810
         Q. ECL. OR TO T 461 - 461
3424 1812
          A-ONE
                TO C 500 - 505
3426 1814
          A-ONE
                 FROM T 461 - 461
3430 1816
                 TO C 501 - 501 , T 503 , T 507 , T 509
          A-ONE
, T 510
3436 1822
          COPY
                 FROM C 487 - 490
3440 1824
          COPY
                 TO C 400 - 407
3442 1826
        CONSTANT TO T 463 - 464
        ( 22 ) TO T 465 - 472
        ( 42 ) TO T 473 - 480
        ( 360 ) TO T 481 - 488
        ( 377 ) TO T 489 - 496
3450 1832
        DECODER TO C 436 - 446
3452 1834
          ROM ADR, FROM T 465 - 476
                    GO TO 530 RTN 1908
                     GO TO 2664 V-I PRINT OUT
3454 1836
          COPY
                   FROM T 208 - 212
                   TO C 404 - 412 , T 411 , C 204
3456 1838
          COPY
3462 1842
          ROM ADR. TO T 499 - 510 , STORE ROM ADR: 1843
                   FROM T 1 - 10
3464 1844
          COPY
3466 1846
          COPY
                   TO T 0 - 9
3470 1848
                   FROM T 15 - 24
          COPY
3472 1850
          COPY
                   TO T 16 - 24 , T 351
3475 1853
          COPY
                   FROM T 11 - 12 , T 0 , T 351 , T 13
, T 14
3503 1859
          COPY
                   TO T 10 - 15
```

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```
-(2048-2091) D/A INPUT OR OUTPUT INFO
        -SUBROUTINE FOR ONE PIN
                   FROM T 286 - 293
4000 2048 D/A
4002 2050
           EXT, CONT TO T 381 - 384
          DECODER FROM T 379 - 379 ,C 384
4004 2052
           DECODER TO C 381 - 381 , T 382
4007 2055
                    FROM T 382 - 382
4012 2058
           COPY
4014 2060
           COPY
                    TO T 383 - 383
           ROM ADR. FROM T 380 - 391
4016 2062
                      GO TO 2050 WAITING FOR 'READY' SIGNAL FROM D/A
                      GO TO 2064 WRITE DATA INTO D/A
                      GO TO 2078 READ DATA FROM D/A
        -TRANSFER INFORMATION TO D/A
                   TO T 224 - 229
4020 2064 D/A
4022 2066
          D/A
                    FROM T 302 - 314
4024 2068
                    FROM T 404 - 408
          D/A
4026 2070
                    FROM T 314 - 332
          D/A
                    FROM T 326 - 344
4030 2072
          D/A
                    FROM T 338 - 350
4032 2074
          D/A
          ROM ADR. FROM T 212 - 223
4034 2076
                      GO TO 512 FINISHED WRITING DATA INTO D/A
        -TRANSFER INFORMATION FROM D/A
4036 2078 D/A
                   TO T 302 - 307
                        T 302 - 314
4040 2080
         D/A
                   TO
         D/A
                        T 404 - 408
                   TO
4042 2082
                   TO
                        T 314 - 332
4044 2084
          D/A
                        T 326 - 344
4046 2086
          D/A
                   TO
                    TO T 338 - 350
4050 2088
          D/A
          ROM ADR. FROM T 212 - 223
4052 2090
                     GO TO 512 FINISHED READING DATA FROM D/A
        -(2092-2151) CONVERT BINARY DATA FROM D/A
        -TO DECIMAL INTERCHANGE DATA POSITION
                   FROM T 231 - 240
4054 2092 COPY
                    TO C 231 - 240
4056 2094
          COPY
         Q.ECL.OR TO C 410 - 410 ,C 412 ,C 415
4060 2096
                 FROM C 240 - 240
4064 2100
          A -ONE
                   TO T 381 - 381 , T 383 , T 386
         A -ONE
4066 2102
                    FROM C 239 - 239
          A -ONE
4072 2106
4074 2108 A-ONE
                   TO T 385 - 385 , T 387
                    FROM T 238 - 238 , T 237 , T 236 , T 235
4077 2111 COPY
T 234 T 233 T 232 T 231
                    TO T 389 - 396
4110 2120 COPY
                    FROM T 233 - 234 ,T 511 ,T 233 ,T 232
           COPY
4112 2122
, T 231
           COPY
                    TO T 419 - 433
4120 2128
                    FROM T 457 - 466
4122 2130
           COPY
                    TO T 281 - 290
          COPY
4124 2132
                    FROM T 467 - 473
          COPY
4126 2134
                    TO T 291 - 297
          COPY
4130 2136
          ROM ADR. TO T 499 - 510 , STORE ROM ADR: 2139
4132 2138
           ROM ADR. FROM T 255 - 266
4134 2140
                      GO TO 390 RTN 2142
```

```
FROM T 234 - 234 ,T 232 ,T 231
            COPY
4136 2142
           COPY
                     TO T 419 - 421
4142 2146
                         T 499 - 510 , STORE ROM ADR: 2149
4144 2148
            ROM ADR.
                     TO
4146 2150
                     FROM T 255 - 266
           ROM ADR.
                       GO TO 390 RTN 2152
         -(2152-2191) MULTIPLIER PROGRAMMABLE
         -THRU 448
                          -455
4150 2152
           COPY
                     FROM T 381 - 390
4152 2154
            COPY
                     TO T 231 - 240
4154 2156
            COPY
                     FROM T 391 - 399
4156 2158
           COPY
                          T 241 ~ 249
           Q.ECL.OR TO
                          T 381 - 404
4160 2160
                     FROM T 448 - 451
4162 2162
           A -ONE
                     TO
                          T 448
                                - 451
4164 2164
           A -ONE
                     FROM T 452 - 456
4167 2167
           A -ONE
4171 2169
           A -ONE
                     TO
                         T 452 - 455
                     FROM T 448 - 455
4173 2171
           OR
                     TO T 500 - 500
4175 2173
           OR
                     FROM C 500 - 500
4177 2175
           A -ONE
                                       ,C 501 ,C 502 ,T 503
                     TO T 502 - 507
           A -ONE
4201 2177
                    FROM T 231 - 240
           COPY
42062182
                         T 410 - 419
           COPY
                     TO
4210 2184
                     FROM T 241 - 249
4212 2186
            COPY
                     TO T 420 - 433
4214 2188
            COPY
            ROM ADR. FROM T 255 - 266
4216 2190
                        GO TO 390 RTN 2162
                       GO TO 2192
            ROM ADR. FROM T 267 - 278
4220 2192
                        GO TO 2330
                        GO TO 2338
                       GO TO 2346
         -(2194-2328) READ SET UP DATA FROM D/A
                         - | + |
         -SELECTS ONE OF
         -REPLACE NON CONTINUOUS OPPOSITE I WITH O
           COPY
                     FROM T 381 - 390
4222 2194
                     TO T 465 - 474
4224 2196
           COPY
                     FROM T 395 - 402
4226 2198
           COPY
                     TO T 479 - 486
4230 2200
            COPY
                     FROM T 425 - 430
4232 2202
            COPY
                         T 457 - 463
4234 2204
            COPY
                     TO
                     FROM T 493 - 497
4236 2206
            COPY
4240 2208
            COPY
                     TO
                         C 289 - 293
4242 2210
           DECODER
                     TO
                          T 379 - 390 ,C 391 ,C 287
                          T 499 - 510 ,STORE ROM ADR: 2215
4246 2214
            ROM ADR.
                     TO
4250 2216
            ROM ADR.
                     FROM T 380 - 391
                       GO TO 2048 RTN 2218
                         T 290 - 301
4252 2218
           DECODER TO
4254 2220
           CONSTANT TO
                         T 214 - 215
         ( 70 ) TO T 216 - 223
4257 2223
                     FROM T 392 - 392 , T 406 , C 406
           QUAD OR
4263 2227
           QUAD OR
                          T 406 - 406 , T 464
                    TO
           Q.ECL.OR FROM C 406 - 406 , T 394
4266 2230
4271 2233
           Q.ECL.OR TO
                         T 394 - 394
```



```
4273 2235
               DECODER
                        FROM C 392 - 393
   4275 2237
                        TO T 388 - 390
               DECODER
   4277 2239
                        FROM T 392 - 394
              DECODER
   4301 2241
               DECODER
                       TO T 381 - 387
   4303 2243
               AND OR
                        FROM T 407 - 407
                                         T 383 T 387 T 387
   4310 2248
               AND OR
                       TO T 386 - 386
   4312 2250
                        FROM C 404 - 404 ,T 381 ,T 385 ,T 385
               AND OR
   4317 2255
                       TO T 385 - 385
              AND OR
                       FROM T 385 - 386 ,T 385 ,T 390
   4321 2257
              QUAD OR
   4325 2261
              QUAD OR
                       TO T 432 - 433 , C 431
                        FROM T 432 - 433 ,T 388
   4330 2264
              OR
   4333 2267
              OR
                        TO
                            C 434 - 434
   4335 2269
              NOP
   4336 2270
              ROM ADR. TO T 499 - 510 , STORE ROM ADR: 2271
   4340 2272
              ROM ADR. FROM T 212 - 223
                          GO TO 896 RTN 2274
   4342 2274
              CONSTANT TO T 253 - 254
           ( 206 ) TO T 255 - 262
            ( 241 ) TO T 263 - 270
            ( 221 ) TO T 271 - 278
   4347 2279
                       FROM T 408 - 408 , T 386 , C 405 , T 385
             AND OR
   4354 2284
              AND OR
                       TO T 271 - 271
   4356 2286
              DECODER FROM C 392 - 392 ,T 241 ,T 271
   4362 2290
              DECODER TO T 448 - 449
   4364 2292
              DECODER FROM C 241 - 241 ,T 271
              DECODER TO T 450 - 452 ,C 270
   4367 2295
   4372 2298
              QUAD OR FROM T 271 - 271 ,T 392 ,T 271 ,T 392
   4377 2303
              QUAD OR TO
                            C 271 - 271 ,T 272
   4402 2306
              Q.ECL.OR TO
                            T 451 - 455
              AND OR FROM C 392 - 392 ,T 241 ,C 270 ,C 270
   4404 2308
   4411 2313
              AND OR
                      TO
                           T 452 - 452
   4413 2315
              Q.ECL.OR TO
                            T 381 - 404
   4415 2317
              Q.ECL.OR TO
                           T 410 - 428
   4417 2319
             CONSTANT TO T 499 - 500
           ( 13 ) TO T 501 ~ 508
   4422 2322
                       FROM T 502 - 505 , T 230
              A + B
   4425 2325
              A + B
                       TO T 502 - 505
4427 2327
              ROM ADR, FROM T 499 - 510
                          GO TO 2092
                          GO TO 2100
            -4 BIT SHIFT REGISTER
            -DIV 10 EACH
            -4 BIT SHIFT REGISTER
            -DIV 10
            -DIV 1
  4432 2330
              COPY
                       FROM T 385 - 394
  4434 2332
              COPY
                       TO T 381 - 390
  4436 2334
              COPY
                       FROM T 395 - 404
  4440 2336
              COPY
                       TO
                           T 391 - 404
  4442 2338
                       FROM T 385 - 394
              COPY
  4444 2340
              COPY
                       TO T 381 - 390
  4446 2342
              COPY
                       FROM T 395 - 404
  4450 2344
              COPY
                       TO T 391 - 404
  4452 2346
              COPY
                       FROM C 281 - 287
  4454 2348
              COPY
                       TO
                           C 500 - 507
```

```
4456 2350 ROM ADR. FROM T 212 - 223
                      GO TO 512 RTN 2364
                                    2376
                                    2414
        -(2352-2522) STATE AND V.I.
        -PIN SET UP PRINT OUT
4460 2352 CONSTANT TO T 413 - 414
        ( 64 ) TO T 415 - 422
        ( 161 ) TO T 423 - 430
4464 2356 COPY FROM T 511 - 511 ,T 511 ,C 492
4470 2360
          COPY
                    TO T 392 - 394
         ROM ADR. FROM T 416 - 427
4472 2362
                     GO TO 2202 READ IN -1 RTN 2364
4474 2364
                    FROM T 391 - 394 ,T 492
           COPY
                    TO T 475 - 478 , T 394
4477 2367
          COPY
          DECODER TO C 392 - 393
4502 2370
4504 2372 CONSTANT TO T 413 - 414
        ( 111 ) TO T 415 - 422
        ( 214 ) TO T 423 - 430
4510 2376 ROM ADR. FROM T 414 - 425
                      GO TO 2194 READ IN +1 RTN 2378
4512 2378
          COPY
                    FROM T 289 - 297
4514 2380
           COPY
                    TO C 410 - 418
4516 2382
           COPY
                    FROM T 474 - 476
                    TO C 419 - 421
4520 2384
           COPY
                    FROM T 477 - 486
4522 2386
          COPY
                    TO C 422 - 433
4524 2388
          COPY
4526 2390 CONSTANT TO T 228 - 229
       ( 204 ) TO T 230 - 237
        ( 1 ) TO T 238 - 245
4532 2394 ROM ADR. TO T 499 - 510 , STORE ROM ADR: 2395
4534 2396 ROM ADR. FROM T 230 - 241
                      GO. TO 388
        -GO TO DEC SUBTRACT
                -(+1) (-1)
                 FROM T 391 - 394 ,T 434 ,T 492
TO T 475 - 478 ,T 491 ,T 393 ,C 392 ,T
4536 2398
          COPY
4542 2402
          COPY
         CONSTANT TO T 413 - 414
4550 2408
       ( 111 ) TO T 415 - 422
        ( 324 ) TO T 423 - 430
4554 2412 ROM ADR. FROM T 414 - 425
                      GO TO 2194 READ + OR - V
                    FROM T 289 - 297
4556 2414
          COPY
4560 2416
          COPY
                    TO T 465 - 473
4562 2418
                    FROM T 397 - 403 ,C 230
          COPY
4565 2421
          COPY
                    TO T 401 - 408
4567 2423
          NOP
4570 2424
          CONSTANT TO T 417 - 418
    ( 224 ) TO T 419 - 426
       ( 364 ) TO T 427 - 434
4574 2428 ROM ADR. TO T 499 - 510 .STORE ROM ADR: 2429
4576 2430 ROM ADR. FROM T 417 - 428
                      GO TO 592 LOAD BLANK IN PRINT OUT FIELD
```

```
TO C 397 - 400 , T 301 , C 294
4600 2432
           DECODER
           DECODER FROM T 351 - 351 ,C 204
4604 2436
4607 2439
           DECODER TO T 409 - 410
4611 2441
           CONSTANT TO C 500 - 501
         ( 275 ) TO C 502 - 509
           ROM ADR. TO T 412 - 423 , STORE ROM ADR: 2445
4614 2444
4616 2446
           ROM ADR. FROM T 212 - 223
                       GO TO 512 THEN 2586 RTN 2448
                                 (FORMAT FOR V PRINTOUT)
4620 2448
           COPY
                    FROM C 465 - 474
4622 2450
           COPY
                    TO C 381 - 396 , C 235 , C 294
4626 2454
           NOP
                    FROM T 475 - 476 .C 491 ,T 410
4627 2455
           COPY
                    TO T 391 - 392 ,T 408 ,T 409 ,T 393
4633 2459
           COPY
                    FROM T 477 - 486
4640 2464
           COPY
4642 2466
           COPY
                    TO
                        T 397 - 407
4644 2468
           DECODER TO
                         T 429 - 430 , T 277
4647 2471
           CONSTANT TO C 500 - 501
         ( 275 ) TO C 502 - 509
4652 2474
           ROM ADR. TO T 412 - 423 ,STORE ROM ADR: 2475
4654 2476
           ROM ADR. FROM T 212 - 223
                       GO TO 512 THEN 2586(FORMAT FOR I PRINTOUT)
            -(2478-2496) FORMAT FOR I PRINTER
         -CONVERT PIN NUMBER FROM B INTO DECIMAL
         -USING DECIMAL ADDER
                    FROM T 435 - 439
4656 2478
          COPY
                     TO T 381 - 404
4660 2480
           COPY
4662 2482
           COPY
                    FROM T 439 - 439 ,T 439
                   TO T 411 - 433 ,C 410
4665 2485
          COPY
                  TO T 291 - 295
4670 2488
          A -ONE
4672 2490 CONSTANT TO T 462 - 463
        ( 206 ) TO T 464 -471
        (1) TO T 472 - 479
4771111
        ( 1 ) TO T 472 - 479
4676 2494 ROM ADR. TO T 499 - 510 ,STORE ROM ADR: 2495
4700 2496 ROM ADR. FROM T 464 - 475
                       GO TO 390
         -CONVERT DECIMAL TO 6 BIT ASCII
         -SURPRESS LEADING ZERO SET UP 'I'
4702 2498
           COPY
                    FROM T 381 - 386
4704 2500
           COPY
                    TO T 338 - 341 ,T 344 ,T 345 ,C 342
                    FROM T 344 - 347
4711 2505
           OR
                    TO T 348 - 348
4713 2507
           OR
4715 2509
           A -ONE
                    TO T 236 - 241 , T 237 , C 230 , T 293
4722 2514
           COPY
                    FROM T 440 - 446
4724 2516
           COPY
                    TO T 500 - 507 , C 508 , C 391 , C 203
4731 2521
           ROM ADR. FROM T 212 - 223
                       GO TO 512
4734 2524
           Q.ECL.OR TO C 326 - 349
4736 2526
          PIN DRV TO T 319 - 349
4740 2528 CONSTANT TO C 500 - 501
        ( 210 ) TO C 502 - 509
```

4744 2532 4746 2534 4750 2536 4753 2539 4756 2542 4762 2546 4766 2550 4770 2552 4772 2554 4775 2557 4777 2559 5001 2561 5003 2563	NOP -(2532-2564) -PRINT OUT COPY COPY A -ONE A -ONE COPY COPY COPY COPY COPY COPY COPY A -ONE A -ONE A -ONE A -ONE A -ONE A -ONE A -ONE	FROM TO FROM TO FROM TO FROM TO FROM TO FROM	C 49 C 31 T 32 T 32 T 32 T 33 T 33 T 34 T 34 C 223 T 213 T 213 T 213	3 - 9 - 9 - 9 - 9 - 9 - 9 - 9 - 9 - 9 -	DATA  - 497 - 324 - 323 - 329 - 340 - 339 - 349 - 223 - 223	, T , T , T	319	3 9 , 1 9 , 7	T 223 T 215		
5006 2566 5011 2569 5013 2571 5015 2573 5020 2576 5024 2580 .C 430	DECODER DECODER DECODER DECODER COPY COPY	FROM TO FROM TO FROM TO	C 408 T 381 T 408 C 383 T 408 T 381	-	4 0 9 3 8 2 4 0 9 3 8 4 4 0 8 3 8 1	, T , T	203 294 383 384	, C	408 429	, Т	408
5032 2586 5034 2588 5036 2590 5040 2592 5042 2594 5044 2596 5046 2598 5050 2600 5052 2602 5056 2606	-(2586-2663) -1ST PASS V -2ND PASS I COPY COPY COPY COPY COPY COPY COPY COPY	TRUNCA:	TE AND	JU 	PRII STIFY 384 293 394 390 404 400 407 407 292 428		293	, т	290		
5060 2608 ,C 412 5066 2614 5070 2616 5073 2619 5075 2621 5100 2624 5102 2626 5104 2628 5106 2630 5110 2632 5112 2634	AND OR  AND OR  OR  AND OR  AND OR  AND OR  OR  OR  OR  OR  OR  OR  OR  OR  OR	TO FROM TO FROM TO FROM TO TO TO TO FROM	C 412 T 396 T 412 T 428 C 294 T 381 T 427 C 219 T 499 T 212 TO 89		428 412 402 412 430 294 388 427 220	, т , с	294 412 294		294 ADR:		412
5114 2636 5121 2641 5123 2643	OR OR COPY	TO	T 390 T 503 T 502				427 337		428	, C	

```
5374 2812
           DECODER TO T 379 - 390
           ROM ADR. TO T 499 - 510 , STORE ROM ADR: 2815
5376 2814
          ROM ADR. FROM T 380 - 391
5400 2816
                      GO TO 2048
         -LOGIC TO CONTROL V OR I
         -MANIPULATION AND RETURN CONTROL
5402 2818 CONSTANT TO T 460 - 461
        ( 200 ) TO T 462 - 469
         ( 243 ) TO T 470 - 477
         (56) TO T 478 - 485
                   FROM C 204 - 204 , T 376
          AND OR
5407 2823
          AND OR
                   TO
                        T 505 - 505
5412 2826
                    TO C 499 - 504 , C 414
5414 2828
          A -ONE
           Q.ECL.OR FROM T 351 - 351 , T 461
5417 2831
                       T 378 - 390 ,C 431
           Q.ECL.OR TO
5422 2834
                   FROM C 406 - 406 , T 351
5425 2837
           AND OR
                   TO T 440 - 446
5430 2840
           AND OR
           Q.ECL.OR FROM C 509 - 511 ,T 351 ,T 492 ,T 440
5432 2842
           Q.ECL.OR TO C 441 - 445
5437 2847
                    FROM T 493 - 497 ,C 406 ,T 204 ,T 505
5441 2849
           COPY
T 351
                    TO C 289 - 293 , T 288 , C 500 , C 507
5447 2855
           COPY
T 376 ,C 465
                    FROM T 442 - 444
5456 2862
           COPY
5460 2864
                    TO T 432 - 434
           COPY
           ROM ADR. FROM T 380 - 391
5462 2866
                       GO TO 2048 BTN 2678 FINISHED PIN INFO PRINTOUT
                                  RTN 2870 GO TO VI TWEEK
                                  RTN 2868 TERMINATE PRINTOUT
           ROM ADR. FROM T 461 - 472
5464 2868
                       GO TO 1808
           Q.ECL.OR TO T 465 - 465
5466 2870
           ROM ADR. FROM T 462 - 473
5470 2872
                       GO TO 896 SELECT REF LEVEL TO BE ADJUSTED
                    FROM T 442 - 444 ,C 278
           AND OR
5472 2874
                   TO T 417 - 417
           AND OR
5475 2877
           Q.ECL.OR FROM T 378 - 378 , T 492
5477 2879
           Q.ECL.OR TO C 418 - 420 ,T 419 ,T 434
5502 2882
           ROM ADR. TO T 499 - 510 , STORE ROM ADR: 2887
5506 2886
           ROM ADR. FROM T 474 - 485
5510 2888
                       GO TO 746 (A+/-1) (A+/-16) B
         -(2890-2833) PRESET RANGE LIMITS
           DECODER FROM C 442 - 442
5512 2890
           DECODER TO C 502 - 504 ,C 416
5514 2892
5517 2895
           NOP
           Q.ECL.OR FROM C 415 - 418 ,T 289
5520 2896
          Q.ECL.OR TO T 431 - 433
5523 2899
                        T 228 - 229
           CONSTANT TO
5525 2901
         ( 175 ) TO T 230 - 237
         (31 ) TO T 238 - 245
         ( 126 ) TO T 246 - 253
         ( 103 ) TO T 254 - 261
         ( 22 ) TO T 262 - 269
         ( 0 ) TO T 270 - 277
```

```
5535 2909 CONSTANT TO T 300 - 301
        ( 175 ) TO T 302 - 309
         (21 ) TO T 310 - 317
         ( 126 ) TO T 318 - 325
         ( 203 ) TO T 326 - 333
         (23) TO T 334 - 341
         ( 276 ) TO T 342 - 349
          AND OR FROM C 441 - 443 ,T 408 ,T 443 ,C 405
5545 2917
5552 2922 AND OR
                    TO T 434 - 434
5554 2924 ROM ADR. FROM T 212 - 223
                       GO TO 512 THEN 2926 SPECIAL V SET -UP
                                  RTN 2934
5556 2926 CONSTANT TO C 306 - 307
        ( 261 ) TO C 308 - 315
         ( 105 ) TO C 316 - 323
        ( 22 ) TO C 324 - 331
5563 2931 DECODER TO T 303 - 304 ,T 338
5566 2934 Q.ECL.OR FROM T 432 - 434 ,T 433 ,C 418
5572 2938
         Q.ECL.OR TO C 429 - 430 ,C 203
5575 2941
         QUAD OR FROM C 429 - 432
           QUAD OR TO T 448 - 448 , T 418 , T 420 , C 441
5577 2943
           ROM ADR. TO T 499 - 510 , STORE ROM ADR: 2949
5604 2948
           ROM ADR. FROM T 462 - 473
5606 2950
                      GO TO 896 SELECT CORRECT RANGE LIMIT
5610 2952
           Q.ECL.OR TO T 433 - 433
5612 2954
           ROM ADR. FROM T 474 - 485
                      GO TO 746 COMPARE (A+B), (A-B) A
         -(2956-2975) COMPARE RANGE LIMIT
         -WITH ADJUST V OR I
5614 2956
           DECODER TO T 431 - 434
5616 2958
           Q.ECL.OR FROM T 284 - 284 , C 418 , T 430 , C 418
.C 418
5624 2964
           Q.ECL.OR TO C 449 - 449 ,C 416 ,T 433
           ROM ADR. TO T 499 - 510 , STORE ROM ADR: 2969
5630 2968
           ROM ADR. FROM T 462 - 473
5632 2970
                      GO TO 896 RTN 2972
5634 972
          Q.ECL.OR TO T 414 - 414
           ROM ADR. FROM T 462 - 473
5636 2974
                      GO TO 896 RTN 2976
           DECODER FROM T 448 - 449 , T 416
5640 2976
5643 2979
           DECODER
                   TO T 204 - 204 , C 434
5646 2982
           COPY
                    FROM T 392 - 392
5650 2984
           COPY
                    TO C 419 - 420
5652 2986
           ROM ADR. TO T 499 - 510
                                     ,STORE ROM ADR: 2987
5654 2988
           ROM ADR. FROM T 474 - 485
                      GO TO 746 PRESET B,A,AB
5656 2990
           COPY
                    FROM T 441 - 444 , T 434 , T 416
5662 2994
           COPY
                    TO T 431 - 434 , T 444 , C 222
5666 2998
          DECODER FROM T 443 - 444 ,C 289
5671 3001
          DECODER TO T 419 - 420
5673 3003
          Q.ECL.OR TO C 236 - 243
```

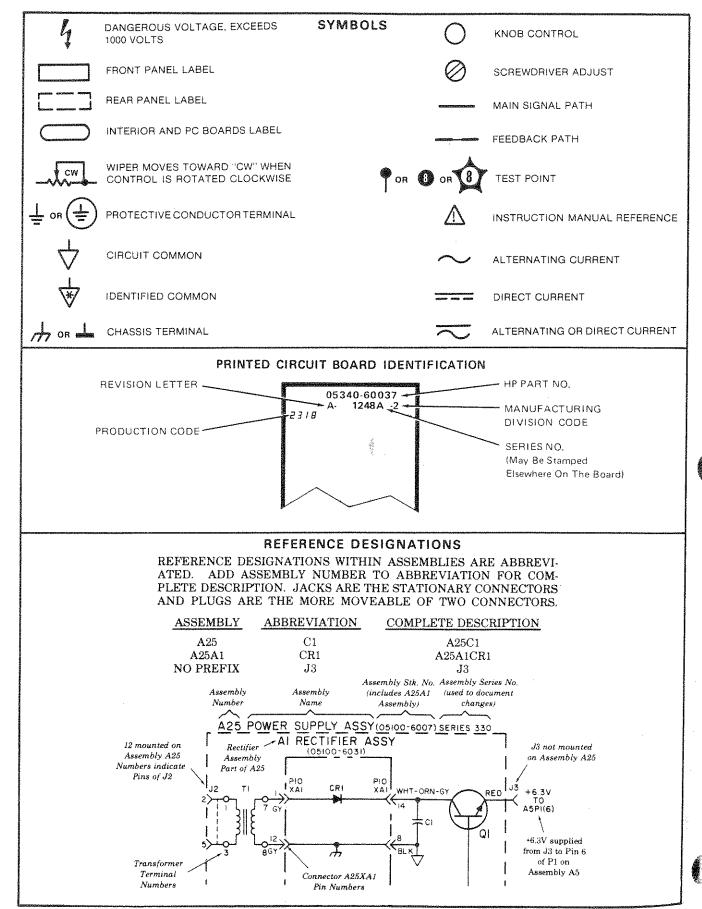


Figure 8-9. Schematic Diagram Notes

8-164. The two main program sources (ROM and Main Memory) control the flow of serial data to and from those blocks located on the left of the block diagram. For example, data needed to test an IC can flow from the Magnetic Card Reader through the RAM where it is formatted and routed to the Main Memory. It can then be sent, via the RAM, to the ALU (Arithmetic Unit), which helps simulate, for reference purposes, the IC under test. Other data passes to the Reference Voltage Generator and Control block. This block converts the data from a binary code into four lines of reference levels that are strobed to the Pin Drivers. The Pin Drivers are responsible for driving the test socket pins with the correct voltages and currents.

#### 8-165. The Memories

8-166. Of major importance are the three memories that control the tester's operation. These are the ROM, the Main Memory, and the RAM. These memories are described in the following paragraphs.

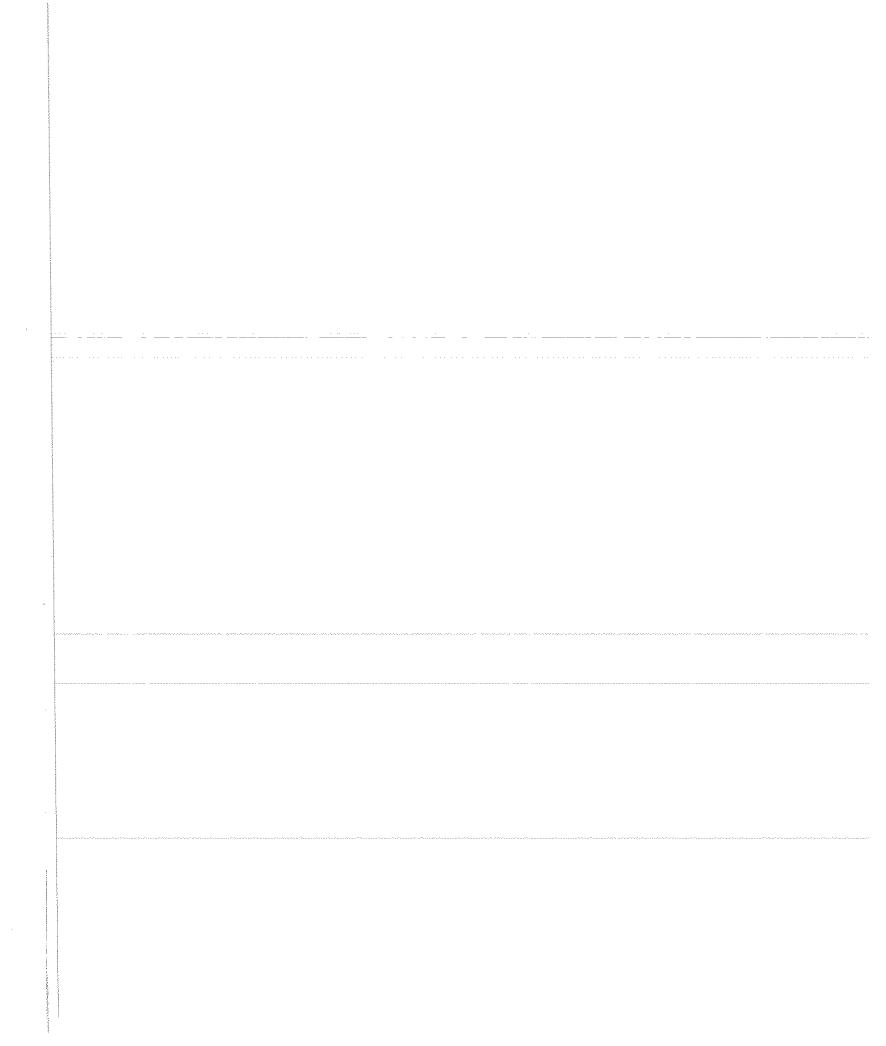
**8-167. THE ROM.** The ROM (Read Only Memory) contains 36,864 bits (3072 x 12) of fixed information. This memory stores the tester's basic operating routine. It allows the tester to follow a given procedure but with the ability to vary its algorithm in accordance with the result of the completed operation and the front panel switch positions. It can also relinquish control to other portions of the tester (e.g., the Main Memory). The ROM controls the tester's operation by way 12 Program Control lines (described later).

8-168. Notice that selection of the ROM program codes (12 lines) is controlled by the ROM Address Register. The Address Register provides 12 address lines to the ROM that enable specific locations (or addresses) within the ROM. The ROM will then output the data contained in the addressed location. The address code can be sequentially advanced by pulsing the Program Advance line, or it can be radically changed (as in a "go-to" statement by enabling the Transfer line and serially clocking in a new address from the RAM. (It must be noted that any information contained in the RAM originated from some other source.) The 11th and 12th lines from the ROM Address Register control whether the program source is the ROM or the Main Memory when both lines are true (11).

**8-169. THE MAIN MEMORY.** The Main Memory contains up to 6144 bits of information that is taken from the magnetic program card. Therefore, this memory contains information pertaining to the testing of a specific IC plus the PASS/FAIL count. Basically, there are four types of information stored in this memory:

- 1. Header information, which is the IC number and the type of test (pass/fail or diagnostic).
- 2. The Setup Data for the IC to be tested, i.e., the codes for the voltages and currents that will be applied to the IC under test.
- 3. The Logic Model program, i.e., the information that will simulate a logic function and generate a stimulus to that function. This produces a reference to which the device under test can be compared.
- 4. The Test Sequence information. This combines 2 and 3 into a specific test. Also, the Main Memory initially stores the check-sum number at the end of the card. If the number of bits transferred from the card agrees with this number, the number is replaced with Pass/Fail storage locations, i.e., locations that hold numbers representing the number of IC's that passed or failed their tests. If the check-sum number does not agree with the counted bits from the card, the word "RELOAD" is printed out.

8-170. These four types of information are serially transferred from the magnetic program card (three bits at a time) and stored in the Main Memory in words that are 24 bits long. Once all the information is stored, it can be removed serially as data to the RAM or as parallel 12-bit words to the Program Control lines.



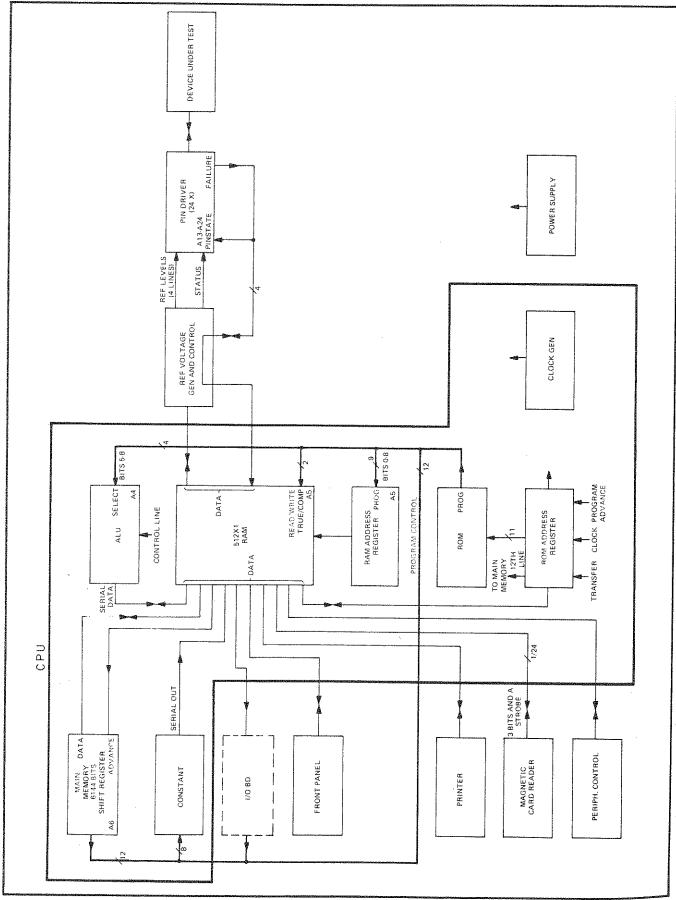


Figure 8-10. Simplified Block Diagram

- 8-171. During the testing of an IC, the ROM relinquishes program control to the Main Memory's logic Model program. This allows the tester to *simulate* the device under test (a model) and to apply a stimulus pattern to the model. This information is then stored in the RAM for access by the ROM program and is-then applied to the actual device under test.
- **8-172. THE RAM.** As previously mentioned, any exchange of data between blocks is accomplished serially and by way of the RAM. The storage capacity of this device is 512 bits long by one-bit wide (512 x 1); expressed differently, there are 512 data locations, each having the capacity of storing one bit of data. This data is stored and retrieved by addressing the RAM Address Register with the nine least-significant bits of the Program Control lines. This method is referred to as presetting. Once preset, however, the address code can be sequentially advanced by clocking the register (for example, if the data word is more than one-bit long). Although described later in more detail, it should be noted that before the RAM is addressed with a RAM Address code, the Processor Memory must first receive another 12-bit code that designates certain operations and functions to be performed within the tester.
- 8-173. Included in this first code is the number of data bits to be automatically transferred to or from the RAM. The subsequent RAM Address code specifies the starting location (presetting) after which, the addresses are automatically and sequentially stepped through until the specified number of bits have been transferred. At this point, additional RAM Address codes may be used to address individual locations within the RAM, one at a time and at specified locations. The tester, however, is still under control of the first 12-bit word that specifies the transmitter or receiver of data.
- 8-174. Figure 8-11 shows the RAM and the particular blocks associated with data transfer. Note that some blocks are strictly senders of data, while others are receivers of data, and still others are bidirectional. Again, none of the blocks can exchange data directly between themselves data must go from one block, through the RAM and then to the second block.
- 8-175. THE ALU. The block located immediately above the RAM (Figure 8-10) represents the tester's ALU (Arithmetic Logic Unit). The ALU functions as a decision-making block as the CPU steps through its algorithm. It also serves as a logic model simulator. This section, which can be viewed as a group of "building blocks", performs either logic functions or arithmetic operations, as determined by a control line. Once the operating mode has been established, four of the Program Control lines (bits 5-8) select the actual function to be performed. For example, assume the control line has chosen a Logic Function operation. The four-line code, then must select the specific function to be performed for example, an eight input OR gate, an Exclusive OR, or perhaps a D type flip-flop. Selection of the logic function is in accordance with the device under test and is accomplished by arranging the "building blocks" so they can simulate a logic function.
- 8-176. Input data is needed, however, for the ALU to actually perform an operation. If no input data is specified, the data inputs are initialized to zero. In the case of the eight-input OR gate, assume that one of the input pins is in the "1" state. The output, then, is also a "1".
- 8-177. Notice that this setup data (i.e., the stimulus for the model) enters the ALU serially it is internally converted to parallel and placed across the OR gate's inputs. The resultant data (the "1" state output from the model OR gate) uses this same block diagram line when it is sent to the RAM for storage.
- 8-178. Each of the first 24 bits in the RAM contains one bit of information that relates to the same pin of the device under test, e.g., RAM address 6 relates to pin 6 of the device. These first 24 bits select the appropriate logic state applied to the device. The logic states are stored in each pin driver and will be described later. The "1" state output of the OR logic model, then, takes its proper place in the RAM to help determine what the device's output should be.

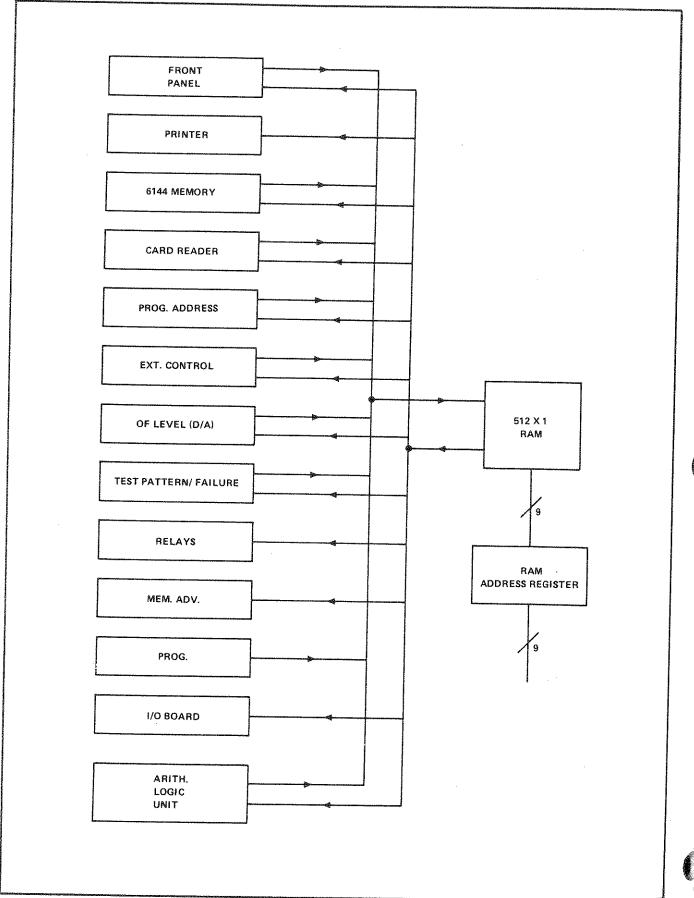


Figure 8-11. Serial Bus Data Flow

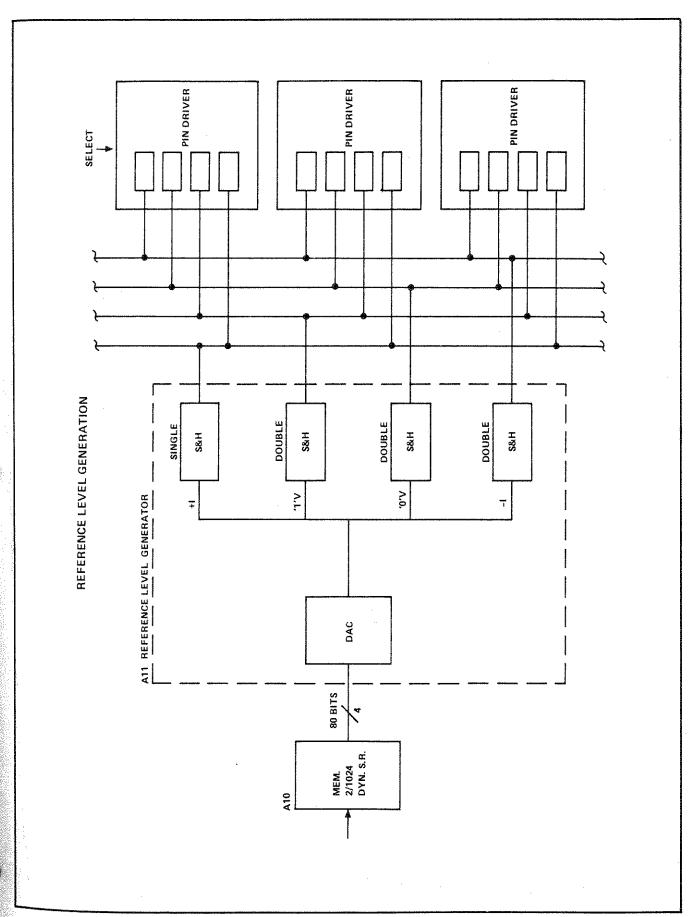


Figure 8-12. Reference Level Generation

### 8-179. Reference Voltages and Pin Drivers

8-180. The upper right portion of the Block Diagram depicts the Refrence Voltage Generator and Control section, along with the Pin Drivers, which drive the Device Under Test. Refer to Figure 8-12, which diagrams these sections in greater detail.

8-181. The memory shown on the left is the Reference Level Storage (RLS) Memory, located on the A10 board. This memory stores setup data that was originally stored on the magnetic program card. The data was accessed by the Card Reader, fed through the RAM, and stored in the Main Memory in the form of 24-bit words. The data is then serially transferred in 24-bit words from the Main Memory and into the RAM, where the data is reconfigured under control of the ROM program. The data is then fed into the Reference Level Storage Memory. A 12-bit Set-up Data word enters the Digital-to-Analog Converter (DAC) in a specific manner: the first four most-significant bits enter the DAC in parallel, followed by the remaining eight bits which, are sent in four 2-bit parallel transfers. This method of transfer allows faster settling time in the DAC than if all data were transferred serially.

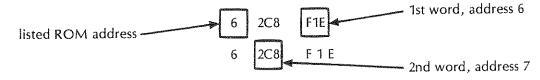
8-182. The DAC converts 11 bits of the 12-bit Setup Data word into a voltage, where upon it is clocked into a Sample and Hold (S&H) circuit (the 12th bit is used to control the range). Once done, the DAC converts the next 12-bit word into a voltage and stores that in the next S&H circuit. This process continues until all four storage circuits are filled (bottom to top), at which time the four voltages are strobed into four other S&H circuits located on the Pin Driver board. There are 12 Pin Driver boards available. Each board contains two "Pin Drivers". The first board drives pins 1 and 2 of the Device Under Test; the second board drives pins 3 and 4, etc., therefore, 12 boards for a 24-pin device.

8-183. This process of transferring data to the DAC, strobing the resultant voltages into Sample and Hold circuits, and transferring that information into the Pin Driver S&H circuits continues until all Pin Drivers contain the required information. This is a continuous operation. At the same time that each pin driver is having its reference levels strobed in, five select lines (also have the RLS memory) strobe that particular pin driver with information that controls certain functions on the Pin Driver boards. For example, to configure the pin driver circuits so they function as an input or an output. Refer to Figures 8-17 and 8-18.

8-184. In addition to the four reference levels and the five control lines, each pin driver must be given logic state information; i.e., is the pin driver's output going to be a logic "1" or a logic "0"? Again, this information is contained in the RAM as a 24-bit word (one bit for each pin driver). The RAM transfers this word, four bits at a time, onto another four-line bus (not the reference level bus), whereupon six strobe pulses fill all pin drivers with logic state data  $(6 \times 4 = 24)$ . Each pin driver circuit places its bit of data into temporary storage until all pin drivers have been set up. Then, another strobe line clocks all pin drivers to simultaneously change state.

### 8-185. ROM PROGRAM CONTROL THEORY

8-186. Table 8-6 lists all program words stored in the ROM. These words are listed in hexadecimal form, Table 8-7 shows the hexadecimal-to-binary conversion. The codes are grouped in a six-character format and are shown next to their respective ROM address codes. Notice, however, that the addresses are given in even numbers only. Actually, each character group contains two three-character words, with the first word being the three characters on the right-hand side and corresponding to the ROM address listed to the left. The second three-character word is on the left, and its address is the listed address plus one. For example:



8-187. Recall that all ROM information transfers onto the Program Control lines in the form of a 12-bit word. Therefore, each three-character word, shown above, translates into a 12-bit word.

8-188. There are four types of words stored in the ROM and these are shown in Table 8-8. Notice that each word is 12 bits long and that the MSB is bit 11. The three most-significant bits designate the type of word or mode of operation:

- 1. A RAM address code.
- 2. A Logic Function or Arithmetic Computation code.
- c. A Data word (specifies a location, e.g., the pin driver, for the purpose of transferring data to or from the RAM).
- 4. A space or NOP (no operation).

8-189. In every transfer of information, the sender and receiver of data must be specified. The following paragraphs offer a closer examination of these Program Control codes and how they affect the tester's operation, followed by examples of decoding some of the words found in the ROM listing.

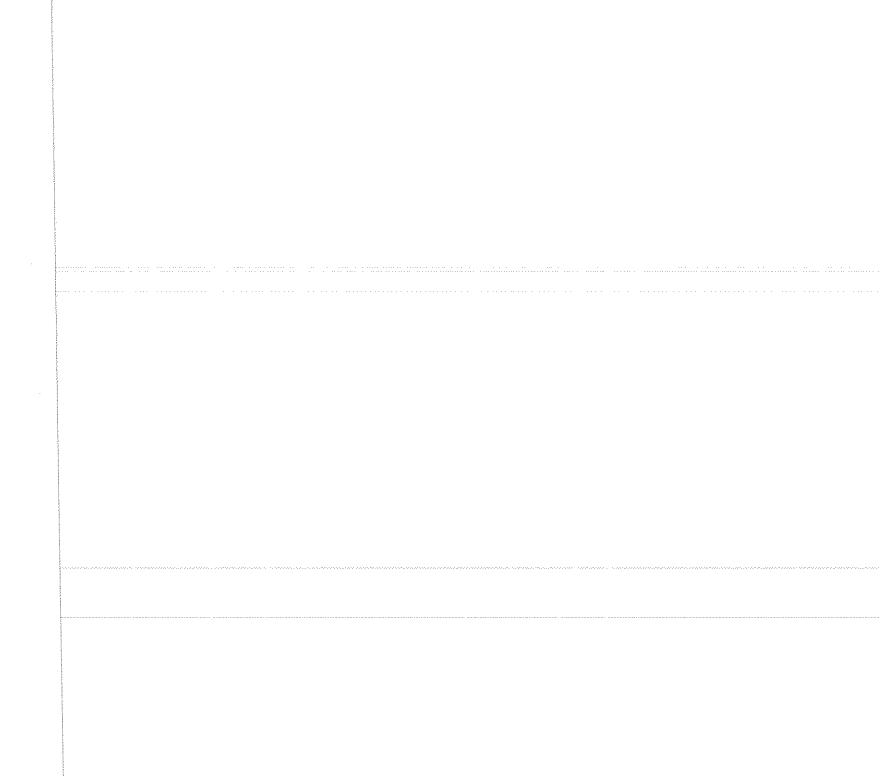


Table 8-6. Hexadecimal ROM Code List

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Table 8-6. Hexadecimal ROM Code List (Continued)

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Table 8-6. Hexadecimal ROM Code List (Continued)

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Table 8-6. Hexadecimal ROM Code List (Continued)

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Table 8-6. Hexadecimal ROM Code List (Continued)

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Table 8-6. Hexadecimal ROM Code List (Continued)

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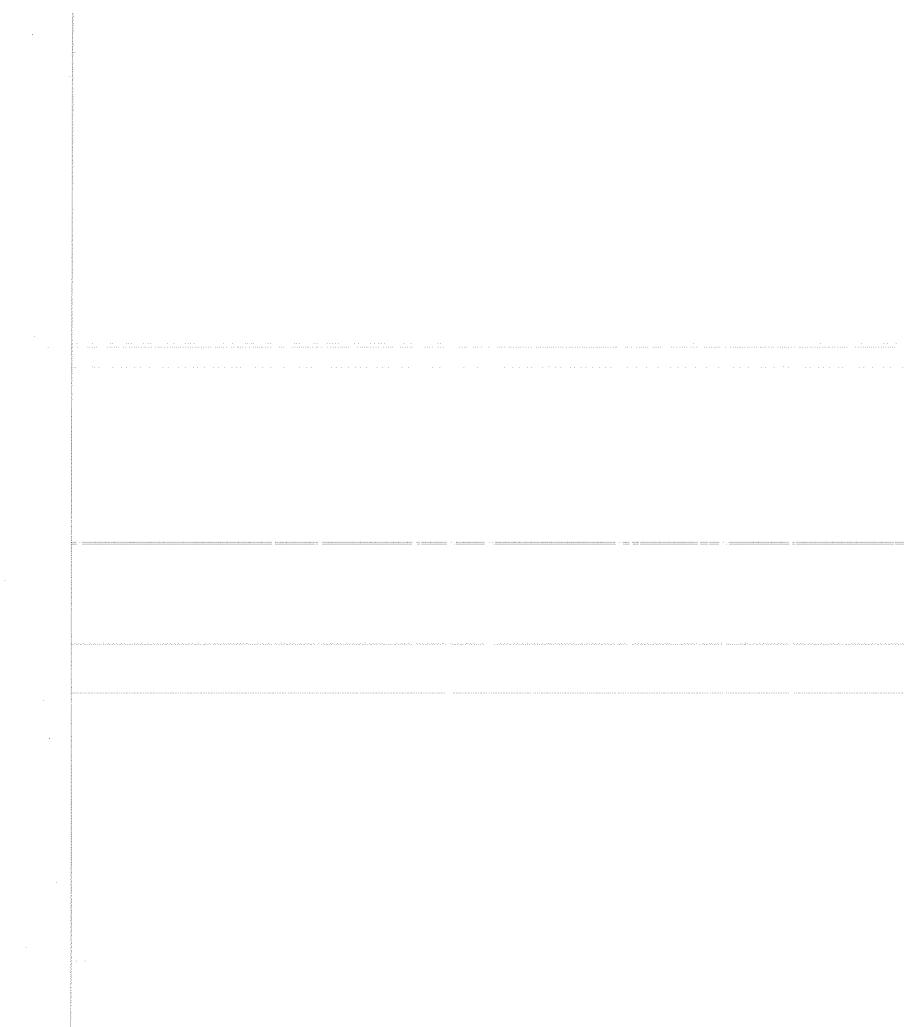


Table 8-7. Hexadecimal-to-Binary Conversion

Character	8	4	2	1
0	0	0	0	0
1	0	0	0	1
2	0	0	1	0
3	0	0	1	1
4	0	1	0	0
5	0	1	0	. 1
6	0	1	1	0
7	0	1	1	1
8	1	0	0	0
9	1	0	0	1
A	1	0	1	0
В	1	0	1	1
C	1	1	0	0
D	1	1	0	1
E	1	1	1	0
F	1	1	1	1

Table 8-8. Processor Instruction Decoder

Bit Number	RAM Address	Logic Function/ Arith Computation	Data Entry/Exit	No Op	Not Used
0 1 2 3 4	RAM	Numbe Bits in W (Take Complen	Vord e	0 0 0	Not Used
5 6 7 8	Address	↑ Op Code	Data Location Code	0 0 0 0	Not Used
9	Read/Write (0) (1)	. 0	1	0	1
10	True/Comp (1) (0)	1	1	0	0
11	0	1	1	1	1

# 8-190. Logic Function/Arithmetic Computation

8-191. As previously mentioned, the second column in Table 8-8 contains codes that represent either a Logic Function or Arithmetic Computation, i.e., a function of the ALU. Again, the first three bits (110) are responsible for selecting this column, or, rather, the mode itself. The result is that whatever serial data is subsequently exchanged will be with respect to the ALU.

8-192. The second four bits designate the op code (operation code), i.e., the specific operation to be performed. These four bits represent an octal code that corresponds to one of those found in Figure 8-13. For example, the octal number representing the AN OR Logic Function is 02. Bits 5 through 8 would contain the binary equivalent of this octal number:

0 2

0 010

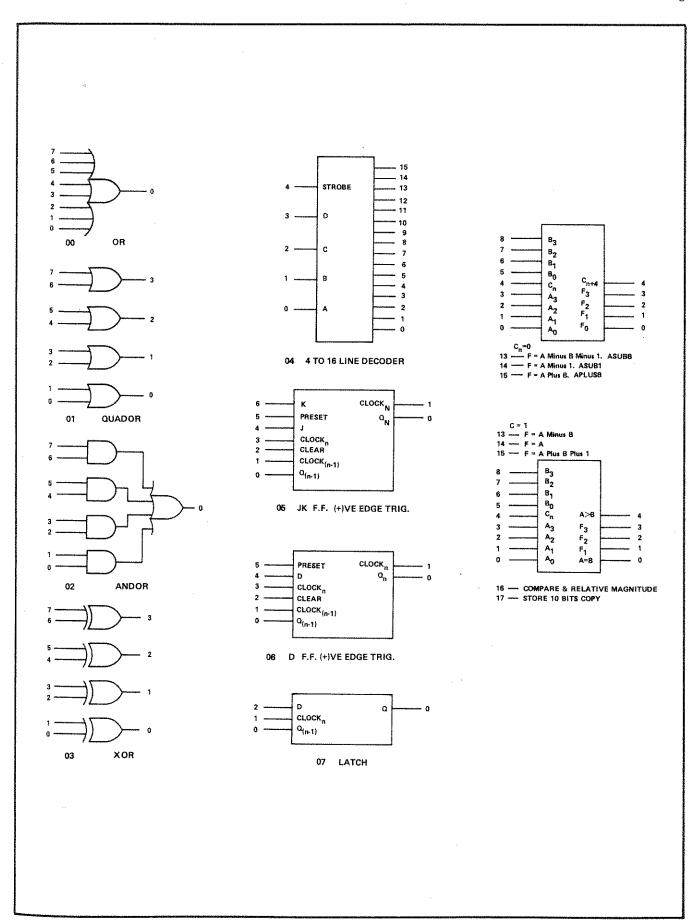
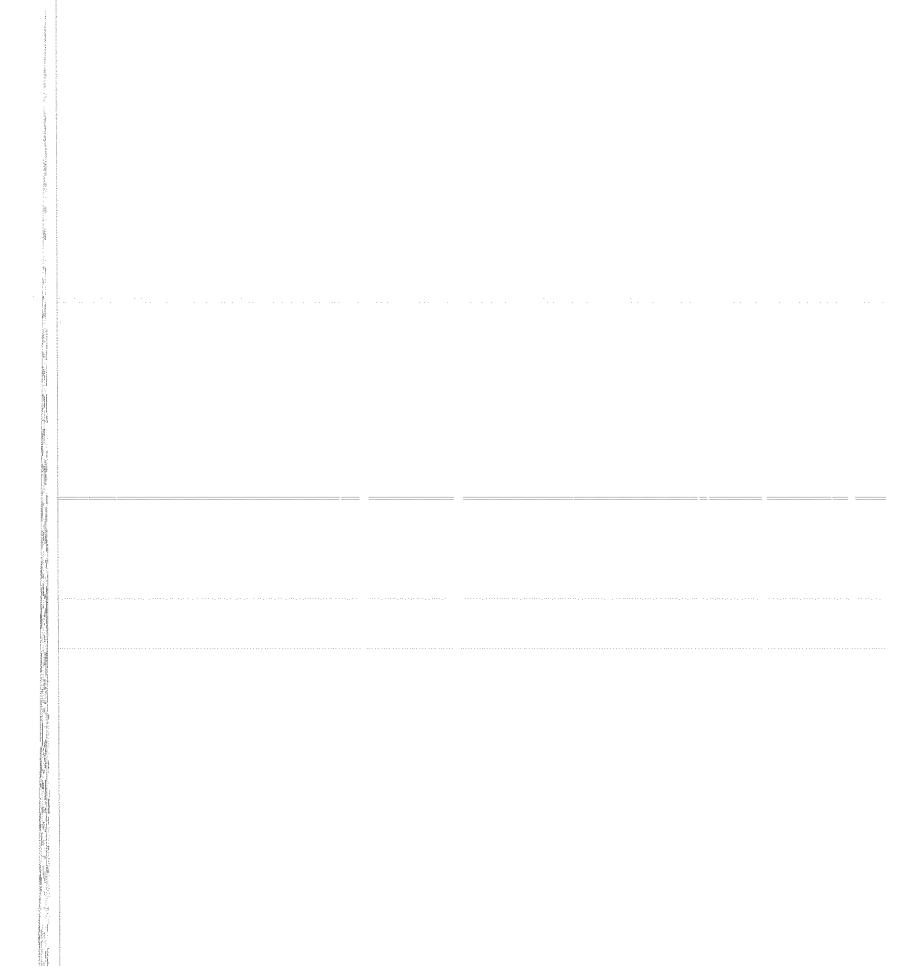


Figure 8-13. Op Code Guide



8-193. The last five bits (Bits 0-4) of the 12-bit word specifies the number of bits involved in the forthcoming data transfer. If the purpose of this transfer were to place a stimulus on the AND OR logic model, up to eight bits of information would be needed (one for each input of the model). Those inputs not specified are set to "0". To place a "1" on each input would require a binary eight; however, the binary code used in this portion of the word is always the complement of the desired number. (The tester keeps track of the number of bits transferred by storing this code into a 5-bit counter. As each bit is transferred, the counter is clocked until it overflows.) Since the

5-bit code is weighted in-binary  $\begin{pmatrix} bit - \frac{4}{16} & \frac{3}{16} & \frac{2}{16} & \frac{1}{16} & \frac$ 

word, it is easier to refer to the zeros than to perform the complement exercise.

8-194. Now that the ALU function has been selected and the number of bits involved in the transfer has been specified, another Program Control word is needed to regulate the process of transferring serial data. This word-type is found in column 1 of Table 8-8 and is called, simply, the RAM Address code.

#### 8-195. RAM Address

8-196. The MSB of the code is a "0" and is responsible for designating this word as a RAM address. The second MSB (bit number 10) determines whether or not the serial data transferring either to or from the RAM is to be complemented (inverted in state). Bit number nine specifies the direction of the transferring data: 0 = "read from the RAM", 1= "write into the RAM". The

8-197. To complete the above example, assume data is being read from the RAM and to the ALU; therefore, the RAM must already contain the information to be sent. (The result of a previous data transfer.) Also, the RAM has been addressed to its starting location by the RAM address code, which was stored in the RAM Address Register. Each time a bit of data is clocked from the RAM, the RAM Address Register advances one location and the "bit counter" increments by one count. This continues until all data bits are transferred from the RAM, at which time the bit counter overflows and ends the transfer process. The Processor Memory sends out a program advance signal and then examines the next Program Control code. This could be another ALU function, for example, or another RAM Address code or a series of these codes that would address individual RAM locations for the purpose of transferring single bits of data.

#### 8-198. Data Entry/Exit

8-199. The next column to be examined is DATA ENTRY/EXIT. This type of word is used when sections of the tester, other than the ALU, require the transfer of serial data to or from the RAM. The code's first three bits (111) specify it as being a DATA ENTRY/EXIT word. The next four bits (Bit numbers 5 through 8) designate the other section of the tester involved in the forthcoming data transfer (the RAM is always one of the two). Table 8-9 shows the octal characters that are found in this portion of the Program Control Word and the corresponding section it represents.

8-200. The last five bits of the word specify the number of serial bits to be transferred. Again, this number is expressed as the complement of the number. Once the Processor Memory has accepted this code (in the same manner as the Logic Function example), a RAM address code is needed to determine the direction of data flow and the starting RAM address.



# Table 8-9. Data Entry/Exit Codes

Code	Data Location
00	Relay
01	Main Memory Advance
02	Data read from eight least significant bits of the Program Control lines
03	I/O Board
10 <sub>8</sub>	Front Panel* (each bit is transferred in order)
11 <sub>8</sub>	Printer
12 <sub>8</sub>	Magnetic Card Reader
13 <sub>8</sub>	Main Memory
148	ROM Address Counter
15 <sub>8</sub>	External Control**
16 <sub>8</sub>	Digital-to-Analog Converter
17 <sub>8</sub>	Pin Driver Board (bit pattern, failure data)
(1) (2) (3) Data (1) (2) (3) (4) (5) (6) (7)	Continue on Fail End on Failure Test Printer
**Exter	rnal Control from the CPU (from the RAM)
20	Record 1 = Read, 0 - Write
21	Load light
22	SRQ – I/O Board
23	Pin Driver on
24	End of Test
25	(Not Used)
26	(Not Used)
. 27	Sort (reject)
Exte	rnal Control to the CPU (to the RAM)
20	Card in
21	MFL (sync)
22	End of Card Record
23	Ready (D/A)
24	Request (printer)



8-201. In this example, as with the Logic Function example, the RAM address word always follows the Logic Function/Arithmetic Computation and Data Entry/Exit words. This is not true of the Special code, found in column 4 of Table 8-8. This code is a no op (no operation) code and performs no actual function. It does not address the RAM Address Register, but it does generate a Program Advance signal to advance the ROM program.

# 8-202. DECODING THE ROM WORDS

8-203. Now that the ROM words have been examined as to their type and function, the following paragraphs will describe the process of decoding the hexadecimal words into 12-bit Program Control words. ROM addresses 6 and 7 will serve as an example for this decoding. Table 8-6 lists these addresses as "6 2C8FIE".

8-204. The decoding process begins by first examining ROM address 6, which contains the word FIE. Referring to Table 8-7, Hexadecimal-to-Binary Conversion, the codes appear as shown below.

8-205. Once the word is converted to this form, Table 8-8 can be used in determining the type of word it is. Notice that the three-most significant bits are all 1's. Locating this in Table 8-8 reveals the word to be a DATA ENTRY/EXIT word.

8-206. The next step is to separate the coded word into sections, as its particular word type demands. In this case

111	1000	11110.
Specifies DATA ENTRY FXIT	Specifies Data Location (108)	Specifies Number of Bits in word in
CATT	(100)	complement form

8-207. The Middle portion of the word is expressed in octal with the first three bits on the right being the LSD. Therefore, this code translates to octal 10. Table 8-9 reveals this Data Location to be the front panel.

8-208. The last step in decoding this word is to examine the last five bits (11110). Table 8-8 points out that this specifies the number of bits in the data word to be transferred and that this information is given in *complement* form. Taking the complement reveals that only one data bit will be transferred:

8-209. Again, an easier method is to consider the zeros to be true. The second part of the transmission information (RAM Address 7) can now be translated. The word in this location is 2C8. This translates as shown.

8-210. A zero in the MSB designates this word as a RAM address code. It can then be sectioned into the particular word-type format, as outlined in Table 8-3.

0	0	1	011001000

8-211. The '0' located in bit 10 specifies that the data bit to be transferred will be inverted in state. The '1' located in bit 9 means the data bit will be written into the RAM. The last step is to decode the RAM address information. The data bit will be written into this location. This conversion appears as follows: 256 128 64 32 16 8 4 2 1 --- weight

0 1 1 0 0 1 0 0 0 --- bit

Therefore, 128 + 64 +8 = RAM Address 200.

8-212. The two words have been combined to give all information necessary for governing the transfer of data. The codes have decreed that one data bit from th front panel is to be written into RAM location 200. Knowing this, Table 8-9 can be referred to, once again, to determine the purpose of the data bit. Noting the asterisk that references "Data from the Front Panel," the transfer of a single bit of data from the front panel means that the bit will be load information. Specifically, "was the LOAD button pushed?" To determine the position of the PRINTER switch, for example, requires transferring seven bits of data; only the seventh bit is of importance. The RAM will store the previous six bits but may later write over that information.

8-213. The tester's ROM sequence and operation is outlined in paragraph 8-149. ROM Mnemonic Code List. Refer to the decimal side of the ROM Address column. The ROM Address 6 line outlines the previous example: front panel data, TO the RAM, take the complement (c) of the transferring data, and place it in RAM location 200 (first or starting address is 200, ending address is 200).

# 8-214. A4 ARITHMETIC/LOGIC UNIT OVERVIEW

8-215. The main purpose of the Arithmetic/Logic Unit board (A4) is to simulate a logic model, as described in the Block Diagram Theory. The simulators, themselves, are actually groups of blocks on the board that may be combined to form a particular function (refer to A4 schematic). The simulators are the ALU (U8) and those groups designated on the schematic: the JK simulator, the 4-16 Line Decoder simulator, etc. The operation involves using a portion of the 12 bit Program Control word (the Op code) to specify the function to be performed (OR, D type F-F, A=B, etc. See Figure 8-13. Once this is determined, serial data is received from the RAM and converted to a parallel format so it can be presented to the inputs of the Model. The results of this operation are then transferred serially back to the RAM (A5) on command.

8-216. The OP CODE-DATA LOC lines entering U22 are also sent to U23. If the lines contain a Data Location code, this code enables one of U23's outputs, provided G1 and G2 are Low. This output enables one of the blocks inside the tester (printer, front panel, etc.) to receive data from the RAM. This particular function is unrelated to the other operations on the ALU board and can be thought of as part of the Processor Memory, A5.

8-217. If the OP CODE-DATA LOC lines entering U22 contain an Op code, then U22 and the encoder gates (U16D, U14A, B, and C, and U13E) present a Select code to the ALU, U8. Once U8 has been coded to perform a function, the data can be placed across the A and B inputs of U8.

8-218. The ALU board accepts the input data on pin 7, the RAM MEM OUT line. The data input control circuit (U11C, U17A, B and U2) controls the loading of data into the Logic Simulation Setup Storage circuit (U3 and U4). This circuit is cleared to '0' prior to use so that only the '1' state data bits change the storage data. The data is not loaded directly into U3 and U4 but, rather, controls whether the devices are preset to accept logic levels from U2. To begin with, U2 is preset such that a '1' is placed on the OA output. Since U17A alternately selects either U10B or U10C to pass the data latched in U11C, then U3(IE) will preset to the same level as the data input. On the next clock pulse, a new bit of '1' state data may be preset into U4(E) in the same manner. (It should be noted that the clock input of U3 and U4 are disabled throughout this process.) After the second clock pulse, the '1' in U2 has shifted to the OD output, which enables the D inputs of U3 and U4 to be preset by incoming data. This process continues until all data is loaded (up to 10 bits) into U3 and U4. The data goes to the different simulators on the board.



8-219. The results of the simulation is fed to the D inputs of U15. When the DATA XFER/LOGIC FUNC line is Low, it enables the STROBE input, which activates the IC. This IC then uses the Op code to select one of the inputs to pass simulator data to U7 where it is shifted back to the RAM on A5.

## 8-220. A5 PROCESSOR MEMORY OVERVIEW

- 8-221. The Processor Memory board contains the 512-bit RAM and its associated Address Register and Word Counter (refer to A5 schematic). Also located on this board are the Constant Converter, the Input Data Selector, and a storage element for the Op Code or Data Location. These blocks operate in accordance with the type of Program Control word placed on Program Control lines, PROG BITS 0-11. The following is a brief statement on each of the schematic blocks.
- **8-222. 512-Bit RAM.** The RAM consists of two Read/Write Memories, U10 and U11. Only one of these memories is addressed at a time. U10 contains locations from 0-255 while U11 covers locations 256-511. Before these memories can be used, PROG BIT 11 must be a "0". This bit is stored in U6A. PROG BIT 8 selects either U10 or U11 for operation, and PROG BIT 9 (through U12) selects the Read or Write mode. Bit 10, stored in U12D(6,12), determines if data into or out of the RAM is to be true or complement.
- **8-223. RAM Address Register.** This register is responsible for addressing the ROM and is formed by U15, U18, and the first bit of U12. The second bit of U12 is an overflow. A new address is loaded into the register when the Q output of U6B is low. Once loaded, the register's address can be incremented by clock pulses. Clocking is controlled by U13A and U13C.
- **8-224.** Word Counter. The Word Counter consists of U16 and the first bit of U9. Loading is enabled by U13B. The number stored in this counter is the complement of the number of bits in the word to be transferred. Counter overflows when all bits have been transferred.
- 8-225. Register/Word Counter Load Control. Depending on the state of the Word Counter, U6B will enable the RAM Address Register to load another address or it will enable U13B to load the Word Counter when the appropriate Program Control word demands this operation.
- 8-226. Program Advance Counter. Under all conditions except a Special code, U1 is loading a binary 15(1111). Whether or not the device outputs a carry to the Program Advance line depends on the output of U2A. With a Constant Code, the device loads a binary 9(1001) one clock pulse after it loads a 15.
- 8-227. Op Code or Data Location Storage. When U13B's output is low, U19 stores either the Op Code or Data Location Code, available on PROG BITS 5-8. This information is fed to A4, as well as being used on A5.
- 8-228. RAM Input Data Selector. The data on the A, B, and Cinput lines can be an Op Code or a Data Location Code. If it is a Data Location code, U13C enables U20 to pass data from the selected data source, through U3A, U4B, and into the RAM. If data is transferred fro the RAM, Program Bits 5 through 8 are used by A4U23 to select the recipient of the data.
- **8-229. Constant Converter.** The Constant Converter, U14, is used when the tester reads the eight least-significant bits from the Program Control lines into RAM storage. This process requires a parallel-to-serial conversion, which U14 provides. Once the 8-bit word is loaded into U14, it is clocked out serially and into the RAM via U7C, U3A, and U4B.

### 8-230. EXAMPLE OF OPERATION

8-231. The following example will outline the Processor Memory's operation with a Data Entry/Exit Code and then a RAM Address code. Refer for a moment to Table 8-8 and note the format

of the Data Entry/Exit word. The first two bits and the High  $\overline{Q}$  output of U6B allow U13B to store the 4-bit Data Location code into U19. The Low output of U13B also loads PROG BITS 0-4 into the Word Counter, U16 and U9. At this time, the Q outputs of U6A and U6B are High and disable the RAM and the LOAD line of the RAM Address Register. The low  $\overline{Q}$  output of the Bit 11 Latch, U6A, disables U13C until the RAM Address Code is presented. When the Data Entry/Exit word is accepted, U13B enables U2A, which allows U1 to output a PROGRAM ADVANCE signal. This is a signal for the program source to present the next Program Control word.

8-232. Once the RAM Address code appears on the Program Control lines, the address (PROG BITS 0-8) is loaded into the RAM Address Register. This is done with the Low Q output of U6B. The same clock pulse that initiates this action also clocks the "0" of PROG BIT 11 onto the Q output of U6A, thus enabling the RAM. If PROG BIT 9 is a "1", it allows data to be written into the RAM by enabling U13A. In this mode, U13C causes U20 to select a data source and transfer the data through U20A, U3A, and the Exclusive OR, U4B. If bit 9 were a "0", the mode would be "read from the RAM". Data would then pass through U2D, U5D, and U5E and out on the RAM MEM OUT line.

8-233. Transferring bits of data, either to or from the RAM, occurs with each clock pulse. These pulses advance both the RAM Address Register and the Word Counter. When in the Write mode, these clock pulses also generate a Read/Write operation on the RAM. After all data bits are transferred, the Word Counter is at a binary 15. This enables U2A, thereby allowing U1 to output a Program Advance.

# 8-234. A6 MAIN MEMORY OVERVIEW

8-235. The Main Memory circuitry is represented on the schematic diagram Figure 8-11. As mentioned in the Block Diagram theory, the Main Memory stores all informatio taken from the magnetic program card. Data enters the memory serially and can be removed serially or in parallel. If removed in parallel, it is in the form of a 12-bit Program Control word and is sent to the Processor Memory board — A5. If removed serially, it is also sent to A5, but it will enter the RAM. During a Logic Model simulation, this memory, not the ROM, has full program control of the tester.

8-236. The actual memory is shown on Sheet 2 of the two schematics representing A6. The top three IC's (U34, 33, and 32) are data switches. Depending on the state of the select line, these IC's transfer a 12-bit word from either the ROM or the Main Memory onto the Program Control lines.

8-237. The middle row of IC's (U36, 26, 19, etc.) are 4-bit Shift Registers that can be loaded with data in two ways: (1) enabled and clocked in a serial mode or (2) enabled and clocked in a parallel mode. These registers never function as anything more than a temporary storage location.

8-238. The bottom row of IC's (U35, 25, 18, etc.) comprise the actual memory. Each IC contains four rows of data with each row being 256 bits long. Data is serially shifted in each row with two clock signals. These clocks are generated on A6 and are shown on Sheet 1. They are basically the same signal but 180° out of phase with one another, hence Ø1 and Ø2. Each clock phase clocks in data.

8-239. A characteristic of the Main Memory is that it is a *dynamic* shift register. This means that once data is stored, the contents of the memory must somehow be changed within a period of time; otherwise, the energy level holding that data bit in memory will decay, and the data will be lost. The memory is changed when Ø1 or Ø2 clock signals occur; however, these signals are not always present. They occur only when the memory is accessed or if new data has not entered within a set period of time (about 0.5 msec). If approximately 0.5 msec elapses with no access of data, the memory goes into a *refresh* mode, which means that the memory shifts itself 256 pieces. This refreshes the memory's energy level and replaces the data to its position prior to the refresh mode.



# 8-240. Loading Data into the Memory

- 8-241. Loading into the memory is done with the help of a circuit (U31 and U22F) shown on the upper right corner of Sheet 1. Recall that when serial data enters the memory, it is in the form of two 12-bit words. This data comes from the RAM and enters A6 on pin 7. The two AND gates of U31 are alternately clocked to pass data from both the RAM MEM OUT line and the Qc output of U17 (Sheet 2). These alternate bits of data enter pin 1 of U36 and are shifted through the middle row of shift registers at twice the rate as data input on the board. After the first 12 bits of data are entered, they appear on the QA and QC outputs of each IC, with the QB and QD outputs holding whatever was being shifted out of U17(11).
- 8-242. The next 12 bits, the second word, is now entered in the same manner: one bit of RAM data then one bit of data from U17(11). This time, however, data from U17(11) will be the first 12-bit data word previously entered. After the second 12 bits are entered, the loading operation is complete. The first word appears on the QA and QC outputs and the second words appears on the QB and QD outputs. (Note the connections to the switching IC's.)
- 8-243. The outputs of the 4-bit shift registers connect to the inputs of the memory shift registers. This data is now loaded into memory with each phase of the two-phase clock.
- 8-244. When memory data is to be passed onto the Program Control lines, the data to be transferred (both 12-bit words) appears on the memory's output lines. It is then parallel loaded into the middle row of shift registers. The 12-bit word on the QB and QD outputs pass through the switches and onto the Program Control lines. Then a *shift-right* operation is performed on the register and the second 12-bit word is read out.
- 8-245. The circuitry represented on Sheet 1 controls the Main Memory's operation. For example, U1 and U2 are presettable binary counters and are used to regulate the 256-bit cycle when the Main Memory is in the refresh mode. Although the counter does not keep track of memory locations during normal data transfer, it can be used to advance the program by N bits. This information is inserted into the Dp input of U1 in a serial manner (8 parallel load operation) and is the complement of the number of bits to be advanced.
- 8-246. When the memory outputs its Setup Data, it is a continuous process and the refresh mode is not needed. Should the memory stop outputting, e.g., if a failure is detected in the Hold on Fail/Step mode, then the refresh mode is necessary.
- 8-247. Assume that the memory has stopped outputting data but the Refresh One-Shot, U12, has not yet timed out. At this point, the outputs of the Main Memory Advance Counter, U1 and U2, are sitting at all one's, including the Carry Output.
- 8-248. The next clock pulse does not clock the counter, because the High on U3B(5) causes U11B to disable the counter. However, because the Refresh One-Shot has not yet timed out, U29A(2) will be High, and this clock pulse will cause U29A to set. This places a High on U11B(5), which keeps the counter disabled through subsequent clock pulses, until the one-shot times out. When this occurs, U29A switches state on the next clock pulse and allows the countr to function, once again. The first clock pulse into the counter sets the carry output Low, which results in clearing U29.
- 8-249. As the counter is being stepped through the counts in the refresh mode, or any other mode, U3B continues to toggle with the clock pulses. This alternately enables and disables the counter. This allows the counter, which is clocked up with 8 MHz, to follow the Main Memory at 4 MHz. This process continues until U1's Carry Output goes high, once again. This removes the Low on U29A(1) and allows the next clock pulse to set the counter with the High on the D input.

8-250. Other elements on Sheet 1 are U27A and B, U29A, and U12, which control the refresh mode. U12 is a retriggerable one-shot. The Q output of the one-shot stays Low as long as it is being triggered by the two gated clock signals. Once these signals stop, the one-shot will time out 0.5 mS later and the refresh operation will begin.

8-251. The Main Memory's phase 1 and phase 2 clock signals are generated by U5A and B, Q1, Q2, and U6. These devices are controlled by U13A. The circuitry to the left of the clock generators are associated with generating the mode control (serial or parallel operation of the Main Memory) and the two clocks for the 24-bit shift register. It is also used for multiplexing the data in and out of the memory.

8-252. U28B prevents the ROM or Main Memory from outputting data onto the Program Control bus. When U28A is clocked, it latches a data bit that indicates whether the program source is the ROM (Q=H) or the Main Memory (Q=L). U29B passes serial data from the Main Memory to the RAM on A5. Since the data is staggered in the memory, the operation for removing it is similar to that of entering it. The data is shifted through the shift register twice. One 12-bit word is read out on the first pass while the second word is temporarily ignored. On the second shift through the shift register, the second 12-bit word is read out.

# 8-253. A7 I/O BOARD BLOCK DIAGRAM THEORY OF OPERATION

8-254. The A7 I/O board (Figure 8-14) is used to interface, control, and format the data exchanged between the HP 9825A Desk Top Computer and the HP 5045A Digital IC Tester.

8-255. The A7 provides a standard HP-IB interface for these units. After the standard HP-IB handshake routine establishes that the 5045A is to receive (LISTEN mode) or send (TALK mode) data to or from the 9825A, the A7 I/O board accepts the data from the initiating unit and formats the data for use by the receiving unit.

### 8-256. LISTEN Mode

8-257. When the A7 I/O board is in the LISTEN mode of operation data is being received from the 9825A and transmitted to the 5045A. A typical sequence of operation is as follows:

- a. The information is loaded in from the HP-IB bus by specifying the letter "I" which initializes the address counter.
- b. The data is then loaded into the Program Buffer Memory.
- c. The Run Flip-Flop is then set by specifying the letter "R" and the data stored in the Program Buffer Memory is transferred to the 5045A Digital IC Tester.

## 8-258. TALK Mode

8-259. The sequence of operation for transferring data from the 5045A to the 9825A requires that a program first be loaded from the 9825A during the listen mode that will generate the data that is to be transferred back to the 9825A. The data generated by the 5045A is then transferred via the serial-to-parallel converter and data selector to the Data Buffer or return address storage. When the A7 I/O board is set to the talk mode, this data is automatically transferred to the 9825A.

# 8-260. A8 PROM BOARD OVERVIEW

8-261. The PROM (programmable read only memory) board contains 36, 864 bits of fixed information arranged in 3072, 12-bit words (refer to A8 schematic). This memory stores the tester's basic operating routine. See Tables 8-6 and 8-7 of the information in hexadecimal and mnemonic operator form. The board is controlled by the 12 ROM ADD lines, the I/O ADDRESS line, and the ROM ADD CNTR XFER EN line. The three most-significant bits of the address lines are decoded in U23, which enables one set of three ROM's (along the horizontal plane of the schematic).

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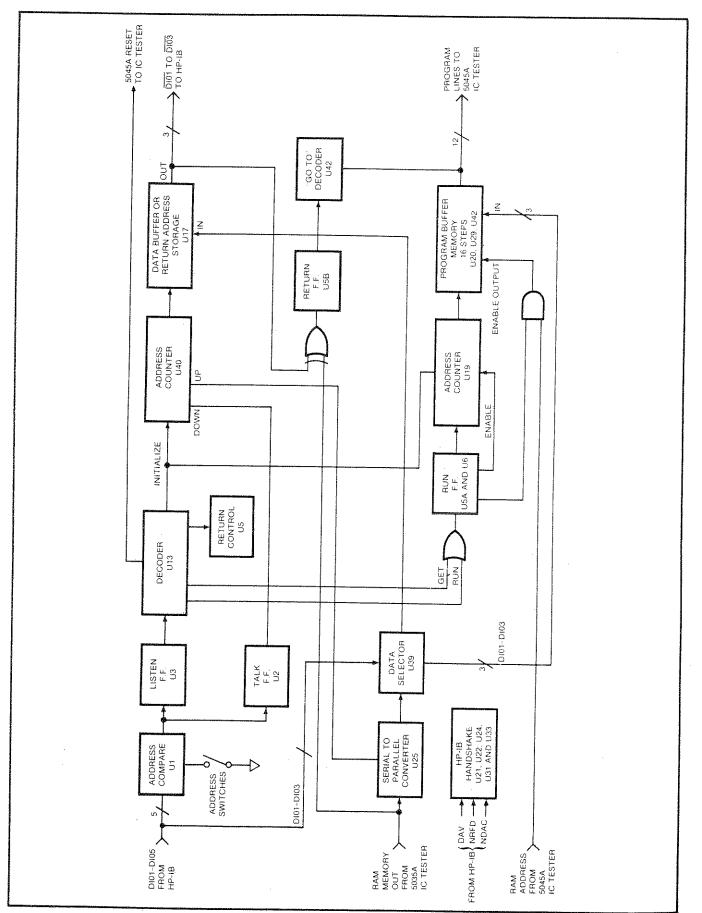
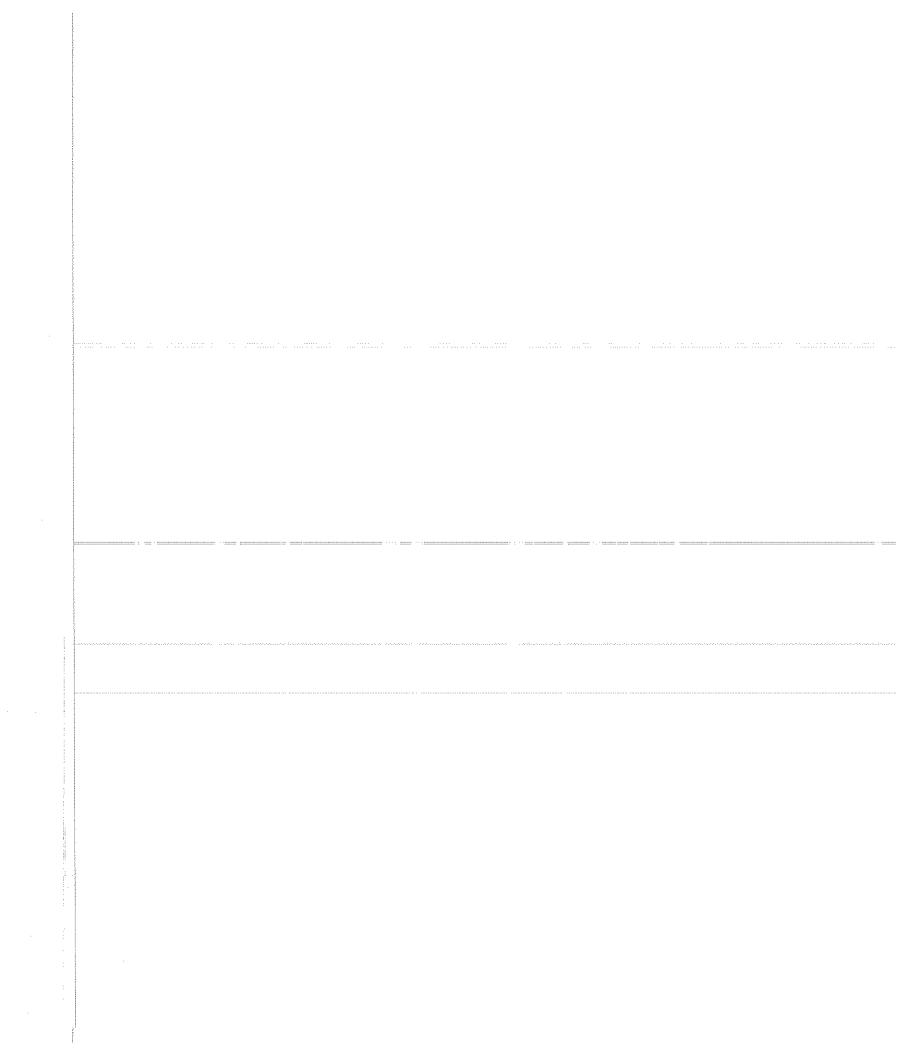


Figure 8-14. A7 I/O Board Block Diagram

- 8-262. Once a three-ROM set is enabled by U23, ROM ADD lines 2-256 drive the "A' inputs on the three devices, thereby, addressing a specific location within each ROM. The "0" outputs of the ROM's present their stored data to the output multiplexers, U8, U16, and U24. Each multiplexer will accept only four of the ROM's eight output lines at a time, as determined by the ROM ADD 1 line, which feeds the selected inputs. When the select input is a logical '0', the multiplexers select the first word, and select the second word with a logical "1". The selected bits exit the multiplexers as 12-bit Program Control words.
- 8-263. When appropriate, U7A and B and U15B act to force a logical "1" in Bit 11 of the Program Control word. This forces the Processor Memory (A5) to interpret any instruction on the lines as Data Entry/Exit or Logic Function/Computation rather than a RAM Address code.
- 8-264. The I/O ADDRESS line inhibits U8, U16, and U24 when ROM addresses 0-15 are selected and the RUN I/O PROG (A9) lines are both active.

## 8-265. A9 ADDRESS BOARD OVERVIEW

- 8-266. The primary function of this board is set up ROM addresses. The ROM Address Register is comprised of U17, U20, and U12 (refer to A9 schematic). The register outputs a binary weighted, 12-bit ROM address code, which goes directly to the ROM board, A8. Under normal operation, the register's code increments with each gated clock pulse in a binary fashion. The PROGRAM ADVANCE line goes High for one clock pulse after the Data Location code is entered and again after the data is actually transferred (following the RAM Address code). If the address is to be changed by many counts, e.g., in a "GO TO" statement, the counter is preset with new address. This is done by pulling the register's LOAD inputs Low while the PROGRAM ADVANCE line is low and clocking in the new address code, which is presented serially on the RAM MEM OUT line. Notice that this line goes to the Dp input of U12. Once the first bit of the new code is clocked in, it is presented on the Qp input. Following this output shows that is is connected to the Dc input. On the next clock pulse, then, the bit that was clocked in first will appear on the Qc output while the second bit appears on the Qp output. This left-shift technique continues until all 12-bits are entered when the ROM ADD CNTR XFER EN line goes High. The last bit entered is the most-significant bit.
- 8-267. Anytime the address is not being loaded and the QC and QD outputs are High, gate U4A is enabled and allows the multiplexers on A6 to select the Main Memory as the program source. Otherwise, the ROM functions as the program source. However, any time the ROM Address Register is being loaded with a new address (either advance or transfer), U2D is enabled and the resultant Low on the INHIBIT READ PROG line disables the A6 multiplexers from passing any data.
- 8-268. U5A, in the lower left corner of the schematic, generates the 8 MHz clock signal. U2A ANDs 4 and 8 MHz to give a 4 MHz signal with narrow pulses. This signal indirectly clocks the ROM Address Register. U15B divides the signal by two to provide a 4 MH signal. When the Main Memory is being accessed, it uses the 8 MHz signal; when it is being refreshed it uses the 8 MHz signal. U9A controls whether U11 passes the 8 or 4 MHz signal onto the MEM CLOCK line. U3A is also gated by U7B to pass the 4 MHz clock signal out to all boards except the pin drivers. This is the main data transfer clock.
- 8-269. When the instrument is first turned on, it is necessary to preset several circuits within the tester to some initial point, e.g., the ROM Address Register is reset to zero. The circuit that does this is R10 and C4, Q1, U10B, U16B, and their associated components. When the instrument first turns on, C4 conducts current rapidly and appears as a short to ground. This keeps Q1 turned off and allows U10B to clear U16B. The resultant High on the  $\overline{Q}$  output pulls the  $\overline{RESET}$  line Low through inverter U3B. Once C4 charges positive enough to turn on Q1, the inverter releases the Low on the CLR line. The D Flip-Flop sets on the next clock pulse, as a result of U1C(8) being High.



8-270. When the Program Control Lines contain a Data Entry/Exit Code that has a Data Location code of 158, it causes A4U23 to pull the EXT CNTL XFER EN line Low. This line disables U4B and causes U21 to perform a paralle load of control lines states available on its inputs. The state of these lines indicate the condition of certain peripheral circuits that are external to the CPU. Once the states are loaded, they can be clocked out serially to the A5 board, where the data bit will be placed in the RAM.

8-271. U13 (External Clock Input) is a serial shift register that accepts data from the RAM on the RAM MEM OUT line. Once the data is fully loaded into this shift register, it is clocked into U18, a buffer/latch device. This second device prevents data from rippling across the output lines as it is being clocked into storage. Once the data is shifted into U18, it is fed out as control lines for other circuits throughout the instrument.

### 8-272. A10 D/A AND PIN DRIVER CONTROL OVERVIEW

8-273. The main function of this board is to store the pin driver voltage and current information. This data is fed to the D/A converter, where it is strobed out to the appropriate pin drivers.

8-274. The Reference Level Storage circuitry is comprised of U6 and U12, which form a 2K shift-register memory (two parallel 1K memories). U18 controls the encoding and decoding of the information. To store data into the memory, the Processor Memory (A5) outputs this data serially to the serial input of U18. It then exits this device on the Qc and Qp outputs, which are connected to the Da inputs on U6 and U12. The data enters the memory in a staggered format, much like the Main Memory. When information is later removed from the memory, it exits on the Qc outputs and is parallel loaded into the Da and DB inputs of U18 via U5A and B. For the VI printout, data can be read out of the memory to the A5 board through U23B, U13F.

8-275. The memory runs at a slower rate than does the information being fed into it: U18 is clocked at a 4 MHz rate while the memory runs at 2 MHz. Actually, there are two clock signals that operate the register (Ø1 and Ø2). Each of these signals are 1 MHz and are out of phase with each other. The phases of the clock are generated by U7B, U11, and the outputs of U1 (QB) and U3 (QA). The signals are then level shifted by RC circuitry R30, R33, C6, C8, R19, CR3 and CR2 (clamps). When data is being read from the memory, U18 is in the parallel mode and the parallel clock used is 2 MHz (from U1 QA).

8-276. The Reference Level Storage has space available for 80 bits of information per pin. There are 24 valid pins plus one extra pin that is set aside as a "sratch pad"; in addition, there are some extra locations that are not used. Table 8-10 shows the data configuration for a given pin. U1, U2, and U3 form a Stack Counter which keeps track of the information in the memory. Although the memory is not regulated by specific locations, or addresses, the position of the data is known by knowing the total number of available locations and by selecting an arbitrary starting point and keeping track of that point. This starting point is defined by the overflow of U2. Notice that an overflow condition (U2 pin 15 goes High) causes U15B to preset the Stack Counter to a predetermined number (506). This absorbs the extra capacity of the counter which is not needed in this specific application. U1 is a decade counter, while U3 and U2 are binary counters. Starting at the left, then, and working across, the D inputs are weighted as follows: 1, 2, 4, 8 (but counts to 10 only) 10, 20, 40, 80, and 160, 320, 640, 1280.

8-277. A second counting circuit Pin Locator Counter is needed to assign groups of bits inside U6 and U12 as those pertaining to a specific pin number. This is done in U1, U4, and U17. U17 and DD input of U4 comprise the Pin Number Locator. By loading the complement (plus one) of the pin number into this counter, the counter will overflow after it has been clocked by the same number of pulses as represents the pin number (e.g., pin 12 would require 11 clock pulses into U4D and U17 to produce an overflow). Since each pin represents 80 bits of data location in the memory, the Pin Number Locator must advance one pin number for every 80 clock pulses

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because these pulses are also advancing the Memory and the Stack Counter. U1 provides a  $\div$ 10 circuit and the first three bits of U4 provide a  $\div$ 8 circuit, together they form a  $\div$ 80 prescaler for the Pin Driver Locator.

8-278. An example of the entire sequence would be as follows. First, the pin number data (in complement form plus one) is loaded from the Processor Memory (A5) into the Pin Number Locator circuit. This is done by enabling U9C via the D/A XFER EN line. The circuit is disabled from counting, however, due to the states of U16A and U22C. The circuit remains disabled until the Stack Counter overflows at U2(15), which signals the reference point. U16A and U22C release the disable level and all three circuits (Stack Counter, Pin Number Locator, and Reference Level Storage) begin counting. After 80 clock pulses pass, the Pin Number Locator is clocked once and the Reference Level Storage is at the beginning of the pin 2 data group. When U17 reaches the desired pin number, the counter overflows and outputs a READY FOR SETUP DATA signal. When the CPU is ready to input the setup data, it sets the DA XFER EN line Low, once again. This results in U9B(6) going Low, which clears U4 and U17 and enables U18 to accept serial data from the RAM. This setup data is stagger-loaded into the memory, U6 and U12.

Table 8-10. Setup Data Configuration	Table 8-10.	Setup	Data	Configur	ation
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Bit No.	1st Group -1 Source	2nd Group -V Source	3rd Group +1 Source	4th Group +V Source
1	1 (MSB)	1 (MSB)	1 (MSB)	1 (MSB)
2	2	2	2	2
3	3	3	3	3
4	4	4	4	4
5	5	5	5	5
6	6	6	6	6
7	7 .	7	7	7
8	8	8	8	8
9	9	9	9	9
10	10	10	10	10
11	11	11	11	11
12	12 (LSB)	12 (LSB)	12 (LSB)	12 (LSB)
13	рí	Ø	J k	В
14	₽,	R	l P	Ь
15	-Gen Continuous	R	, p	l k
16	-Gen Hi/Lo I	Ø	l k	þ
17	Input	b	b	k
18	+Gen Continuous	b	k	b.
19	+Gen Hi/Lo I	b	l b	p
20	Ø	Ø	l k	Ь

8-279. Once setup data has been loaded for all pins, the data can be placed on the bus and strobed into the appropriate circuits. Refer once again to Table 8-10. The first 12 bits under each category of information (-I, -V, +I, +V) is the actual Setup Data word. This word enters the Digital-to-Analog Converter (DAC) on A11 and is converted to an analog level that will ultimately setup the value of a voltage or current source of a pin driver. This data leaves the board on pin 18 through 21 in the following manner: the first four most-significant bits enter the DAC in parallel, followed by the remaining eight bits which are sent in four 2-bit parallel transfers on the DELAYED 1 and DELAYED 2 lines. The remaining five bits of data (-Gen Continuous, etc.) are then clocked into U19 and are clocked into U24 after the three remaining reference levels are set up and as they transfer to the pin driver.

### 8-280. A11 REFERENCE LEVEL GENERATOR OVERVIEW

8-281. This board generates the reference voltages for the plus and minus voltage sources and the plus and minus current sources, located on the pin driver boards. (Refer to A11 schematic.) The board accepts four separate groups of digital data, each of which sets up a reference generator on this board. In order: —I, -V, +I, +V. The four reference voltages are fed onto a four-line bus that goes to all 12 pin driver boards. The reference generators are loaded twice for each pin drivers per board. The pin drivers are loaded sequentially, starting with A13 and ending with A24. This sequence is controlled by the outputs of U25A&B and U24B, which enable the specific pin driver board along with the odd pin and even pin strobe lines, which enable the specific pin drivers. As one set of voltages is being strobed out, another group of data is being converted into an analog level. This keeps the time between groups as short as possible. It also requires only one D/A converter; however, this system calls for two stages of sample and hold circuits.

8-282. The four most-significant bits of data are parallel loaded into U16A&B and U22A&B. The remaining eight bits of the data group are parallel loaded two bits at a time into shift registers U30A&B. The MSB is the sign bit (+ or -), while the remaining 10 bits determine the magnitude. The state of the LSB (available at U30A pin 13) controls some switching circuits, which are described later.

8-283. The outputs of the data latches are fed through buffers U23 and U29 and into a resistor ladder network contained in R76. The summation of this information is presented to one side of op amp U5, while U6 provides a 10.3V reference (3.4V at U5 pin 3) to the other side. The output level of U5 can now be entered into the first sample and hold circuit of the -I reference generator. This is done by holding the STROBE SETUP VOLTAGE High while pulsing the CLOCK 1 line at the same time. This places a High on U19A Q and enables the electronic switch, U21B, to pass the -I reference level from U5, through the buffer amps U20 and U21B where it charges the storage capacitor, C18.

8-284. Once this is done, the other storage capacitors in the remaining reference generators are set up in a like manner. The latches (U16A&B, U22A&B, and U30A&B) accept the next group of data and convert it into an analog level. The STROBE SETUP VOLTAGE line is set low and remains Low for the next three clock pulses of the LOCK 1 line (one clock pulse for each data group). The second clock pulse, then, will cause U19A  $\overline{Q}$  to go Low, but before that can happen, this same clock pulse clocks the High present on U19A  $\overline{Q}$  into the D input of U24A. This turns off Q2 and turns on switch U21D, which allows the -V level from U5 to charge C8. The third clock pulse causes U24A pin 12 to go High, which sets up the +I reference generator by enabling U21C and charging C16. The fourth clock pulse causes U24A pin 11 to go High; this turns off Q4 and sets up the +V reference generator by enabling U15D and charging C7.

8-285. The same line that enables the electronic switch U15D at pin 12 also enables, at the same time, switches U15C, U15B, and U15A, which allow the capacitors in the second sample and hold circuits to be charged; these are, respectively, C13, C9, and C29. During the time each group of data bits was being clocked into the first-stage storage capacitors, the least-significant bit of each group, available at U30A pin 13, was being inverted in Q13 and clocked in shift register U27. At the end of the third clock pulse, the least-significant bit of each of the first three groups is present on the outputs of U27. The LSB of the fourth group is present on the D input of U10A. These four bits are used to select the high or low operating range of the reference generators. When the fourth clock arrives, it enables the range selecting devices and also places the reference levels onto the bus. The setup of each generator is individually described below.

8-286. - I Reference Generator — U9A passes the level of U27 Qc onto range capacitor C26, which enables or disables the range switch U9C.

8-287. +1 Reference Generator — U9B passes the level of U27 QA onto range capacitor C25, which enables or disables the range switch U9D.

8-288. -V Reference Generator — The QB output of U27 is present on the D input of U10B. When fourth clock plse occurs, it clocks this level onto the Q output. The outputs of U10B turn on one of the range switches — U17C (low range) or U17B (high range). This same clock pulse also turns Q6 on and allows U8 to charge the secondary storage capacitor, C3.

8-289. +V Reference Generator — The LSB of the fourth group is present on the D input of U10A. When the fourth clock pulse occurs, it causes U24 QD to go High, and this clocks the level onto the Q output. The outputs of U10A turn on one of the range switches — U17D (low range) or U17A (high range). This same clock pulse also turns Q1 on and allows U7 to charge the secondary storage capacitor, C2.

#### 8-290. A12 PIN DRIVER CONTROL OVERVIEW

8-291. This board controls several of the operations that are necessary just prior to testing of a device and, also, once the testing has started. The board supplies the '1' and '0' state setup data to the pin driver boards (A13-A24) and controls the strobing of that information onto boards. It also controls the fast edge circuitry on the socket driver assembles and the relay operation of the socket assembly. Finally, the A12 board examines the failure data returning from the pin driver boards to determine whether or not the device passed the test. (Refer to the A12 schematic.)

8-292. The six lines located at the upper right of the schematic control the strobing of information onto the pin driver boards. These are the TEST PATTERN/FAILURE STROBE lines and only one line is active at a time. They are driven by the 4-10 line decoder, U18, which is controlled by the DATA SHIFT BIT 2— lines. These lines are directly received from the Word Counter on the Processor Memory board, A5. As the '1' and '0' state setup bits serially enter U11, four bits at a time, the Word Counter on A5 increments its count as each bit is transferred, but U18 does not change state. The timing of the this circuit is as follows. On the first clock pulse into U13A, the DATA SHIFT BIT lines 20 and 21 go high. On the fourth clock pulse, all three inputs to U13A are low. This disables U13B and places a High on the D input of U18. Since this device is a 4 to 10 line decoder the D input enables one of the upper two output lines, which are not used. This effectively disables the lower half of the device. At this time, the next four bits of '1' and '0' setup data are sitting on the outputs of U5 and are now clocked into U5 where they are presented to the pin drivers. The next clock pulse increments the three most significant DATA SHIFT BIT lines and, once again, enables U13B, which returns control to the lower half of U18. This process continues until all pin drivers are loaded with '1' and '0' setup data.

8-293. When the test is initiated, a particular group of information is to be loaded in the Read/Write Memory, U2 when the test is initiated. This data designates which pairs of the device under test are inputs and which are outputs. This information is important because when testing begins, it will cause the fast edge circuits to generate a fast rise time when driving an input pin. In the case of an output pin, the fast edge circuits are not used and the output stage of the device, itself, controls the rise time. The data enters the board serially from the Processor Memory, A5, and is loaded into the DA input of U6. There are six bits needed for each pin number. These bits continue being loaded into U6 and are shift-load, as a string, into U7. When all six bits are entered, the last bit entered appears on the QA output of U6 and is used as a select line for the multiplier, U1. The first bit entered appears on the QB output of U6 and is fed through U1 and is presented to either the DA or DB input of U2. The remaining four bit are present on the output lines of U7 and serve as address lines for U2. Once each group of bits has been setup, as described, the write enable (WE) input of U2 goes Low to store this data in a particular address of the memory.

8-294. After all the '1' and '0' state setup voltages are strobed into the pin drivers, pin 9 of U18 goes Low and resets the counter assembly of U7 and U6. Just prior to each test, clock pulses begin incrementing this counter. The outputs address the memory and pass the fast-edge data through the multiplexer and to the fast-edge circuits via U3D.



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8-295. The A12 board also examines the failure data from the pin drivers. These line comparators of U15, U19, U16, and U20 and the levels are compared to a reference. T of the comparators are parallel loaded into U11. They are then right-shifted one bit at a tit to the clear (CLR) input of U10. If this line is High, it is interpreted as a failure; however, are examined for a failure during the test. The Processor Memory, then supplies data to designates whether or not a particular pin should be examined for failure data. This is acc on the D input of U10. If pin 12 is High, the tester will examine the pin for failure data state is then clocked into U10, unless the CLR input is being held Low, and is available output. The state of the Q output is the failure information: '1' = failure, '0' = no

8-296. At the beginning of the test, the Processor Memory, A5, is sending relay data to board via U3C and U3B. This data governs the closure of these relays. When closed, provide a ground for a particular pin on the device under test that is very near the pin. Th problems associated with long ground lines.

### 8-297. A13-A24 PIN DRIVER OVERVIEW

8-298. The Pin Driver board contains 5 major blocks of circuitry, as shown in the A13-A2 tic diagram. The first four are the positive current source, the "1" voltage source, the source, and the negative current source. The fifth block is the Gating Circuitry that correference level generators' operation. These generators are configured to either drive aran input or load and monitor an output of the device under test (DUT):

8-299. Electronic switches, control gates, and diodes control the various functions generators. (This is represented in a simplified drawing of the generators, Figure 8-15, sh "1" and "0" voltage sources, with the current sources being listed as either +I or -I

8-300. The four reference lines from the Reference Level Generators (A11) are strobed Pin Driver board through electronic switches. Storage capacitors hold these reference noninverting input (+) of each operational amplifier (op amp). The inverting side (-) of this the sense side and monitors the same pin on the device under test as the pin driver indive.

8-301. As an example of driving an input, if the reference level and the sense level are amplifier is balanced and no failure data is generated. If they differ, the voltage source op into saturation and activates the failure line ('1' voltage source shows failure when it goe '0' voltage source shows failure when it goes negative). When a source is not being acti the gates and switches are arranged to balance the op amp.

8-302. Each current source has 3 CMOS gates that are drawn as negative input AND g one of these gates is enabled at a time, as controlled by the Gating Circuitry. When enabl amp output is transferred from the gate's VDD input (for the negative current source) to pin where it controls the current-pass transistor. Two of the gates select either the hij current mode (Low =  $5 \mu A - 2.5 mA$ , High = 2.5 mA - 200 mA), and the third gate routes th output onto the sense line when that current generator is not being used to drive the

8-303. The two voltage sources operate in much the same manner as the current source cuit operation relies on a balanced op amp, which controls the drive voltage through a E transistor pair. When not actively used, the op amp remains balanced through an electror The RC time constant circuit ensures that the feedback switch and shunt switch are not on time during the transition. This ensures that the op amp has a feedback path while the changing.

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